SAR Test Report

For

Applicant Name:	**Xwireless LLC**
Address:	11565 Old Georgetown Road, Rockville, MD, USA
EUT Name:	Mobile Phone
Brand Name:	Vortex
Model Number:	PG65

Issued By

Company Name:	**BTF Testing Lab (Shenzhen) Co., Ltd.**
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Report Number:	BTF240520R00301
Test Standards:	FCC 47 CFR§2.1093 IEC/IEEE 62209-1528: 2020 IEEE C95.1-2019 KDB447498 D04 KDB865664 D01 KDB865664 D02 KDB941225 D01 KDB941225 D05 KDB248227 D01 KDB941225 D06 KDB648474 D04 KDB690783 D01
FCC ID:	2ADLJ-PG65
Test Conclusion:	Pass
Test Date:	2024-05-31 to 2024-06-11
Date of Issue:	2024-06-11
Prepared By:	Amenda Zhong / Project Engineer
Date:	2024-06-11
Approved By:	Ryan.CJ / EMC Manager
Date:	2024-06-11

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Revision History		
Version	Issue Date	Revisions Content
R_V0	2024-06-11	Original
Note:	*Once the revision has been made, then previous versions reports are invalid.*	

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Table of Contents

1. Introduction 4
1.1 Identification of Testing Laboratory 4
1.2 Identification of the Responsible Testing Location 4
1.3 Laboratory Condition 4
1.4 Announcement 4
2. Product Information 5
2.1 Application Information 5
2.2 Manufacturer Information 5
2.3 Factory Information 5
2.4 General Description of Equipment under Test (EUT) 5
2.5 Equipment under Test Ancillary Equipment 5
2.6 Technical Information 5
3. Summary of Test Results 7
3.1 Test Standards 7
3.2 Device Category and SAR Limit 7
3.3 Test Result Summary 8
3.4 Test Uncertainty 9
4. Measurement System 11
4.1 Specific Absorption Rate (SAR) Definition 11
4.2 MVG SAR System 11
5. System Verification 16
5.1 Purpose of System Check 16
5.2 System Check Setup 16
6. TEST POSITION CONFIGURATIONS 17
6.1 Head Exposure Conditions 17
6.2 Body-worn Position Conditions 22
6.3 Hotspot Mode Exposure Position Conditions 23
6.4 Product Specific 10g Exposure Consideration 23
7. Measurement Procedure 24
7.1 Measurement Process Diagram 24
7.2 SAR Scan General Requirement 25
7.3 Measurement Procedure 26
7.4 Area & Zoom Scan Procedure 26
8. Conducted RF Output Power 27
8.1 GSM 27
8.2 WCDMA 28
8.3 LTE 29
8.4 Wi-Fi 46
8.5 Bluetooth 47
9. Test Exclusion Consideration 48
9.1 SAR Test Exclusion Consideration Table 48
10. Test Result 49
11. SAR Measurement Variability 57
12. Simultaneous Transmission 58
12.1 Simultaneous Transmission Mode Considerations 58
12.2 Sum SAR of Simultaneous Transmission 58
13. Test Equipment List 59
ANNEX A Simulating Liquid Verification Result 60
ANNEX B System Check Result 60
ANNEX C SAR Dipole Calibrations 61
ANNEX D Test Data 80
ANNEX E SAR Test Setup Photos 158
ANNEX F EUT External and Internal Photos 160
ANNEX G Calibration Information 160

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1. Introduction

1.1 Identification of Testing Laboratory

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Phone Number:	+86-0755-23146130
Fax Number:	+86-0755-23146130

1.2 Identification of the Responsible Testing Location

Test Location:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Description:	All measurement facilities used to collect the measurement data are located at F101,201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
FCC Registration Number	518915
Designation Number	CN1330

1.3 Laboratory Condition

Ambient Temperature:	21℃ to 25℃
Ambient Relative Humidity:	48% to 59%
Ambient Pressure:	100 kPa to 102 kPa

1.4 Announcement

(1) The test report reference to the report template version v0.

(2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.

(3) The test report is invalid if there is any evidence and/or falsification.

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2. Product Information

2.1 Application Information

Company Name:	Xwireless LLC
Address:	11565 Old Georgetown Road, Rockville, MD, USA

2.2 Manufacturer Information

Company Name:	Xwireless LLC
Address:	11565 Old Georgetown Road, Rockville, MD, USA

2.3 Factory Information

Company Name:	HUAYUESHITONG SOFTWARE TECHNOLOGY CO., LIMITED
Address:	Room 703-704, Building B, Phase 1, Wanke Yuncheng Innovation Valley, Xili S treet, Nanshan District, Shenzhen

2.4 General Description of Equipment under Test (EUT)

EUT Name	Mobile Phone
Under Test Model Name	PG65
Sample No.	BTFSN240520014/6 E1-E6

2.5 Equipment under Test Ancillary Equipment

Ancillary Equipment 1	Rechargeable Battery	
	Capacity	3000mAh
	Rated Voltage	3.8V

2.6 Technical Information

Network and Wireless connectivity	2G Network GSM/GPRS/EGPRS 850/1900 3G Network WCDMA/HSDPA/HSUPA Band 2/4/5 4G Network FDD LTE Band 2/4/5/12/13/25/26/66/71 TDD LTE Band 41 2.4G WIFI 802.11b, 802.11g, 802.11n(HT20/40) 5G WIFI 802.11a, 802.11n(HT20/40), 802.11ac(VHT20/40/80) BT (EDR+BLE)

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The requirement for the following technical information of the EUT was tested in this report:

Operating Mode	GSM, WCDMA, LTE, WLAN, Bluetooth		
Frequency Range	GSM 850	TX: 824 ~ 849 MHz	RX: 869 ~ 894 MHz
	GSM 1900	TX: 1850 ~ 1910 MHz	RX: 1930 ~ 1990 MHz
	WCDMA Band 2	TX: 1850 ~ 1910 MHz	RX: 1930 ~ 1990 MHz
	WCDMA Band 4	TX: 1710 ~ 1755 MHz	RX: 2110 ~ 2155 MHz
	WCDMA Band 5	TX: 824 ~ 849 MHz	RX: 869 ~ 894 MHz
	LTE Band 2	TX: 1850 ~ 1910 MHz	RX: 1930 ~ 1990 MHz
	LTE Band 4	TX: 1710 ~ 1755 MHz	RX: 2110 ~ 2155 MHz
	LTE Band 5	TX: 824 ~ 849 MHz	RX: 869 ~ 894 MHz
	LTE Band 12	TX: 698 ~ 716 MHz	RX: 728 ~ 746 MHz
	LTE Band 13	TX: 777 ~ 787 MHz	RX: 746 ~ 756 MHz
	LTE Band 25	TX: 1850 ~ 1915 MHz	RX: 1930 ~ 1995 MHz
	LTE Band 26 part 90	TX: 814.7 ~ 823.3 MHz	RX: 859.7 ~ 868.3 MHz
	LTE Band 26 part 22	TX: 824.7 ~ 848.3 MHz	RX: 869.7 ~ 893.3 MHz
	LTE Band 66	TX: 1710 ~ 1780 MHz	RX: 2110 ~ 2200 MHz
	LTE Band 71	TX: 663 ~ 698 MHz	RX: 617 ~ 652 MHz
	LTE Band 41	2496 ~ 2690 MHz	
	802.11b/g/n(HT20)	2412 ~ 2462 MHz	
	802.11n(HT40)	2422 ~ 2452 MHz	
	802.11a /802.11n(HT20/40) /802.11ac(VHT20/40/80)	5150 ~ 5250 MHz 5725 ~ 5850 MHz	
	Bluetooth	2402 ~ 2480 MHz	
Antenna Type	WWAN: PIFA Antenna WLAN: PIFA Antenna BT: PIFA Antenna		
Hotspot Function	Support		
Power Reduction	Not Support		
Exposure Category	General Population/Uncontrolled exposure		
EUT Stage	Portable Device		
Product	Type		
	☐ Production unit	☒ Identical prototype	

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3. Summary of Test Results

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 2.1093	Radiofrequency radiation exposure evaluation: portable devices
2	IEC/IEEE 62209-1528: 2020	Measurement procedure for the assessment of specific absorption rate of human exposure to radio frequency fields from hand-held and body-mounted wireless communication devices - Part 1528: Human models, instrumentation, and procedures (Frequency range of 4 MHz to 10 GHz)
3	IEEE C95.1-2019	IEEE Standard for Safety Levels with Respect to Human Exposure to Electric, Magnetic, and Electromagnetic Fields, 0 Hz to 300 GHz
4	KDB447498 D04	Interim General RF Exposure Guidance v01
5	KDB865664 D01	SAR measurement 100MHz to 6GHz v01r04
6	KDB865664 D02	RF Exposure Reporting v01r02
7	KDB941225 D01	3G SAR Procedures v03r01
8	KDB941225 D05	SAR for LTE Devices v02r05
9	KDB248227 D01	802.11 Wi-Fi SAR v02r02
10	KDB941225 D06	Hotspot Mode v02r01
11	KDB648474 D04	Handset SAR v01r03
12	KDB690783 D01	SAR Listings on Grant v01r03

3.2 Device Category and SAR Limit

This device belongs to portable device category because its radiating structure is allowed to be used within 20 centimeters of the body of the user. Limit for General Population/Uncontrolled exposure should be applied for this device, it is 1.6 W/kg as averaged over any 1 gram of tissue.

Body Position	SAR Value (W/Kg)	
	General Population/ Uncontrolled Exposure	Occupational/ Controlled Exposure
Whole-Body SAR (averaged over the entire body)	0.08	0.4
Partial-Body SAR (averaged over any 1 gram of tissue)	1.60	8.0
SAR for hands, wrists, feet and ankles (averaged over any 10 grams of tissue)	4.0	20.0

NOTE:
General Population/Uncontrolled Exposure: Locations where there is the exposure of individuals who have no knowledge or control of their exposure. General population/uncontrolled exposure limits are applicable to situations in which the general public may be exposed or in which persons who are exposed as a consequence of their employment may not be made fully aware of the potential for exposure or cannot exercise control over their exposure. Members of the general public would come under this category when exposure is not employment- related; for example, in the case of a wireless transmitter that exposes persons in its vicinity.

Occupational/Controlled Exposure: Locations where there is exposure that may be incurred by persons who are aware of the potential for exposure, In general, occupational/controlled exposure limits are applicable to situations in which persons are exposed as a consequence of their employment, who have been made fully aware of the potential for exposure and can exercise control over their exposure. This exposure category is also applicable when the exposure is of a transient nature due to incidental passage through a location where the exposure levels may be higher than the general population/uncontrolled limits, but the exposed person is fully aware of the potential for exposure and can exercise control over his or her exposure by leaving the area or by some other appropriate means.

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3.3 Test Result Summary

The maximum results of Specific Absorption Rate (SAR) found during test as bellows:

<Highest Reported standalone SAR Summary>

Exposure Position	Frequency Band	Reported SAR (W/kg)	Equipment Class	Highest Reported SAR (W/kg)
Head 1-g SAR (0 mm Gap)	GSM 850	1.115	PCE	**1.164**
	GSM 1900	0.750		
	WCDMA Band II	0.957		
	WCDMA Band IV	1.032		
	WCDMA Band V	0.150		
	LTE Band 2	1.044		
	LTE Band 4	0.793		
	LTE Band 5	0.197		
	LTE Band 12	0.139		
	LTE Band 13	0.107		
	LTE Band 25	**1.164**		
	LTE Band 26 part 90	0.190		
	LTE Band 26 part 22	0.231		
	LTE Band 41	1.070		
	LTE Band 66	0.780		
	LTE Band 71	0.070		
	WLAN 2.4 GHz	0.260	DTS	
	WLAN 5.2 GHz	0.398	NII	
	WLAN 5.8 GHz	0.232		
	Bluetooth	0.045	DSS	
Exposure Position	**Frequency Band**	**Reported SAR (W/kg)**	**Equipment Class**	**Highest Reported SAR (W/kg)**
Hotspot(Body) 1-g SAR (10 mm Gap)	GSM 850	0.368	PCB	**0.799**
	GSM 1900	0.799		
	WCDMA Band II	0.616		
	WCDMA Band IV	0.464		
	WCDMA Band V	0.144		
	LTE Band 2	0.719		
	LTE Band 4	0.798		
	LTE Band 5	0.156		
	LTE Band 12	0.127		
	LTE Band 13	0.084		
	LTE Band 25	0.798		
	LTE Band 26 part 90	0.135		
	LTE Band 26 part 22	0.148		
	LTE Band 41	0.498		
	LTE Band 66	**0.799**		
	LTE Band 71	0.076		
	WLAN 2.4 GHz	0.176	DTS	
	WLAN 5.2 GHz	0.198	NII	
	WLAN 5.8 GHz	0.387		

This device is in compliance with Specific Absorption Rate(SAR) for general population/uncontrolled exposure limits (1.6 W/kg) specified in FCC47 CFR part 2(2.1093) and ANSI/IEEE C95.1-2019, and had been tested in accordance with the measurement methods and procedures specified in IEC/IEEE 62209-1528: 2020.

<Highest Reported Simultaneous SAR>

Exposure Position	Simultaneous Configuration	Highest Reported Simultaneous Transmission SAR (W/kg)	Limit (W/kg)	Verdict
Head 1-g SAR (0 mm Gap)	LTE band 25 +5G WIFI	1.562	1.6	Pass
Hotspot(Body) 1-g SAR (10 mm Gap)	LTE band 66 + 5G WIFI	0.997	1.6	Pass

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3.4 Test Uncertainty

3.4.1 Measurement uncertainly evaluation for SAR test

Measurement uncertainly evaluation for SAR test (300MHz to 6GHz)

Uncertainty Component	Tol (+- %)	Prob. Dist.	Div.	Ci (1g)	Ci (10g)	1g Ui (+- %)	10 g Ui (+-%)	Vi veff
Measurement System								
Probe calibration	5.8	N	1	1	1	5.80	5.80	∞
Axial Isotropy	3.5	R	√3	√0.5	√0.5	1.43	1.43	∞
Hemispherical Isotropy	5.9	R	√3	√0.5	√0.5	2.41	2.41	∞
Boundary effect	1.0	R	√3	1	1	0.58	0.58	∞
Linearity	4.7	R	√3	1	1	2.71	2.71	∞
System detection limits	1.0	R	√3	1	1	0.58	0.58	∞
Modulation response	3.0	R	√3	1	1	1.73	1.73	∞
Readout Electronics	0.5	N	1	1	1	0.50	0.50	∞
Response Time	0	R	√3	1	1	0.00	0.00	∞
Integration Time	1.4	R	√3	1	1	0.81	0.81	∞
RF ambient Conditions - Noise	3.0	R	√3	1	1	1.73	1.73	∞
RF ambient Conditions - Reflections	3.0	R	√3	1	1	1.73	1.73	∞
Probe positioner Mechanical Tolerance	1.4	R	√3	1	1	0.81	0.81	∞
Probe positioning with respect to Phantom Shell	1.4	R	√3	1	1	0.81	0.81	∞
Extrapolation, interpolation and integration Algorithms for Max. SAR Evaluation	2.3	R	√3	1	1	1.33	1.33	∞
Test sample Related								
Test sample positioning	2.6	N	1	1	1	2.60	2.60	11
Device Holder Uncertainty	3.0	N	1	1	1	3.00	3.00	7
Output power Variation - SAR drift measurement	5.0	R	√3	1	1	2.89	2.89	∞
SAR scaling	2.0	R	√3	1	1	1.15	1.15	∞
Phantom and Tissue Parameters								
Phantom Shell Uncertainty - Shape,Thickness and Permittivity	4	R	√3	1	1	2.31	2.31	∞
Uncertainty in SAR correction for deviation in permittivity and conductivity	2.0	N	1	1	0.84	2.00	1.68	∞
Liquid conductivity measurement	4.0	N	1	0.78	0.71	3.12	2.84	5
Liquid permittivity measurement	5.0	N	1	0.23	0.26	1.15	1.30	5
Liquid Conductivity - Temperature Uncertainty	2.5	R	√3	0.78	0.71	1.13	1.02	∞
Liquid permittivity - Temperature Uncertainty	2.5	R	√3	0.23	0.26	0.33	0.38	∞
Combined Standard Uncertainty		RSS				10.47	10.34	
Expanded Uncertainty (95% Confidence interval)		k				20.95	20.69	

* This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

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3.4.2 Measurement uncertainly evaluation for system check

Uncertainty Component	Tol (+- %)	Prob. Dist.	Div.	Ci (1g)	Ci (10 g)	1g Ui (+-%)	10 g Ui (+-%)	Vi veff
Measurement System								
Probe calibration	5.8	N	1	1	1	5.80	5.80	∞
Axial Isotropy	3.5	R	√3	1	1	2.02	2.02	∞
Hemispherical Isotropy	5.9	R	√3	0	0	0.00	0.00	∞
Boundary effect	1	R	√3	1	1	0.58	0.58	∞
Linearity	4.7	R	√3	1	1	2.71	2.71	∞
System detection limits	1	R	√3	1	1	0.58	0.58	∞
Modulation response	0	N	√3	0	0	0.00	0.00	∞
Readout Electronics	0.5	N	1	1	1	0.50	0.50	∞
Response Time	0	R	√3	0	0	0.00	0.00	∞
Integration Time	1.4	R	√3	0	0	0.00	0.00	∞
RF ambient Conditions - Noise	3	R	√3	1	1	1.73	1.73	∞
RF ambient Conditions - Reflections	3	R	√3	1	1	1.73	1.73	∞
Probe positioner Mechanical Tolerance	1.4	R	√3	1	1	0.81	0.81	∞
Probe positioning with respect to Phantom Shell	1.4	R	√3	1	1	0.81	0.81	∞
Extrapolation, interpolation and integration Algorithms for Max. SAR Evaluation	2.3	R	√3	1	1	1.33	1.33	∞
Dipole								
Deviation of experimental source from numerical source	5	N	1	1	1	5.00	5.00	∞
Input Power and SAR driftmeasurement	0.5	R	√3	1	1	0.29	0.29	∞
Dipole Axis to Liquid Dist.	2.0	R	√3	1	1	1.15	1.15	∞
Phantom and Tissue Parameters								
Phantom Shell Uncertainty - Shape,Thickness and Permittivity	4	R	√3	1	1	2.31	2.31	∞
Uncertainty in SAR correction for deviation in permittivity and conductivity	2.0	N	1	1	0.84	2.00	1.68	∞
Liquid conductivity measurement	4	N	1	0.78	0.71	3.12	2.84	5
Liquid permittivity measurement	5.0	N	1	0.23	0.26	1.15	1.30	5
Liquid Conductivity - Temperature Uncertainty	2.5	R	√3	0.78	0.71	1.13	1.02	∞
Liquid permittivity - Temperature Uncertainty	2.5	R	√3	0.23	0.26	0.33	0.38	∞
Combined Standard Uncertainty		RSS				10.16	10.03	
Expanded Uncertainty (95% Confidence interval)		k				20.32	20.06	

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4. Measurement System

4.1 Specific Absorption Rate (SAR) Definition

SAR is related to the rate at which energy is absorbed per unit mass in an object exposed to a radio field. The SAR distribution in a biological body is complicated and is usually carried out by experimental techniques or numerical modeling. The standard recommends limits for two tiers of groups, occupational/controlled and general population/uncontrolled, based on a person's awareness and ability to exercise control over his or her exposure. In general, occupational/controlled exposure limits are higher than the limits for general population/uncontrolled.

The SAR definition is the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dv) of a given density (ρ). The equation description is as below:

$$\mathbf{SAR} = \frac{d}{dt}\left(\frac{dW}{dm}\right) = \frac{d}{dt}\left(\frac{dW}{\rho dv}\right)$$

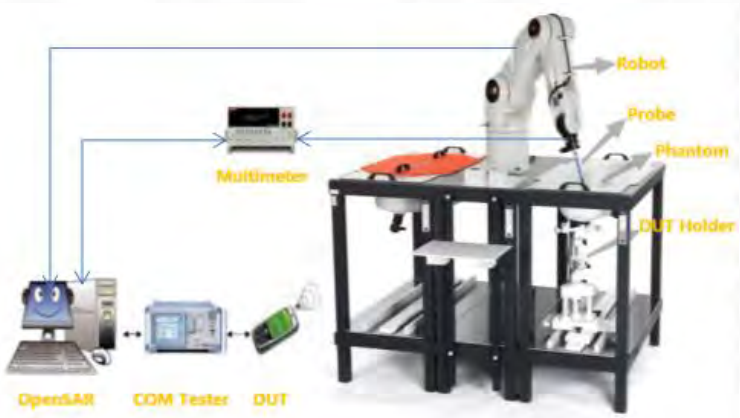
SAR is expressed in units of Watts per kilogram (W/kg) SAR measurement can be related to the electrical field in the tissue by

$$\mathbf{SAR} = \frac{\sigma E^2}{\rho}$$

Where: σ is the conductivity of the tissue,
ρ is the mass density of the tissue and E is the RMS electrical field strength.

4.2 MVG SAR System

4.2.1 SAR system diagram



4.2.2 Robot

A standard high precision 6-axis robot (Denso) with teaches pendant with Scanning System
· It must be able to scan all the volume of the phantom to evaluate the tridimensional distribution of SAR.
· Must be able to set the probe orthogonal of the surface of the phantom (±30°).
· Detects stresses on the probe and stop itself if necessary to keep the integrity of the probe.

4.2.3 E-Field Probe

For the measurements, the Specific Dosimetric SSE2 E-Field Probe with following specifications is used:

- Dynamic range: 0.01-100 W/kg
- Tip diameter: 2mm for SSE2
- Distance between probe tip and sensor centre: 1mm for SSE2
- Distance between sensor centre and the inner phantom surface: 2mm for f>=4GHz.
- Probe linearity: <0.25dB.
- Axial Isotropy: <0.25dB.
- Spherical Isotropy: <0.50dB.
- Calibration range: 150 to 6000 MHz for head & body simulating liquid
- Angle between probe axis (evaluation axis) and surface normal line: less than 20°.

4.2.4 Phantoms

SAM Phantom

For the measurements the Specific Anthropomorphic Mannequin (SAM) defined by the IEEE SCC-34/SC2 group is used. The probe scanning of the E-Field is done in the 2 halves of the normalized head. The normalized shape of the phantom corresponds to the dimensions of 90% of an adult head size. It enables the dosimetric evaluation of left and right-hand phone usage and includes an additional flat phantom part for the simplified body performance check.The phantom set-up includes a cover, which prevents the evaporation of the liquid.

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SAM Phantom

The thickness of the phantom amounts to 2 mm±0.2 mm. The materials for the phantom do not affect the radiation of the device under test (DUT) : εr' <5
The head is filled with tissue simulating liquid. The hand do not have to be modeled.

TWIN SAM phantom			
	Mechanical	Electrical	
Overall thickness	2±0.2 mm(except ear area)	Relative permittivity	3.4
Dimensions	1000 mm(L) x 500 mm(W) x 200 mm(H)	Loss tangent	0.02
Maximum volume	27 L		
Material	Fiberglass based		

ELLIPTICAL Phantom

The phantom is for Body performance check filled with tissue-equivalent liquid to a depth of at least 150 mm, whose shell material is resistant to damage or reaction with tissue-equivalent liquid chemicals.

ELLI Phantom

The shape of the phantom is an ellipse with length 600mm±5mm and width 400mm±5mm.
The phantom shell is made of low-loss and low-permittivity material, having loss tangent tanδ ≤ 0.05 and relative permittivity:
εr' ≤ 5 for f ≤ 3 GHz
3 ≤εr' ≤ 5 for f > 3 GHz
The thickness of the bottom-wall of the flat phantom is 2.0 mm with a tolerance of ± 0.2 mm.

Technical & mechanical characteristics	
Shell thickness	2 mm ± 0.2 mm
Filling volume	25 L
Dimensions	600 mm x 400 mm x 200mm
Permittivity	4.4
Loss tangent	0.017

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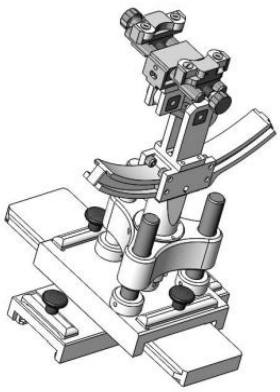
4.2.5 Device Holder



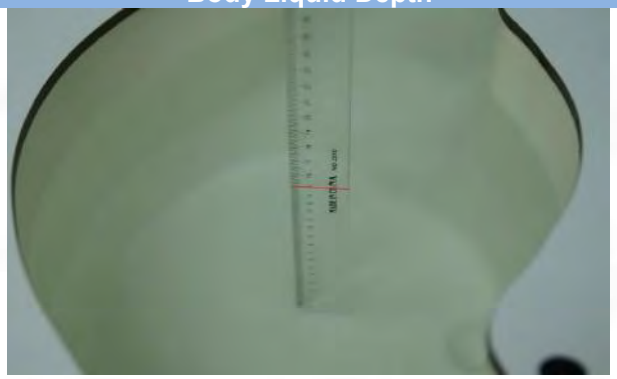
System Material	Permittivity	Loss tangent
Delrin	3.7	0.005

(The positioning system allows obtaining cheek and tilting position with a very good accuracy. In compliance with CENELEC, the tilt angle uncertainty is lower than 1°.)

System Material	Permittivity	Loss tangent
PMMA	2.9	0.028

4.2.6 Simulating Liquid

For SAR measurement of the field distribution inside the phantom, the phantom must be filled with homogeneous tissue simulating liquid to a depth of at least 15 cm. For head SAR testing, the liquid height from the ear reference point (ERP) of the phantom to the liquid top surface is larger than 15 cm. For body SAR testing, the liquid height from the center of the flat phantom to the liquid top surface is larger than 15 cm. The nominal dielectric values of the tissue simulating liquids in the phantom and the tolerance of 5%.

Head Liquid Depth	Body Liquid Depth
	

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The following table gives the recipes for tissue simulating liquid and the theoretical Conductivity/Permittivity.

Head (Reference IEEE1528)								
Frequency (MHz)	Water (%)	Sugar (%)	Cellulose (%)	Salt (%)	Preventol (%)	DGBE (%)	Conductivity σ (S/m)	Permittivity ε
750	41.1	57.0	0.2	1.4	0.2	0	0.89	41.9
835	40.3	57.9	0.2	1.4	0.2	0	0.90	41.5
900	40.3	57.9	0.2	1.4	0.2	0	0.97	41.5
1800, 1900, 2000	55.2	0	0	0.3	0	44.5	1.4	40.0
2450	55.0	0	0	0.1	0	44.9	1.80	39.2
2600	54.9	0	0	0.1	0	45.0	1.96	39.0
Frequency (MHz)	Water (%)	Hexyl Carbitol (%)			Triton X-100 (%)		Conductivity σ (S/m)	Permittivity ε
5200	62.52	17.24			17.24		4.66	36.0
5800	62.52	17.24			17.24		5.27	35.3
Body (From instrument manufacturer)								
Frequency (MHz)	Water (%)	Sugar (%)	Cellulose (%)	Salt (%)	Preventol (%)	DGBE (%)	Conductivity σ (S/m)	Permittivity ε
750	51.7	47.2	0	0.9	0.1	0	0.96	55.5
835	50.8	48.2	0	0.9	0.1	0	0.97	55.2
900	50.8	48.2	0	0.9	0.1	0	1.05	55.0
1800, 1900, 2000	70.2	0	0	0.4	0	29.4	1.52	53.3
2450	68.6	0	0	0.1	0	31.3	1.95	52.7
2600	68.2	0	0	0.1	0	31.7	2.16	52.5
Frequency(MHz)	Water	DGBE (%)			Salt (%)		Conductivity σ (S/m)	Permittivity ε
5200	78.60	21.40			/		5.30	49.00
5800	78.50	21.40			0.1		6.00	48.20

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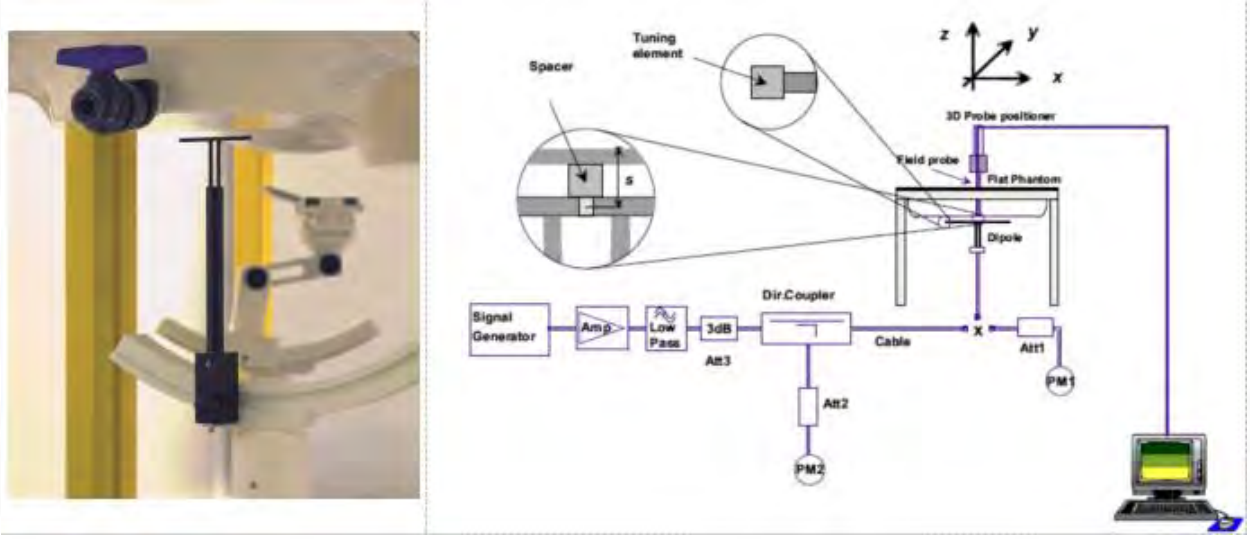
5. System Verification

5.1 Purpose of System Check

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal SAR measurements in a simplified setup with a well characterized source. The setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

5.2 System Check Setup



6. TEST POSITION CONFIGURATIONS

According to KDB 648474 D04 Handset, handsets are tested for SAR compliance in head, body-worn accessory and other use configurations described in the following subsections.

6.1 Head Exposure Conditions

Head exposure is limited to next to the ear voice mode operations. Head SAR compliance is tested according to the test positions defined in IEC IEEE 62209-1528:2020 using the SAM phantom illustrated as below.

6.1.1 Definition of the cheek position

The cheek position is established using steps a) to j) as follows.

(a) Configure the DUT for voice operation, if necessary. For example, for a DUT with a flip.a)swivel, or slide cover piece, open the cover if this is consistent with voice operation. If theDUT can also be used with the cover closed, both configurations shall be tested.

(b) Define two imaginary lines on the DUT, the vertical centreline and the horizontal linerelative to the DUT in vertical orientation as shown in Figure 15.

(c) The vertical centreline passes through two points on the front side of the DUT: themidpoint of the width w of the DUT at the level of the acoustic output (Point A inFigure 15), and the midpoint of the width wp at the bottom of the DUT (Point B). Thehorizontal line is perpendicular to the vertical centerline, and passes through the centre ofthe acoustic output (Fiqure 15). The two lines intersect at Point A. Note that for manyDUTs, Point A coincides with the centre of the acoustic output. However, the acousticoutput could be located elsewhere on the horizontal line. Also note that the verticacentreline is not necessarily parallel to the front face of the DUT, especially for clamshellDUTs,DUTs with flip cover pieces, and other irregularly shaped DUTs.

(d) Position the DUT close to the surface of the phantom such that Point A is on the (virtualextension of the line passing through points RE (right-ear ear reference point) and LEleft-ear ear reference point) on the phantom (see Figure 16a) and Figure 16b)). The planedetermined by the vertical centreline and the horizontal line of the DUT shall be parallel tothe sagittal plane of the phantom.

(e) Translate the DUT towards the phantom along the line passing through RE and LE untilethe DUT touches the ear (see Figure 16c)).

(f) Rotate the DUT around the (virtual) LE-RE Line until the DUT vertical centreline is in thef)reference plane(see Figure 16d)).

(g) Rotate the DUT around its vertical centreline until the plane established by the DUTgvertical centreline and horizontal line is parallel to the N-F line (see Annex G), and thentranslate the DUT towards the phantom along the LE-RE line until DUT Point A touchesthe ear at the ERP (ear reference point) (see Figure 16e))

(h) While keeping Point A on the line passing through RE and LE and maintaining the DUT incontact with the pinna, rotate the DUT about the N-F line until any point on the DUT is incontact with a phantom point below the pinna (cheek) (see Figure 16f)). The physicaangles of rotation shall be documented.

(i) While keeping DUT Point A in contact with the ERP rotate the DUT around a lineperpendicular to the plane established by the DUT vertical centreline and horizontal lineand passing through DUT Point A, until the DUT vertical centreline is in the referenceplane(see Figure 16g)).

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(j) Verify that the cheek position is correct as follows:
1) the N-F line is in the plane established by the DUT vertical centreline and horizontalline;
2) DUT Point A touches the pinna at the ERP
3) the DUT vertical centreline is in the reference plane.

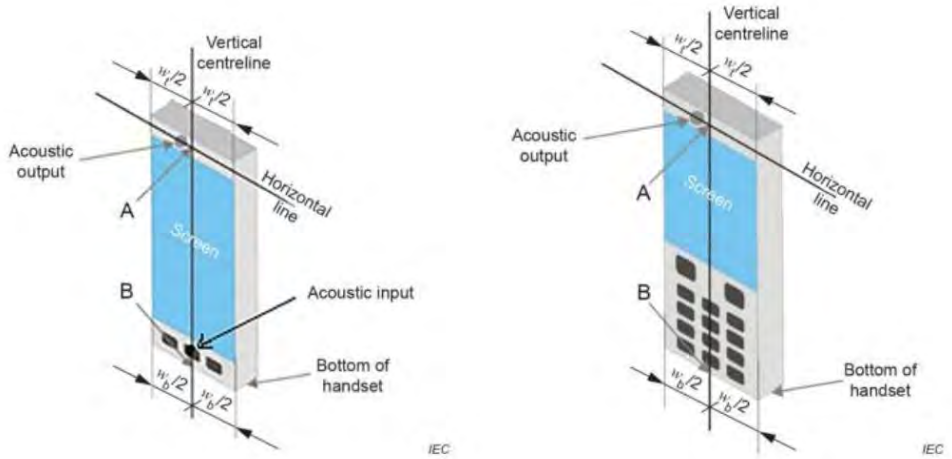
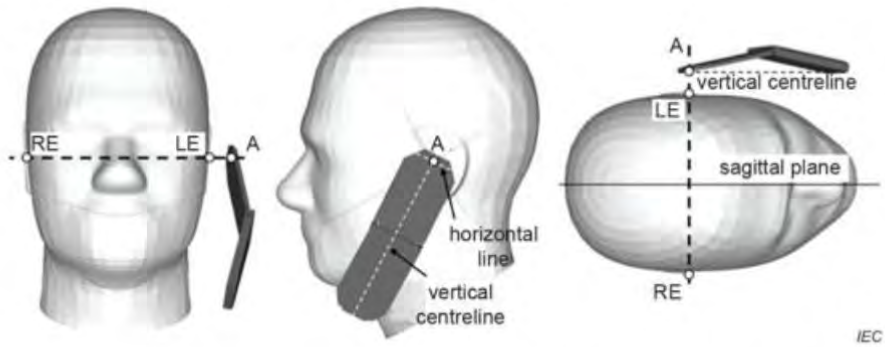


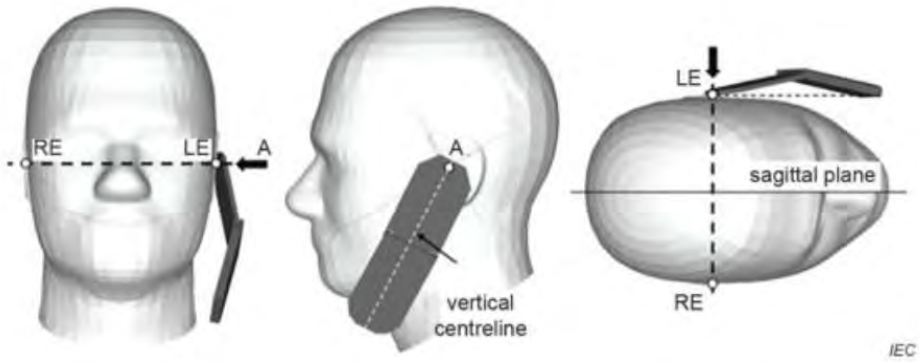
Figure 15 - Vertical and horizontal reference lines and referencepoints A and B on two example device types: a full touch-screensmart phone (left) and a DUT with a keypad (right)

NOTE The reference points for the right-ear ear reference point (RE), left-ear ear reference point (LE), and mouth (M), which establish the reference plane for DUT positioning, are indicated. This device position shall be maintained for the sagittal phantom test set-up shown in Figure G.4.

a) Phone position 1 – cheek position

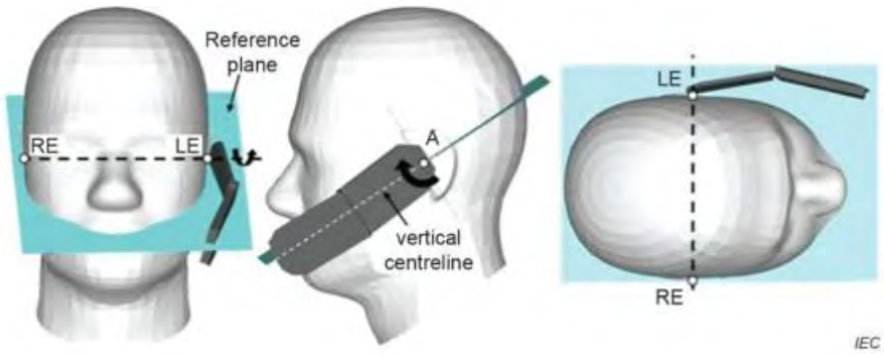


b) One possible DUT position against the head after applying 7.2.4.2.2 c)



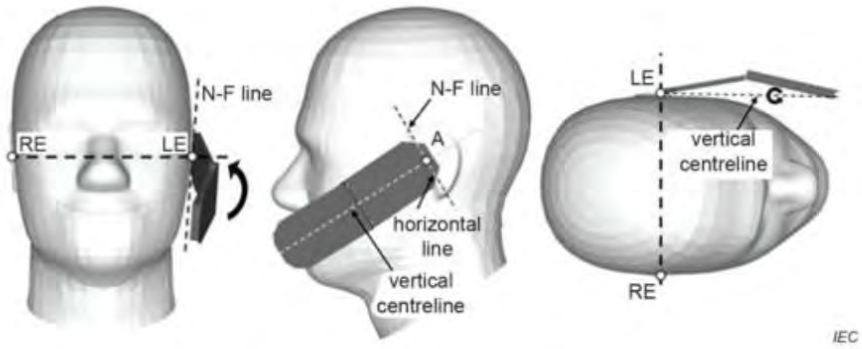
NOTE The black arrows show the direction of translation of the DUT for 7.2.4.2.2 d).

c) DUT position after applying 7.2.4.2.2 d)



NOTE The curved black arrows show the direction of rotation of the DUT for 7.2.4.2.2 e).

d) DUT position after applying 7.2.4.2.2 e)



NOTE The curved black arrows show the direction of rotation of the DUT for 7.2.4.2.2 f).

e) DUT position after applying 7.2.4.2.2 f)

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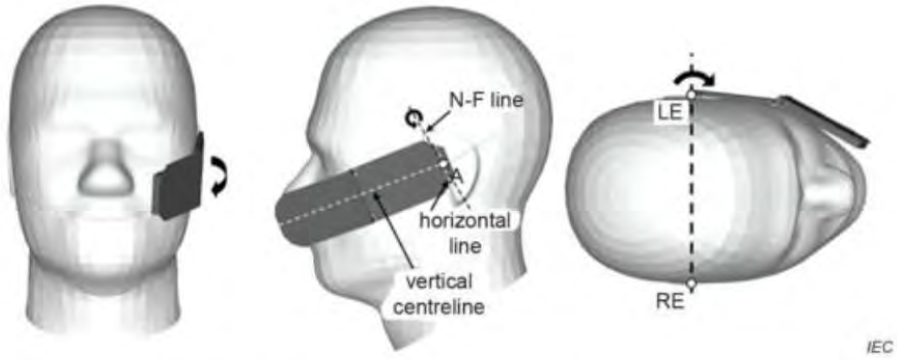

NOTE The curved black arrows show the direction of rotation of the DUT for 7.2.4.2.2 g)

f) DUT position after applying 7.2.4.2.2 g)

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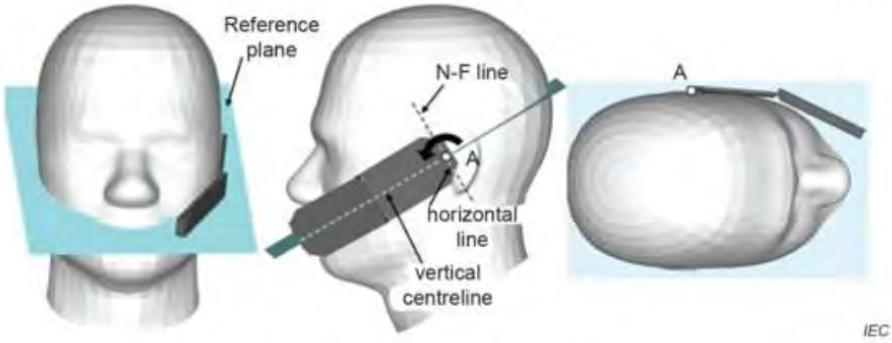


NOTE The curved black arrows show the direction of rotation of the DUT for 7.2.4.2.2 h).

g) DUT position after applying 7.2.4.2.2 h)

Figure 16 – Cheek position of the DUT on the left side of SAM where the device position shall be maintained for the phantom test set-up

6.1.2 Definition of the tilt position

The tilt position is established using steps a) through d) as follows.

(a) Repeat steps a) through j) of 7.2.4.2.2 to place the DUT in the cheek positiona)(see Figure16).

(b) While maintaining the orientation of the DUT, move the DUT away from the pinna alongb)the line passing through RE and LE far enough to allow a rotation of the DUT away fromthe cheek by 15°.

(c) Rotate the DUT around the horizontal line by 15°(see Figure 17).

(d) While maintaining the orientation of the DUT. move the DUT towards the phantom on aline passing through RE and LE until any part of the DUT touches the ear. The tilt positionis obtained when the contact is on the pinna. If the contact is at any location other thanthe pinna, e.g. an extended antenna in contact with the back of the head phantom, theangle of the DUT shall be reduced. in this case, the tilt position is obtained if any part ofthe DUT is in contact with the pinna and a second point on the DUT is in contact with thephantom,e.g.the antenna in contact with the back of the head.

Key

M Mouth reference point

LE Left-ear ear reference point

RE Right-ear ear reference point

This device position shall be maintained for the phantom test set-up.

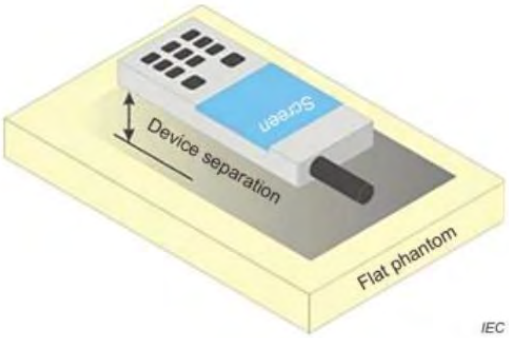
Figure 17 – Tilt position of the DUT on the left side of SAM

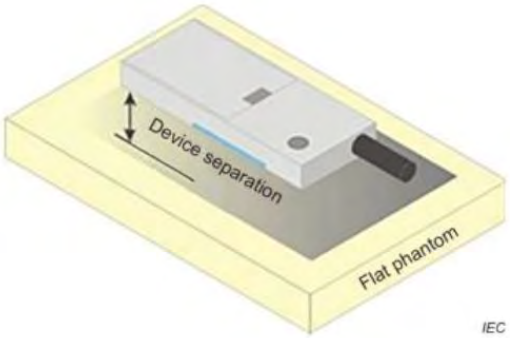
6.2 Body-worn Position Conditions

Body-worn accessory exposure is typically related to voice mode operations when handsets are carried in body-worn accessories. The body-worn accessory procedures in KDB 447498 are used to test for body-worn accessory SAR compliance, without a headset connected to it. This enables the test results for such configuration to be compatible with that required for hotspot mode when the body-worn accessory test separation distance is greater than or equal to that required for hotspot mode. When the reported SAR for a body-worn accessory.

Body-worn accessories that do not contain metallic or conductive components may be tested according to worst-case exposure configurations, typically according to the smallest test separation distance required for the group of body-worn accessories with similar operating and exposure characteristics. All body-worn accessories containing metallic components are tested in conjunction with the host device.

Body-worn accessory SAR compliance is based on a single minimum test separation distance for all wireless and operating modes applicable to each body-worn accessory used by the host, and according to the relevant voice and/or data mode transmissions and operations. If a body-worn accessory supports voice only operations in its normal and expected use conditions, testing of data mode for body-worn compliance is not required. A conservative minimum test separation distance for supporting off-the-shelf body-worn accessories that may be acquired by users of consumer handsets is used to test for body-worn accessory SAR compliance. This distance is determined by the handset manufacturer, according to the requirements of Supplement C 01-01. Devices that are designed to operate on the body of users using lanyards and straps, or without requiring additional body-worn accessories, will be tested using a conservative minimum test separation distance <= 5 mm to support compliance.





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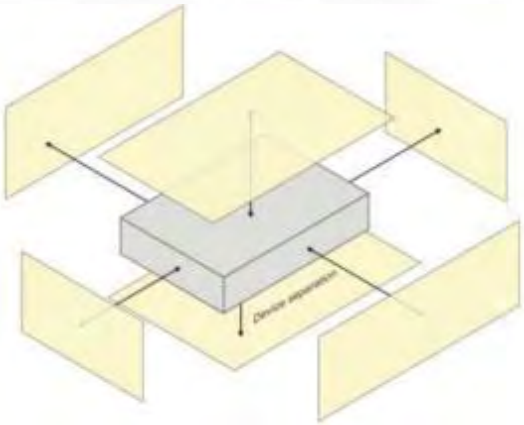
6.3 Hotspot Mode Exposure Position Conditions

For handsets that support hotspot mode operations, with wireless router capabilities and various web browsing functions, the relevant hand and body exposure conditions are tested according to the hotspot SAR procedures in KDB 941225. A test separation distance of 10 mm is required between the phantom and all surfaces and edges with a transmitting antenna located within 25 mm from that surface or edge. When the form factor of a handset is smaller than 9 cm x 5 cm, a test separation distance of 5 mm (instead of 10 mm) is required for testing hotspot mode. When the separation distance required for body-worn accessory testing is larger than or equal to that tested for hotspot mode, in the same wireless mode and for the same surface of the phone, the hotspot mode SAR data may be used to support body-worn accessory SAR compliance for that particular configuration (surface).



6.4 Product Specific 10g Exposure Consideration

According with FCC KDB 648474 D04, for smart phones with a display diagonal dimension > 15.0 cm or an overall diagonal dimension > 16.0 cm that provide similar mobile web access and multimedia support found in mini-tablets or UMPC mini-tablets that support voice calls next to the ear, unless it is confirmed otherwise through KDB inquiries, the following phablet procedures should be applied to evaluate SAR compliance for each applicable wireless modes and frequency band. Devices marketed as phablets, regardless of form factors and operating characteristics must be tested as a phablet to determine SAR compliance;

The UMPC mini-tablet procedures must also be applied to test the SAR of all surfaces and edges with an antenna located at ≤ 25 mm from that surface or edge, in direct contact with a flat phantom, for 10-g extremity SAR according to the body-equivalent tissue dielectric parameters in KDB 865664 to address interactive hand use exposure conditions. The UMPC mini-tablet 1-g SAR at 5 mm is not required. When hotspot mode applies, 10-g extremity SAR is required only for the surfaces and edges with hotspot mode 1-g reported SAR > 1.2 W/kg.

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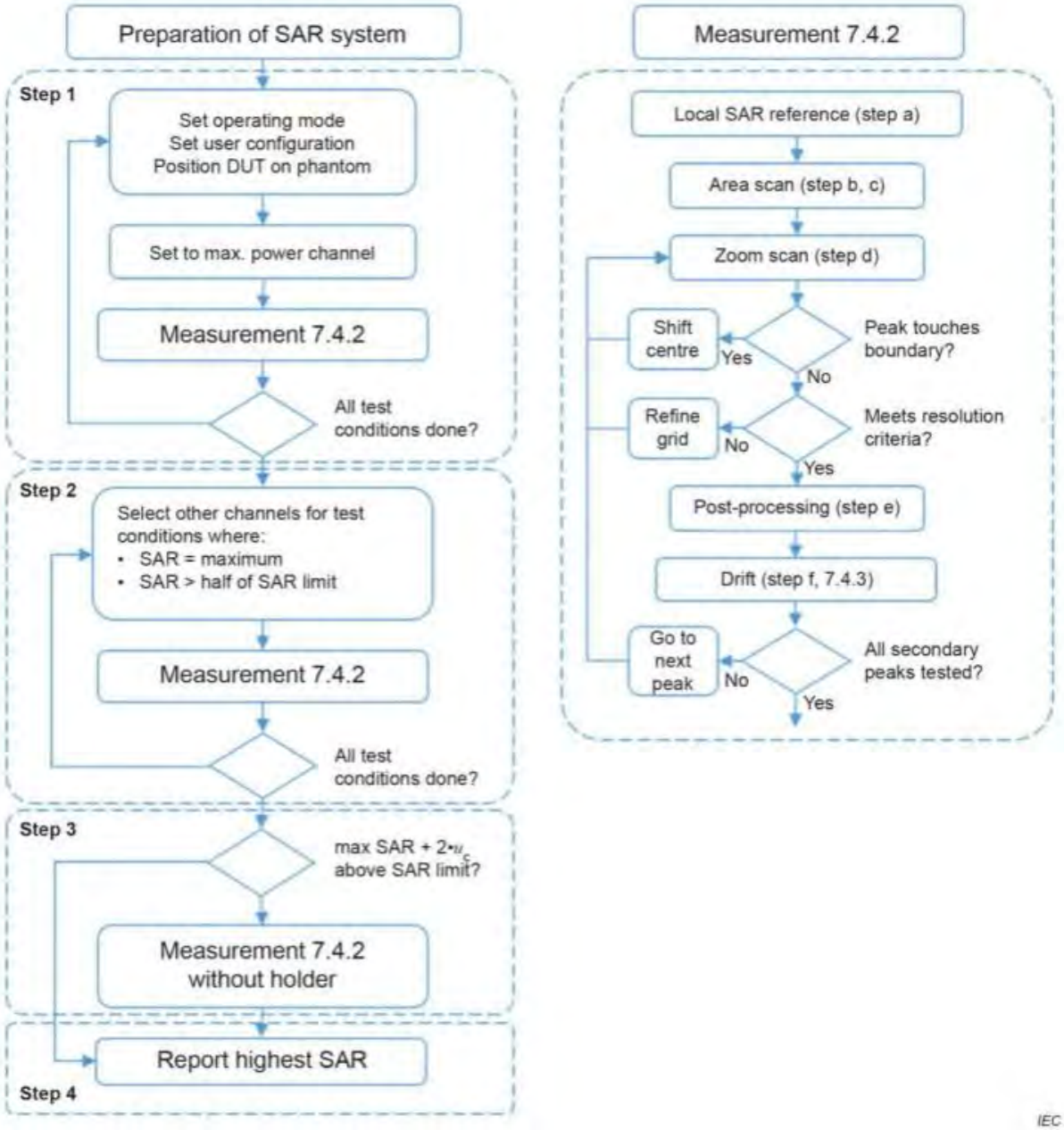
7. Measurement Procedure

7.1 Measurement Process Diagram

Body SAR



7.2 SAR Scan General Requirement

Probe boundary effect error compensation is required for measurements with the probe tip closer than half a probe tip diameter to the phantom surface. Both the probe tip diameter and sensor offset distance must satisfy measurement protocols; to ensure probe boundary effect errors are minimized and the higher fields closest to the phantom surface can be correctly measured and extrapolated to the phantom surface for computing 1 g SAR. Tolerances of the post-processing algorithms must be verified by the test laboratory for the scan resolutions used in the SAR measurements, according to the reference distribution functions specified in IEC/IEEE 62209-1528: 2020.

Table 3 – Area scan parameters

Parameter	DUT transmit frequency being tested	
	$f \leq 3$ GHz	3 GHz < $f \leq 10$ GHz
Maximum distance between the measured points (geometric centre of the sensors) and the inner phantom surface (z_{M1} in Figure 20 in mm)	5 ± 1	$\delta \ln(2)/2 \pm 0{,}5$ [a]
Maximum spacing between adjacent measured points in mm (see O.8.3.1)[b]	20, or half of the corresponding zoom scan length, whichever is smaller	$60/f$, or half of the corresponding zoom scan length, whichever is smaller
Maximum angle between the probe axis and the phantom surface normal (α in Figure 20)[c]	5° (flat phantom only) 30° (other phantoms)	5° (flat phantom only) 20° (other phantoms)
Tolerance in the probe angle	1°	1°

[a] δ is the penetration depth for a plane-wave incident normally on a planar half-space.

[b] See Clause O.8 on how Δx and Δy may be selected for individual area scan requirements.

[c] The probe angle relative to the phantom surface normal is restricted due to the degradation in the measurement accuracy in fields with steep spatial gradients. The measurement accuracy decreases with increasing probe angle and increasing frequency. This is the reason for the tighter probe angle restriction at frequencies above 3 GHz.

Table 4 – Zoom scan parameters

Parameter	DUT transmit frequency being tested	
	$f \leq 3$ GHz	3 GHz < $f \leq 10$ GHz
Maximum distance between the closest measured points and the phantom surface (z_{M1} in Figure 20 and Table 3, in mm)	5	$\delta \ln(2)/2$ [a]
Maximum angle between the probe axis and the phantom surface normal (α in Figure 20)	5° (flat phantom only) 30° (other phantoms)	5° (flat phantom only) 20° (other phantoms)
Maximum spacing between measured points in the x- and y-directions (Δx and Δy, in mm)	8	$24/f$ [b]
For uniform grids: Maximum spacing between measured points in the direction normal to the phantom shell (Δz_1 in Figure 20, in mm)	5	$10/(f - 1)$
For graded grids: Maximum spacing between the two closest measured points in the direction normal to the phantom shell (Δz_1 in Figure 20, in mm)	4	$12/f$
For graded grids: Maximum incremental increase in the spacing between measured points in the direction normal to the phantom shell ($R_z = \Delta z_2/\Delta z_1$ in Figure 20)	1,5	1,5
Minimum edge length of the zoom scan volume in the x- and y-directions (L_z in O.8.3.2, in mm)	30	22
Minimum edge length of the zoom scan volume in the direction normal to the phantom shell (L_h in O.8.3.2 in mm)	30	22
Tolerance in the probe angle	1°	1°

[a] δ is the penetration depth for a plane-wave incident normally on a planar half-space.

[b] This is the maximum spacing allowed, which might not work for all circumstances.

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7.3 Measurement Procedure

The following steps are used for each test position

a. Establish a call with the maximum output power with a base station simulator. The connection between the mobile and the base station simulator is established via air interface

b. Measurement of the local E-field value at a fixed location. This value serves as a reference value for calculating a possible power drift.

c. Measurement of the SAR distribution with a grid of 8 to 16mm * 8 to16 mm and a constant distance to the inner surface of the phantom. Since the sensors cannot directly measure at the inner phantom surface, the values between the sensors and the inner phantom surface are extrapolated. With these values the area of the maximum SAR is calculated by an interpolation scheme.

d. Around this point, a cube of 30 * 30 * 30 mm or 32 * 32 *32 mm is assessed by measuring 5 or 8 * 5 or 8*4 or 5 mm. With these data, the peak spatial-average SAR value can be calculated.

7.4 Area & Zoom Scan Procedure

First Area Scan is used to locate the approximate location(s) of the local peak SAR value(s). The measurement grid within an Area Scan is defined by the grid extent, grid step size and grid offset. Next, in order to determine the EM field distribution in a three-dimensional spatial extension, Zoom Scan is required. The Zoom Scan is performed around the highest E-field value to determine the averaged SAR-distribution over 10 g. Area scan and zoom scan resolution setting follows KDB 865664 D01v01r04 quoted below.

When the 1 g SAR of the highest peak is within 2 dB of the SAR limit, additional zoom scans are required for other peaks within 2 dB of the highest peak that have not been included in any zoom scan to ensure there is no increase in SAR.

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8. Conducted RF Output Power

8.1 GSM

Mode: GSM850		Maximum Tune-up(dBm)	Burst Average Power (dBm)			Division Factors	Frame-Average Power (dBm)		
			CH128	CH190	CH251		CH128	CH190	CH251
			824.2MHz	836.6MHz	848.8MHz		824.2MHz	836.6MHz	848.8MHz
GSM		**28.50**	27.82	27.77	**28.10**	-9.03	18.79	18.74	**19.07**
GPRS (GMSK)	1Tx slot	28.50	27.88	27.83	28.13	-9.03	18.85	18.80	19.10
	2Tx slots	**26.00**	**25.79**	25.66	25.58	-6.02	**19.77**	19.64	19.56
	3Tx slots	24.00	23.80	23.65	23.58	-4.26	19.54	19.39	19.32
	4Tx slots	22.00	21.77	21.61	21.49	-3.01	18.76	18.60	18.48
EGPRS (8PSK)	1Tx slot	20.00	19.62	19.99	19.56	-9.03	10.59	10.96	10.53
	2Tx slots	19.00	18.56	18.80	18.21	-6.02	12.54	12.78	12.19
	3Tx slots	19.50	19.14	16.52	15.75	-4.26	14.88	12.26	11.49
	4Tx slots	14.50	14.15	14.27	13.85	-3.01	11.14	11.26	10.84
Mode: GSM1900		**Maximum Tune-up(dBm)**	**Burst Average Power (dBm)**			**Division Factors**	**Frame-Average Power (dBm)**		
			CH512	CH661	CH810		CH512	CH661	CH810
			1850.2MHz	1880.0MHz	1909.8MHz		1850.2MHz	1880.0MHz	1909.8MHz
GSM		**23.50**	**23.07**	22.91	22.60	-9.03	**14.04**	13.88	13.57
GPRS (GMSK)	1Tx slot	24.00	23.52	23.33	23.09	-9.03	14.49	14.30	14.06
	2Tx slots	22.00	21.57	21.65	21.70	-6.02	15.55	15.63	15.68
	3Tx slots	**20.50**	20.11	20.25	**20.34**	-4.26	15.85	15.99	**16.08**
	4Tx slots	18.50	18.02	18.20	18.33	-3.01	15.01	15.19	15.32
EGPRS (8PSK)	1Tx slot	20.00	19.95	19.57	19.82	-9.03	10.92	10.54	10.79
	2Tx slots	19.00	18.25	17.92	18.93	-6.02	12.23	11.90	12.91
	3Tx slots	16.00	15.89	15.55	15.59	-4.26	11.63	11.29	11.33
	4Tx slots	15.00	13.72	14.95	13.28	-3.01	10.71	11.94	10.27

Note:
1) Division Factors
To average the power, the division factor is as follows:
1Tx-slot = 1 transmit time slot out of 8 time slots=> conducted power divided by (8/1) => -9.03dB
2Tx-slots = 2 transmit time slots out of 8 time slots=> conducted power divided by (8/2) => -6.02dB
3Tx-slots = 3 transmit time slots out of 8 time slots=> conducted power divided by (8/3) => -4.26dB
4Tx-slots = 4 transmit time slots out of 8 time slots=> conducted power divided by (8/4) => -3.01dB

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8.2 WCDMA

Mode		Maximum Tune-up(dBm)	WCDMA Band II		
			Conducted Power (dBm)		
			CH9262	CH9400	CH9538
			1852.4	1880.0	1907.6
RMC 12.2K		**22.00**	21.95	21.92	**22.00**
HSDPA	Subtest-1	21.50	20.89	21.42	21.48
	Subtest-2	21.50	20.88	21.43	21.49
	Subtest-3	21.50	20.88	21.44	21.49
	Subtest-4	21.50	20.84	21.39	21.44
HSUPA	Subtest-1	19.50	18.73	19.40	19.32
	Subtest-2	19.50	18.88	19.18	19.28
	Subtest-3	19.50	18.86	18.94	19.49
	Subtest-4	19.50	18.63	19.22	19.03
	Subtest-5	19.50	18.38	18.88	19.29
Mode		Maximum Tune-up(dBm)	WCDMA Band IV		
			Conducted Power (dBm)		
			CH1312	CH1413	CH1513
			1712.4	1732.6	1752.6
RMC 12.2K		**22.50**	**22.30**	22.27	22.19
HSDPA	Subtest-1	22.00	21.34	20.92	21.83
	Subtest-2	22.00	21.37	20.93	21.83
	Subtest-3	22.00	21.39	20.95	21.84
	Subtest-4	22.00	21.33	20.89	21.79
HSUPA	Subtest-1	20.00	19.25	18.93	19.78
	Subtest-2	20.00	19.43	18.68	19.76
	Subtest-3	20.00	19.42	18.90	19.77
	Subtest-4	19.50	19.40	18.48	19.46
	Subtest-5	20.00	18.93	18.75	19.92
Mode		Maximum Tune-up(dBm)	WCDMA Band V		
			Conducted Power (dBm)		
			CH4132	CH4183	CH4233
			826.4	836.6	846.6
RMC 12.2K		**24.00**	**23.79**	23.75	23.74
HSDPA	Subtest-1	23.00	22.07	22.58	22.35
	Subtest-2	23.00	22.07	22.62	22.38
	Subtest-3	23.00	22.11	22.63	22.40
	Subtest-4	23.00	22.07	22.55	22.31
HSUPA	Subtest-1	21.00	20.11	20.68	20.47
	Subtest-2	21.00	20.12	20.74	19.99
	Subtest-3	21.00	19.64	20.50	20.26
	Subtest-4	20.50	19.64	20.23	20.21
	Subtest-5	21.00	19.63	20.72	20.26
Per KDB 941225 D01, when the maximum output power and tune-up tolerance specified for production units in a secondary mode is ≤1/2dB higher than the primary mode (RMC12.2kbps) or when the highest reported SAR of the primary mode is scaled by the ratio of specified maximum output power and tune-up tolerance of secondary to primary mode and the adjusted SAR is ≤ 1.2 W/kg, SAR measurement is not required for the secondary mode.					

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8.3 LTE

Band 2

LTE-FDD Band 2				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		18607	18900	19193
					1850.7MHz	1880.0MHz	1909.3MHz
1.4MHz	QPSK	1	0	23.00	22.57	22.39	22.59
			2	23.00	22.72	22.40	22.58
			5	23.00	22.68	22.45	22.60
		3	0	23.00	22.71	22.50	22.66
			2	23.00	22.71	22.55	22.66
			3	23.00	22.73	22.59	22.59
		6	0	22.00	21.61	21.53	21.57
	16QAM	1	0	22.00	21.80	21.27	21.80
			2	22.00	21.77	21.27	21.77
			5	22.00	21.76	21.30	21.75
		3	0	22.00	21.65	21.42	21.76
			2	22.00	21.71	21.44	21.82
			3	22.00	21.67	21.45	21.77
		6	0	21.00	20.74	20.68	20.78
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18615	18900	19185
					1851.5MHz	1880.0MHz	1908.5MHz
3MHz	QPSK	1	0	22.00	21.71	21.42	21.47
			7	22.00	21.61	21.42	21.64
			14	22.00	21.71	21.41	21.62
		8	0	22.00	21.67	21.40	21.61
			4	22.00	21.64	21.39	21.60
			7	22.00	21.62	21.53	21.59
		15	0	22.00	21.61	21.52	21.58
	16QAM	1	0	22.00	21.71	21.51	21.58
			7	22.00	21.69	21.51	21.58
			14	22.00	21.68	21.50	21.57
		8	0	22.00	21.68	21.50	21.57
			4	22.00	21.66	21.50	21.57
			7	22.00	21.66	21.49	21.57
		15	0	22.00	21.66	21.49	21.57

Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18625	18900	19175
					1852.5MHz	1880.0MHz	1907.5MHz
5MHz	QPSK	1	0	23.00	22.69	22.58	22.69
			13	23.00	22.61	22.42	22.73
			24	23.00	22.64	22.45	22.67
		12	0	22.00	21.76	21.49	21.62
			6	22.00	21.62	21.53	21.71
			13	22.00	21.70	21.62	21.60
		25	0	22.00	21.63	21.59	21.68
	16QAM	1	0	22.00	21.00	21.74	21.60
			13	22.00	20.98	21.73	21.71
			24	22.00	20.95	21.78	21.60
		12	0	21.00	20.80	20.71	20.63
			6	21.00	20.80	20.67	20.64
			13	21.00	20.79	20.71	20.70
		25	0	21.00	20.91	20.79	20.75

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LTE-FDD Band 2				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		18650	18900	19150
					1855.0MHz	1880.0MHz	1905.0MHz
10MHz	QPSK	1	0	23.00	22.62	22.54	22.51
			25	23.00	22.57	22.55	22.54
			49	23.00	22.55	22.56	22.49
		25	0	22.00	21.65	21.66	21.49
			13	22.00	21.55	21.66	21.63
			25	22.00	21.61	21.56	21.69
		50	0	22.00	21.56	21.56	21.68
	16QAM	1	0	22.50	22.08	21.45	22.37
			25	22.50	21.96	21.51	22.31
			49	22.50	21.92	21.48	22.42
		25	0	21.00	20.77	20.91	20.73
			13	21.00	20.81	20.83	20.79
			25	21.00	20.79	20.91	20.75
		50	0	21.00	20.84	20.75	20.73
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18675	18900	19125
					1857.5MHz	1880.0MHz	1902.5MHz
15MHz	QPSK	1	0	23.00	22.64	22.49	22.51
			38	23.00	22.54	22.50	22.60
			74	23.00	22.54	22.54	22.60
		36	0	22.00	21.62	21.51	21.53
			18	22.00	21.68	21.54	21.56
			39	22.00	21.62	21.63	21.54
		75	0	22.00	21.64	21.57	21.49
	16QAM	1	0	22.50	22.03	21.69	22.05
			38	22.50	21.96	21.73	22.08
			74	22.50	21.92	21.70	22.10
		36	0	21.00	20.73	20.85	20.72
			18	21.00	20.71	20.72	20.72
			39	21.00	20.70	20.80	20.72
		75	0	21.00	20.80	20.71	20.73
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18700	18900	19100
					1860.0MHz	1880.0MHz	1900.0MHz
20MHz	QPSK	1	0	**23.00**	**22.83**	22.52	22.76
			50	23.00	22.71	22.48	22.74
			99	23.00	22.67	22.53	22.80
		50	0	22.00	**21.60**	21.62	21.52
			25	22.00	21.60	21.46	21.61
			50	22.00	21.50	21.59	21.56
		100	0	22.00	21.53	21.56	21.53
	16QAM	1	0	22.50	21.72	22.39	21.67
			50	22.50	21.64	22.30	21.68
			99	22.50	21.60	22.44	21.74
		50	0	21.00	20.82	20.64	20.68
			25	21.00	20.86	20.66	20.78
			50	21.00	20.85	20.69	20.66
		100	0	21.00	20.75	20.77	20.68

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Band 4

LTE-FDD Band 4				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		19957	20175	20393
					1710.7MHz	1732.5MHz	1754.3MHz
1.4MHz	QPSK	1	0	22.50	22.41	22.48	22.37
			2	23.00	22.45	22.50	22.32
			5	23.00	22.45	22.54	22.35
		3	0	22.50	22.46	22.44	22.38
			2	22.50	22.38	22.48	22.34
			3	22.50	22.31	22.41	22.36
		6	0	21.50	21.34	21.43	21.32
	16QAM	1	0	22.50	21.46	22.18	22.14
			2	22.50	21.53	22.17	22.17
			5	22.50	21.49	22.17	22.21
		3	0	22.00	21.45	21.64	21.23
			2	22.00	21.41	21.65	21.16
			3	22.00	21.36	21.70	21.11
		6	0	21.00	20.58	20.70	20.54
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	19965	20175	20385
					1711.5MHz	1732.5MHz	1753.5MHz
3MHz	QPSK	1	0	22.50	22.36	22.42	22.16
			7	22.50	22.42	22.36	22.21
			14	22.50	22.33	22.36	22.23
		8	0	21.50	21.47	21.42	21.33
			4	21.50	21.43	21.45	21.35
			7	21.50	21.42	21.41	21.32
		15	0	21.50	21.38	21.40	21.31
	16QAM	1	0	23.00	22.39	21.47	22.61
			7	23.00	22.40	21.49	22.53
			14	22.50	22.37	21.42	22.21
		8	0	21.00	20.82	20.72	20.61
			4	21.00	20.83	20.75	20.59
			7	21.00	20.85	20.75	20.58
		15	0	21.00	20.69	20.61	20.54
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	19976	20175	20375
					1712.5MHz	1732.5MHz	1752.5MHz
5MHz	QPSK	1	0	22.50	22.46	22.41	22.37
			13	22.50	22.38	22.21	22.22
			24	22.50	22.32	22.23	22.22
		12	0	21.50	21.38	21.39	21.26
			6	21.50	21.41	21.38	21.29
			13	22.00	21.50	21.34	21.22
		25	0	21.50	21.42	21.35	21.34
	16QAM	1	0	22.50	21.11	22.04	21.84
			13	22.50	21.10	22.00	21.77
			24	22.50	21.12	22.05	21.81
		12	0	21.00	20.58	20.53	20.41
			6	21.00	20.57	20.53	20.46
			13	21.00	20.57	20.51	20.45
		25	0	21.00	20.62	20.55	20.46

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LTE-FDD Band 4				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20000	20175	20350
					1715.0MHz	1732.5MHz	1750.0MHz
10MHz	QPSK	1	0	22.50	22.30	22.36	22.26
			25	22.50	22.33	22.31	22.28
			49	22.50	22.32	22.33	22.17
		25	0	21.50	21.43	21.39	21.31
			13	21.50	21.49	21.39	21.37
			25	21.50	21.42	21.29	21.21
		50	0	21.50	21.49	21.46	21.31
	16QAM	1	0	23.00	22.18	21.45	22.75
			25	23.00	22.25	21.42	22.91
			49	23.00	22.20	21.40	22.74
		25	0	21.00	20.56	20.67	20.46
			13	21.00	20.56	20.67	20.57
			25	21.00	20.55	20.67	20.47
		50	0	21.00	20.69	20.51	20.64
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20025	20175	20325
					1717.5MHz	1732.5MHz	1747.5MHz
15MHz	QPSK	1	0	22.50	22.26	22.25	22.43
			38	22.50	22.40	22.17	22.40
			74	22.50	22.33	22.18	22.36
		36	0	21.50	21.36	21.45	21.23
			18	21.50	21.44	21.46	21.38
			39	21.50	21.38	21.38	21.32
		75	0	21.50	21.40	21.36	21.20
	16QAM	1	0	22.50	22.21	22.23	22.27
			38	22.50	22.29	22.27	22.23
			74	22.50	22.27	22.28	22.27
		36	0	21.00	20.70	20.57	20.56
			18	21.00	20.67	20.55	20.56
			39	21.00	20.62	20.49	20.48
		75	0	21.00	20.59	20.54	20.44
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20050	20175	20300
					1720.0MHz	1732.5MHz	1745.0MHz
20MHz	QPSK	1	0	23.00	22.57	22.42	22.48
			50	23.00	22.52	22.41	22.34
			99	**23.00**	**22.61**	22.29	22.28
		50	0	22.00	**21.50**	21.38	21.21
			25	21.50	21.48	21.30	21.23
			50	21.50	21.42	21.37	21.43
		100	0	21.50	21.41	21.38	21.27
	16QAM	1	0	23.00	22.07	22.70	22.31
			50	23.00	22.03	22.73	22.30
			99	23.00	22.08	22.83	22.22
		50	0	21.00	20.63	20.51	20.58
			25	21.00	20.68	20.48	20.60
			50	21.00	20.68	20.47	20.67
		100	0	21.00	20.61	20.57	20.37

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Band 5

LTE-FDD Band 5				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20407	20525	20643
					824.7MHz	836.5MHz	848.3MHz
1.4MHz	QPSK	1	0	23.50	23.33	23.19	23.08
			2	23.50	23.35	23.23	23.10
			5	23.50	23.38	23.25	22.84
		3	0	23.50	23.36	23.23	23.19
			2	23.50	23.37	23.21	23.19
			3	23.50	23.38	23.18	23.16
		6	0	22.50	22.38	22.30	22.14
	16QAM	1	0	23.00	22.39	22.77	22.69
			2	23.50	22.36	22.84	23.03
			5	23.00	22.43	22.82	22.64
		3	0	22.50	22.19	22.30	22.14
			2	22.50	22.18	22.25	22.15
			3	22.50	22.13	22.28	22.06
		6	0	21.50	21.40	21.39	21.32
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20415	20525	20635
					825.5MHz	836.5MHz	847.5MHz
3MHz	QPSK	1	0	23.50	23.32	23.25	23.10
			7	23.50	23.35	23.23	23.04
			14	23.50	23.32	23.23	22.98
		8	0	22.50	22.36	22.17	22.22
			4	22.50	22.35	22.23	22.18
			7	22.50	22.22	22.17	22.21
		15	0	22.50	22.37	22.19	22.14
	16QAM	1	0	23.00	22.75	22.76	22.97
			7	23.00	22.67	22.89	22.98
			14	23.00	22.52	22.84	22.95
		8	0	22.00	21.59	21.26	21.41
			4	22.00	21.60	21.39	21.39
			7	21.50	21.43	21.41	21.42
		15	0	21.50	21.36	21.38	21.32

LTE-FDD Band 5				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20425	20525	20625
					826.5MHz	836.5MHz	846.5MHz
5MHz	QPSK	1	0	23.50	23.38	23.27	23.34
			13	23.50	23.33	23.12	23.36
			24	23.50	23.24	23.04	23.29
		12	0	22.50	22.41	22.19	22.28
			6	22.50	22.35	22.23	22.22
			13	22.50	22.27	22.25	22.26
		25	0	22.50	22.28	22.32	22.17
	16QAM	1	0	23.00	22.10	22.84	22.93
			13	23.00	21.95	22.78	22.83
			24	23.00	21.95	22.88	22.83
		12	0	21.50	21.44	21.24	21.31
			6	21.50	21.39	21.33	21.32
			13	21.50	21.38	21.32	21.36
		25	0	21.50	21.46	21.41	21.36

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20450	20525	20600
					829.0MHz	836.5MHz	844.0MHz
10MHz	QPSK	1	0	**23.50**	**23.30**	23.11	23.18
			25	23.50	23.14	23.20	23.16
			49	23.50	23.05	23.24	23.11
		25	0	22.50	22.23	22.23	22.38
			13	22.50	**22.33**	22.28	22.15
			25	22.50	22.23	22.20	22.20
		50	0	22.50	22.33	22.22	22.28
	16QAM	1	0	23.50	23.13	22.27	23.47
			25	23.50	23.28	22.22	22.94
			49	23.50	23.25	22.26	22.89
		25	0	22.00	21.35	21.45	21.50
			13	22.00	21.37	21.50	21.47
			25	22.00	21.48	21.52	21.43
		50	0	21.50	21.46	21.39	21.47

Band 12

LTE-FDD Band 12				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		23017	23095	23173
					699.7MHz	707.5MHz	715.3MHz
1.4MHz	QPSK	1	0	23.50	23.08	22.79	22.69
			2	23.50	23.07	22.93	22.74
			5	23.50	23.08	22.96	22.76
		3	0	23.50	23.04	22.88	22.92
			2	23.50	23.05	22.88	22.89
			3	23.00	22.97	22.86	22.85
		6	0	22.00	21.89	21.82	21.75
	16QAM	1	0	22.00	21.44	21.95	21.89
			2	22.50	21.39	21.85	22.22
			5	22.00	21.48	21.98	21.89
		3	0	22.00	21.74	21.84	21.71
			2	22.00	21.77	21.90	21.72
			3	22.00	21.75	21.85	21.71
		6	0	21.50	21.07	20.95	21.31
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	23025	23095	23165
					700.5MHz	707.5MHz	714.5MHz
3MHz	QPSK	1	0	23.00	22.92	22.89	22.99
			7	23.00	22.91	22.97	22.95
			14	23.00	22.79	22.96	22.96
		8	0	22.00	21.96	21.88	21.97
			4	22.00	21.94	22.00	21.97
			7	22.50	21.96	21.99	22.02
		15	0	22.50	21.93	22.07	22.00
	16QAM	1	0	22.50	21.74	22.04	22.14
			7	22.50	21.56	22.02	22.17
			14	22.50	21.71	22.06	22.18
		8	0	22.00	21.15	21.09	21.52
			4	22.00	21.14	21.08	21.57
			7	22.00	21.29	21.00	21.52
		15	0	21.50	20.98	21.01	21.46

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	23035	23095	23155
					701.5MHz	707.5MHz	713.5MHz
5MHz	QPSK	1	0	23.50	23.01	22.87	22.96
			13	23.00	22.99	22.91	22.78
			24	23.50	23.06	22.89	22.86
		12	0	22.50	22.04	21.94	21.86
			6	22.50	22.03	21.95	21.92
			13	22.00	21.98	21.98	21.97
		25	0	22.50	22.08	21.97	21.88
	16QAM	1	0	22.50	22.05	21.11	21.98
			13	22.50	22.18	21.19	21.96
			24	22.50	22.17	21.23	21.91
		12	0	21.50	21.06	20.97	20.84
			6	21.50	21.19	20.95	21.36
			13	21.50	21.15	20.95	21.33
		25	0	22.00	21.16	21.01	21.52
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	23060	23095	23130
					704.0MHz	707.5MHz	711.0MHz
10MHz	QPSK	1	0	23.00	22.83	22.77	22.77
			25	23.00	22.85	22.79	22.70
			49	**23.00**	22.79	**22.87**	22.73
		25	0	22.50	22.02	**21.83**	21.73
			13	22.00	21.97	21.79	21.79
			25	22.00	21.88	21.82	21.88
		50	0	23.00	22.83	21.83	21.75
	16QAM	1	0	22.50	21.86	21.38	22.40
			25	23.00	21.90	21.32	22.56
			49	23.00	21.88	21.32	22.51
		25	0	21.00	20.99	20.97	20.73
			13	21.00	20.93	20.91	20.87
			25	21.50	20.98	20.95	21.34
		50	0	21.00	20.99	20.75	20.80

Band 13

LTE-FDD Band 13				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		23205	23230	23255
					779.5MHz	782.0MHz	784.5MHz
5MHz	QPSK	1	0	22.50	22.47	22.49	22.39
			13	23.00	22.53	22.47	22.38
			24	22.50	22.44	22.46	22.42
		12	0	21.50	21.47	21.42	21.48
			6	21.50	21.43	21.49	21.49
			13	22.00	21.52	21.44	21.56
		25	0	22.00	21.51	21.48	21.47
	16QAM	1	0	21.50	21.48	20.62	21.49
			13	22.00	21.60	20.57	21.49
			24	22.00	21.58	20.57	21.60
		12	0	21.00	20.51	20.41	20.52
			6	21.00	20.56	20.81	20.51
			13	21.00	20.47	20.44	20.90
		25	0	21.00	20.53	20.94	20.55

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	23230
					782.0MHz
10MHz	QPSK	1	0	22.50	22.34
			25	**22.50**	**22.40**
			49	22.50	22.38
		25	0	21.50	21.44
			13	21.50	21.41
			25	22.00	**21.47**
		50	0	21.50	21.46
	16QAM	1	0	21.50	21.18
			25	21.50	21.21
			49	22.00	21.23
		25	0	21.00	20.59
			13	21.50	21.07
			25	21.00	20.57
		50	0	21.00	20.90

Band 25

LTE-FDD Band 25				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26047	26365	26683
					1850.7MHz	1882.5MHz	1914.3MHz
1.4MHz	QPSK	1	0	22.00	21.59	21.41	21.53
			2	22.00	21.66	21.41	21.58
			5	22.00	21.63	21.41	21.60
		3	0	22.00	21.57	21.49	21.62
			2	22.00	21.56	21.55	21.63
			3	22.00	21.53	21.49	21.68
		6	0	21.00	20.60	20.52	20.57
	16QAM	1	0	21.00	20.15	20.85	20.65
			2	21.00	20.12	20.91	20.65
			5	21.00	20.13	20.87	20.70
		3	0	21.00	20.56	20.79	20.60
			2	21.00	20.57	20.77	20.58
			3	21.00	20.50	20.78	20.60
		6	0	20.00	19.74	19.65	19.64
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26055	26365	26675
					1851.5MHz	1882.5MHz	1913.5MHz
3MHz	QPSK	1	0	22.00	21.52	21.36	21.48
			7	22.00	21.52	21.37	21.53
			14	22.00	21.55	21.36	21.50
		8	0	21.00	20.64	20.48	20.57
			4	21.00	20.62	20.55	20.55
			7	21.00	20.56	20.53	20.62
		15	0	21.00	20.58	20.50	20.57
	16QAM	1	0	21.50	20.88	20.46	21.36
			7	21.50	20.84	20.45	21.31
			14	21.50	20.89	20.45	21.31
		8	0	20.00	19.85	19.62	19.83
			4	20.00	19.86	19.69	19.83
			7	20.00	19.93	19.68	19.85
		15	0	20.00	19.76	19.65	19.74

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26065	26365	26665
					1852.5MHz	1882.5MHz	1912.5MHz
5MHz	QPSK	1	0	22.00	21.54	21.36	21.51
			13	22.00	21.50	21.40	21.59
			24	22.00	21.50	21.45	21.61
		12	0	21.00	20.60	20.50	20.62
			6	21.00	20.60	20.45	20.63
			13	21.00	20.60	20.60	20.61
		25	0	21.00	20.64	20.55	20.60
	16QAM	1	0	21.00	19.86	20.68	20.69
			13	21.00	19.86	20.71	20.76
			24	21.00	19.89	20.72	20.85
		12	0	20.00	19.67	19.70	19.69
			6	20.00	19.70	19.67	19.75
			13	20.00	19.67	19.71	19.76
		25	0	20.00	19.82	19.80	19.74

LTE-FDD Band 25				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26090	26365	26640
					1855.0MHz	1882.5MHz	1910.0MHz
10MHz	QPSK	1	0	22.00	21.56	21.46	21.63
			25	22.00	21.62	21.49	21.60
			49	22.00	21.58	21.59	21.66
		25	0	21.00	20.52	20.63	20.59
			13	21.00	20.63	20.46	20.54
			25	21.00	20.53	20.49	20.61
		50	0	21.00	20.61	20.53	20.62
	16QAM	1	0	21.00	20.90	19.99	20.75
			25	21.50	20.90	20.04	21.28
			49	21.50	20.84	20.05	21.35
		25	0	20.00	19.74	19.80	19.71
			13	20.00	19.68	19.83	19.68
			25	20.00	19.73	19.80	19.74
		50	0	20.00	19.72	19.64	19.73
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26115	26365	26615
					1857.5MHz	1882.5MHz	1907.5MHz
15MHz	QPSK	1	0	22.00	21.45	21.49	21.53
			38	22.00	21.48	21.57	21.62
			74	22.00	21.53	21.58	21.65
		36	0	21.00	20.60	20.51	20.52
			18	21.00	20.59	20.49	20.48
			39	21.00	20.64	20.50	20.62
		75	0	21.00	20.67	20.48	20.48
	16QAM	1	0	21.50	21.04	21.05	21.29
			38	21.50	21.03	21.00	21.37
			74	21.50	21.02	21.00	21.44
		36	0	20.00	19.75	19.69	19.61
			18	20.00	19.78	19.66	19.68
			39	20.00	19.70	19.68	19.71
		75	0	20.00	19.73	19.71	19.70

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26140	26365	26590
					1860.0MHz	1882.5MHz	1905.0MHz
20MHz	QPSK	1	0	22.00	21.56	21.60	21.46
			50	22.00	21.55	21.64	21.48
			99	**22.00**	21.52	**21.74**	21.56
		50	0	21.00	20.63	20.55	20.57
			25	21.00	20.67	**20.63**	20.65
			50	21.00	20.51	20.48	20.49
		100	0	21.00	20.54	20.57	20.53
	16QAM	1	0	21.50	20.75	21.37	20.63
			50	21.50	20.76	21.47	20.69
			99	22.00	20.65	21.55	20.76
		50	0	20.00	19.78	19.60	19.63
			25	20.00	19.74	19.68	19.70
			50	20.00	19.73	19.66	19.66
		100	0	20.00	19.79	19.72	19.70

Band 26 Part90

LTE-FDD Band 26 Part90				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26697	26740	26783
					814.7MHz	819.0MHz	823.3MHz
1.4MHz	QPSK	1	0	23.50	23.33	23.15	23.30
			2	23.50	23.30	23.25	19.19
			5	23.50	23.28	23.15	19.09
		3	0	23.00	22.87	22.82	20.72
			2	23.00	22.76	22.76	20.72
			3	23.00	22.85	22.76	20.66
		6	0	21.00	20.65	20.62	19.09
	16QAM	1	0	23.50	21.07	23.19	19.11
			2	23.50	21.09	23.18	19.21
			5	22.50	22.37	22.35	19.17
		3	0	22.00	21.77	21.76	19.98
			2	22.00	21.81	21.79	20.23
			3	21.50	20.65	21.44	20.04
		6	0	21.00	20.66	20.91	19.38
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26705	26740	26775
					815.5MHz	819.0MHz	822.5MHz
3MHz	QPSK	1	0	21.50	21.28	21.31	21.20
			7	21.50	21.19	21.23	21.32
			14	21.50	21.27	21.27	21.23
		8	0	19.00	18.73	18.60	18.83
			4	19.50	18.75	18.69	19.19
			7	19.50	18.64	18.69	19.18
		15	0	19.50	18.69	18.70	19.14
	16QAM	1	0	21.50	21.08	20.58	20.88
			7	22.00	21.56	21.01	20.56
			14	21.50	20.60	21.15	21.14
		8	0	19.00	18.97	18.84	18.85
			4	19.50	18.80	18.90	19.40
			7	19.50	19.01	18.78	19.48
		15	0	19.50	18.76	18.68	19.30

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LTE-FDD Band 26 Part90				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26715	26740	26765
					816.5MHz	819.0MHz	821.5MHz
5MHz	QPSK	1	0	21.50	21.19	21.23	21.09
			13	21.50	21.14	21.25	21.34
			24	21.50	21.23	21.27	21.28
		12	0	19.00	18.71	18.85	18.85
			6	19.00	18.63	18.71	18.80
			13	19.50	18.87	18.86	19.17
		25	0	19.00	18.81	18.71	18.76
	16QAM	1	0	21.00	19.89	20.46	20.78
			13	21.00	20.66	19.90	20.61
			24	21.00	20.37	20.90	20.23
		12	0	19.00	18.67	18.63	18.90
			6	19.00	18.71	18.66	18.75
			13	19.50	18.66	18.69	19.19
		25	0	19.00	18.81	18.57	18.78
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26740		
					819.0MHz		
10MHz	QPSK	1	0	**23.50**	**23.26**		
			25	23.50	23.20		
			49	23.50	23.25		
		25	0	21.50	**21.35**		
			13	21.50	21.31		
			25	21.50	21.28		
		50	0	21.50	21.32		
	16QAM	1	0	23.50	23.25		
			25	23.50	23.49		
			49	23.00	22.68		
		25	0	21.50	21.34		
			13	21.50	21.38		
			25	22.00	21.56		
		50	0	21.50	21.33		

Band 26 Part22

LTE-FDD Band 26 Part22				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26797	26915	27033
					824.7MHz	836.5MHz	848.3MHz
1.4MHz	QPSK	1	0	23.50	23.27	23.05	18.64
			2	23.50	23.24	23.22	18.69
			5	23.50	23.33	23.16	18.66
		3	0	23.00	22.81	22.69	20.62
			2	23.00	22.79	22.70	20.73
			3	23.00	22.74	22.70	20.70
		6	0	21.00	20.73	20.76	18.73
	16QAM	1	0	22.50	20.24	22.13	18.58
			2	23.00	22.90	22.89	18.57
			5	23.00	22.98	22.86	21.59
		3	0	22.00	21.65	21.52	20.15
			2	22.00	21.74	21.59	19.51
			3	22.00	20.67	21.52	19.62
		6	0	21.00	20.72	20.75	18.77

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26805	26915	27025
					825.5MHz	836.5MHz	847.5MHz
3MHz	QPSK	1	0	21.50	21.39	21.09	21.12
			7	21.50	21.24	21.22	21.01
			14	21.50	21.16	21.14	21.24
		8	0	19.50	18.84	18.74	19.09
			4	19.50	18.70	18.65	19.05
			7	19.00	18.64	18.57	18.74
		15	0	19.00	18.66	18.64	18.98
	16QAM	1	0	21.50	20.32	20.71	21.43
			7	22.00	20.89	20.36	21.85
			14	21.50	20.87	21.04	20.53
		8	0	19.50	18.99	18.78	19.40
			4	19.50	18.99	18.77	19.22
			7	19.00	18.76	18.93	18.89
		15	0	19.50	18.83	18.72	19.16
LTE-FDD Band 26 Part22				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		26815	26915	27015
					826.5MHz	836.5MHz	846.5MHz
5MHz	QPSK	1	0	21.50	21.29	21.16	21.24
			13	21.50	21.21	21.15	21.03
			24	21.50	21.13	21.14	21.24
		12	0	19.50	18.81	18.73	19.12
			6	19.50	18.67	18.65	19.06
			13	19.50	18.70	18.67	19.10
		25	0	19.50	18.72	18.68	19.05
	16QAM	1	0	21.00	20.48	20.77	20.22
			13	21.50	19.82	20.45	21.11
			24	21.00	20.82	20.17	20.52
		12	0	19.50	18.66	18.66	19.17
			6	19.00	18.64	18.58	18.97
			13	19.00	18.52	18.64	18.99
		25	0	19.50	18.73	18.59	19.23
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26840	26915	26990
					829.0MHz	836.5MHz	844.0MHz
10MHz	QPSK	1	0	23.50	23.31	23.05	23.23
			25	23.50	23.27	23.18	23.31
			49	23.50	23.14	23.19	23.17
		25	0	21.50	21.29	21.22	21.23
			13	21.50	21.27	21.21	21.20
			25	22.00	21.59	21.16	21.10
		50	0	21.50	21.21	21.16	21.28
	16QAM	1	0	23.50	23.28	22.48	22.86
			25	23.50	23.26	23.21	22.95
			49	23.50	22.95	23.46	22.94
		25	0	21.50	21.34	21.48	21.38
			13	21.50	21.24	21.29	21.35
			25	22.00	21.73	21.27	21.32
		50	0	21.50	21.27	21.30	21.37

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	26865	26915	26965
					831.5MHz	836.5MHz	841.5MHz
15MHz	QPSK	1	0	**23.50**	**23.25**	23.19	23.02
			38	23.50	23.03	23.13	23.10
			74	23.50	23.17	23.05	23.14
		36	0	21.50	21.24	21.18	21.14
			18	22.00	**21.52**	21.13	21.29
			39	21.50	21.20	21.20	21.03
		75	0	22.00	21.57	21.18	21.15
	16QAM	1	0	23.50	22.97	23.45	22.98
			38	23.50	23.20	22.91	23.05
			74	23.50	23.41	23.21	22.97
		36	0	21.50	21.30	21.31	21.20
			18	22.00	21.70	21.36	21.22
			39	21.50	21.28	21.20	21.26
		75	0	22.00	21.75	21.32	21.30

Band 41

LTE-TDD Band 41				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		39675	40620	41565
					2498.5MHz	2593.0MHz	2687.5MHz
5MHz	QPSK	1	0	21.00	20.26	20.99	20.89
			13	21.50	20.26	20.95	21.02
			24	21.00	20.25	20.84	20.83
		12	0	20.50	19.40	20.06	20.09
			6	20.50	19.29	19.99	20.02
			13	20.50	19.32	20.08	19.95
		25	0	20.00	19.35	19.94	19.97
	16QAM	1	0	21.00	20.99	20.58	20.80
			13	21.00	20.91	20.76	20.59
			24	21.00	20.79	20.58	20.60
		12	0	19.50	18.44	19.04	19.05
			6	19.50	18.31	19.08	19.11
			13	19.50	18.18	19.06	19.05
		25	0	19.50	18.53	19.14	19.23
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	39700	40620	41540
					2501.0MHz	2593.0MHz	2685.0MHz
10MHz	QPSK	1	0	21.00	20.38	20.90	20.97
			25	21.00	20.39	20.94	20.82
			49	21.00	20.31	20.92	20.89
		25	0	20.00	19.41	19.89	19.97
			13	20.00	19.35	19.98	19.95
			25	20.00	19.32	19.90	19.95
		50	0	20.00	18.94	19.56	19.50
	16QAM	1	0	22.00	20.47	21.56	21.11
			25	21.50	19.85	21.39	20.45
			49	22.00	20.06	21.66	20.40
		25	0	20.00	18.81	19.17	19.51
			13	19.50	18.78	19.20	19.36
			25	19.50	18.83	19.34	19.28
		50	0	19.00	18.11	18.83	18.65

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LTE-TDD Band 41				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		39725	40620	41515
					2503.5MHz	2593.0MHz	2682.5MHz
15MHz	QPSK	1	0	21.50	20.25	21.01	21.18
			38	21.50	20.22	20.88	21.24
			74	21.50	20.22	21.02	20.93
		36	0	20.00	19.32	19.88	19.98
			18	20.50	19.32	19.97	20.01
			39	20.50	19.27	20.01	20.01
		75	0	20.00	18.99	19.58	19.61
	16QAM	1	0	22.00	19.88	21.51	20.68
			38	22.00	19.86	21.59	20.52
			74	22.00	19.81	21.67	20.64
		36	0	19.50	18.38	18.97	19.21
			18	19.50	18.38	19.16	19.30
			39	19.50	18.66	19.13	19.07
		75	0	19.00	18.16	18.83	18.85
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	39750	40620	41490
					2506.0MHz	2593.0MHz	2680.0MHz
20MHz	QPSK	1	0	**21.50**	20.48	20.84	**21.08**
			50	21.00	20.35	20.87	20.91
			99	21.00	20.57	20.83	20.86
		50	0	20.00	19.25	19.97	19.99
			25	20.00	19.26	19.93	19.96
			50	20.50	19.31	19.88	**20.02**
		100	0	20.00	19.00	19.65	19.59
	16QAM	1	0	22.00	20.77	20.61	21.81
			50	21.50	20.63	20.76	21.41
			99	21.50	20.91	20.63	21.46
		50	0	19.50	18.46	19.24	19.37
			25	19.50	18.55	19.25	19.29
			50	19.50	18.54	19.24	19.28
		100	0	19.50	18.46	19.17	19.18

Band 66

LTE-FDD Band 66				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		131979	132322	132665
					1710.7MHz	1745.0MHz	1779.3MHz
1.4MHz	QPSK	1	0	23.00	22.89	22.68	21.71
			2	23.00	22.93	22.69	21.76
			5	23.00	22.90	22.79	21.85
		3	0	23.00	22.89	22.81	21.79
			2	23.00	22.87	22.89	21.74
			3	23.00	22.88	22.80	21.83
		6	0	22.00	21.90	21.91	21.80
	16QAM	1	0	22.50	21.46	22.19	21.77
			2	22.50	21.36	22.21	21.75
			5	22.50	21.47	22.15	21.73
		3	0	22.00	21.91	21.70	21.72
			2	22.00	21.87	21.65	21.76
			3	22.00	21.91	21.71	21.74
		6	0	22.00	21.01	21.12	21.74

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	131987	132322	132657
					1711.5MHz	1745.0MHz	1778.5MHz
3MHz	QPSK	1	0	23.50	22.83	23.01	22.79
			7	23.00	22.81	22.93	22.71
			14	23.00	22.79	22.96	22.73
		8	0	22.00	21.87	21.84	21.76
			4	22.00	21.84	21.94	21.83
			7	22.00	21.83	21.95	21.79
		15	0	22.00	21.81	21.88	21.78
	16QAM	1	0	23.00	22.21	21.68	22.75
			7	23.00	22.17	21.67	22.67
			14	23.00	22.14	21.61	22.64
		8	0	21.50	21.21	21.34	21.08
			4	21.50	21.20	21.35	21.06
			7	21.50	21.16	21.35	21.02
		15	0	21.50	21.04	21.01	20.94
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	131997	132322	132647
					1712.5MHz	1745.0MHz	1777.5MHz
5MHz	QPSK	1	0	23.00	22.79	22.82	22.88
			13	23.00	22.78	22.68	22.84
			24	23.00	22.77	22.65	22.83
		12	0	22.00	21.75	21.84	21.72
			6	22.00	21.89	21.73	21.72
			13	22.00	21.96	21.82	21.73
		25	0	22.00	21.93	21.74	21.71
	16QAM	1	0	22.00	21.08	22.00	21.88
			13	22.00	21.07	21.93	21.91
			24	22.00	21.11	21.97	21.94
		12	0	21.50	21.02	20.99	20.75
			6	21.50	21.03	20.96	20.69
			13	21.00	20.97	20.99	20.72
		25	0	21.50	21.09	21.00	20.78

Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	132022	132322	132622
					1715.0MHz	1745.0MHz	1775.0MHz
10MHz	QPSK	1	0	23.00	22.71	22.89	22.70
			25	23.00	22.83	22.82	22.76
			49	23.00	22.82	22.81	22.68
		25	0	22.00	21.88	21.90	21.76
			13	22.00	21.94	21.90	21.65
			25	22.00	21.87	21.81	21.75
		50	0	22.00	21.98	21.87	21.71
	16QAM	1	0	23.00	22.32	21.74	22.65
			25	22.50	22.37	21.75	22.00
			49	22.50	22.34	21.35	22.01
		25	0	21.50	21.02	21.12	21.00
			13	21.50	21.00	21.18	21.04
			25	21.50	21.08	21.09	21.04
		50	0	21.50	21.03	20.97	21.00

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LTE-FDD Band 66				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		132047	132322	132597
					1717.5MHz	1745.0MHz	1772.5MHz
15MHz	QPSK	1	0	23.00	22.70	22.71	22.67
			38	23.00	22.76	22.75	22.65
			74	23.00	22.84	22.66	22.66
		36	0	22.00	21.84	21.77	21.75
			18	22.00	21.87	21.86	21.81
			39	22.00	21.82	21.79	21.68
		75	0	22.00	21.84	21.86	21.84
	16QAM	1	0	23.00	22.20	22.17	22.56
			38	23.00	22.21	22.11	22.70
			74	23.00	22.26	22.09	22.63
		36	0	21.50	21.06	20.98	20.92
			18	21.50	21.17	21.01	20.92
			39	21.50	21.13	21.01	20.84
		75	0	21.50	21.04	21.04	20.92
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	132072	132322	132572
					1720.0MHz	1745.0MHz	1770.0MHz
20MHz	QPSK	1	0	23.00	23.00	22.84	22.84
			50	23.50	23.04	22.89	23.04
			99	**23.50**	**23.09**	22.81	22.95
		50	0	22.00	21.86	21.87	21.81
			25	22.00	**21.90**	21.85	21.87
			50	22.00	21.82	21.89	21.76
		100	0	22.00	21.89	21.87	21.75
	16QAM	1	0	23.00	21.86	22.90	22.13
			50	23.00	21.95	22.79	22.18
			99	23.00	21.95	22.72	22.18
		50	0	21.50	21.09	20.93	20.98
			25	21.50	21.10	20.90	21.06
			50	21.50	21.16	20.95	20.94
		100	0	21.50	21.08	21.02	20.89

Band 71

LTE-FDD Band 71				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		133147	133297	133447
					665.5MHz	680.5MHz	695.5MHz
5MHz	QPSK	1	0	22.00	21.77	21.67	21.36
			13	22.00	21.72	21.57	21.44
			24	22.50	22.12	21.51	21.38
		12	0	21.00	20.67	20.59	20.43
			6	21.00	20.74	20.48	20.57
			13	21.00	20.65	20.48	20.53
		25	0	21.00	20.75	20.55	20.54
	16QAM	1	0	21.50	21.24	20.30	20.98
			13	21.50	21.21	20.15	21.07
			24	22.00	21.74	20.22	21.08
		12	0	20.50	19.64	20.04	19.93
			6	20.50	19.60	20.02	19.55
			13	20.50	19.68	20.01	19.46
		25	0	20.50	19.60	20.14	19.65

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	133172	133297	133422
					668.0MHz	680.5MHz	693.0MHz
10MHz	QPSK	1	0	22.00	21.84	21.65	21.68
			25	22.50	22.19	21.64	21.69
			49	22.00	21.76	21.61	21.60
		25	0	21.00	20.78	20.73	20.45
			13	21.50	21.24	20.49	20.62
			25	21.00	20.76	20.55	20.60
		50	0	21.50	21.20	20.55	20.68
	16QAM	1	0	22.50	21.68	20.70	22.07
			25	22.50	22.06	20.60	21.79
			49	22.00	21.68	20.58	21.72
		25	0	20.00	19.77	19.67	19.39
			13	20.50	20.18	20.25	19.59
			25	20.50	20.24	20.19	19.58
		50	0	20.50	20.20	20.07	19.51
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	133197	133297	133397
					670.5MHz	680.5MHz	690.5MHz
15MHz	QPSK	1	0	22.00	21.73	21.63	21.43
			38	22.00	21.67	21.57	21.40
			74	22.00	21.59	21.50	21.44
		36	0	21.50	21.13	20.66	20.93
			18	21.00	20.67	20.58	20.51
			39	21.50	21.16	20.68	20.42
		75	0	21.00	20.62	20.59	20.46
	16QAM	1	0	22.50	21.41	22.31	21.25
			38	22.00	21.36	21.81	21.11
			74	22.50	21.38	22.19	21.16
		36	0	20.50	20.24	19.49	20.03
			18	20.50	20.17	20.10	19.57
			39	20.50	20.10	19.56	20.03
		75	0	20.50	20.07	20.09	19.52

Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	133222	133322	133372
					673.0MHz	683.0MHz	688.0MHz
20MHz	QPSK	1	0	**22.00**	**21.74**	20.10	19.49
			50	22.00	21.66	20.01	19.94
			99	22.00	21.54	19.66	19.49
		50	0	21.50	**21.16**	18.59	18.42
			25	21.00	20.73	18.96	18.94
			50	21.00	20.65	18.96	18.39
		100	0	19.50	18.59	19.00	19.01
	16QAM	1	0	20.50	19.76	20.04	18.88
			50	20.50	19.74	20.02	19.17
			99	20.50	20.17	19.40	18.78
		50	0	18.50	18.18	16.91	16.68
			25	18.50	17.97	17.60	18.03
			50	19.00	18.45	18.40	18.75
		100	0	18.50	18.04	18.09	18.23

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8.4 Wi-Fi

2.4G

Band (GHz)	Mode	Channel	Freq. (MHz)	Average Power (dBm)	Maximum Tune-up(dBm)	SAR Test Require.
2.4g Wifi (2.4~2.4835)	802.11b	1	2412	14.43	14.50	No
		6	2437	**15.31**	**15.50**	Yes
		11	2462	12.57	13.00	No
	802.11g	1	2412	14.96	15.00	No
		6	2437	16.19	16.50	No
		11	2462	12.42	12.50	No
	802.11n(HT20)	1	2412	15.59	16.00	No
		6	2437	**16.67**	**17.00**	Yes
		11	2462	13.05	13.50	No
	802.11n(HT40)	3	2422	15.29	15.50	No
		6	2437	15.66	16.00	No
		9	2452	12.95	13.00	No
Note: SAR is not required for the following 2.4 GHz OFDM conditions as the highest reported SAR for DSSS is adjusted by the ratio of OFDM to DSSS specified maximum output power and the adjusted SAR is ≤ 1.2W/kg.						

5G

Band (GHz)	Mode	Channel	Freq. (MHz)	Average Power (dBm)	Maximum Tune-up(dBm)	SAR Test Require.
U-NII-1 (5.150~5.250)	802.11a	36	5180	**11.52**	**12.00**	Yes
		40	5200	10.40	10.50	No
		48	5240	9.97	10.00	No
	802.11n(HT20)	36	5180	11.28	11.50	No
		40	5200	9.90	10.00	No
		48	5240	9.54	10.00	No
	802.11ac(VHT20)	36	5180	10.86	11.00	No
		40	5200	9.76	10.00	No
		48	5240	9.31	9.50	No
	802.11n(HT40)	38	5190	11.03	11.50	No
		46	5230	10.29	10.50	No
	802.11ac(VHT40)	38	5190	10.94	11.00	No
		46	5230	10.25	10.50	No
	802.11ac(VHT80)	42	5210	10.24	10.50	No

Band (GHz)	Mode	Channel	Freq. (MHz)	Average Power (dBm)	Maximum Tune-up(dBm)	SAR Test Require.
U-NII-3 (5.725~5.850)	802.11a	149	5745	12.20	12.50	No
		157	5785	10.44	10.50	No
		165	5825	11.90	12.00	No
	802.11n(HT20)	149	5745	**12.61**	**13.00**	Yes
		157	5785	10.20	10.50	No
		165	5825	11.54	12.00	No
	802.11ac(VHT20)	149	5745	11.42	11.50	No
		157	5785	10.25	10.50	No
		165	5825	11.77	12.00	No
	802.11n(HT40)	151	5755	11.87	12.00	No
		159	5795	10.85	11.00	No
	802.11ac(VHT40)	151	5755	11.89	12.00	No
		159	5795	10.58	11.00	No
	802.11ac(VHT80)	155	5775	10.93	11.00	No

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8.5 Bluetooth

	Mode	Maximum Tune-up(dBm)	Average Conducted Output Power (dBm)		
EDR			0	39	78
			2402MHz	2441MHz	2480MHz
	GFSK	5.00	4.56	3.36	2.04
	π/4QPSK	5.00	4.56	4.52	2.69
	8DPSK	**5.00**	4.79	**4.80**	2.90
BLE	Mode	Maximum Tune-up(dBm)	Average Conducted Output Power (dBm)		
			0	20	39
			2402MHz	2440MHz	2480MHz
	1Mbps	-1.50	-1.72	-3.21	-4.14
	2Mbps	-1.50	-1.65	-3.12	-3.95

Channel	Frequency (GHz)	Max. Tune-up Power (dBm)	Max. Power (mW)	Test distance (mm)	Exclusion thresholds for 1-g SAR(mW)	RF exposure evaluation required
39	2.441	5.00	3.16	0	2.75	Yes
39	2.441	5.00	3.16	10	10.28	No

Note

1. Per KDB 447498 D04 Interim General RF Exposure Guidance v01, the 1-g SAR test exclusion thresholds for 300 MHz to 6 GHz at *test separation distances* ≤ 40 cm are determined by:

$$P_{th}\,(\mathrm{mW}) = \begin{cases} ERP_{20\,\mathrm{cm}}(d/20\,\mathrm{cm})^x & d \le 20\,\mathrm{cm} \\ ERP_{20\,\mathrm{cm}} & 20\,\mathrm{cm} < d \le 40\,\mathrm{cm} \end{cases} \quad (B.2)$$

where

$$x = -\log_{10}\left(\frac{60}{ERP_{20\,\mathrm{cm}}\sqrt{f}}\right)$$

$$P_{th}\,(\mathrm{mW}) = ERP_{20\,\mathrm{cm}}\,(\mathrm{mW}) = \begin{cases} 2040f & 0.3\,\mathrm{GHz} \le f < 1.5\,\mathrm{GHz} \\ 3060 & 1.5\,\mathrm{GHz} \le f \le 6\,\mathrm{GHz} \end{cases} \quad (B.1)$$

and f is in GHz, d is the separation distance (cm), and ERP_{20cm} is per Formula (B.1).

*When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine estimated SAR.

2. Per KDB 248227 D01 v02r02, choose the highest output power channel to test SAR and determine further SAR exclusion.
3. The output power of all data rate were prescan, just the worst case (the lowest data rate) of all mode were shown in report.

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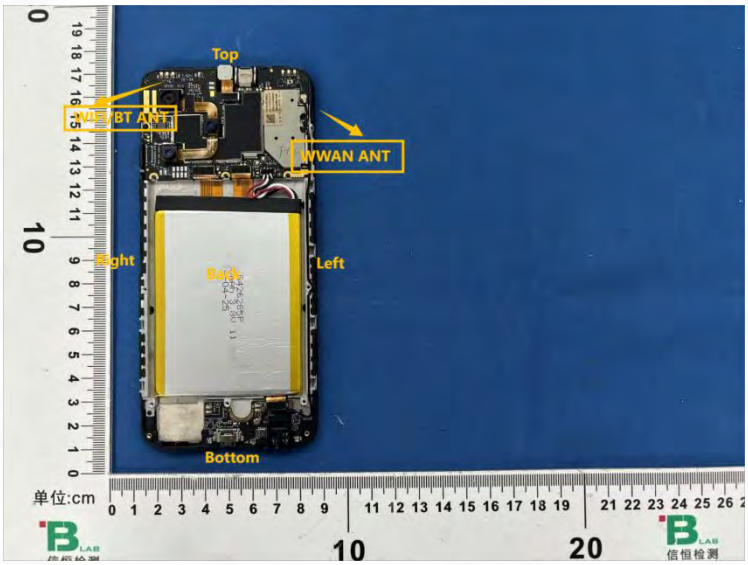
9. Test Exclusion Consideration

Antenna information:



WWAN Main Antenna	GSM/WCDMA/LTE TX/RX
WLAN/BT Antenna	WLAN/BT TX/RX

Note:
1. KDB 447498 D04v01, particular DUT edges were not required to be evaluated for SAR if the antenna-to-edge distance is greater than 2.5cm.
2. Per KDB648474 D04,10-g extremity SAR is not required when Body-Worn mode 1-g reported SAR<1.2W/Kg.

Distance of The Antenna to the EUT surface and edge (mm)						
Antenna	Front Side (mm)	Back Side (mm)	Left Edge (mm)	Right Edge (mm)	Top Edge (mm)	Bottom Edge (mm)
WWAN	<25	<25	<25	70	<25	147
BT/Wifi	<25	<25	63	<25	<25	157
Positions for SAR tests: Hotspot mode						
Antenna	Front Side (mm)	Back Side (mm)	Left Edge (mm)	Right Edge (mm)	Top Edge (mm)	Bottom Edge (mm)
WWAN	Yes	Yes	Yes	No	Yes	No
BT/Wifi	Yes	Yes	No	Yes	Yes	No

9.1 SAR Test Exclusion Consideration Table

Per KDB 447498 requires when the standalone SAR test exclusion of section 4.3.1 is applied to an antenna that transmits simultaneously with other antennas, the standalone SAR must be estimated according to the following format to determine simultaneous transmission SAR test exclusion:

(max.power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] · [√f(GHz) / x] W/kg for test separation distances ≤ 50 mm;
where x = 7.5 for 1-g SAR, and x= 18.75 for 10-g SAR.
0.4 W/Kg for 1-g SAR and 1.0 W/kg for 10-g SAR, when the test separation distances is > 50 mm

Mode	Channel	Frequency (GHz)	Max tune-up power (dBm)	Max. Power (mW)	Exposure Position	Body-worn
					Test Dist.(mm)	10
BT	39	2.441	5.00	3.16	Estimated SAR(W/kg)	0.066

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10. Test Result

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GSM 850 (voice)	Left Cheek	251	848.8	1.720	1.005	100.00	1.000	28.10	28.50	1.096	1.101	/
	Left Tilt	251	848.8	0.860	0.500	100.00	1.000	28.10	28.50	1.096	0.548	/
	Right Cheek	128	824.2	-0.630	0.997	100.00	1.000	27.82	28.00	1.042	1.039	/
	Right Cheek	190	836.6	-1.540	0.992	100.00	1.000	27.77	28.00	1.054	1.046	/
	Right Cheek	251	848.8	-2.860	1.017	100.00	1.000	28.10	28.50	1.096	**1.115**	1#
	Right Cheek -repeat	251	848.8	1.220	1.004	100.00	1.000	28.10	28.50	1.096	1.100	/
	Right Tilt	251	848.8	-3.150	0.506	100.00	1.000	28.10	28.50	1.096	0.555	/
Body(10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GSM 850 (voice)	Front	251	848.8	-1.430	0.308	100.00	1.000	28.10	28.50	1.096	0.338	/
	Back	251	848.8	4.180	0.329	100.00	1.000	28.10	28.50	1.096	0.361	/
	Left	251	848.8	-3.170	0.288	100.00	1.000	28.10	28.50	1.096	0.316	/
	Top	251	848.8	1.310	0.256	100.00	1.000	28.10	28.50	1.096	0.281	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GPRS 850+2slots	Front	128	824.2	-3.520	0.324	100.00	1.000	25.79	26.00	1.050	0.340	/
	Back	128	824.2	-0.590	0.350	100.00	1.000	25.79	26.00	1.050	**0.368**	2#
	Left	128	824.2	0.990	0.301	100.00	1.000	25.79	26.00	1.050	0.316	/
	Top	128	824.2	-1.130	0.278	100.00	1.000	25.79	26.00	1.050	0.292	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GSM 1900 (voice)	Left Cheek	512	1850.2	-1.150	0.672	100.00	1.000	23.07	23.50	1.104	0.742	/
	Left Tilt	512	1850.2	-0.250	0.340	100.00	1.000	23.07	23.50	1.104	0.375	/
	Right Cheek	512	1850.2	1.230	0.679	100.00	1.000	23.07	23.50	1.104	**0.750**	3#
	Right Tilt	512	1850.2	0.700	0.345	100.00	1.000	23.07	23.50	1.104	0.381	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GSM 1900 (voice)	Front	512	1850.2	1.220	0.694	100.00	1.000	23.07	23.50	1.104	0.766	/
	Back	512	1850.2	-2.330	0.723	100.00	1.000	23.07	23.50	1.104	0.798	/
	Left	512	1850.2	1.040	0.664	100.00	1.000	23.07	23.50	1.104	0.733	/
	Top	512	1850.2	-3.270	0.636	100.00	1.000	23.07	23.50	1.104	0.702	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GPRS 1900+3slots	Front	810	1909.8	-0.940	0.746	100.00	1.000	20.34	20.50	1.038	0.774	/
	Back	810	1909.8	3.280	0.770	100.00	1.000	20.34	20.50	1.038	**0.799**	4#
	Left	810	1909.8	1.760	0.721	100.00	1.000	20.34	20.50	1.038	0.748	/
	Top	810	1909.8	-2.320	0.698	100.00	1.000	20.34	20.50	1.038	0.725	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 2 (RMC*)	Left Cheek	9538	1907.6	-1.000	0.952	100.00	1.000	22.00	22.00	1.000	0.952	/
	Left Tilt	9538	1907.6	0.820	0.472	100.00	1.000	22.00	22.00	1.000	0.472	/
	Right Cheek	9262	1852.4	2.090	0.936	100.00	1.000	21.95	22.00	1.012	0.947	/
	Right Cheek	9400	1880.0	1.470	0.933	100.00	1.000	21.92	22.00	1.019	0.951	/
	Right Cheek	9538	1907.6	-2.650	0.957	100.00	1.000	22.00	22.00	1.000	**0.957**	5#
	Right Cheek -repeat	9538	1907.6	1.660	0.950	100.00	1.000	22.00	22.00	1.000	0.950	/
	Right Tilt	9538	1907.6	-3.330	0.478	100.00	1.000	22.00	22.00	1.000	0.478	/
Body(hotspot open, 10mm Gap)												

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Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 2 (RMC*)	Front	9538	1907.6	-4.120	0.587	100.00	1.000	22.00	22.00	1.000	0.587	/
	Back	9538	1907.6	-2.270	0.616	100.00	1.000	22.00	22.00	1.000	**0.616**	6#
	Left	9538	1907.6	-2.850	0.563	100.00	1.000	22.00	22.00	1.000	0.563	/
	Top	9538	1907.6	-3.810	0.532	100.00	1.000	22.00	22.00	1.000	0.532	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 4 (RMC*)	Left Cheek	1312	1712.4	3.570	0.982	100.00	1.000	22.30	22.50	1.047	1.028	/
	Left Tilt	1312	1712.4	-0.460	0.480	100.00	1.000	22.30	22.50	1.047	0.503	/
	Right Cheek	1312	1712.4	1.730	0.986	100.00	1.000	22.30	22.50	1.047	**1.032**	7#
	Right Cheek -repeat	1312	1712.4	2.480	0.980	100.00	1.000	22.30	22.50	1.047	1.026	/
	Right Cheek	1413	1732.6	4.030	0.975	100.00	1.000	22.27	22.50	1.054	1.028	/
	Right Cheek	1513	1752.6	-1.370	0.960	100.00	1.000	22.19	22.50	1.074	1.043	/
	Right Tilt	1312	1712.4	-3.530	0.485	100.00	1.000	22.30	22.50	1.047	0.508	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 4 (RMC*)	Front	1312	1712.4	2.020	0.422	100.00	1.000	22.30	22.50	1.047	0.442	/
	Back	1312	1712.4	3.200	0.443	100.00	1.000	22.30	22.50	1.047	**0.464**	8#
	Left	1312	1712.4	-1.560	0.403	100.00	1.000	22.30	22.50	1.047	0.422	/
	Top	1312	1712.4	-0.520	0.377	100.00	1.000	22.30	22.50	1.047	0.395	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 5 (RMC*)	Left Cheek	4132	826.4	2.660	0.138	100.00	1.000	23.79	24.00	1.050	0.145	/
	Left Tilt	4132	826.4	1.020	0.055	100.00	1.000	23.79	24.00	1.050	0.058	/
	Right Cheek	4132	826.4	-3.410	0.143	100.00	1.000	23.79	24.00	1.050	**0.150**	9#
	Right Tilt	4132	826.4	-3.190	0.061	100.00	1.000	23.79	24.00	1.050	0.064	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 5 (RMC*)	Front	4132	826.4	4.150	0.137	100.00	1.000	23.79	24.00	1.050	**0.144**	10#
	Back	4132	826.4	-2.970	0.113	100.00	1.000	23.79	24.00	1.050	0.119	/
	Left	4132	826.4	2.700	0.095	100.00	1.000	23.79	24.00	1.050	0.100	/
	Top	4132	826.4	-4.170	0.083	100.00	1.000	23.79	24.00	1.050	0.087	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 2 (BW: 20MHz)	1RB	Left Cheek	18700	1860.0	-1.030	0.995	100.00	1.000	22.83	23.00	1.040	1.035	/
		Left Tilt	18700	1860.0	3.460	0.507	100.00	1.000	22.83	23.00	1.040	0.527	/
		Right Cheek	18700	1860.0	-2.640	1.004	100.00	1.000	22.83	23.00	1.040	**1.044**	11#
		Right Cheek -repeat	18700	1860.0	0.880	0.997	100.00	1.000	22.83	23.00	1.040	1.037	/
		Right Cheek	18900	1880.0	1.480	0.932	100.00	1.000	22.52	23.00	1.117	1.041	/
		Right Cheek	19100	1900.0	2.210	0.952	100.00	1.000	22.76	23.00	1.057	1.006	/
		Right Tilt	18700	1860.0	-0.830	0.512	100.00	1.000	22.83	23.00	1.040	0.532	/
	50%RB	Left Cheek	18700	1860.0	0.960	0.981	100.00	1.000	21.60	22.00	1.096	1.075	/
		Left Tilt	18700	1860.0	-3.780	0.480	100.00	1.000	21.60	22.00	1.096	0.526	/
		Right Cheek	18700	1860.0	1.560	0.988	100.00	1.000	21.60	22.00	1.096	1.083	/
		Right Tilt	18700	1860.0	0.890	0.486	100.00	1.000	21.60	22.00	1.096	0.533	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 2 (BW: 20MHz)	1RB	Front	18700	1860.0	-2.210	0.665	100.00	1.000	22.83	23.00	1.040	0.692	/
		Back	18700	1860.0	3.090	0.691	100.00	1.000	22.83	23.00	1.040	**0.719**	12#
		Left	18700	1860.0	1.620	0.642	100.00	1.000	22.83	23.00	1.040	0.668	/

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		Top	18700	1860.0	-3.610	0.625	100.00	1.000	22.83	23.00	1.040	0.650	/
	50%RB	Front	18700	1860.0	-1.240	0.643	100.00	1.000	21.60	22.00	1.096	0.705	/
		Back	18700	1860.0	-3.680	0.671	100.00	1.000	21.60	22.00	1.096	0.735	/
		Left	18700	1860.0	-1.580	0.619	100.00	1.000	21.60	22.00	1.096	0.678	/
		Top	18700	1860.0	1.220	0.600	100.00	1.000	21.60	22.00	1.096	0.658	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 4 (BW: 20MHz)	1RB	Left Cheek	20050	1720.0	1.290	0.720	100.00	1.000	22.61	23.00	1.094	0.788	/
		Left Tilt	20050	1720.0	3.780	0.350	100.00	1.000	22.61	23.00	1.094	0.383	/
		Right Cheek	20050	1720.0	-0.490	0.725	100.00	1.000	22.61	23.00	1.094	**0.793**	13#
		Right Tilt	20050	1720.0	-2.650	0.354	100.00	1.000	22.61	23.00	1.094	0.387	/
	50%RB	Left Cheek	20050	1720.0	-3.690	0.692	100.00	1.000	21.50	22.00	1.122	0.776	/
		Left Tilt	20050	1720.0	2.720	0.335	100.00	1.000	21.50	22.00	1.122	0.376	/
		Right Cheek	20050	1720.0	0.170	0.703	100.00	1.000	21.50	22.00	1.122	0.789	/
		Right Tilt	20050	1720.0	1.070	0.341	100.00	1.000	21.50	22.00	1.122	0.383	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 4 (BW: 20MHz)	1RB	Front	20175	1732.5	-0.590	0.705	100.00	1.000	22.61	23.00	1.094	0.771	/
		Back	20175	1732.5	-3.100	0.729	100.00	1.000	22.61	23.00	1.094	**0.798**	14#
		Left	20175	1732.5	-3.970	0.675	100.00	1.000	22.61	23.00	1.094	0.738	/
		Top	20175	1732.5	-1.210	0.642	100.00	1.000	22.61	23.00	1.094	0.702	/
	50%RB	Front	20175	1732.5	-2.790	0.682	100.00	1.000	21.50	22.00	1.122	0.765	/
		Back	20175	1732.5	-3.630	0.702	100.00	1.000	21.50	22.00	1.122	0.788	/
		Left	20175	1732.5	-1.850	0.653	100.00	1.000	21.50	22.00	1.122	0.733	/
		Top	20175	1732.5	-3.630	0.634	100.00	1.000	21.50	22.00	1.122	0.711	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 5 (BW: 10MHz)	1RB	Left Cheek	20450	829.0	-1.140	0.182	100.00	1.000	23.30	23.50	1.047	0.191	/
		Left Tilt	20450	829.0	3.460	0.087	100.00	1.000	23.30	23.50	1.047	0.091	/
		Right Cheek	20450	829.0	-2.620	0.188	100.00	1.000	23.30	23.50	1.047	**0.197**	15#
		Right Tilt	20450	829.0	-2.400	0.093	100.00	1.000	23.30	23.50	1.047	0.097	/
	50%RB	Left Cheek	20450	829.0	1.410	0.172	100.00	1.000	22.33	22.50	1.040	0.179	/
		Left Tilt	20450	829.0	-3.750	0.076	100.00	1.000	22.33	22.50	1.040	0.079	/
		Right Cheek	20450	829.0	-0.290	0.176	100.00	1.000	22.33	22.50	1.040	0.183	/
		Right Tilt	20450	829.0	0.920	0.082	100.00	1.000	22.33	22.50	1.040	0.085	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 5 (BW: 10MHz)	1RB	Front	20450	829.0	-3.540	0.149	100.00	1.000	23.30	23.50	1.047	**0.156**	16#
		Back	20450	829.0	3.650	0.126	100.00	1.000	23.30	23.50	1.047	0.132	/
		Left	20450	829.0	-0.420	0.104	100.00	1.000	23.30	23.50	1.047	0.109	/
		Top	20450	829.0	-2.980	0.085	100.00	1.000	23.30	23.50	1.047	0.089	/
	50%RB	Front	20450	829.0	0.570	0.128	100.00	1.000	22.33	22.50	1.040	0.133	/
		Back	20450	829.0	-4.860	0.115	100.00	1.000	22.33	22.50	1.040	0.120	/
		Left	20450	829.0	-0.700	0.086	100.00	1.000	22.33	22.50	1.040	0.089	/
		Top	20450	829.0	0.440	0.067	100.00	1.000	22.33	22.50	1.040	0.070	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 12 (BW: 10MHz)	1RB	Left Cheek	23095	707.5	2.020	0.130	100.00	1.000	22.87	23.00	1.030	0.134	/
		Left Tilt	23095	707.5	4.910	0.062	100.00	1.000	22.87	23.00	1.030	0.064	/
		Right Cheek	23095	707.5	-2.970	0.135	100.00	1.000	22.87	23.00	1.030	**0.139**	17#
		Right Tilt	23095	707.5	-3.500	0.067	100.00	1.000	22.87	23.00	1.030	0.069	/

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	50%RB	Left Cheek	23095	707.5	-1.820	0.121	100.00	1.000	21.83	22.00	1.040	0.126	/
		Left Tilt	23095	707.5	-4.780	0.055	100.00	1.000	21.83	22.00	1.040	0.057	/
		Right Cheek	23095	707.5	-2.360	0.125	100.00	1.000	21.83	22.00	1.040	0.130	/
		Right Tilt	23095	707.5	1.070	0.059	100.00	1.000	21.83	22.00	1.040	0.061	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 12 (BW: 10MHz)	1RB	Front	23095	707.5	0.640	0.123	100.00	1.000	22.87	23.00	1.030	**0.127**	18#
		Back	23095	707.5	-3.140	0.104	100.00	1.000	22.87	23.00	1.030	0.107	/
		Left	23095	707.5	-2.570	0.095	100.00	1.000	22.87	23.00	1.030	0.098	/
		Top	23095	707.5	-1.080	0.083	100.00	1.000	22.87	23.00	1.030	0.085	/
	50%RB	Front	23095	707.5	2.660	0.110	100.00	1.000	21.83	22.00	1.040	0.114	/
		Back	23095	707.5	-2.890	0.093	100.00	1.000	21.83	22.00	1.040	0.097	/
		Left	23095	707.5	-2.740	0.081	100.00	1.000	21.83	22.00	1.040	0.084	/
		Top	23095	707.5	0.590	0.070	100.00	1.000	21.83	22.00	1.040	0.073	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 13 (BW: 10MHz)	1RB	Left Cheek	23230	782.0	1.260	0.100	100.00	1.000	22.40	22.50	1.023	0.102	/
		Left Tilt	23230	782.0	2.650	0.051	100.00	1.000	22.40	22.50	1.023	0.052	/
		Right Cheek	23230	782.0	-4.730	0.105	100.00	1.000	22.40	22.50	1.023	**0.107**	19#
		Right Tilt	23230	782.0	-4.660	0.056	100.00	1.000	22.40	22.50	1.023	0.057	/
	50%RB	Left Cheek	23230	782.0	-1.260	0.083	100.00	1.000	21.47	21.50	1.007	0.084	/
		Left Tilt	23230	782.0	-3.680	0.042	100.00	1.000	21.47	21.50	1.007	0.042	/
		Right Cheek	23230	782.0	-3.120	0.091	100.00	1.000	21.47	21.50	1.007	0.092	/
		Right Tilt	23230	782.0	0.110	0.046	100.00	1.000	21.47	21.50	1.007	0.046	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 13 (BW: 10MHz)	1RB	Front	23230	782.0	4.090	0.082	100.00	1.000	22.40	22.50	1.023	**0.084**	20#
		Back	23230	782.0	3.570	0.076	100.00	1.000	22.40	22.50	1.023	0.078	/
		Left	23230	782.0	-2.290	0.066	100.00	1.000	22.40	22.50	1.023	0.068	/
		Top	23230	782.0	-3.240	0.053	100.00	1.000	22.40	22.50	1.023	0.054	/
	50%RB	Front	23230	782.0	-4.340	0.077	100.00	1.000	21.47	21.50	1.007	0.078	/
		Back	23230	782.0	-4.110	0.071	100.00	1.000	21.47	21.50	1.007	0.071	/
		Left	23230	782.0	-3.500	0.060	100.00	1.000	21.47	21.50	1.007	0.060	/
		Top	23230	782.0	-0.370	0.047	100.00	1.000	21.47	21.50	1.007	0.047	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 25 (BW: 20MHz)	1RB	Left Cheek	26365	1882.5	1.440	1.087	100.00	1.000	21.74	22.00	1.062	1.154	/
		Left Tilt	26365	1882.5	0.790	0.558	100.00	1.000	21.74	22.00	1.062	0.593	/
		Right Cheek	26140	1860.0	2.160	0.980	100.00	1.000	21.52	22.00	1.117	1.095	/
		Right Cheek	26365	1882.5	-3.740	1.096	100.00	1.000	21.74	22.00	1.062	**1.164**	21#
		Right Chee-repeat	26365	1882.5	1.470	1.090	100.00	1.000	21.74	22.00	1.062	1.158	/
		Right Cheek	26590	1905.0	0.290	0.989	100.00	1.000	21.56	22.00	1.107	1.095	/
		Right Tilt	26365	1882.5	-0.040	0.564	100.00	1.000	21.74	22.00	1.062	0.599	/
	50%RB	Left Cheek	26365	1882.5	-3.860	1.024	100.00	1.000	20.63	21.00	1.089	1.115	/
		Left Tilt	26365	1882.5	-2.720	0.546	100.00	1.000	20.63	21.00	1.089	0.595	/
		Right Cheek	26365	1882.5	-4.640	1.032	100.00	1.000	20.63	21.00	1.089	1.124	/
		Right Tilt	26365	1882.5	-1.810	0.552	100.00	1.000	20.63	21.00	1.089	0.601	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 25 (BW: 20MHz)	1RB	Front	26365	1882.5	0.560	0.732	100.00	1.000	21.74	22.00	1.062	0.777	/
		Back	26365	1882.5	-0.060	0.751	100.00	1.000	21.74	22.00	1.062	**0.798**	22#
		Left	26365	1882.5	-3.730	0.706	100.00	1.000	21.74	22.00	1.062	0.750	/

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		Top	26365	1882.5	-2.640	0.662	100.00	1.000	21.74	22.00	1.062	0.703	/
	50%RB	Front	26365	1882.5	-1.700	0.716	100.00	1.000	20.63	21.00	1.089	0.780	/
		Back	26365	1882.5	-3.830	0.735	100.00	1.000	20.63	21.00	1.089	0.800	/
		Left	26365	1882.5	-1.020	0.686	100.00	1.000	20.63	21.00	1.089	0.747	/
		Top	26365	1882.5	-2.290	0.642	100.00	1.000	20.63	21.00	1.089	0.699	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 26 part 90 (BW:10MHz)	1RB	Left Cheek	26740	819.0	3.680	0.173	100.00	1.000	23.26	23.50	1.057	0.183	/
		Left Tilt	26740	819.0	2.510	0.091	100.00	1.000	23.26	23.50	1.057	0.096	/
		Right Cheek	26740	819.0	2.950	0.180	100.00	1.000	23.26	23.50	1.057	**0.190**	23#
		Right Tilt	26740	819.0	-0.200	0.096	100.00	1.000	23.26	23.50	1.057	0.101	/
	50%RB	Left Cheek	26740	819.0	-1.220	0.162	100.00	1.000	21.35	21.50	1.035	0.168	/
		Left Tilt	26740	819.0	-4.940	0.083	100.00	1.000	21.35	21.50	1.035	0.086	/
		Right Cheek	26740	819.0	1.360	0.168	100.00	1.000	21.35	21.50	1.035	0.174	/
		Right Tilt	26740	819.0	-2.770	0.088	100.00	1.000	21.35	21.50	1.035	0.091	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 26 part 90 (BW:10MHz)	1RB	Front	26740	819.0	-3.300	0.128	100.00	1.000	23.26	23.50	1.057	**0.135**	24#
		Back	26740	819.0	4.630	0.107	100.00	1.000	23.26	23.50	1.057	0.113	/
		Left	26740	819.0	-4.450	0.089	100.00	1.000	23.26	23.50	1.057	0.094	/
		Top	26740	819.0	-0.780	0.076	100.00	1.000	23.26	23.50	1.057	0.080	/
	50%RB	Front	26740	819.0	-2.060	0.111	100.00	1.000	21.35	21.50	1.035	0.115	/
		Back	26740	819.0	-1.050	0.098	100.00	1.000	21.35	21.50	1.035	0.101	/
		Left	26740	819.0	0.980	0.078	100.00	1.000	21.35	21.50	1.035	0.081	/
		Top	26740	819.0	-3.250	0.066	100.00	1.000	21.35	21.50	1.035	0.068	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 26 part 22 (BW:10MHz)	1RB	Left Cheek	26865	831.5	-3.360	0.211	100.00	1.000	23.25	23.50	1.059	0.223	/
		Left Tilt	26865	831.5	0.190	0.102	100.00	1.000	23.25	23.50	1.059	0.108	/
		Right Cheek	26865	831.5	3.550	0.218	100.00	1.000	23.25	23.50	1.059	**0.231**	25#
		Right Tilt	26865	831.5	-1.190	0.108	100.00	1.000	23.25	23.50	1.059	0.114	/
	50%RB	Left Cheek	26865	831.5	-2.610	0.193	100.00	1.000	21.52	22.00	1.117	0.216	/
		Left Tilt	26865	831.5	-2.070	0.082	100.00	1.000	21.52	22.00	1.117	0.092	/
		Right Cheek	26865	831.5	0.810	0.201	100.00	1.000	21.52	22.00	1.117	0.225	/
		Right Tilt	26865	831.5	-3.680	0.086	100.00	1.000	21.52	22.00	1.117	0.096	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 26 part 22 (BW:10MHz)	1RB	Front	26865	831.5	-3.800	0.140	100.00	1.000	23.25	23.50	1.059	**0.148**	26#
		Back	26865	831.5	0.750	0.121	100.00	1.000	23.25	23.50	1.059	0.128	/
		Left	26865	831.5	-1.610	0.103	100.00	1.000	23.25	23.50	1.059	0.109	/
		Top	26865	831.5	-1.600	0.089	100.00	1.000	23.25	23.50	1.059	0.094	/
	50%RB	Front	26865	831.5	-3.160	0.122	100.00	1.000	21.52	22.00	1.117	0.136	/
		Back	26865	831.5	-3.090	0.105	100.00	1.000	21.52	22.00	1.117	0.117	/
		Left	26865	831.5	0.640	0.087	100.00	1.000	21.52	22.00	1.117	0.097	/
		Top	26865	831.5	-4.110	0.071	100.00	1.000	21.52	22.00	1.117	0.079	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 41 (BW: 20MHz)	1RB	Left Cheek	41490	2680.0	1.670	0.966	100.00	1.000	21.08	21.50	1.102	1.065	/
		Left Tilt	41490	2680.0	-2.090	0.462	100.00	1.000	21.08	21.50	1.102	0.509	/
		Right Cheek	39750	2506.0	-0.520	0.933	100.00	1.000	20.48	20.50	1.005	0.938	/
		Right Cheek	40620	2593.0	4.220	0.952	100.00	1.000	20.84	21.00	1.038	0.988	/

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		Right Cheek	41490	2680.0	-3.760	0.971	100.00	1.000	21.08	21.50	1.102	**1.070**	27#
		Right Cheek -repeat	41490	2680.0	1.580	0.966	100.00	1.000	21.08	21.50	1.102	1.065	/
		Right Tilt	41490	2680.0	-0.430	0.469	100.00	1.000	21.08	21.50	1.102	0.517	/
	50%RB	Left Cheek	41490	2680.0	-4.290	0.947	100.00	1.000	20.02	20.50	1.117	1.058	/
		Left Tilt	41490	2680.0	-3.290	0.448	100.00	1.000	20.02	20.50	1.117	0.500	/
		Right Cheek	41490	2680.0	0.050	0.952	100.00	1.000	20.02	20.50	1.117	1.063	/
		Right Tilt	41490	2680.0	-2.640	0.453	100.00	1.000	20.02	20.50	1.117	0.506	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 41 (BW: 20MHz)	1RB	Front	41490	2680.0	1.300	0.428	100.00	1.000	21.08	21.50	1.102	0.472	/
		Back	41490	2680.0	-2.730	0.452	100.00	1.000	21.08	21.50	1.102	**0.498**	28#
		Left	41490	2680.0	2.010	0.403	100.00	1.000	21.08	21.50	1.102	0.444	/
		Top	41490	2680.0	-0.840	0.375	100.00	1.000	21.08	21.50	1.102	0.413	/
	50%RB	Front	41490	2680.0	-4.840	0.407	100.00	1.000	20.02	20.50	1.117	0.455	/
		Back	41490	2680.0	-2.310	0.431	100.00	1.000	20.02	20.50	1.117	0.481	/
		Left	41490	2680.0	-0.120	0.380	100.00	1.000	20.02	20.50	1.117	0.424	/
		Top	41490	2680.0	-3.070	0.352	100.00	1.000	20.02	20.50	1.117	0.393	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 66 (BW: 20MHz)	1RB	Left Cheek	132072	1720.0	3.160	0.702	100.00	1.000	23.09	23.50	1.099	0.771	/
		Left Tilt	132072	1720.0	0.910	0.361	100.00	1.000	23.09	23.50	1.099	0.397	/
		Right Cheek	132072	1720.0	-1.650	0.710	100.00	1.000	23.09	23.50	1.099	**0.780**	29#
		Right Tilt	132072	1720.0	-2.520	0.368	100.00	1.000	23.09	23.50	1.099	0.404	/
	50%RB	Left Cheek	132072	1720.0	-4.580	0.691	100.00	1.000	21.90	22.00	1.023	0.707	/
		Left Tilt	132072	1720.0	-3.380	0.350	100.00	1.000	21.90	22.00	1.023	0.358	/
		Right Cheek	132072	1720.0	-0.160	0.697	100.00	1.000	21.90	22.00	1.023	0.713	/
		Right Tilt	132072	1720.0	-4.690	0.356	100.00	1.000	21.90	22.00	1.023	0.364	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 66 (BW: 20MHz)	1RB	Front	132072	1720.0	-0.880	0.696	100.00	1.000	23.09	23.50	1.099	0.765	/
		Back	132072	1720.0	-4.790	0.727	100.00	1.000	23.09	23.50	1.099	**0.799**	30#
		Left	132072	1720.0	-2.880	0.651	100.00	1.000	23.09	23.50	1.099	0.715	/
		Top	132072	1720.0	-2.280	0.627	100.00	1.000	23.09	23.50	1.099	0.689	/
	50%RB	Front	132072	1720.0	0.800	0.675	100.00	1.000	21.90	22.00	1.023	0.691	/
		Back	132072	1720.0	-1.390	0.705	100.00	1.000	21.90	22.00	1.023	0.721	/
		Left	132072	1720.0	-4.910	0.632	100.00	1.000	21.90	22.00	1.023	0.647	/
		Top	132072	1720.0	-0.940	0.601	100.00	1.000	21.90	22.00	1.023	0.615	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 71 (BW: 20MHz)	1RB	Left Cheek	133222	673.0	2.640	0.062	100.00	1.000	21.74	22.00	1.062	0.066	/
		Left Tilt	133222	673.0	1.690	0.030	100.00	1.000	21.74	22.00	1.062	0.032	/
		Right Cheek	133222	673.0	-3.930	0.066	100.00	1.000	21.74	22.00	1.062	**0.070**	31#
		Right Tilt	133222	673.0	-2.590	0.034	100.00	1.000	21.74	22.00	1.062	0.036	/
	50%RB	Left Cheek	133222	673.0	-3.060	0.057	100.00	1.000	21.16	21.50	1.081	0.062	/
		Left Tilt	133222	673.0	2.300	0.026	100.00	1.000	21.16	21.50	1.081	0.028	/
		Right Cheek	133222	673.0	-1.780	0.061	100.00	1.000	21.16	21.50	1.081	0.066	/
		Right Tilt	133222	673.0	-1.980	0.029	100.00	1.000	21.16	21.50	1.081	0.031	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 71 (BW: 20MHz)	1RB	Front	133222	673.0	2.890	0.072	100.00	1.000	21.74	22.00	1.062	**0.076**	32#
		Back	133222	673.0	0.760	0.068	100.00	1.000	21.74	22.00	1.062	0.072	/
		Left	133222	673.0	-2.730	0.061	100.00	1.000	21.74	22.00	1.062	0.065	/

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		Top	133222	673.0	-3.170	0.052	100.00	1.000	21.74	22.00	1.062	0.055	/
	50%RB	Front	133222	673.0	-3.900	0.067	100.00	1.000	21.16	21.50	1.081	0.072	/
		Back	133222	673.0	-1.410	0.062	100.00	1.000	21.16	21.50	1.081	0.067	/
		Left	133222	673.0	-2.160	0.054	100.00	1.000	21.16	21.50	1.081	0.058	/
		Top	133222	673.0	-2.460	0.047	100.00	1.000	21.16	21.50	1.081	0.051	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
2.4g (2.4~2.4835) 802.11b	Left Cheek	6	2437	1.360	0.243	100.00	1.000	15.31	15.50	1.045	0.254	/
	Left Tilt	6	2437	2.650	0.122	100.00	1.000	15.31	15.50	1.045	0.127	/
	Right Cheek	6	2437	-2.540	0.249	100.00	1.000	15.31	15.50	1.045	**0.260**	33#
	Right Tilt	6	2437	-0.170	0.127	100.00	1.000	15.31	15.50	1.045	0.133	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
2.4g (2.4~2.4835) 802.11b	Front	6	2437	3.320	0.133	100.00	1.000	15.31	15.50	1.045	0.139	/
	Back	6	2437	-4.070	0.168	100.00	1.000	15.31	15.50	1.045	**0.176**	34#
	Right	6	2437	-0.240	0.086	100.00	1.000	15.31	15.50	1.045	0.090	/
	Top	6	2437	-1.060	0.107	100.00	1.000	15.31	15.50	1.045	0.112	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
2.4g (2.4~2.4835) 802.11n(HT20)	Left Cheek	6	2437.0	1.460	0.176	100.00	1.000	16.67	17.00	1.079	0.190	/
	Left Tilt	6	2437.0	-0.380	0.087	100.00	1.000	16.67	17.00	1.079	0.094	/
	Right Cheek	6	2437.0	1.120	0.182	100.00	1.000	16.67	17.00	1.079	0.196	/
	Right Tilt	6	2437.0	0.420	0.092	100.00	1.000	16.67	17.00	1.079	0.099	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
2.4g (2.4~2.4835) 802.11n(HT20)	Front	6	2437.0	4.480	0.093	100.00	1.000	16.67	17.00	1.079	0.100	/
	Back	6	2437.0	3.080	0.102	100.00	1.000	16.67	17.00	1.079	0.110	/
	Right	6	2437.0	-3.440	0.076	100.00	1.000	16.67	17.00	1.079	0.082	/
	Top	6	2437.0	0.160	0.087	100.00	1.000	16.67	17.00	1.079	0.094	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-1 (5.150~5.250) 802.11a	Left Cheek	36	5180	0.850	0.351	100.00	1.000	11.52	12.00	1.117	0.392	/
	Left Tilt	36	5180	-1.240	0.177	100.00	1.000	11.52	12.00	1.117	0.198	/
	Right Cheek	36	5180	3.530	0.356	100.00	1.000	11.52	12.00	1.117	**0.398**	35#
	Right Tilt	36	5180	-1.330	0.182	100.00	1.000	11.52	12.00	1.117	0.203	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-1 (5.150~5.250) 802.11a	Front	36	5180	0.190	0.135	100.00	1.000	11.52	12.00	1.117	0.151	/
	Back	36	5180	-2.660	0.177	100.00	1.000	11.52	12.00	1.117	**0.198**	36#
	Right	36	5180	-1.980	0.101	100.00	1.000	11.52	12.00	1.117	0.113	/
	Top	36	5180	1.000	0.118	100.00	1.000	11.52	12.00	1.117	0.132	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-3 (5.725~5.850) 802.11n(HT20)	Left Cheek	149	5745	-1.350	0.206	100.00	1.000	12.61	13.00	1.094	0.225	/
	Left Tilt	149	5745	0.060	0.110	100.00	1.000	12.61	13.00	1.094	0.120	/
	Right Cheek	149	5745	-1.270	0.212	100.00	1.000	12.61	13.00	1.094	**0.232**	37#
	Right Tilt	149	5745	0.800	0.113	100.00	1.000	12.61	13.00	1.094	0.124	/

Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.

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U-NII-3 (5.725~5.850) 802.11n(HT20)	Front	149	5745	-0.720	0.321	100.00	1.000	12.61	13.00	1.094	0.351	/
	Back	149	5745	2.340	0.354	100.00	1.000	12.61	13.00	1.094	**0.387**	38#
	Right	149	5745	-1.740	0.264	100.00	1.000	12.61	13.00	1.094	0.289	/
	Top	149	5745	1.120	0.297	100.00	1.000	12.61	13.00	1.094	0.325	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Bluetooth	Left Cheek	39	2441	2.360	0.039	100.00	1.000	4.80	5.00	1.047	0.041	/
	Left Tilt	39	2441	-1.020	0.022	100.00	1.000	4.80	5.00	1.047	0.023	/
	Right Cheek	39	2441	-1.890	0.043	100.00	1.000	4.80	5.00	1.047	**0.045**	39#
	Right Tilt	39	2441	0.810	0.025	100.00	1.000	4.80	5.00	1.047	0.026	/

Note:

1. The maximum SAR Value of each test band is marked bold.
2. SAR plot is provided only for the highest measured SAR in each exposure configuration, wireless mode and frequency band combination.
3. Per KDB 447498 D04 v01, for each exposure position, if the highest output power channel Reported SAR ≤ 0.8W/kg, other channels SAR testing is not necessary.
4. Per KDB 447498 D04 v01, head/body-worn use is evaluated with the device positioned at 0mm/10 mm from a head/flat phantom respectively filled with head tissue-equivalent medium.
5. Per KDB Publication 941225 D06 where SAR test considerations for handsets (L x W ≥ 9 cm x 5 cm) are based on a composite test separation distance of 10 mm from the front, back and edges of the device with antennas 2.5 cm or closer to the edge of the device, determined from general mixed use conditions for this type of devices. Since the hotspot SAR results may overlap with the body-worn accessory SAR requirements, the more conservative configurations can be considered, thus excluding some body-worn accessory SAR tests.
6. Per KDB 447498 D04 v01, the report SAR is measured SAR value adjusted for maximum tune-up tolerance. Scaling Factor=10^[(tune-up limit power(dBm) - Ave.power power (dBm))/10], where tune-up limit is the maximum rated power among all production units.
   Reported SAR(W/kg)=Measured SAR (W/kg)*Scaling Factor.

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11. SAR Measurement Variability

According to KDB 865664 D01, SAR measurement variability was assessed for each frequency band, which is determined by the SAR probe calibration point and tissue-equivalent medium used for the device measurements. When both head and body tissue-equivalent media are required for SAR measurements in a frequency band, the variability measurement procedures should be applied to the tissue medium with the highest measured SAR, using the highest measured SAR configuration for that tissue-equivalent medium. Alternatively, if the highest measured SAR for both head and body tissue-equivalent media are ≤ 1.45 W/kg and the ratio of these highest SAR values, i.e., largest divided by smallest value, is ≤ 1.10, the highest SAR configuration for either head or body tissue-equivalent medium may be used to perform the repeated measurement. These additional measurements are repeated after the completion of all measurements requiring the same head or body tissue-equivalent medium in a frequency band. The test device should be returned to ambient conditions (normal room temperature) with the battery fully charged before it is re-mounted on the device holder for the repeated measurement(s) to minimize any unexpected variations in the repeated results.

SAR repeated measurement procedure:

1. When the highest measured SAR is < 0.80 W/kg, repeated measurement is not required.
2. When the highest measured SAR is >= 0.80 W/kg, repeat that measurement once.
3. If the ratio of largest to smallest SAR for the original and first repeated measurements is > 1.20, or when the original or repeated measurement is >= 1.45 W/kg, perform a second repeated measurement.
4. If the ratio of largest to smallest SAR for the original, first and second repeated measurements is > 1.20, and the original, first or second repeated measurement is >= 1.5 W/kg, perform a third repeated measurement.

Note: For 1g SAR, the highest measured 1g SAR is 1.096 < 0.80 W/kg, repeated measurement is as below.

Mode	Position	Ch.	Freq. (MHz)	1g Meas SAR (W/kg)	the ratio of largest to smallest SAR for the original and first repeated measurements
GSM 850	Right Cheek	251	848.8	1.017	1.013
	Right Cheek (repeated)	251	848.8	1.004	
WCDMA Band II	Right Cheek	9538	1907.6	0.957	1.007
	Right Cheek (repeated)	9538	1907.6	0.950	
WCDMA Band IV	Right Cheek	1312	1712.4	0.986	1.006
	Right Cheek (repeated)	1312	1712.4	0.980	
LTE band 2	Right Cheek	18700	1860.0	1.004	1.007
	Right Cheek (repeated)	18700	1860.0	0.997	
LTE band 25	Right Cheek	26365	1882.5	1.096	1.006
	Right Cheek (repeated)	26365	1882.5	1.090	
LTE band 41	Right Cheek	41490	2680.0	0.971	1.005
	Right Cheek (repeated)	41490	2680.0	0.966	

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12. Simultaneous Transmission

Simultaneous transmission SAR test exclusion is determined for each operating configuration and exposure condition according to the reported standalone SAR of each applicable simultaneous transmitting antenna. When the sum of SAR 1g of all simultaneously transmitting antennas in an operating mode and exposure condition combination is within the SAR limit (SAR 1g 1.6 W/kg), the simultaneous transmission SAR is not required. When the sum of SAR 1g is greater than the SAR limit (SAR 1g 1.6 W/kg), SAR test exclusion is determined by the SAR to Peak Location Ratio (SPLSR).

12.1 Simultaneous Transmission Mode Considerations

Simultaneous transmission SAR test exclusion is determined for each operating configuration and exposure condition according to the reported standalone SAR of each applicable simultaneous transmitting antenna. The device has 2 Tx antennas, WWAN main antenna, Wifi/BT antenna supports 2.4G/5G Wi-Fi and BT. The 2 antennas can always transmit simultaneously. The work mode combination is showed as below table.

Application Simultaneous Transmission information:

NO.	Configuration	Head	Body-worn
1	WWAN+WIFI(2.4g)	Yes	Yes
2	WWAN+WIFI(5g)	Yes	Yes
3	WWAN+BT	Yes	Yes

12.2 Sum SAR of Simultaneous Transmission

Head

Band	Test Position	Channel Type	Scaled				Σ SAR (W/kg) WWAN + WIFI 2.4G	Σ SAR (W/kg) WWAN + WIFI 5G	Σ SAR (W/kg) WWAN + BT	SPLSR	Remark
			WWAN	WIFI 2.4G	WIFI 5G	Bluetooth					
LTE band 25	Left Cheek	1RB	1.154	0.254	0.392	0.041	1.408	1.546	1.195	N/A	N/A
	Left Tilt		0.593	0.127	0.198	0.023	0.720	0.791	0.616	N/A	N/A
	Right Cheek		**1.164**	**0.260**	**0.398**	**0.045**	1.424	**1.562**	1.209	N/A	N/A
	Right Tilt		0.599	0.133	0.203	0.026	0.732	0.802	0.625	N/A	N/A
	Left Cheek	50%RB	1.115	0.254	0.392	0.041	1.369	1.507	1.156	N/A	N/A
	Left Tilt		0.595	0.127	0.198	0.023	0.722	0.793	0.618	N/A	N/A
	Right Cheek		1.124	**0.260**	**0.398**	**0.045**	1.384	1.522	1.169	N/A	N/A
	Right Tilt		0.601	0.133	0.203	0.026	0.734	0.804	0.627	N/A	N/A

Hotspot(body-worn)

Band	Test Position	Channel Type	Scaled				Σ SAR (W/kg) WWAN + WIFI 2.4G	Σ SAR (W/kg) WWAN + WIFI 5G	Σ SAR (W/kg) WWAN + BT	SPLSR	Remark
			WWAN	WIFI 2.4G	WIFI 5G	Bluetooth					
LTE band 66	Front	1RB	0.765	0.139	0.151	0.066	0.904	0.916	0.831	N/A	N/A
	Back		**0.799**	**0.176**	**0.198**	0.066	0.975	**0.997**	0.865	N/A	N/A
	Left		0.715	/	/	/	0.715	0.715	0.715	N/A	N/A
	Right		/	0.090	0.113	0.066	0.090	0.113	0.066	N/A	N/A
	Top		0.689	0.112	0.132	0.066	0.801	0.821	0.755	N/A	N/A
	Front	50%RB	0.691	0.139	0.151	0.066	0.830	0.842	0.757	N/A	N/A
	Back		0.721	**0.176**	**0.198**	0.066	0.897	0.919	0.787	N/A	N/A
	Left		0.647	/	/	/	0.647	0.647	0.647	N/A	N/A
	Right		/	0.090	0.113	0.066	0.090	0.113	0.066	N/A	N/A
	Top		0.615	0.112	0.132	0.066	0.727	0.747	0.681	N/A	N/A

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13. Test Equipment List

Description	Manufacturer	Model	Serial No./Version	Cal. Date	Cal. Due
E-Field Probe	MVG	SSE2	04/22 EPGO365	2024/02/06	2025/02/05
6 1/2 Digital Multimeter	Keithley	DMM6500	4527164	2023/11/16	2024/11/15
Wideband Radio Communication Tester	ROHDE & SCHWARZ	CMW500	161997	2023/11/16	2024/11/15
MXG Vector Signal Generator	Agilent	N5182A	MY46240163	2023/11/16	2024/11/15
E-Series Avg. Power Sensor	KEYSIGHT	E9300A	MY55050017	2024/03/20	2025/03/19
EPM Series Power Meter	KEYSIGHT	E4418B	MY41293435	2024/03/20	2025/03/19
10dB Attenuator	MIDWEST MICROWAVE	263-10dB	/	2024/03/20	2025/03/19
Coupler	MERRIMAC	CWM-10R-10.8G	LOT-83391	2024/03/20	2025/03/19
750MHz Validation Dipole	MVG	SID750	07/22 DIP 0G750-655	2023/02/06	2025/02/05
835MHz Validation Dipole	MVG	SID835	07/22 DIP 0G835-656	2023/02/06	2025/02/05
1800MHz Validation Dipole	MVG	SID1800	07/22 DIP 1G800-657	2023/02/06	2025/02/05
1900MHz Validation Dipole	MVG	SID1900	07/22 DIP 1G900-658	2023/02/06	2025/02/05
2450MHz Validation Dipole	MVG	SID2450	07/22 DIP 2G450-662	2023/02/06	2025/02/05
2600MHz Validation Dipole	MVG	SID2600	07/22 DIP 2G600-663	2023/02/06	2025/02/05
5200MHz-5800MHz Validation Dipole	MVG	SID5000	07/22 DIP5G000-670	2023/02/06	2025/02/05
LIMESAR Dielectric Probe	MVG	SCLMP	06/22 OCPG88	/	/
ENA Series Network Analyzer	Agilent	E5071B	MY42301221	2023/11/16	2024/11/15
Thermometer	Riters	DT-232	21A11	2024/03/20	2025/03/19
Antenna network emulator	MVG	ANTA 74	07/22 ANTA 74	/	/
SAM Phantom	MVG	SAM	07/22 SAM149	/	/
Mobile Phone Positioning System	MVG	MSH 118	07/22 MSH 118	/	/
Mechanical Calibration Kit	PNA	/	/	/	/
Open SAR test software	MVG	/	V5.3.5	/	/

Note: For dipole antennas, BTF has adopted 3 years as calibration intervals, and on annual basis, every measurement dipole has been evaluated and is in compliance with the following criteria:

1. There is no physical damage on the dipole;
2. System validation with specific dipole is within 10% of calibrated value;
3. Return-loss in within 20% of calibrated measurement.
4. Impedance (real or imaginary parts) in within 5 Ohms of calibrated measurement.

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ANNEX A Simulating Liquid Verification Result

The dielectric parameters of the liquids were verified prior to the SAR evaluation using an SCLMP Dielectric Probe Kit.

Dielectric performance of tissue simulating liquid									
Frequency (MHz)	εr		σ(s/m)		Delta (εr)	Delta (σ)	Limit	Temp (℃)	Date
	Target	Measured	Target	Measured					
750	41.90	41.80	0.89	0.86	0.24%	3.37%	±5%	20.0	31/5/2024
835	41.50	41.41	0.90	0.87	0.22%	3.33%	±5%	20.0	3/6/2024
1800	40.00	39.91	1.40	1.37	0.23%	2.14%	±5%	20.0	4/6/2024
1900	40.00	39.88	1.40	1.41	0.30%	-0.71%	±5%	20.0	5/6/2024
2450	39.20	39.08	1.80	1.81	0.31%	-0.56%	±5%	20.0	6/6/2024
2600	39.00	38.88	1.96	1.97	0.31%	-0.51%	±5%	20.0	7/6/2024
5200	36.00	35.88	4.66	4.70	0.33%	-0.86%	±5%	20.0	11/6/2024
5800	35.30	35.18	5.27	5.31	0.34%	-0.76%	±5%	20.0	11/6/2024
NOTE: The dielectric parameters of the tissue-equivalent liquid should be measured under similar ambient conditions and within 2 ℃ of the conditions expected during the SAR evaluation to satisfy protocol requirements.									

ANNEX B System Check Result

Comparing to the original SAR value provided by MVG, the validation data should be within its specification of 10 %(for 10 g).

Frequency (MHz)	Input Power (mW)	10g SAR (W/Kg)	1g SAR (W/Kg)	10g SAR 1W input power normalized (W/Kg)	1g SAR 1W input power normalized (W/Kg)	10g SAR Standard target (1W) (W/Kg)	1g SAR Standard target (1W) (W/Kg)	1g SAR Deviation	10g SAR Deviation
750	16	0.092	0.138	5.75	8.63	5.55	8.49	3.60%	1.59%
835	16	0.106	0.163	6.63	10.19	6.22	9.56	6.51%	6.56%
1800	16	0.312	0.588	19.50	36.75	20.10	38.40	-2.99%	-4.30%
1900	16	0.322	0.630	20.13	39.38	20.50	39.70	-1.83%	-0.82%
2450	16	0.352	0.793	22.00	49.56	23.86	54.4	-7.80%	-8.89%
2600	16	0.421	0.866	26.31	54.13	24.60	55.30	6.96%	-2.12%
5200	13	0.288	1.019	22.15	78.38	21.29	73.88	4.06%	6.10%
5800	13	0.277	0.981	21.31	75.46	21.5	74.21	-0.89%	1.69%

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ANNEX C SAR Dipole Calibrations

Justification for Extended SAR Dipole Calibrations

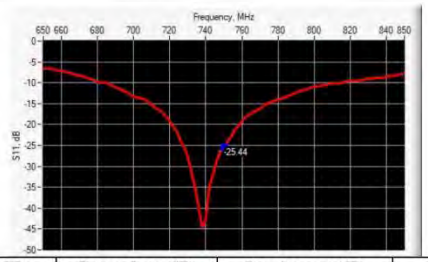
Referring to KDB 865664D01V01r04, if dipoles are verified in return loss (<-20dB, within 20% of prior calibration)and in impedance (within 5 ohm of prior calibration). the annual calibration is not necessary and the calibrationinterval can be extended.While calibration intervals not exceed 3 years.

07/22 DIP 2G450-662 SID2450 2450MHz Validation Dipole Calibrations

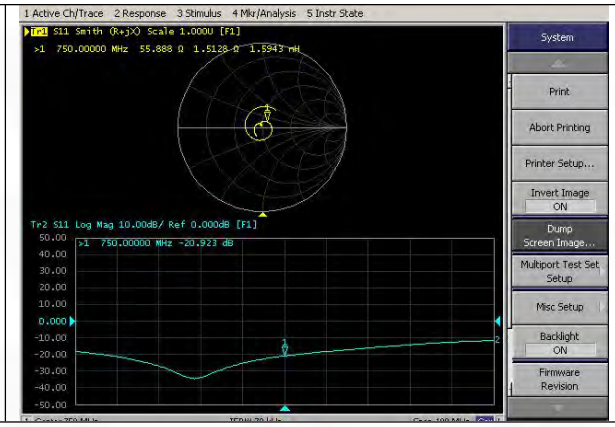
Frequency (MHz)	Return loss(dB)		Impedance(Ω)				error range（%）		Results	Date of Measurement
	measurement	target	measurement		target		Return loss(±20%)	Impedance(±5 Ω)	(P/F)	
			real part	imaginary part	real part	imaginary part				
CW750	-20.92	-25.44	55.89	1.5	55.2	-1.2	-17.77%	3.4	P	2/5/2024
CW835	-29.88	-26.27	52.8	-1.7	52.5	-4.2	13.74%	2.8	P	2/5/2024
CW1800	-24.55	-26.54	52.4	-0.2	52.8	+3.8	-7.50%	4.4	P	2/5/2024
CW1900	-25.67	-23.01	51.9	-5.3	51.0	-7.0	11.56%	2.6	P	2/5/2024
CW2450	-24.37	-21.23	48.3	5.7	49.4	+8.6	14.79%	4.0	P	2/5/2024
CW2600	-20.56	-23.05	57.3	5.7	54.3	+5.5	-10.80%	3.2	P	2/5/2024
CW5200	-21.14	-20.29	58.4	-4.5	58.76	-4.43	4.19%	0.43	P	2/5/2024
CW5800	-28.88	-28.48	50.8	0.1	50.12	-3.76	1.40%	4.34	P	2/5/2024

Dipole calibration report data	Self-examination data

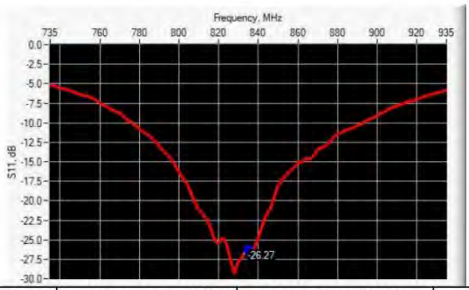
750MHz Dipole



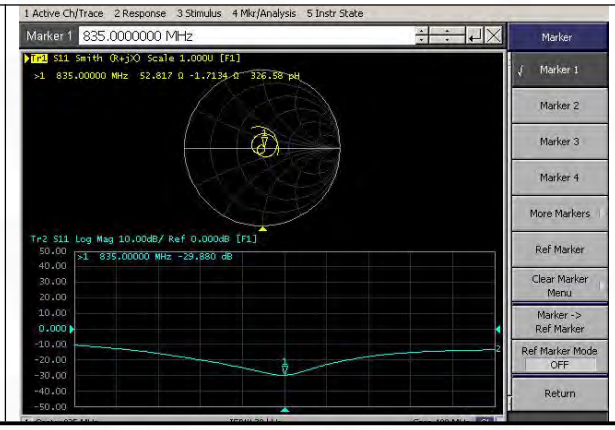
Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
750	-25.44	-20	55.2 Ω - 1.2 jΩ



835MHz Dipole



Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
835	-26.27	-20	52.5 Ω - 4.2 jΩ



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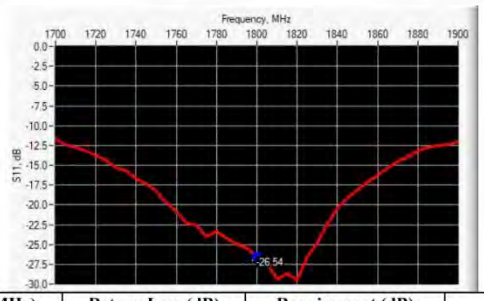
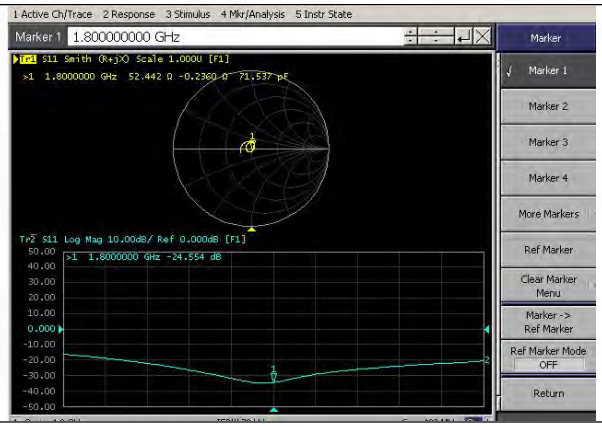
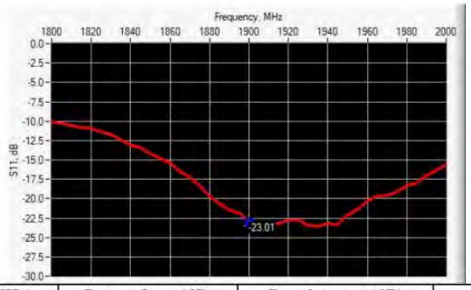
1800MHz Dipole

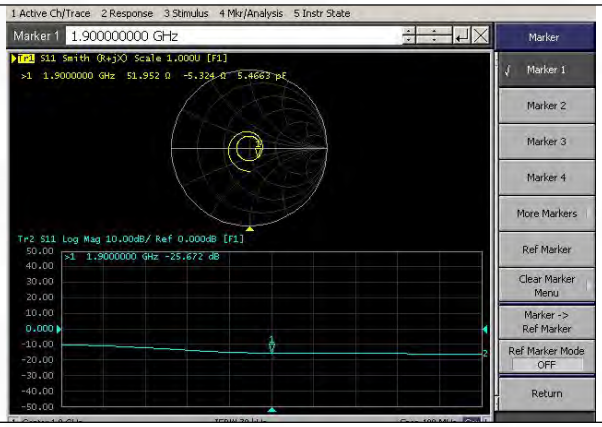




Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
1800	-26.54	-20	52.8 Ω + 3.8 jΩ

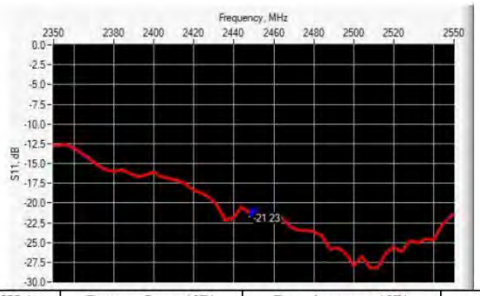
1900MHz Dipole

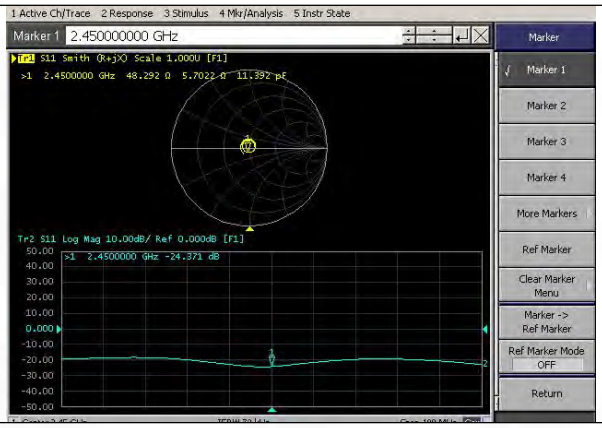




Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
1900	-23.01	-20	51.0 Ω - 7.0 jΩ

2450MHz Dipole





Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
2450	-21.23	-20	49.4 Ω + 8.6 jΩ

2600MHz Dipole

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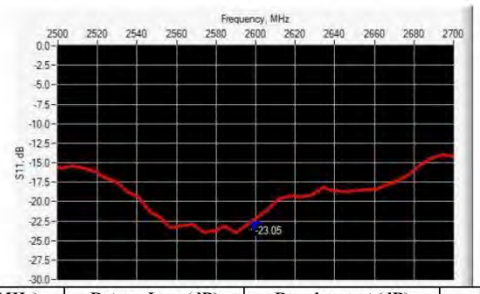
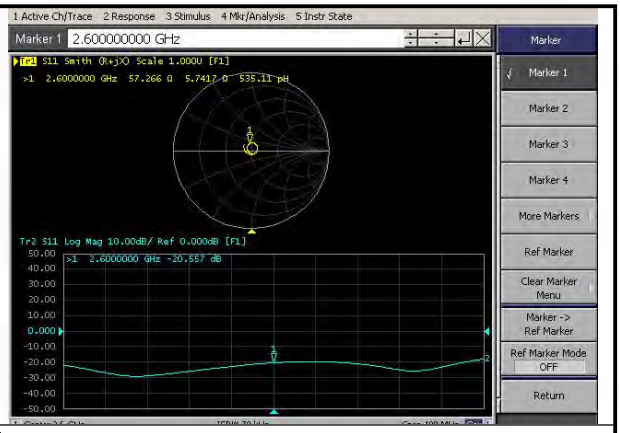
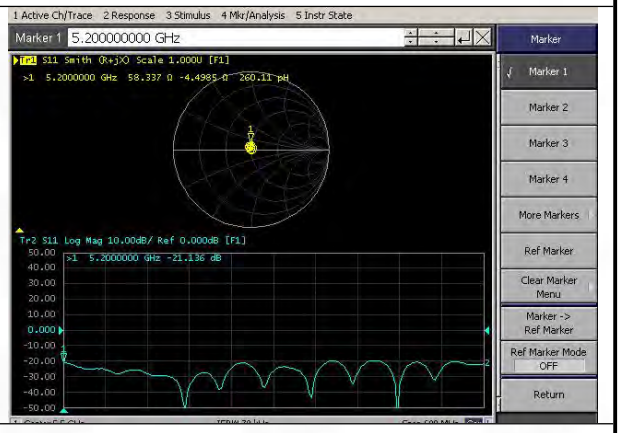


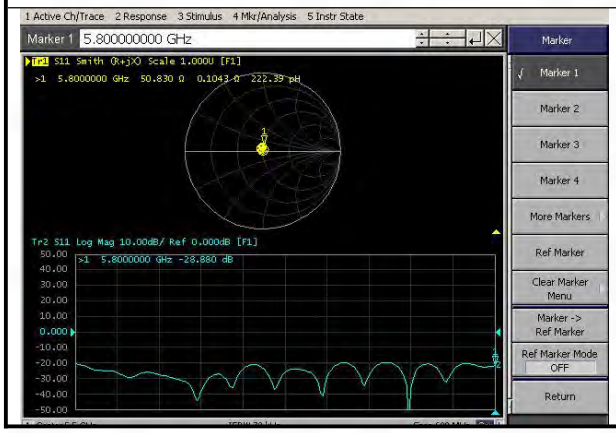


Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
2600	-23.05	-20	54.3 Ω + 5.5 jΩ

5000MHz Dipole

Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
5200	-20.29	-20	58.76 Ω - 4.43 jΩ
5400	-29.09	-20	53.46 Ω + 0.61 jΩ
5600	-31.06	-20	52.76 Ω - 0.45 jΩ
5800	-28.48	-20	50.12 Ω - 3.76 jΩ





System Performance Check Data (750 MHz)

System check at 750 MHz

Date of measurement: 31/5/2024

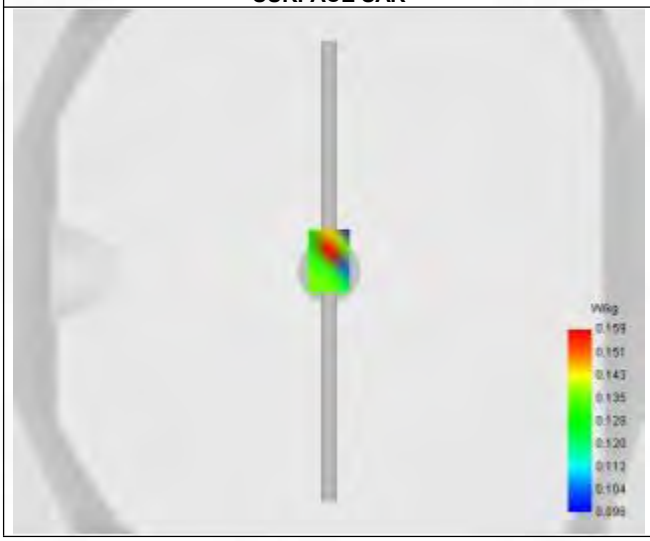
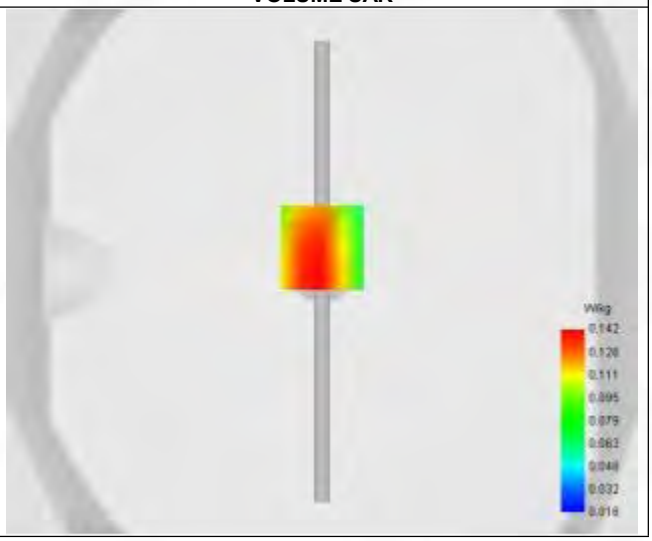
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.65
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW750
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	750.000
Relative permitivity (real part)	41.800
Relative permitivity (imaginary part)	21.460
Conductivity (S/m)	0.860

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=9.00 ; SAR Peak: 0.20 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.092
SAR 1g (W/Kg)	0.138
Variation (%)	-2.190
Horizontal validation criteria: minimum distance (mm)	9.285
Vertical validation criteria: SAR ratio M2/M1 (%)	64.79%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.287	0.142	0.092	0.073	0.042

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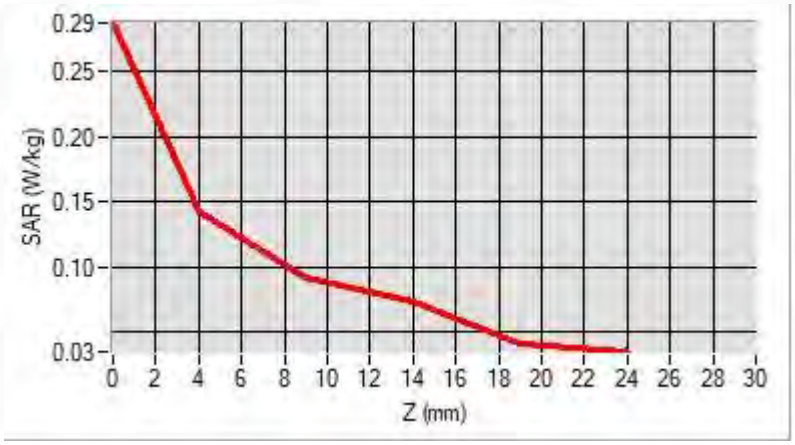
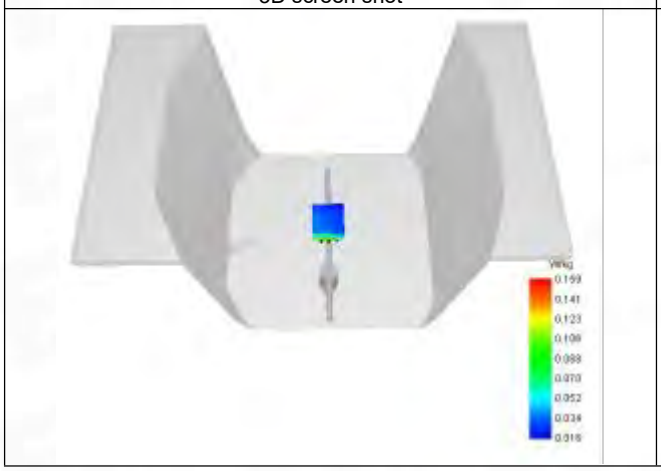
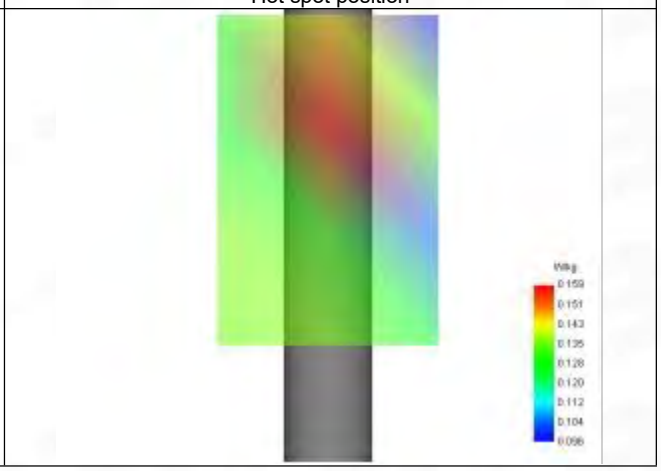


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (835 MHz)

System check at 835 MHz

Date of measurement: 3/6/2024

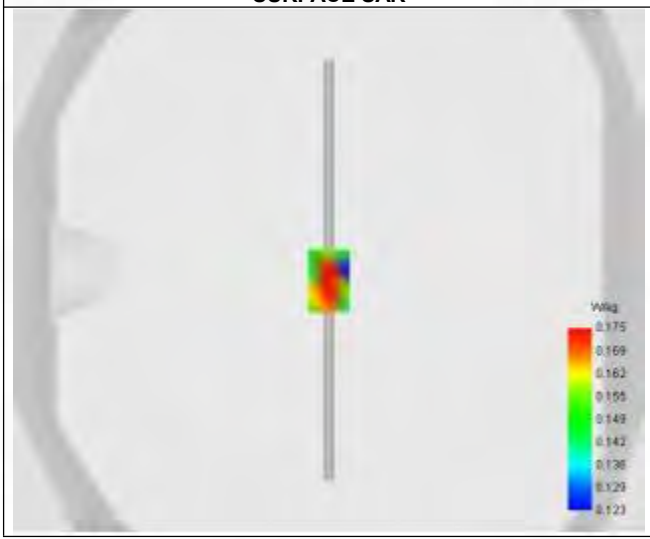
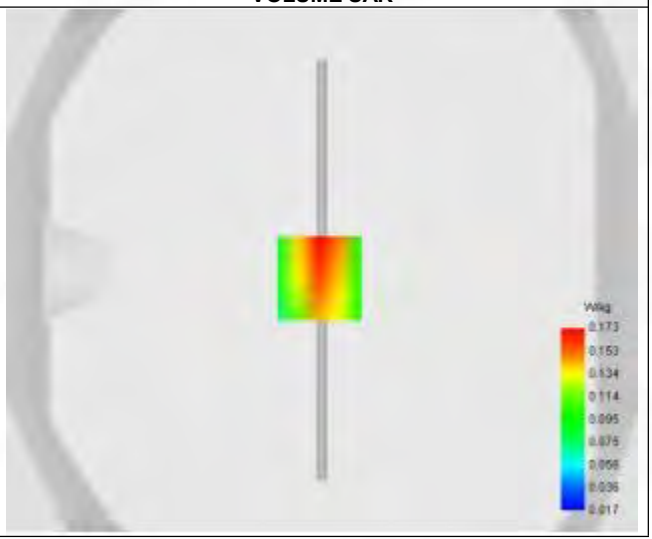
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW835
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	835.000
Relative permitivity (real part)	41.410
Relative permitivity (imaginary part)	19.490
Conductivity (S/m)	0.870

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=-3.00 ; SAR Peak: 0.26 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.106
SAR 1g (W/Kg)	0.163
Variation (%)	-3.390
Horizontal validation criteria: minimum distance (mm)	8.487
Vertical validation criteria: SAR ratio M2/M1 (%)	66.47%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.059	0.173	0.115	0.061	0.072

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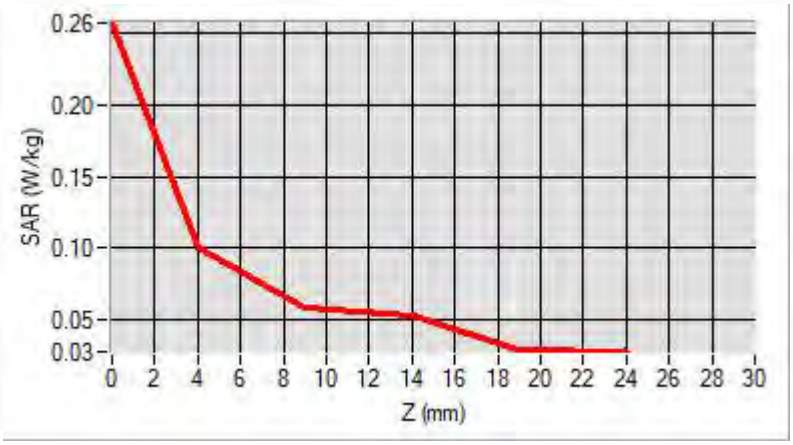
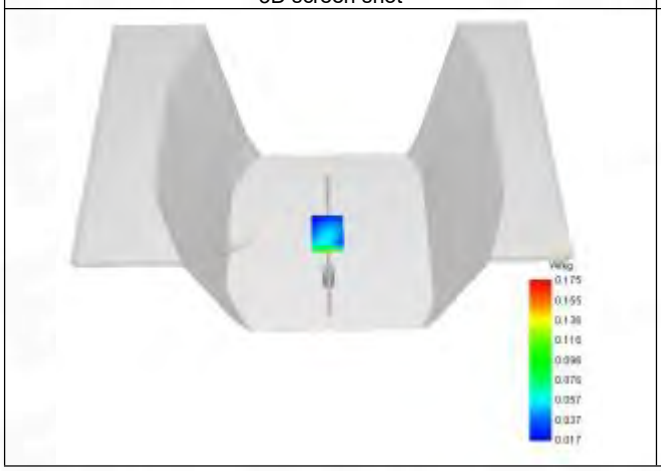
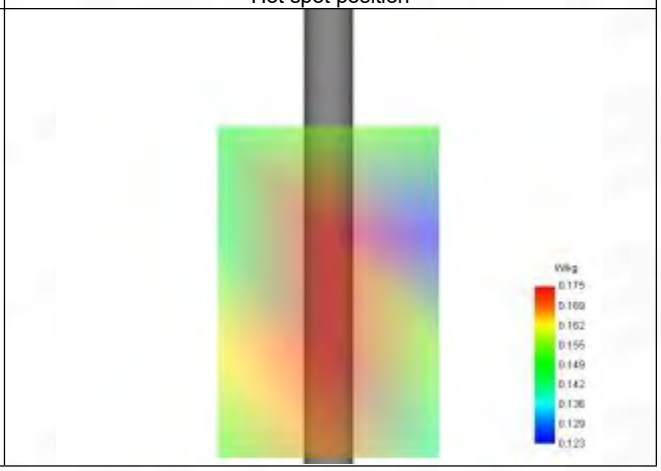


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (1800 MHz)

System check at 1800 MHz

Date of measurement: 4/6/2024

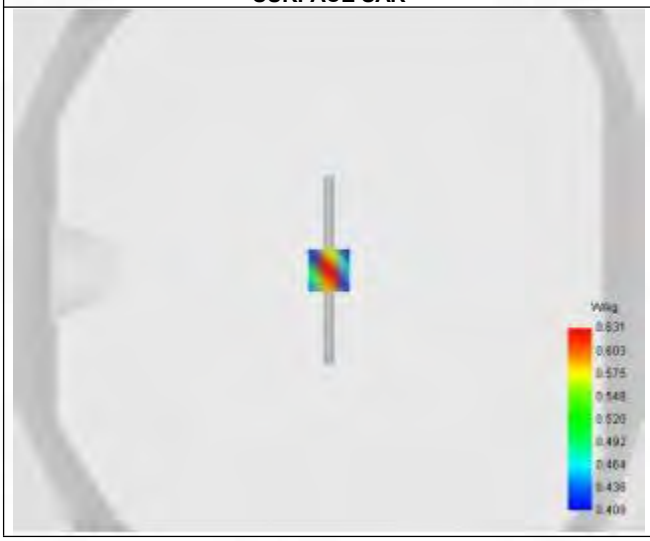
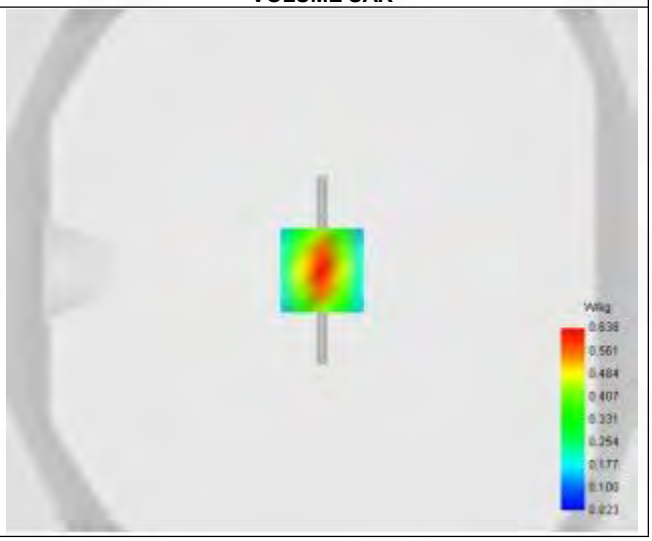
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.96
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW1800
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	1800.000
Relative permitivity (real part)	39.910
Relative permitivity (imaginary part)	14.090
Conductivity (S/m)	1.370

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.00 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.312
SAR 1g (W/Kg)	0.588
Variation (%)	-0.250
Horizontal validation criteria: minimum distance (mm)	8.698
Vertical validation criteria: SAR ratio M2/M1 (%)	55.80%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.003	0.638	0.356	0.204	0.127

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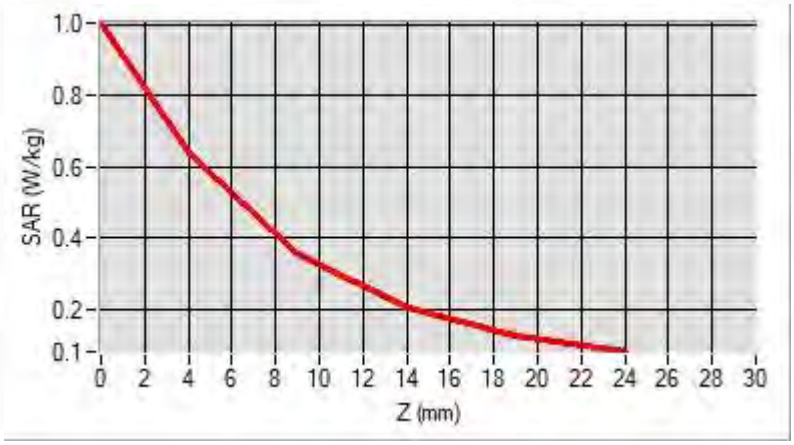
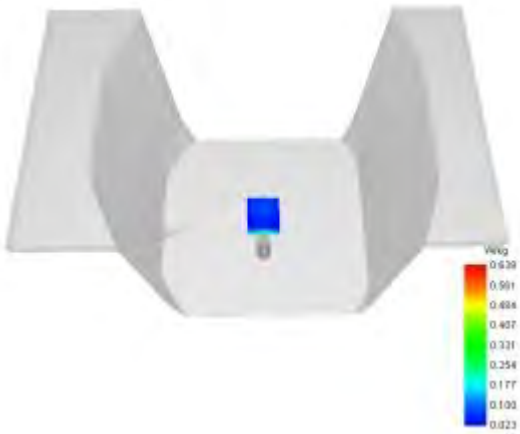
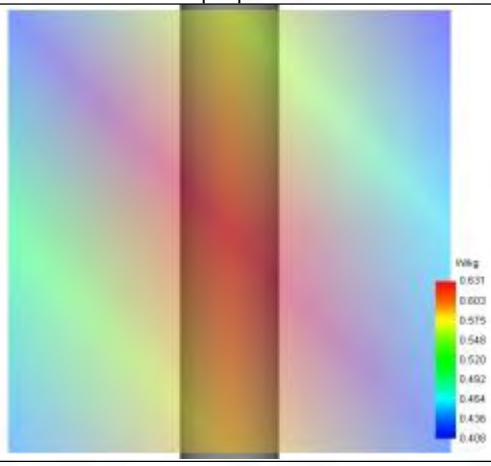


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (1900 MHz)

System check at 1900 MHz

Date of measurement: 5/6/2024

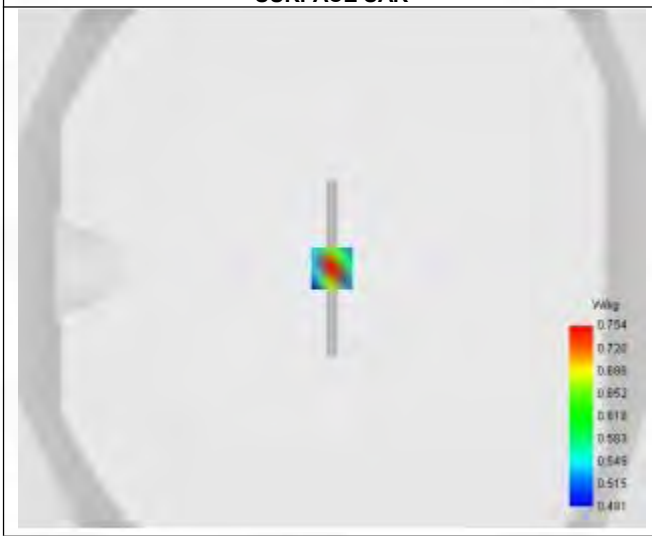
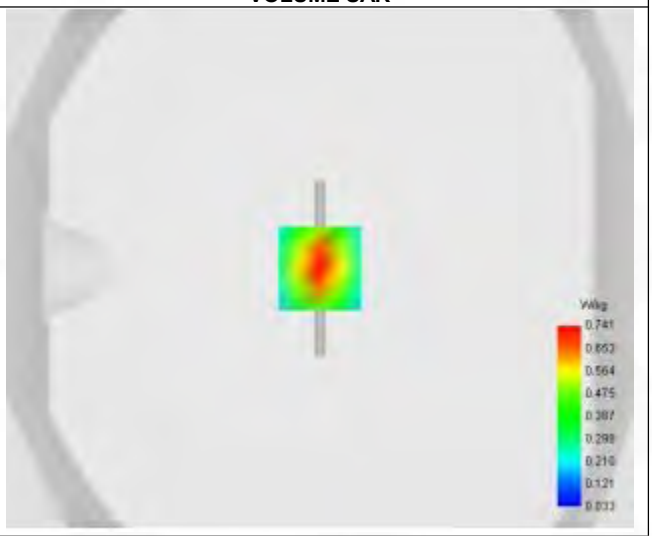
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW1900
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	1900.000
Relative permitivity (real part)	39.880
Relative permitivity (imaginary part)	13.380
Conductivity (S/m)	1.410

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.18 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.322
SAR 1g (W/Kg)	0.630
Variation (%)	-2.080
Horizontal validation criteria: minimum distance (mm)	8.699
Vertical validation criteria: SAR ratio M2/M1 (%)	52.96%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.201	0.759	0.402	0.239	0.156

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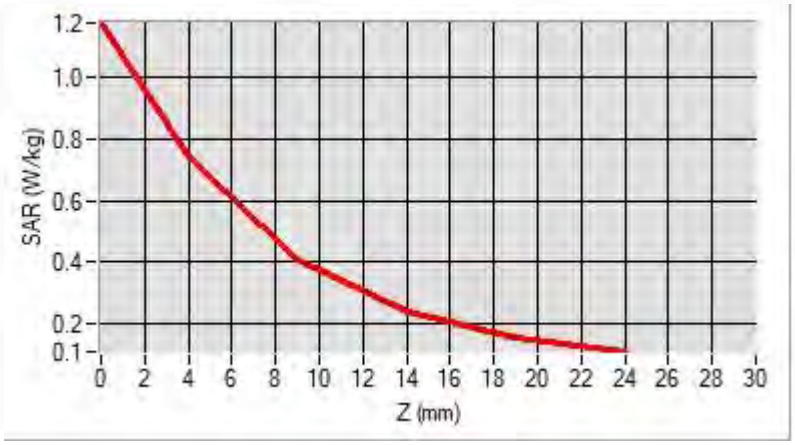
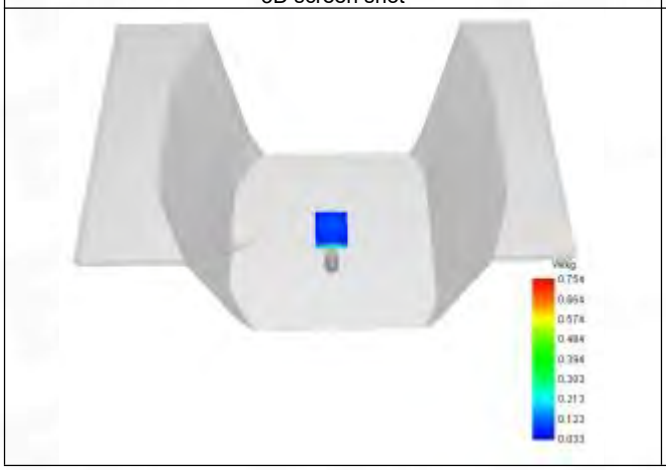
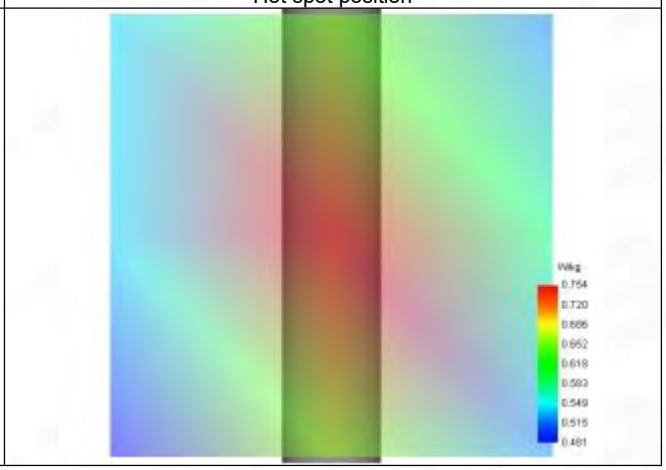


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (2450 MHz)

System check at 2450 MHz

Date of measurement: 6/6/2024

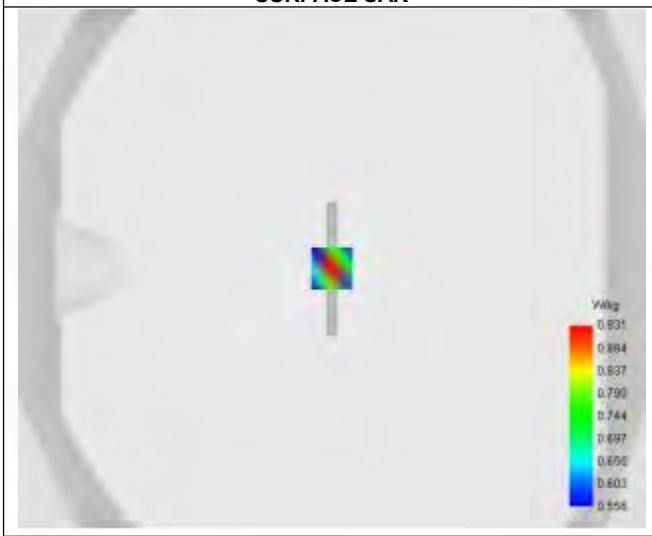
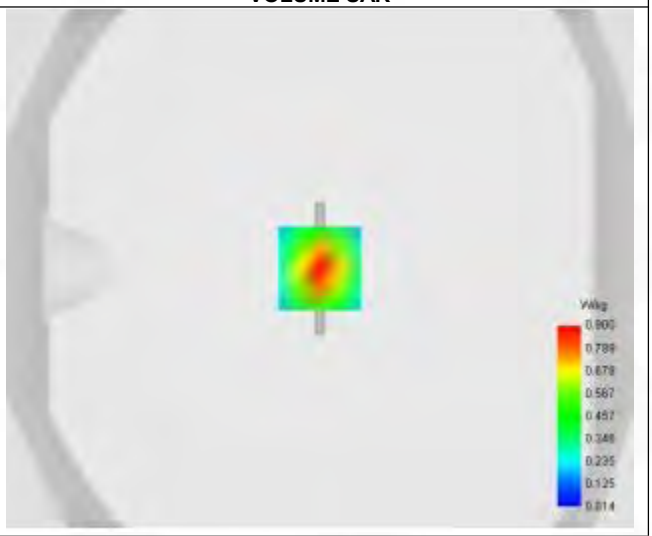
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=5mm dy=5mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW2450
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	2450.000
Relative permitivity (real part)	39.080
Relative permitivity (imaginary part)	13.340
Conductivity (S/m)	1.810

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.47 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.352
SAR 1g (W/Kg)	0.793
Variation (%)	-2.570
Horizontal validation criteria: minimum distance (mm)	9.787
Vertical validation criteria: SAR ratio M2/M1 (%)	53.00%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.466	0.900	0.477	0.261	0.158

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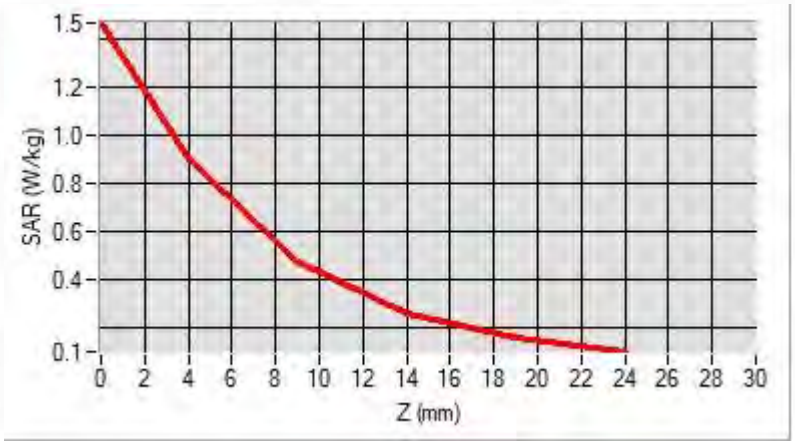
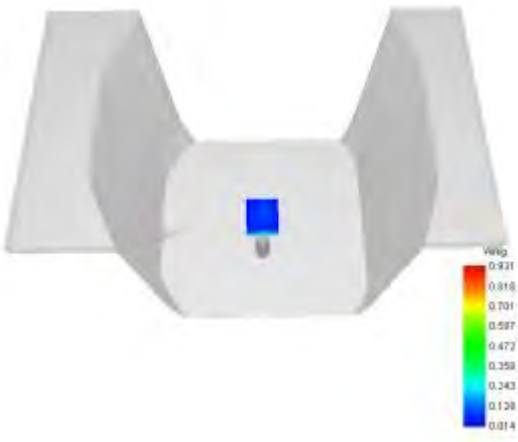
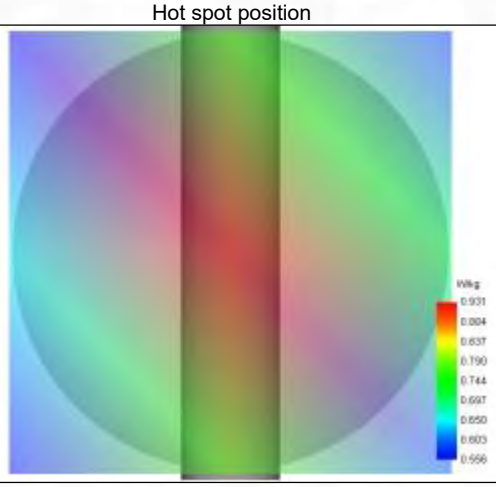


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (2600 MHz)

System check at 2600 MHz

Date of measurement: 7/6/2024

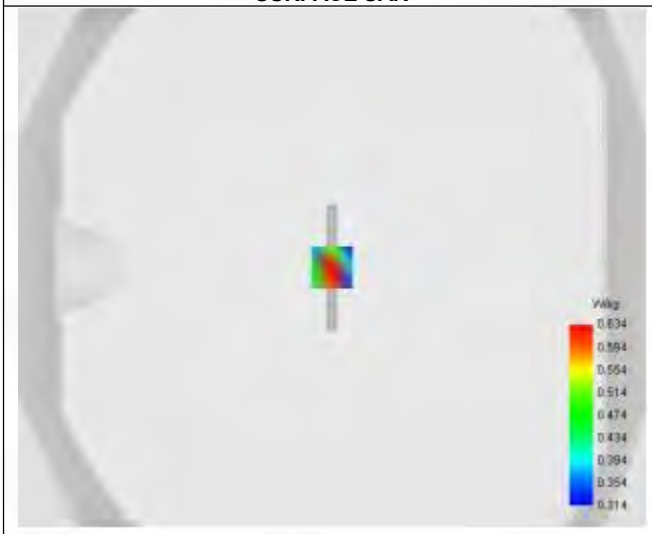
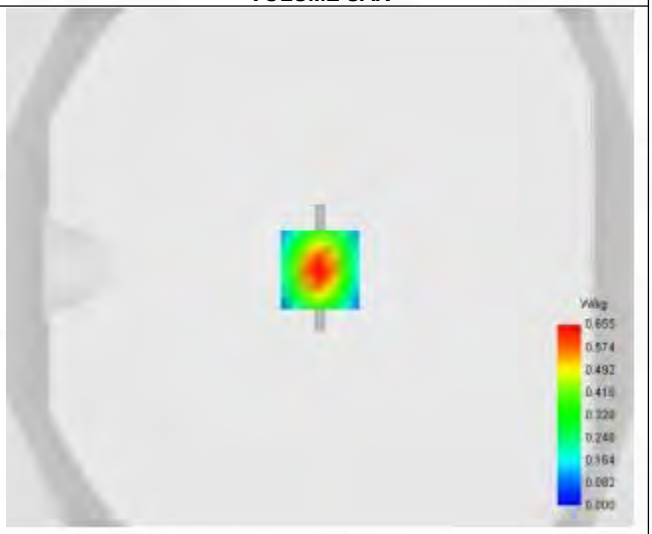
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.40
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=5mm dy=5mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW2600
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	2600.000
Relative permitivity (real part)	38.880
Relative permitivity (imaginary part)	12.690
Conductivity (S/m)	1.970

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=-1.00 ; SAR Peak: 1.02 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.421
SAR 1g (W/Kg)	0.866
Variation (%)	2.980
Horizontal validation criteria: minimum distance (mm)	9.362
Vertical validation criteria: SAR ratio M2/M1 (%)	54.81%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.020	0.655	0.359	0.187	0.091

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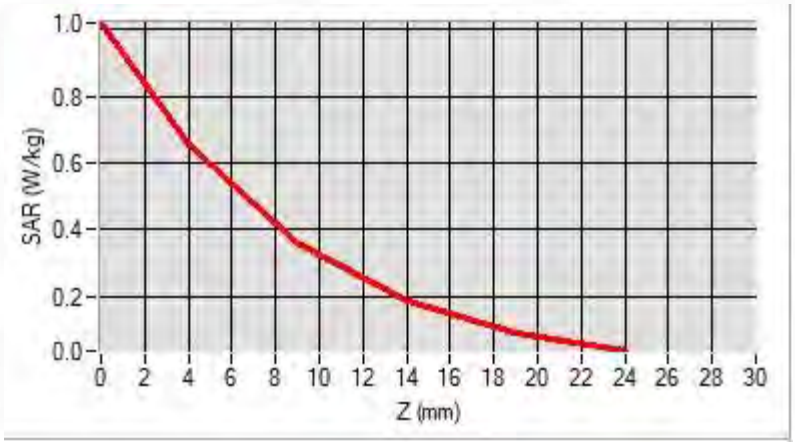
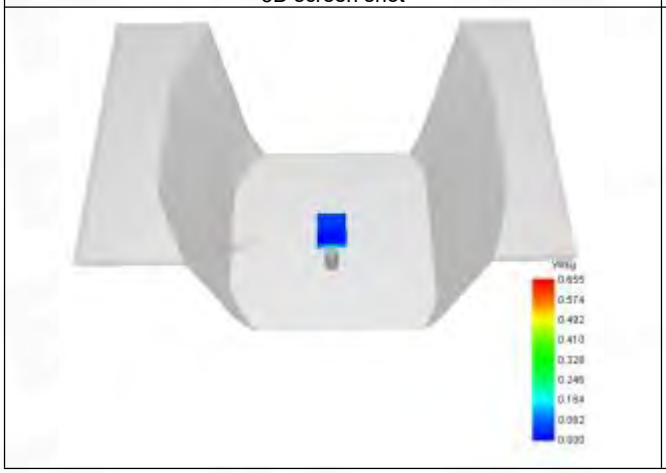
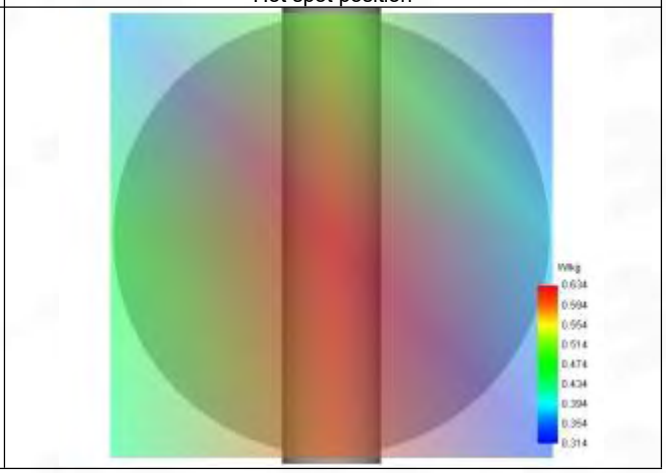


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (5200 MHz)

System check at 5200 MHz

Date of measurement: 11/6/2024

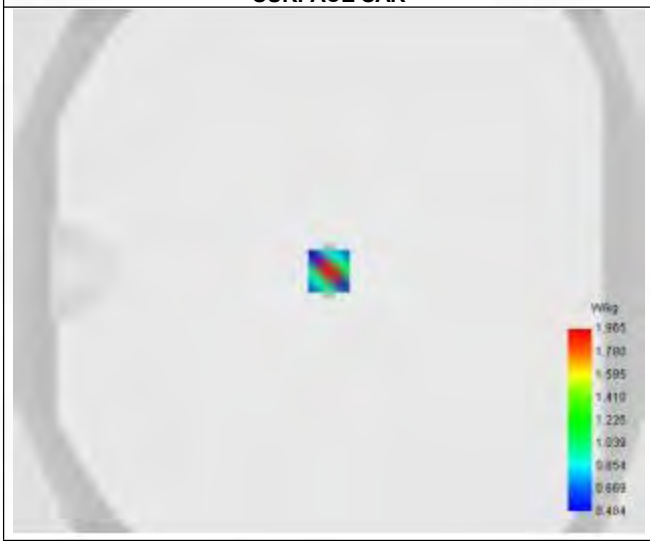
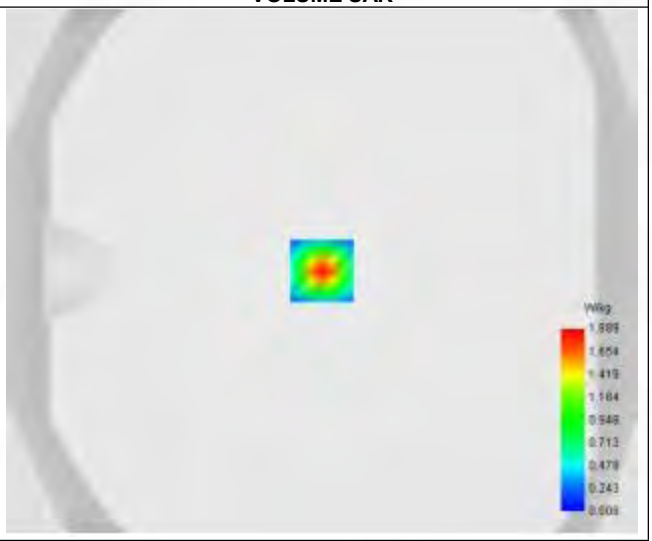
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW5200
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	5200.000
Relative permitivity (real part)	35.880
Relative permitivity (imaginary part)	16.250
Conductivity (S/m)	4.700

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 3.38 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.288
SAR 1g (W/Kg)	1.019
Variation (%)	-3.400
Horizontal validation criteria: minimum distance (mm)	6.287
Vertical validation criteria: SAR ratio M2/M1 (%)	54.05%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	3.268	1.889	1.021	0.523	0.266	0.142	0.085	0.060	0.052

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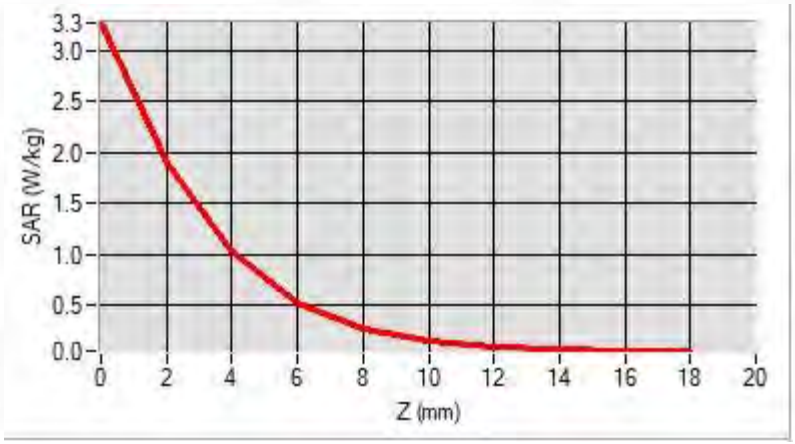
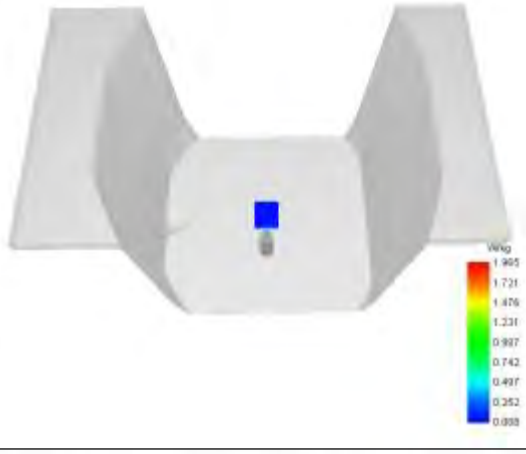
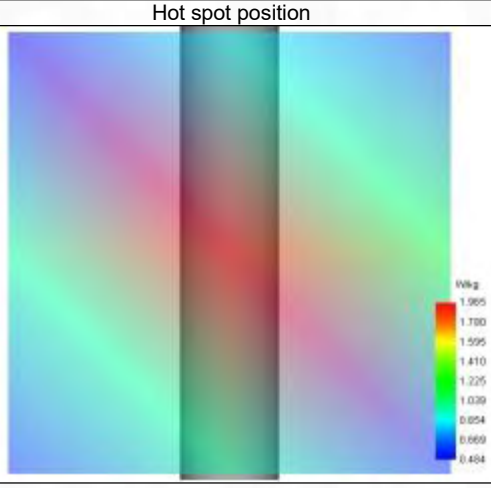


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (5800 MHz)

System check at 5800 MHz

Date of measurement: 11/6/2024

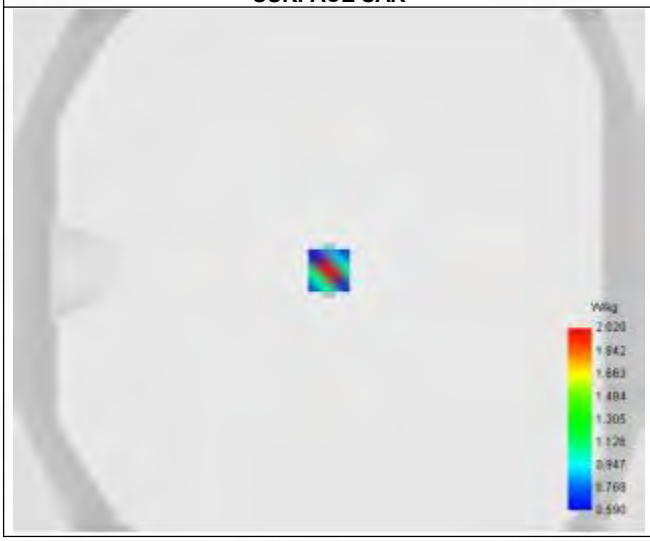
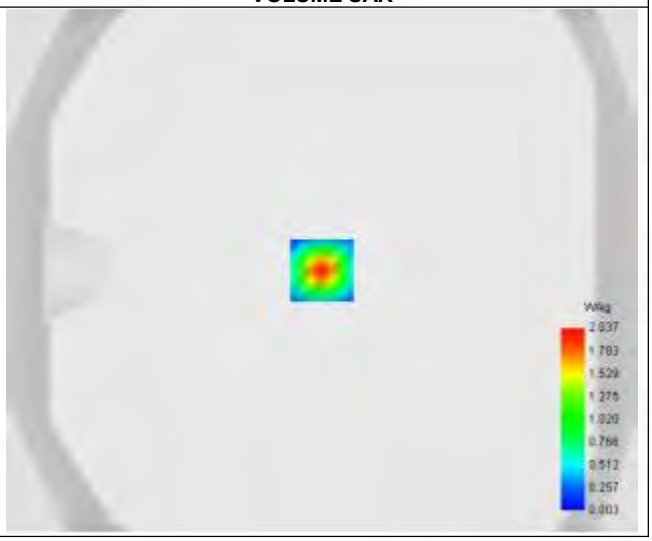
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.04
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW5800
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	5800.000
Relative permitivity (real part)	35.180
Relative permitivity (imaginary part)	16.480
Conductivity (S/m)	5.310

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 4.17 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.277
SAR 1g (W/Kg)	0.981
Variation (%)	0.490
Horizontal validation criteria: minimum distance (mm)	7.145
Vertical validation criteria: SAR ratio M2/M1 (%)	44.92%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	3.948	2.037	0.915	0.361	0.135	0.055	0.033	0.037	0.059

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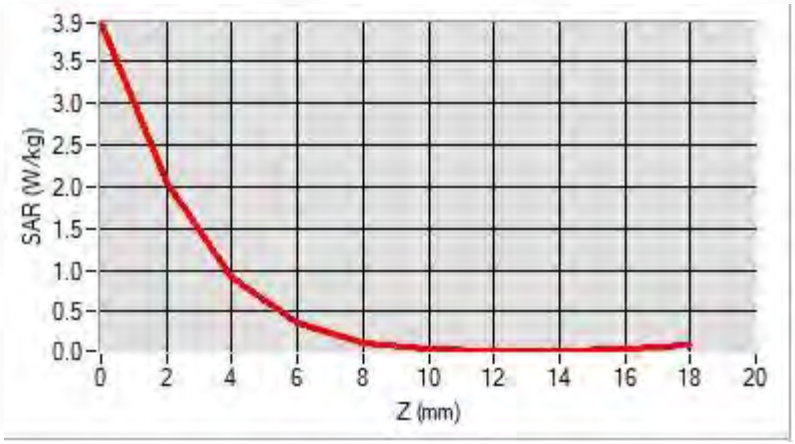
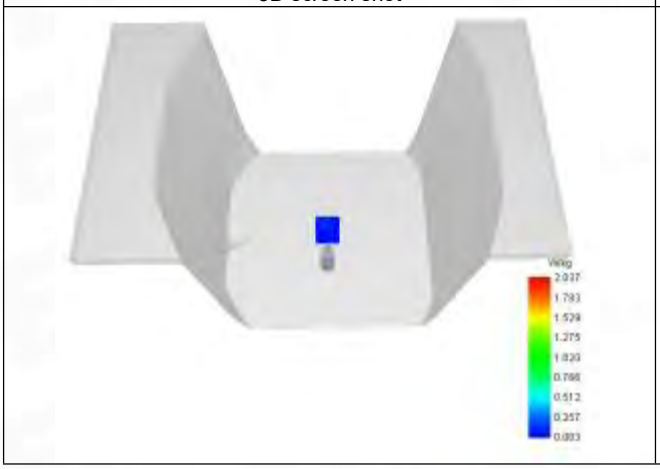
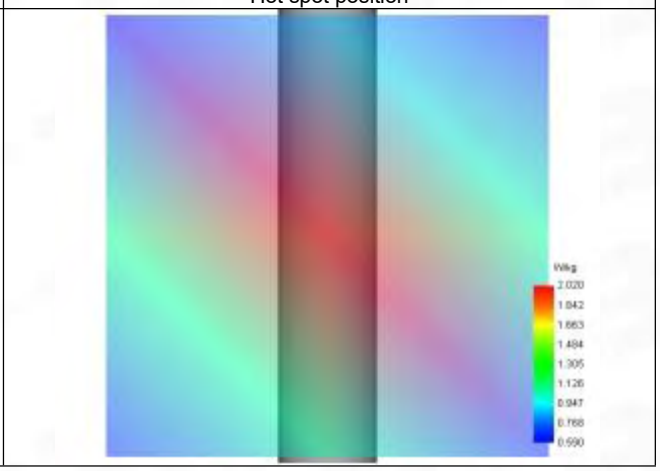


F. 3D Image

3D screen shot	Hot spot position
	

ANNEX D Test Data

1-Head with front position in dist. 0mm on Channel 251 in GSM850 voice

SAR Measurement at GSM850 (Cheek, Right)

Date of measurement: 3/6/2024

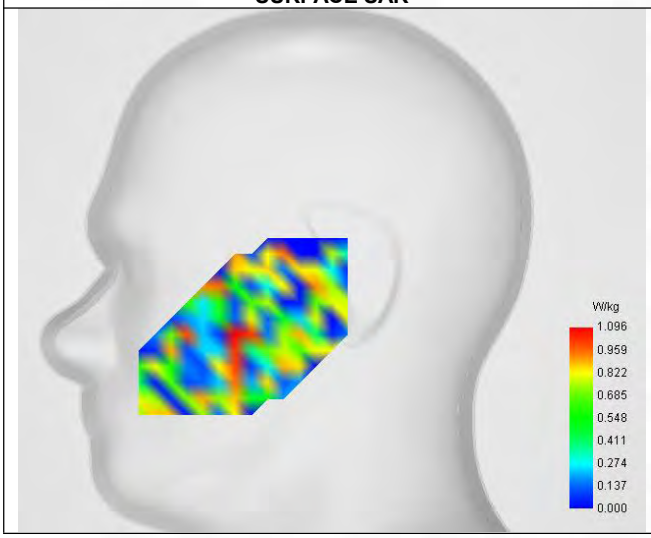
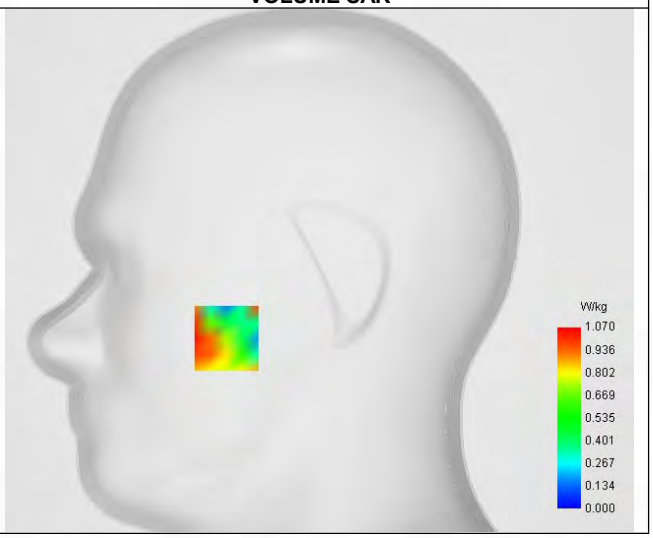
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	GSM850
Channels	Higher (251)
Signal	TDMA (GSM)
Modulation	GMSK

B. Permitivity

Frequency (MHz)	848.800
Relative permitivity (real part)	41.389
Relative permitivity (imaginary part)	19.413
Conductivity (S/m)	0.877

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-46.00, Y=-34.00 ; SAR Peak: 3.85 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.647
SAR 1g (W/Kg)	1.017
Variation (%)	-2.860
Horizontal validation criteria: minimum distance (mm)	8.954
Vertical validation criteria: SAR ratio M2/M1 (%)	53.51%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	3.465	1.054	0.564	0.820	0.828

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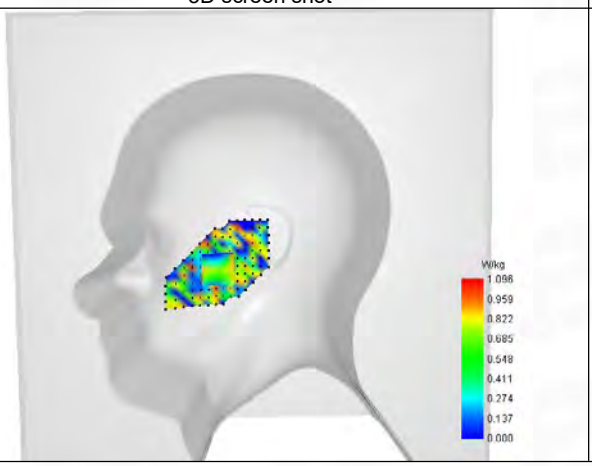
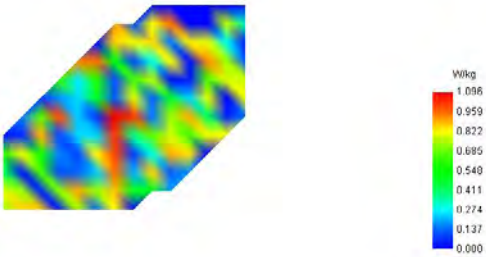
F. 3D Image

3D screen shot	Hot spot position
	

2-Body with back position in dist. 10mm on Channel 128 in GPRS850+2slots

SAR Measurement at GPRS850 (Body, Validation Plane)

Date of measurement: 3/6/2024

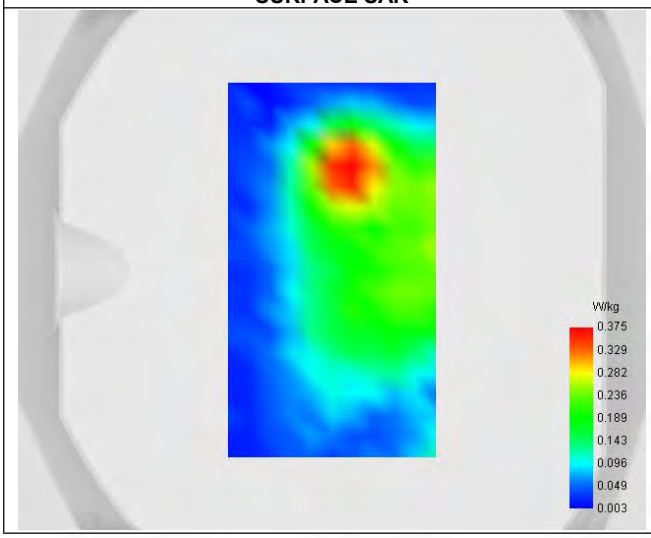
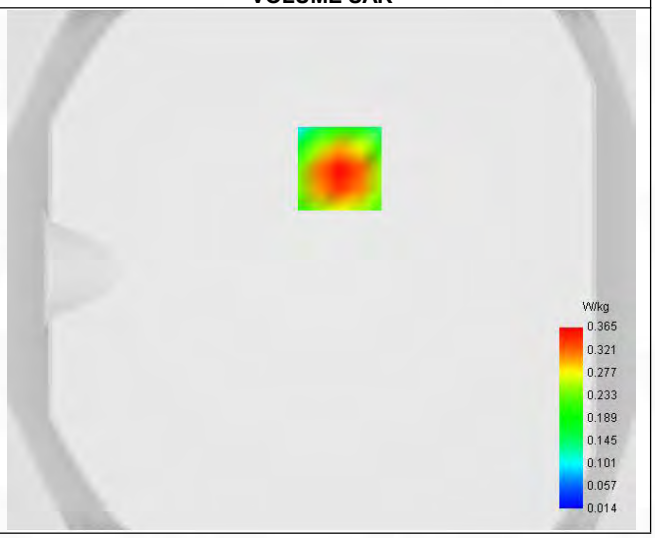
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	GPRS850
Channels	Lower (128)
Signal	TDMA (GPRS)
Modulation	GMSK (CS-1)
TX-slots	2

B. Permitivity

Frequency (MHz)	824.200
Relative permitivity (real part)	41.460
Relative permitivity (imaginary part)	19.740
Conductivity (S/m)	0.869

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=7.00, Y=39.00 ; SAR Peak: 0.55 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.205
SAR 1g (W/Kg)	0.350
Variation (%)	-0.590
Horizontal validation criteria: minimum distance (mm)	9.264
Vertical validation criteria: SAR ratio M2/M1 (%)	59.45%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.549	0.365	0.217	0.134	0.090

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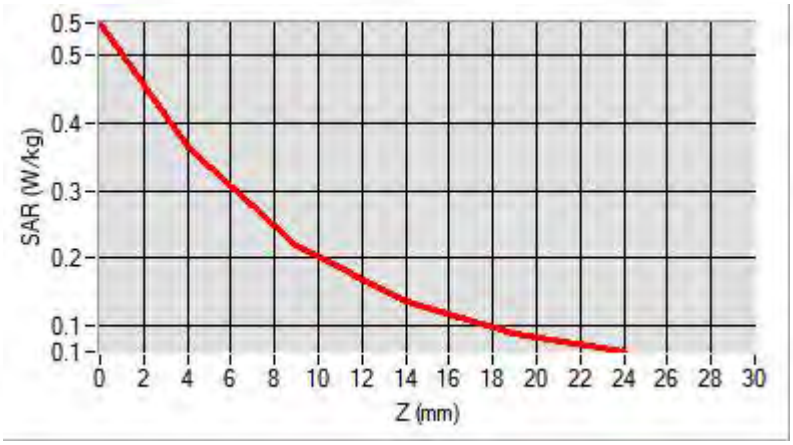
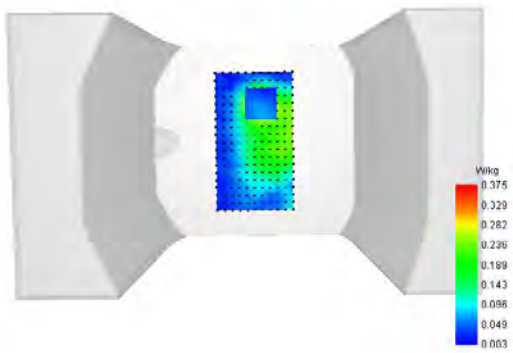
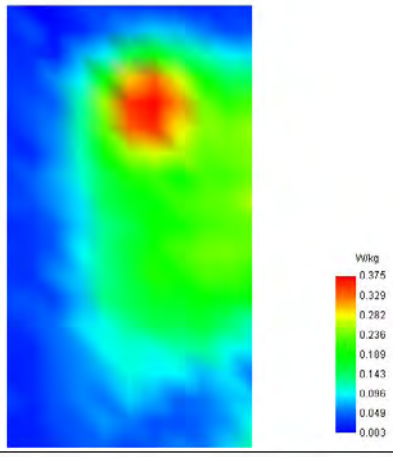


F. 3D Image

3D screen shot	Hot spot position
	

3-Head with front position in dist. 0mm on Channel 512 in GSM1900 voice

SAR Measurement at GSM1900 (Cheek, Right)

Date of measurement: 4/6/2024

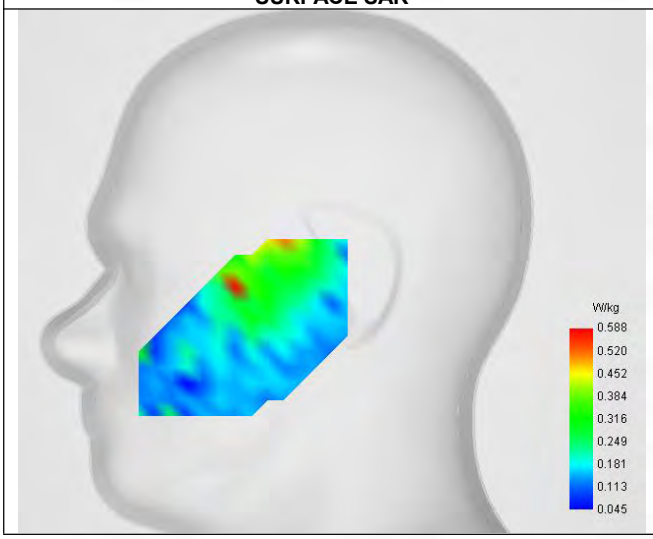
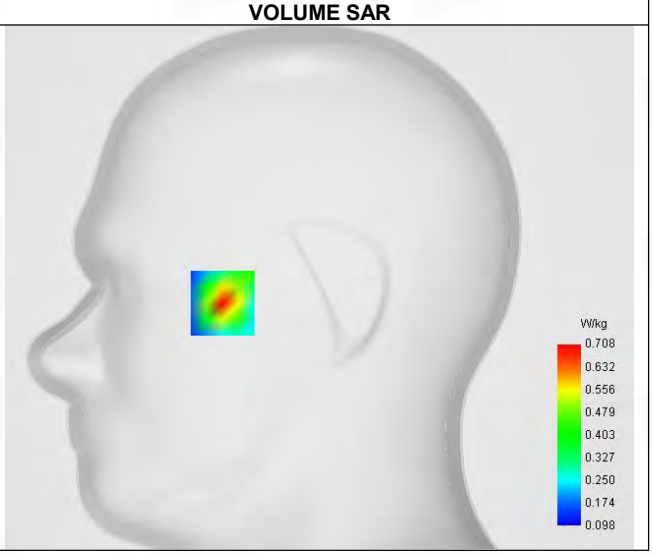
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	GSM1900
Channels	Lower (512)
Signal	TDMA (GSM)
Modulation	GMSK

B. Permitivity

Frequency (MHz)	1850.200
Relative permitivity (real part)	39.895
Relative permitivity (imaginary part)	13.734
Conductivity (S/m)	1.390

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-48.00, Y=-8.00 ; SAR Peak: 1.50 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.345
SAR 1g (W/Kg)	0.679
Variation (%)	1.230
Horizontal validation criteria: minimum distance (mm)	8.715
Vertical validation criteria: SAR ratio M2/M1 (%)	49.72%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.506	0.708	0.352	0.117	0.113

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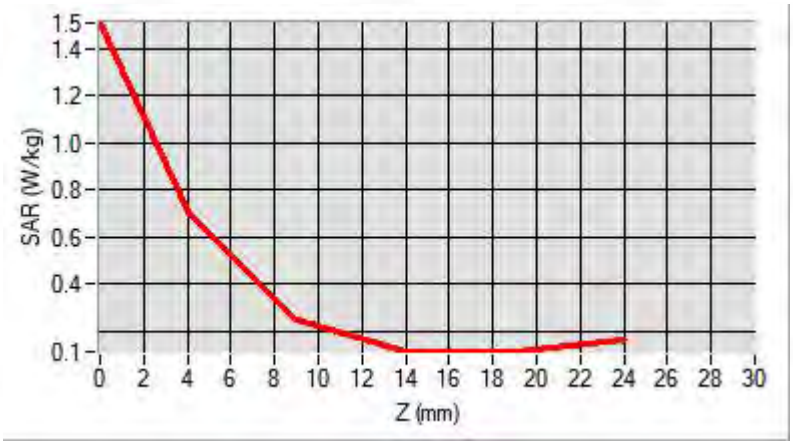
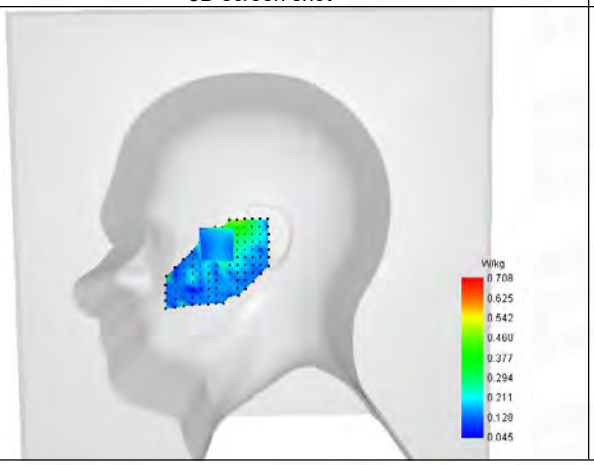
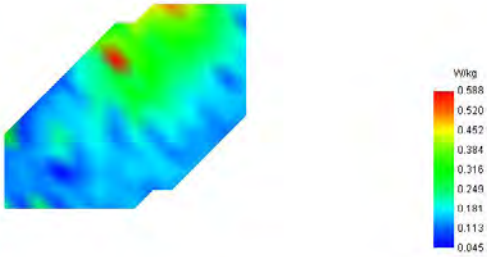


F. 3D Image

3D screen shot	Hot spot position
	

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4-Body with back position in dist. 10mm on Channel 810 in GPRS1900+3slots

SAR Measurement at GPRS1900 (Body, Validation Plane)

Date of measurement: 5/6/2024

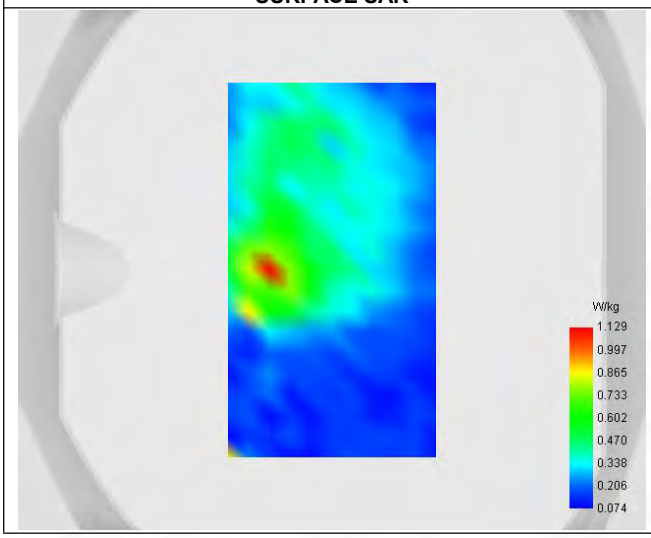
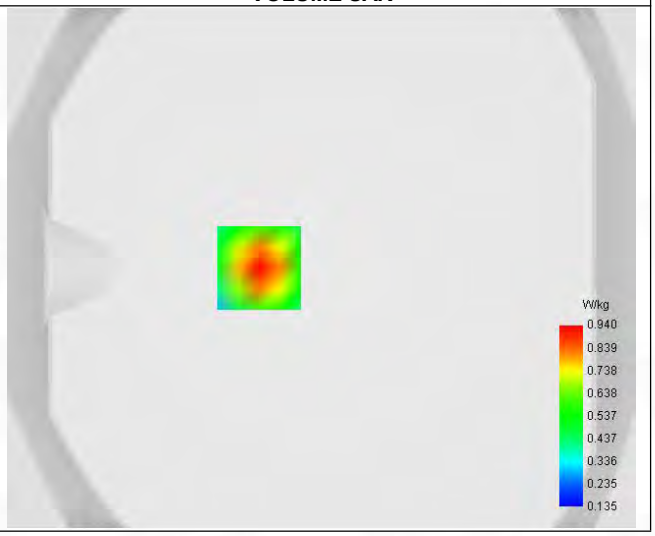
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	GPRS1900
Channels	Higher (810)
Signal	TDMA (GPRS)
Modulation	GMSK (CS-1)
TX-slots	3

B. Permitivity

Frequency (MHz)	1909.800
Relative permitivity (real part)	39.866
Relative permitivity (imaginary part)	13.379
Conductivity (S/m)	1.417

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-24.00, Y=0.00 ; SAR Peak: 1.45 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.536
SAR 1g (W/Kg)	0.770
Variation (%)	3.280
Horizontal validation criteria: minimum distance (mm)	8.533
Vertical validation criteria: SAR ratio M2/M1 (%)	59.26%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.449	0.940	0.557	0.366	0.285

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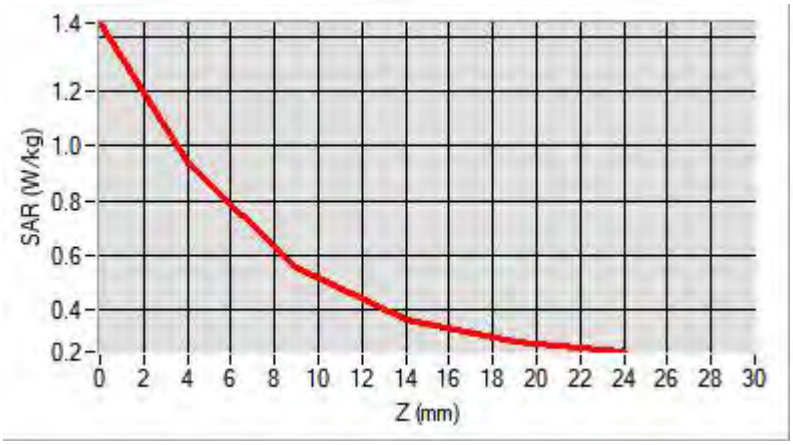
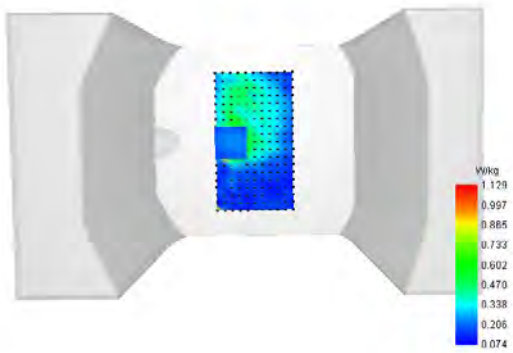
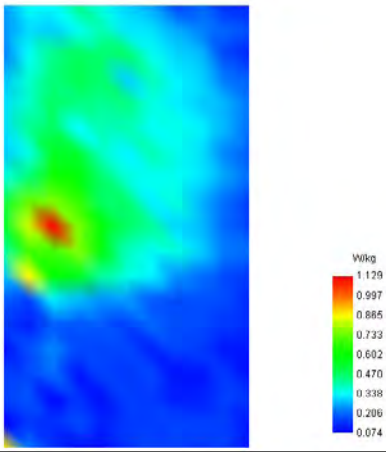


F. 3D Image

3D screen shot	Hot spot position
	

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5-Head with front position in dist. 0mm on Channel 9538 in WCDMA Band 2

SAR Measurement at Band 2 (1900) (Cheek, Right)

Date of measurement: 5/6/2024

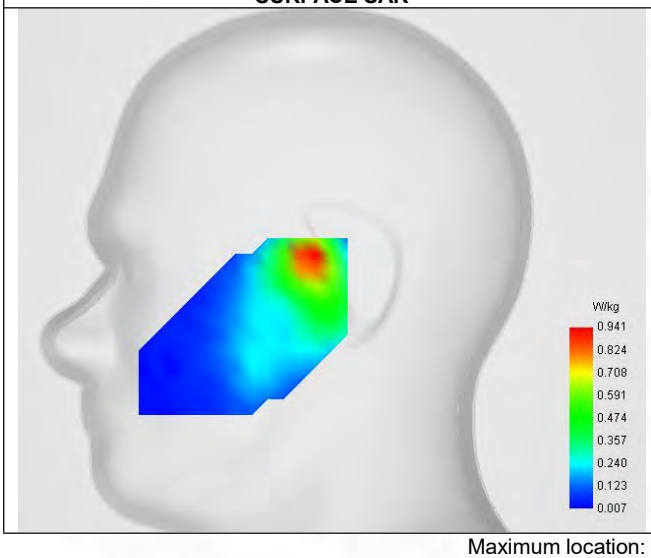
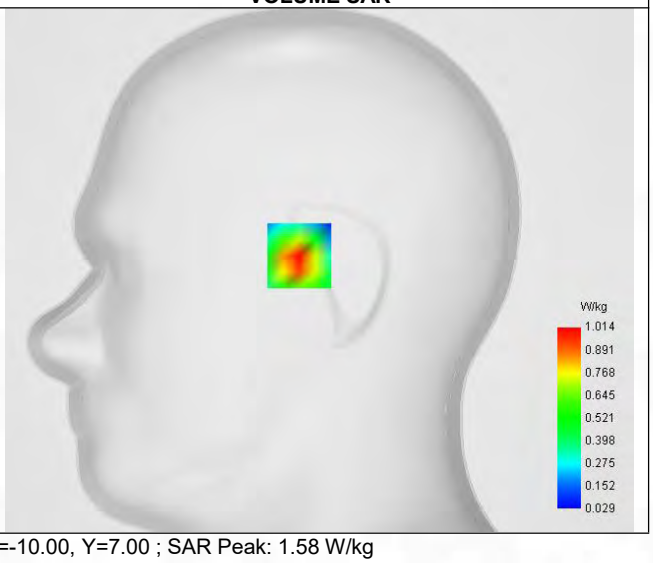
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.07
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	Band 2 (1900)
Channels	Higher (9538)
Signal	WCDMA
Mode	Release 99
Connection Type	RMC, 12.2 kbps

B. Permitivity

Frequency (MHz)	1907.600
Relative permitivity (real part)	39.869
Relative permitivity (imaginary part)	13.379
Conductivity (S/m)	1.416

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-10.00, Y=7.00 ; SAR Peak: 1.58 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.501
SAR 1g (W/Kg)	0.957
Variation (%)	-2.650
Horizontal validation criteria: minimum distance (mm)	8.626
Vertical validation criteria: SAR ratio M2/M1 (%)	56.41%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.566	1.014	0.572	0.319	0.181

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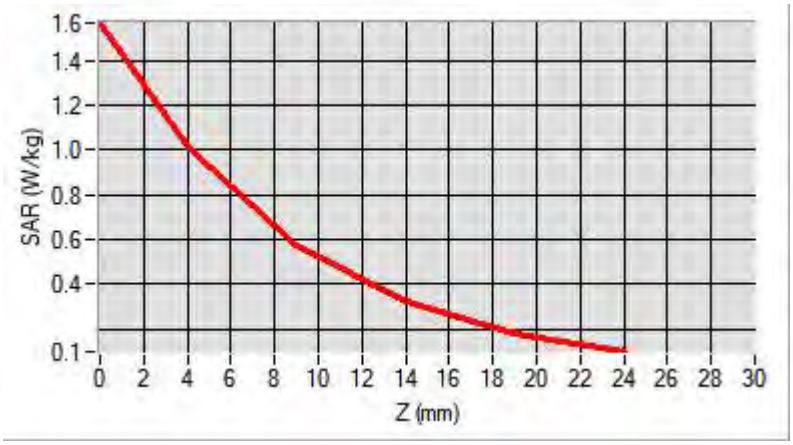
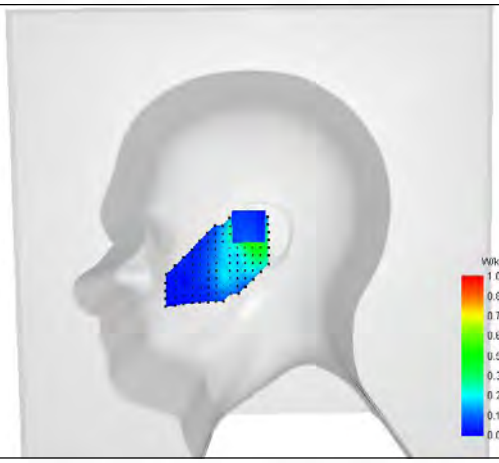
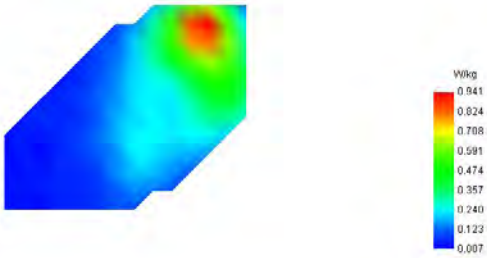


F. 3D Image

3D screen shot	Hot spot position
	

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6-Body with back position in dist. 10mm on Channel 9538 in WCDMA Band 2

SAR Measurement at Band 2 (1900) (Body, Validation Plane)

Date of measurement: 5/6/2024

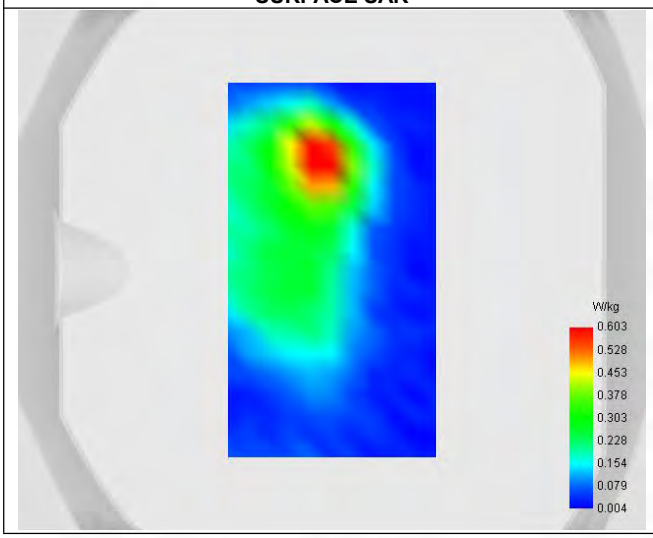
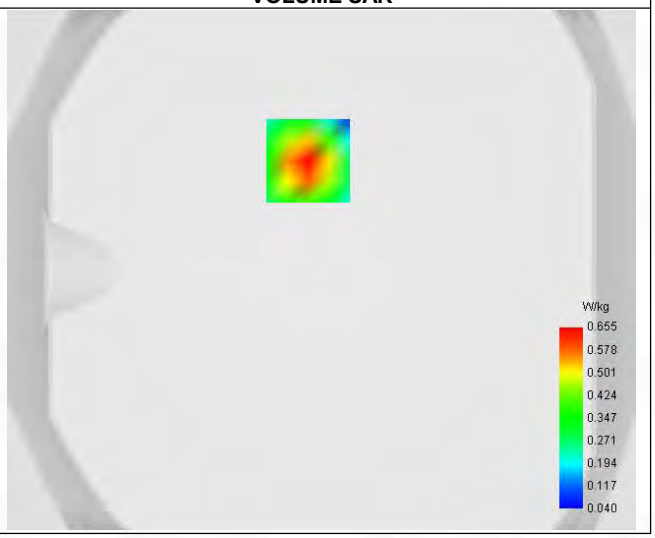
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	Band 2 (1900)
Channels	Higher (9538)
Signal	WCDMA
Mode	Release 99
Connection Type	RMC, 12.2 kbps

B. Permitivity

Frequency (MHz)	1907.600
Relative permitivity (real part)	39.869
Relative permitivity (imaginary part)	13.379
Conductivity (S/m)	1.416

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-5.00, Y=42.00 ; SAR Peak: 1.05 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.326
SAR 1g (W/Kg)	0.616
Variation (%)	-2.270
Horizontal validation criteria: minimum distance (mm)	8.756
Vertical validation criteria: SAR ratio M2/M1 (%)	53.89%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.049	0.655	0.353	0.192	0.111

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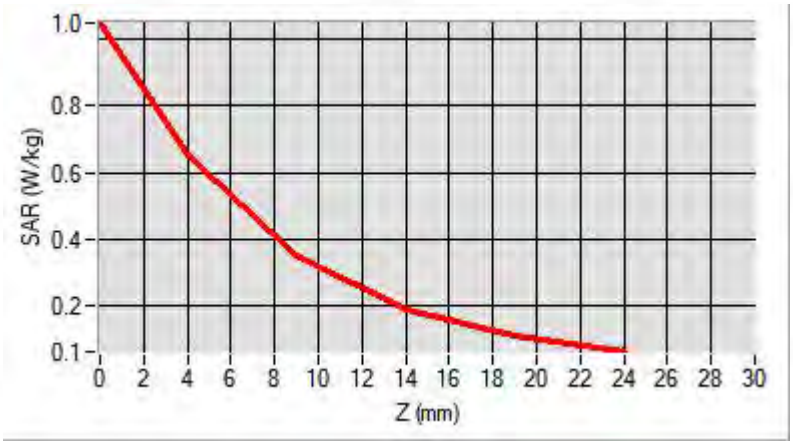
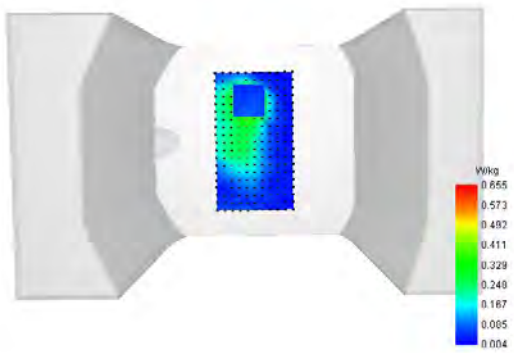
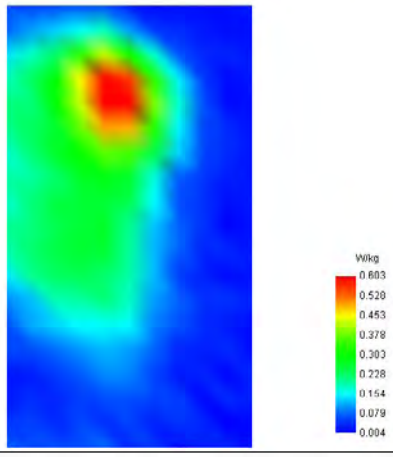


F. 3D Image

3D screen shot	Hot spot position
	

7-Head with front position in dist. 0mm on Channel 1312 in WCDMA Band 4

SAR Measurement at Band 4 (1700) (Cheek, Right)

Date of measurement: 4/6/2024

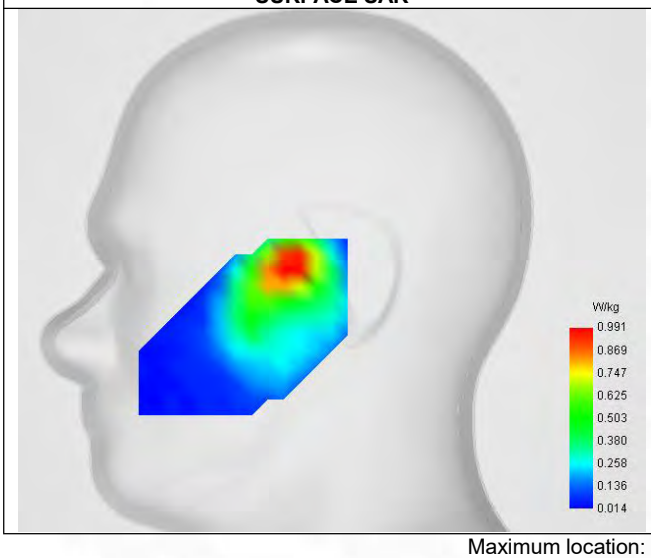
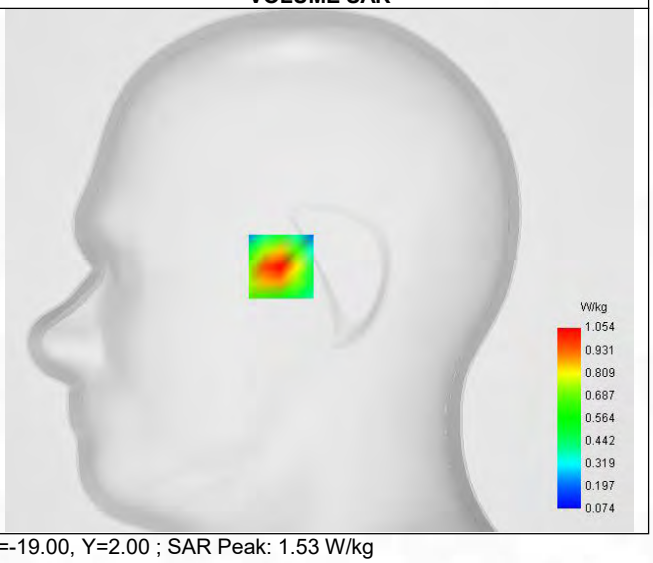
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.96
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	Band 4 (1700)
Channels	Lower (1312)
Signal	WCDMA
Mode	Release 99
Connection Type	RMC, 12.2 kbps

B. Permitivity

Frequency (MHz)	1712.400
Relative permitivity (real part)	40.046
Relative permitivity (imaginary part)	14.580
Conductivity (S/m)	1.325

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-19.00, Y=2.00 ; SAR Peak: 1.53 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.569
SAR 1g (W/Kg)	0.986
Variation (%)	1.730
Horizontal validation criteria: minimum distance (mm)	8.932
Vertical validation criteria: SAR ratio M2/M1 (%)	62.90%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.510	1.054	0.663	0.417	0.265

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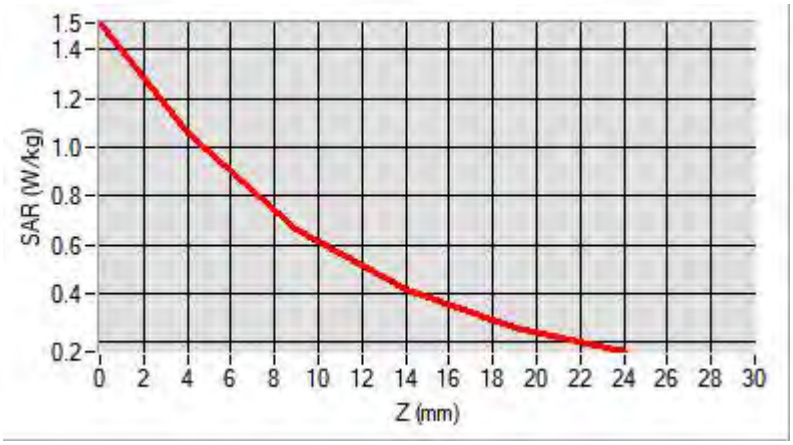
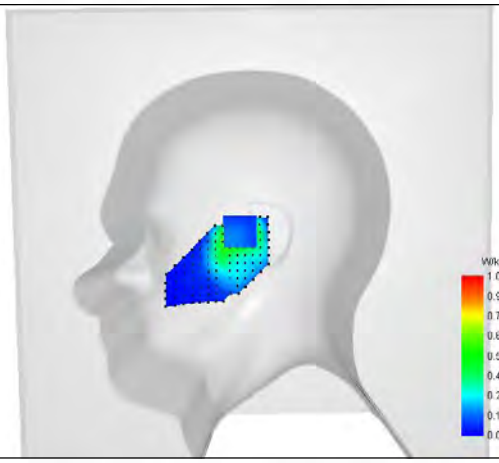
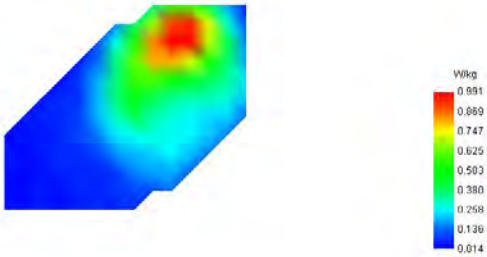


F. 3D Image

3D screen shot	Hot spot position
	

8-Body with back position in dist. 10mm on Channel 1312 in WCDMA Band 4

SAR Measurement at Band 4 (1700) (Body, Validation Plane)

Date of measurement: 4/6/2024

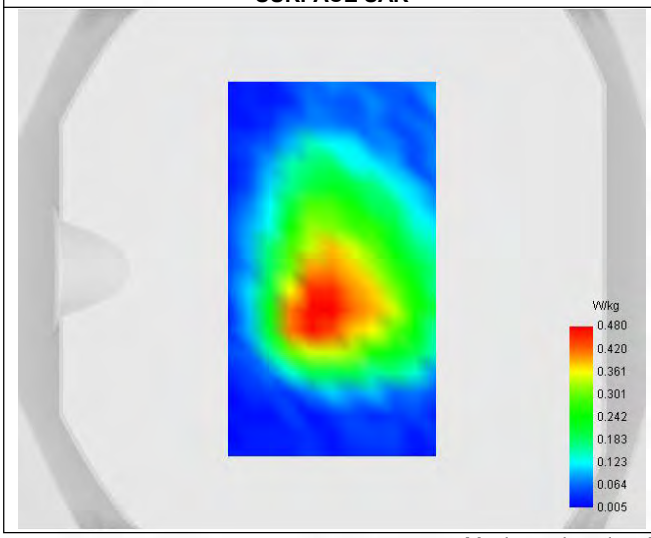
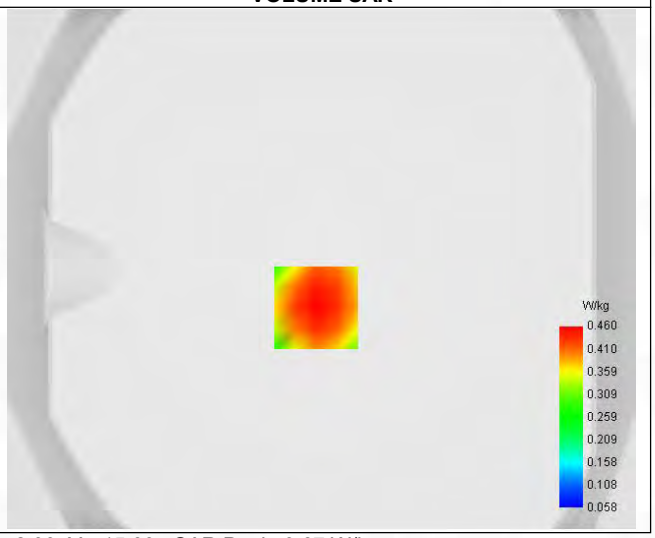
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.96
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	Band 4 (1700)
Channels	Lower (1312)
Signal	WCDMA
Mode	Release 99
Connection Type	RMC, 12.2 kbps

B. Permitivity

Frequency (MHz)	1712.400
Relative permitivity (real part)	40.046
Relative permitivity (imaginary part)	14.580
Conductivity (S/m)	1.325

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-2.00, Y=-15.00 ; SAR Peak: 0.67 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.288
SAR 1g (W/Kg)	0.443
Variation (%)	3.200
Horizontal validation criteria: minimum distance (mm)	9.264
Vertical validation criteria: SAR ratio M2/M1 (%)	62.17%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.667	0.460	0.286	0.180	0.117

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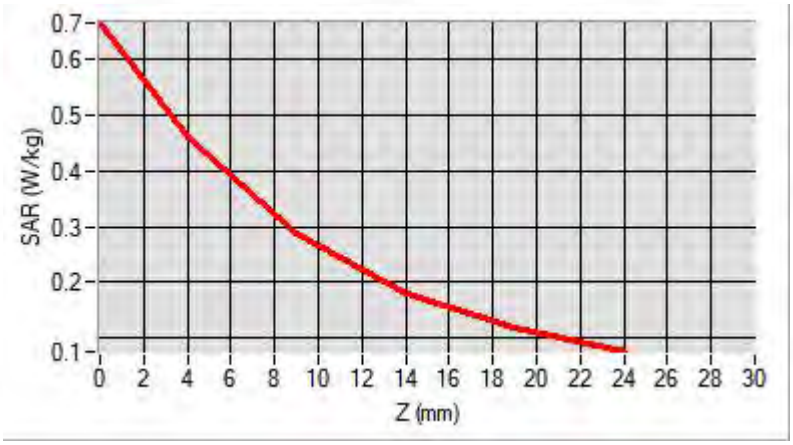
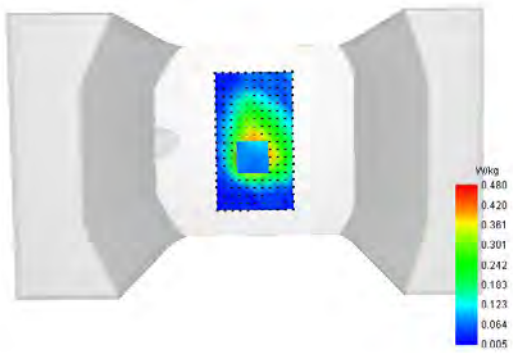
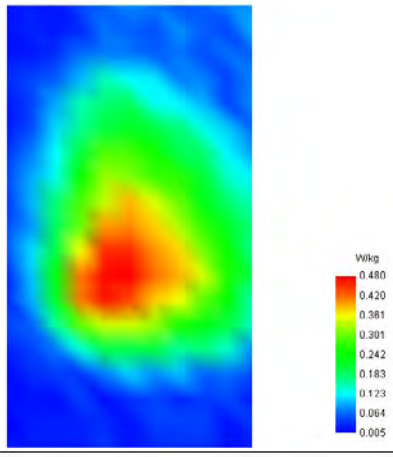


F. 3D Image

3D screen shot	Hot spot position
	

9-Head with front position in dist. 0mm on Channel 4132 in WCDMA Band 5

SAR Measurement at Band 5 (850) (Cheek, Right)

Date of measurement: 3/6/2024

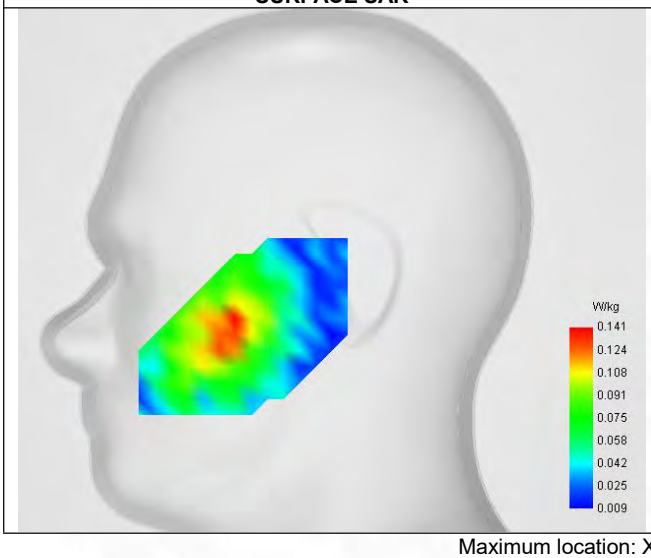
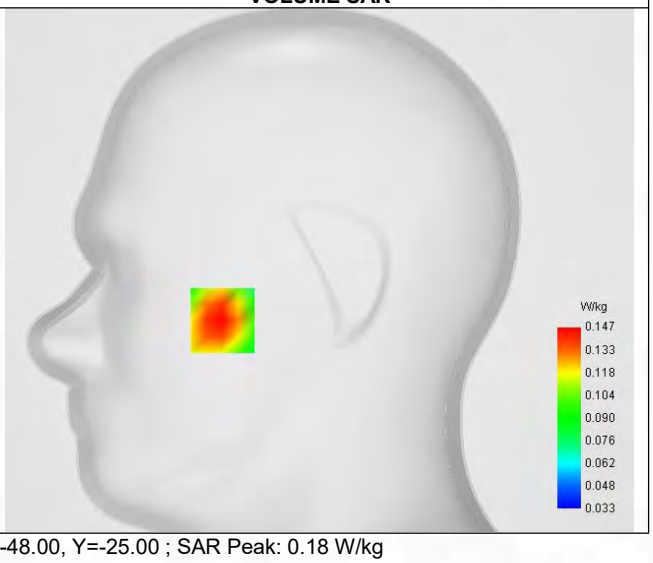
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	Band 5 (850)
Channels	Lower (4132)
Signal	WCDMA
Mode	Release 99
Connection Type	RMC, 12.2 kbps

B. Permitivity

Frequency (MHz)	826.400
Relative permitivity (real part)	41.449
Relative permitivity (imaginary part)	19.689
Conductivity (S/m)	0.869

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-48.00, Y=-25.00 ; SAR Peak: 0.18 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.107
SAR 1g (W/Kg)	0.143
Variation (%)	-3.410
Horizontal validation criteria: minimum distance (mm)	9.455
Vertical validation criteria: SAR ratio M2/M1 (%)	68.71%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.167	0.147	0.101	0.085	0.070

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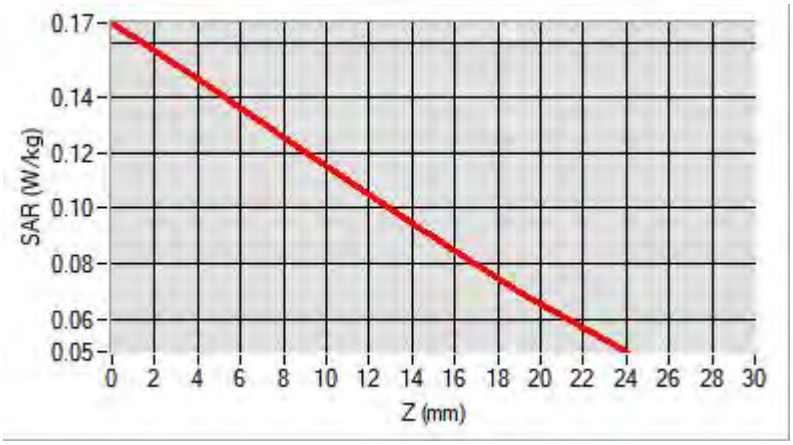
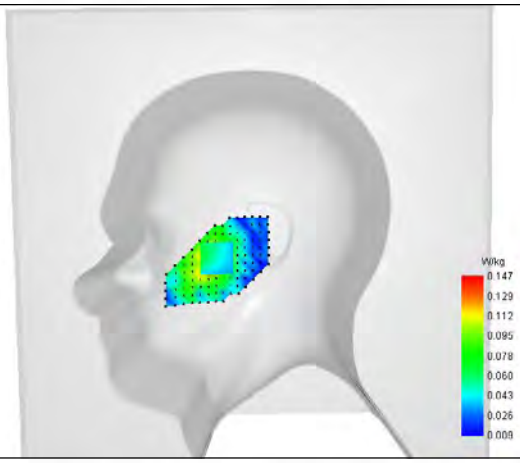
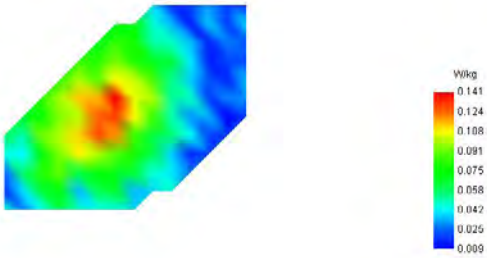


F. 3D Image

3D screen shot	Hot spot position
	

10-Body with front position in dist. 10mm on Channel 4132 in WCDMA Band 5

SAR Measurement at Band 5 (850) (Body, Validation Plane)

Date of measurement: 3/6/2024

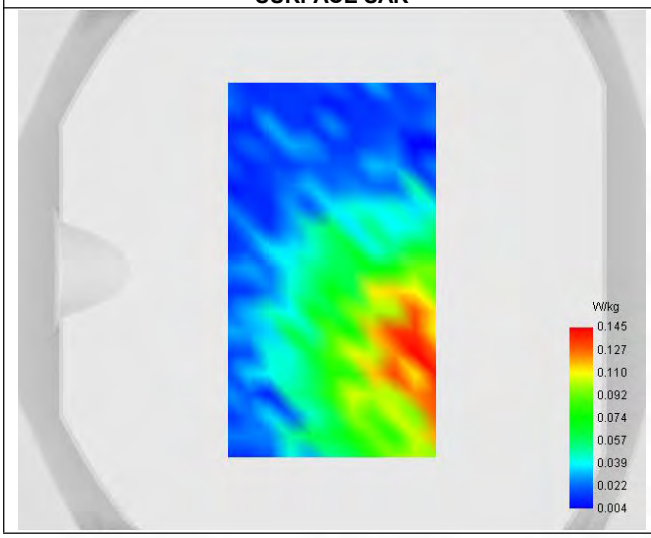
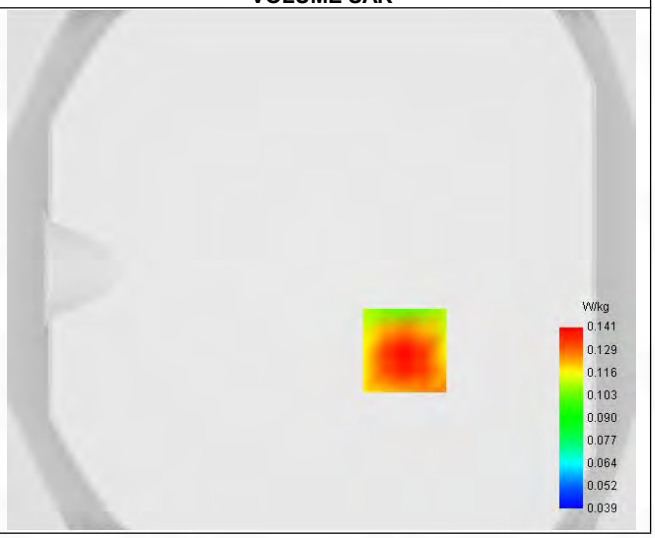
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	Band 5 (850)
Channels	Lower (4132)
Signal	WCDMA
Mode	Release 99
Connection Type	RMC, 12.2 kbps

B. Permitivity

Frequency (MHz)	826.400
Relative permitivity (real part)	41.449
Relative permitivity (imaginary part)	19.689
Conductivity (S/m)	0.869

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=32.00, Y=-31.00 ; SAR Peak: 0.19 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.101
SAR 1g (W/Kg)	0.137
Variation (%)	4.150
Horizontal validation criteria: minimum distance (mm)	9.452
Vertical validation criteria: SAR ratio M2/M1 (%)	72.34%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.187	0.141	0.102	0.077	0.062

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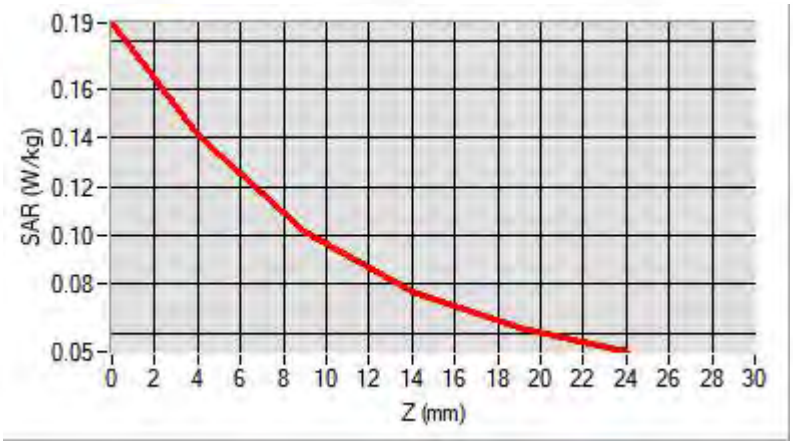
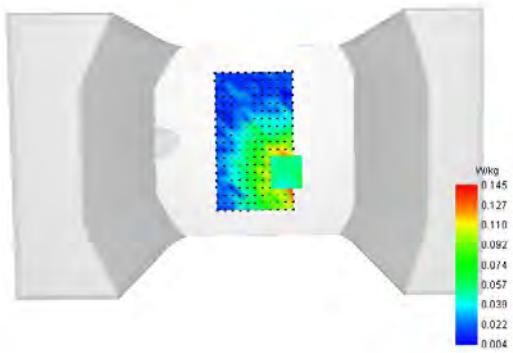
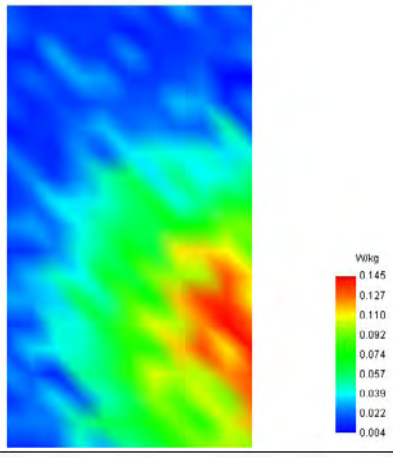


F. 3D Image

3D screen shot	Hot spot position
	

11-Head with front position in dist. 0mm on Channel 18700 in LTE band 2

SAR Measurement at LTE band 2 (Cheek, Right)

Date of measurement: 4/6/2024

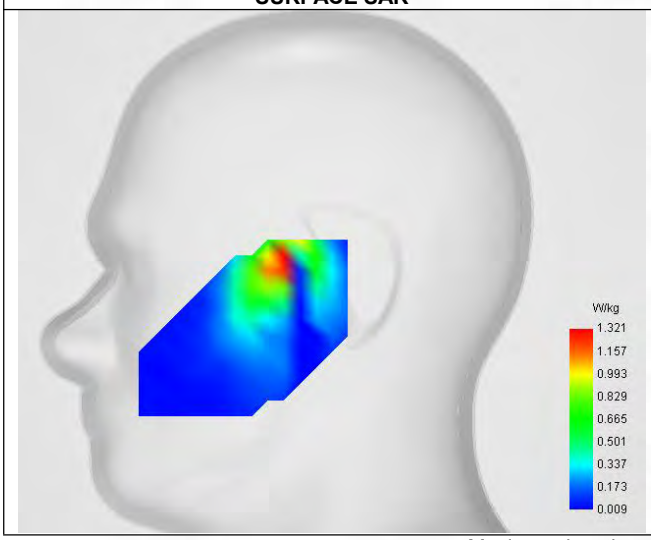
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.07
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 2
Channels	Lower (18700)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1

B. Permitivity

Frequency (MHz)	1851.090
Relative permitivity (real part)	39.895
Relative permitivity (imaginary part)	13.727
Conductivity (S/m)	1.390

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-26.00, Y=3.00 ; SAR Peak: 1.52 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.570
SAR 1g (W/Kg)	1.004
Variation (%)	-2.640
Horizontal validation criteria: minimum distance (mm)	8.936
Vertical validation criteria: SAR ratio M2/M1 (%)	63.68%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00

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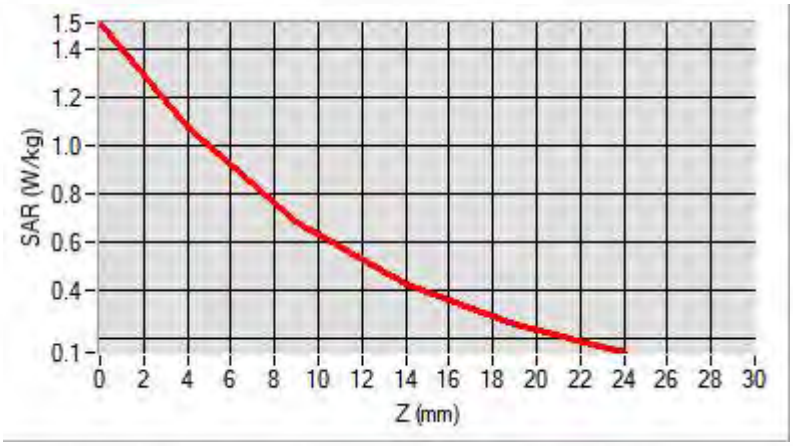
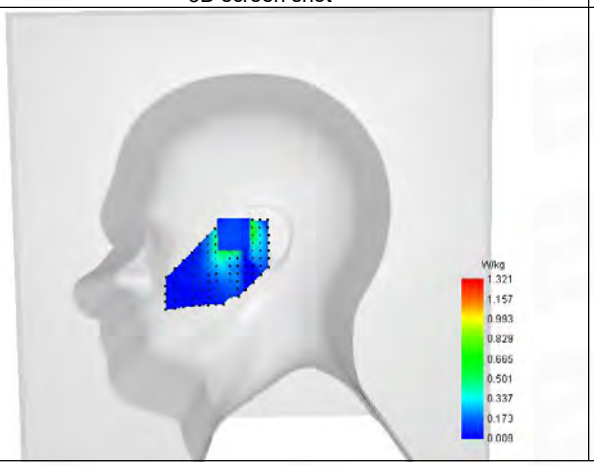
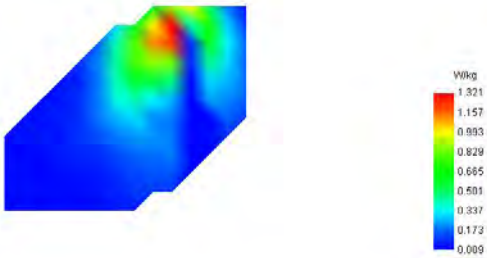
SAR (W/Kg)	1.508	1.071	0.682	0.424	0.256



F. 3D Image

3D screen shot	Hot spot position
	

12-Body with back position in dist. 10mm on Channel 18700 in LTE band 2

SAR Measurement at LTE band 2 (Body, Validation Plane)

Date of measurement: 4/6/2024

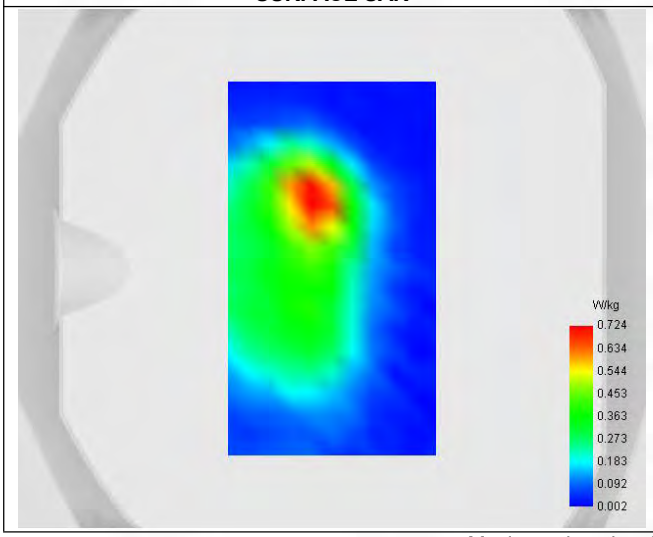
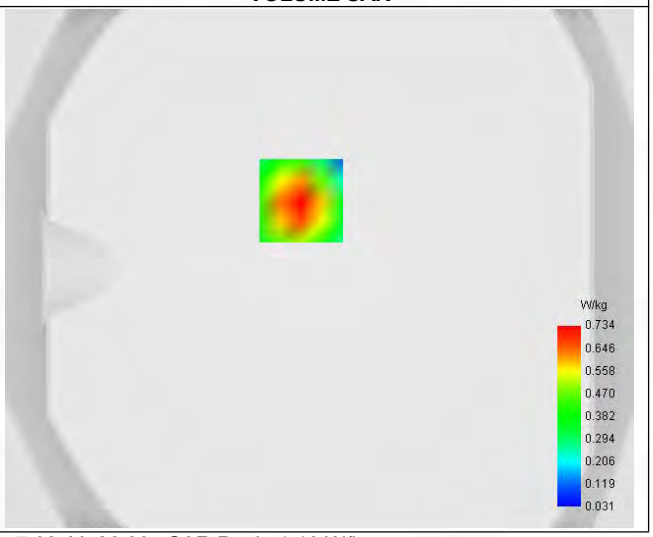
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 2
Channels	Lower (18700)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1

B. Permitivity

Frequency (MHz)	1851.090
Relative permitivity (real part)	39.895
Relative permitivity (imaginary part)	13.727
Conductivity (S/m)	1.390

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-7.00, Y=26.00 ; SAR Peak: 1.10 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.389
SAR 1g (W/Kg)	0.691
Variation (%)	3.090
Horizontal validation criteria: minimum distance (mm)	9.451
Vertical validation criteria: SAR ratio M2/M1 (%)	58.68%

E. Z Axis Scan

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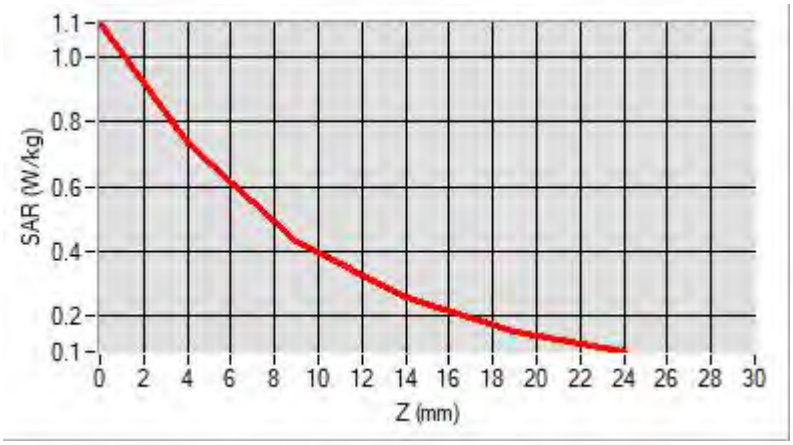
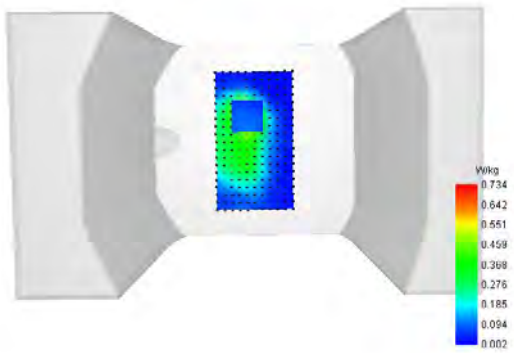
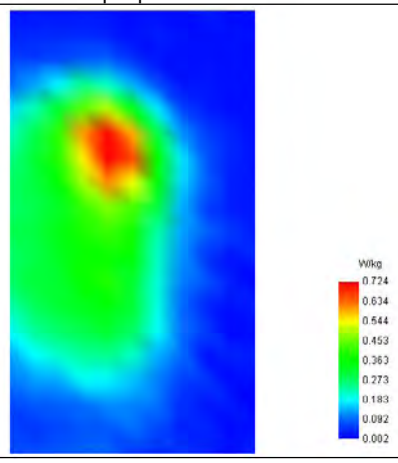
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.103	0.734	0.432	0.255	0.155



F. 3D Image

3D screen shot	Hot spot position
	

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13-Head with front position in dist. 0mm on Channel 20050 in LTE band 4

SAR Measurement at LTE band 4 (Cheek, Right)

Date of measurement: 4/6/2024

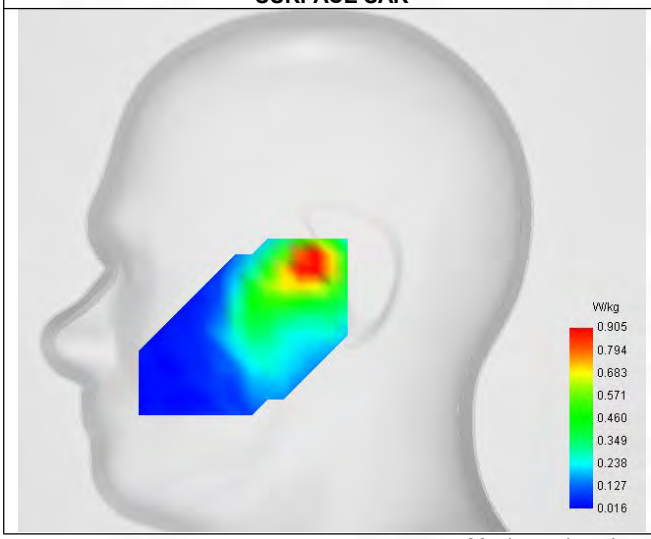
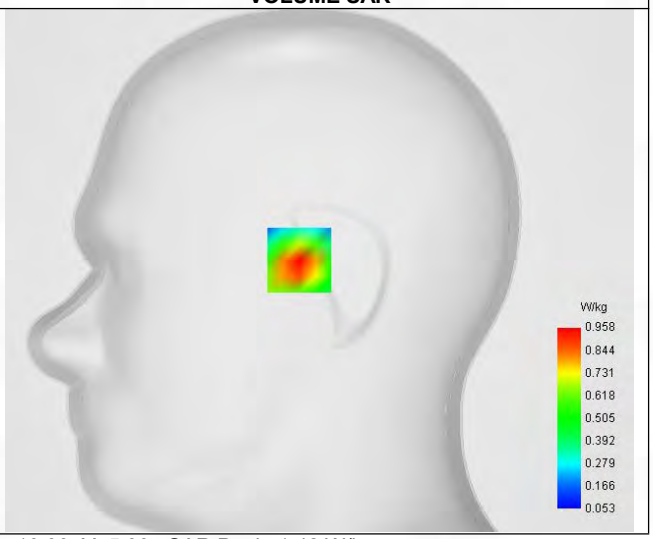
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.79
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 4
Channels	Lower (20050)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	99
RB size	1

B. Permitivity

Frequency (MHz)	1728.910
Relative permitivity (real part)	40.021
Relative permitivity (imaginary part)	14.488
Conductivity (S/m)	1.333

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-10.00, Y=5.00 ; SAR Peak: 1.42 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.411
SAR 1g (W/Kg)	0.725
Variation (%)	-0.490
Horizontal validation criteria: minimum distance (mm)	8.154
Vertical validation criteria: SAR ratio M2/M1 (%)	60.33%

E. Z Axis Scan

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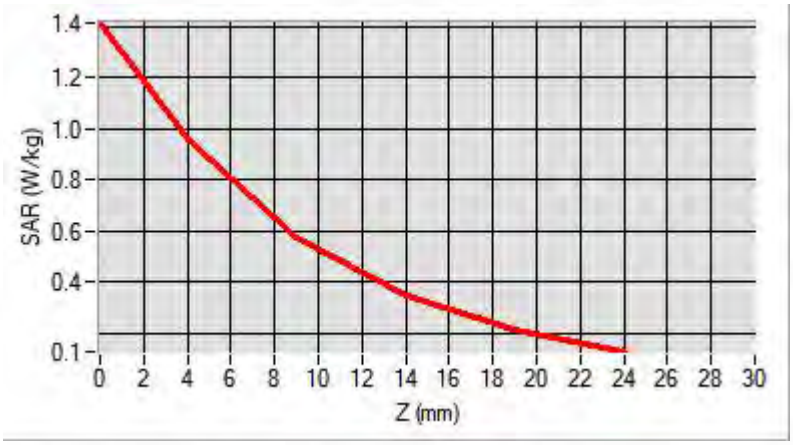
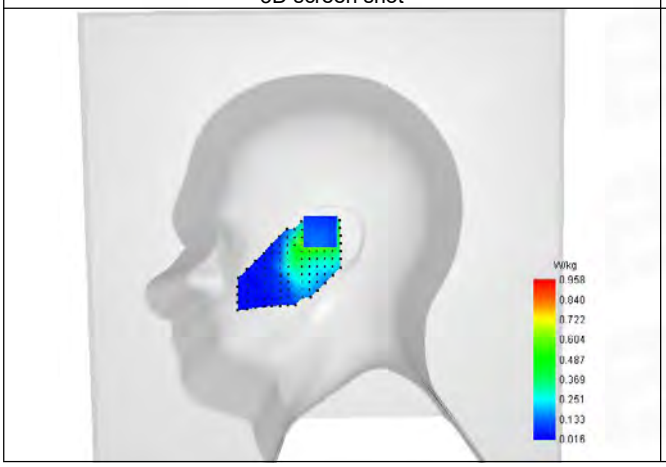
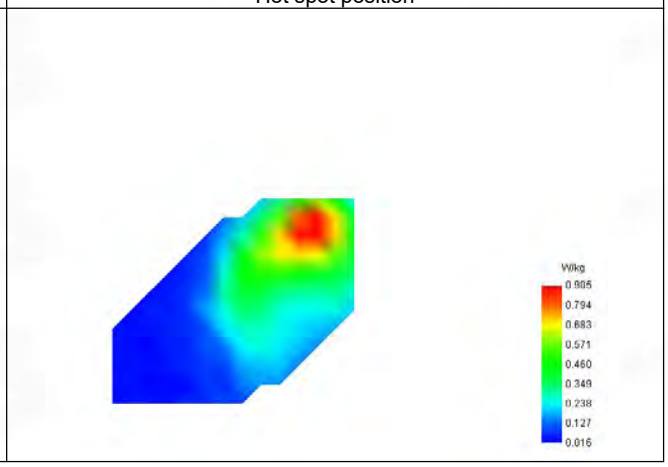
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.414	0.958	0.578	0.349	0.215



F. 3D Image

3D screen shot	Hot spot position
	

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14-Body with back position in dist. 10mm on Channel 20050 in LTE band 4

SAR Measurement at LTE band 4 (Body, Validation Plane)

Date of measurement: 4/6/2024

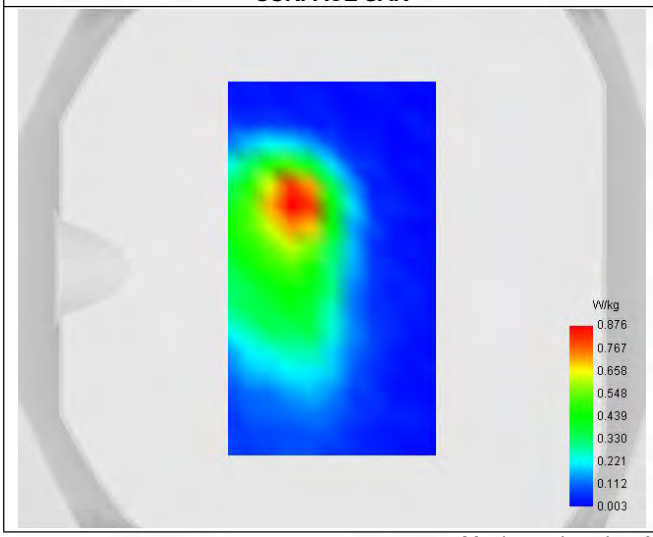
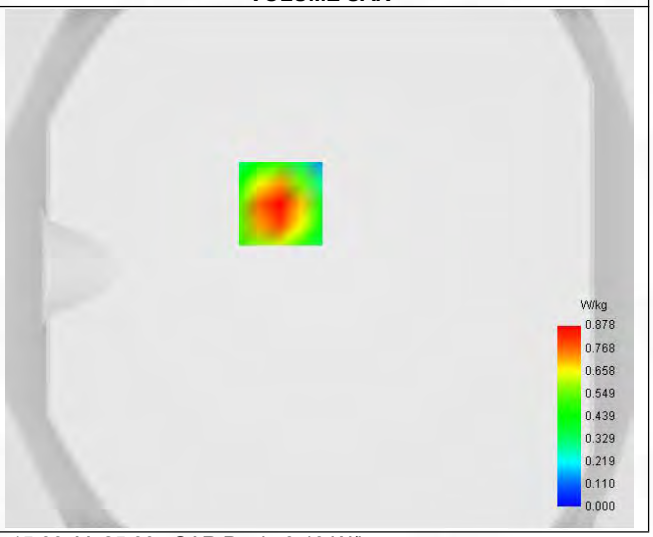
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.96
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 4
Channels	Lower (20050)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	99
RB size	1

B. Permitivity

Frequency (MHz)	1728.910
Relative permitivity (real part)	40.021
Relative permitivity (imaginary part)	14.488
Conductivity (S/m)	1.333

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-15.00, Y=25.00 ; SAR Peak: 3.40 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.466
SAR 1g (W/Kg)	0.729
Variation (%)	-3.100
Horizontal validation criteria: minimum distance (mm)	8.625
Vertical validation criteria: SAR ratio M2/M1 (%)	48.41%

E. Z Axis Scan

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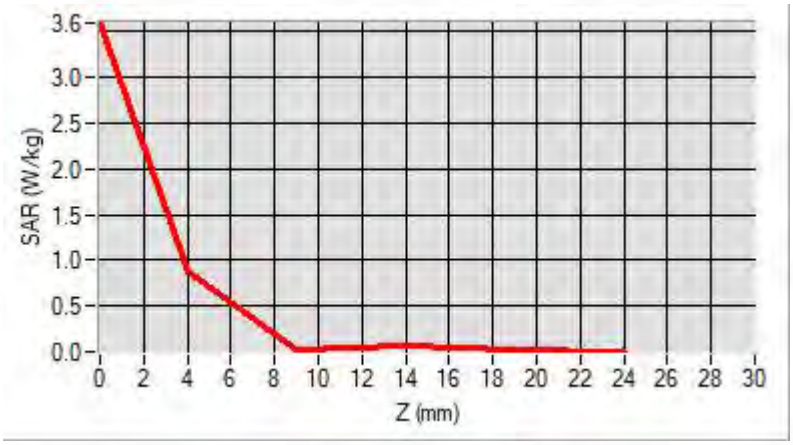
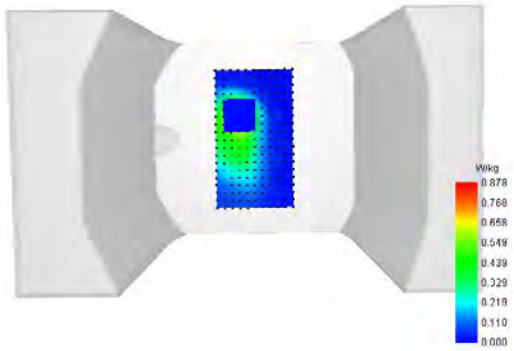
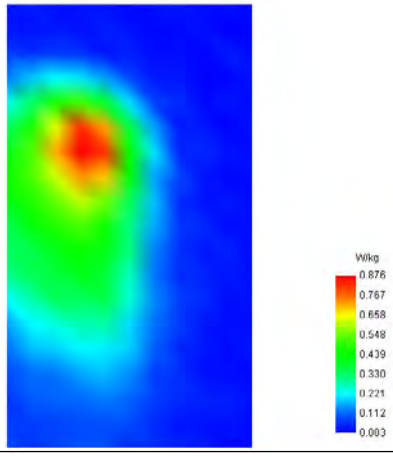
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	3.596	0.878	0.425	0.270	0.116



F. 3D Image

3D screen shot	Hot spot position
	

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15-Head with front position in dist. 0mm on Channel 20450 in LTE band 5

SAR Measurement at LTE band 5 (Cheek, Right)

Date of measurement: 3/6/2024

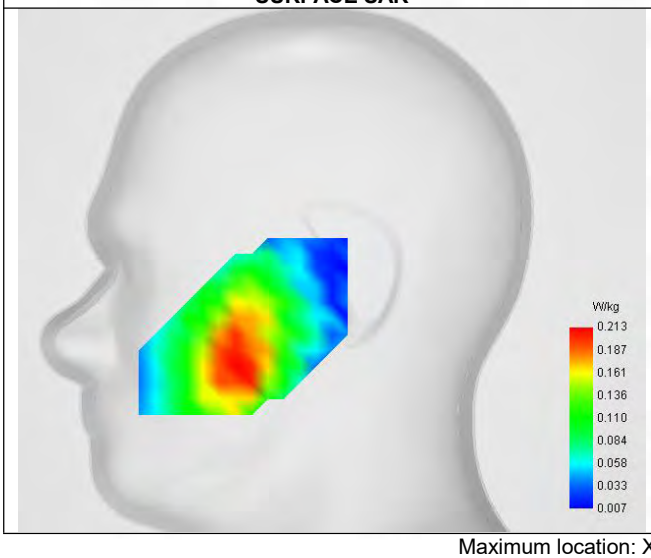
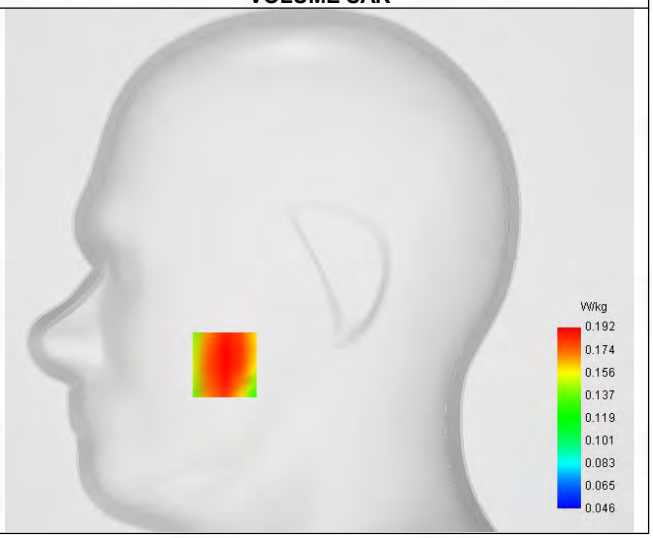
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 5
Channels	Lower (20450)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1

B. Permitivity

Frequency (MHz)	824.590
Relative permitivity (real part)	41.458
Relative permitivity (imaginary part)	19.731
Conductivity (S/m)	0.869

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-47.00, Y=-47.00 ; SAR Peak: 0.22 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.151
SAR 1g (W/Kg)	0.188
Variation (%)	-2.620
Horizontal validation criteria: minimum distance (mm)	8.544
Vertical validation criteria: SAR ratio M2/M1 (%)	73.44%

E. Z Axis Scan

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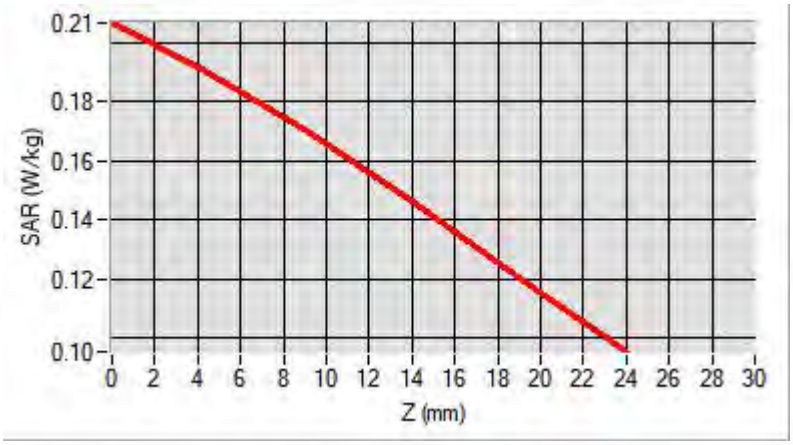
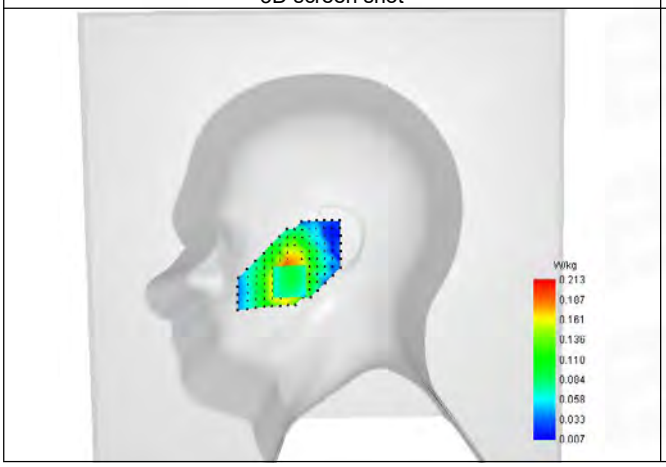
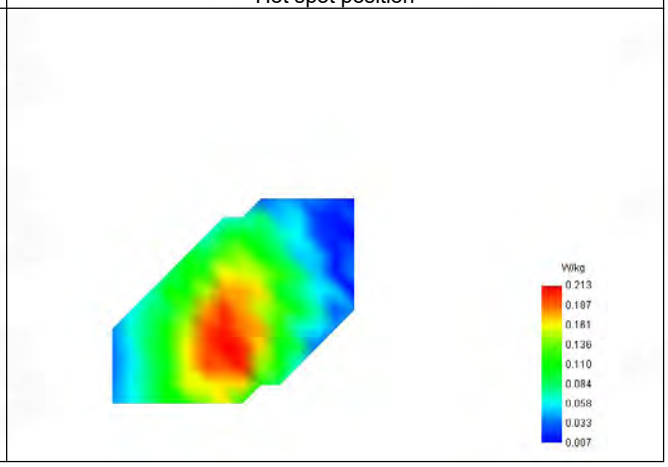
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.207	0.192	0.141	0.116	0.090



F. 3D Image

3D screen shot	Hot spot position
	

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16-Body with front position in dist. 10mm on Channel 20450 in LTE band 5

SAR Measurement at LTE band 5 (Body, Validation Plane)

Date of measurement: 3/6/2024

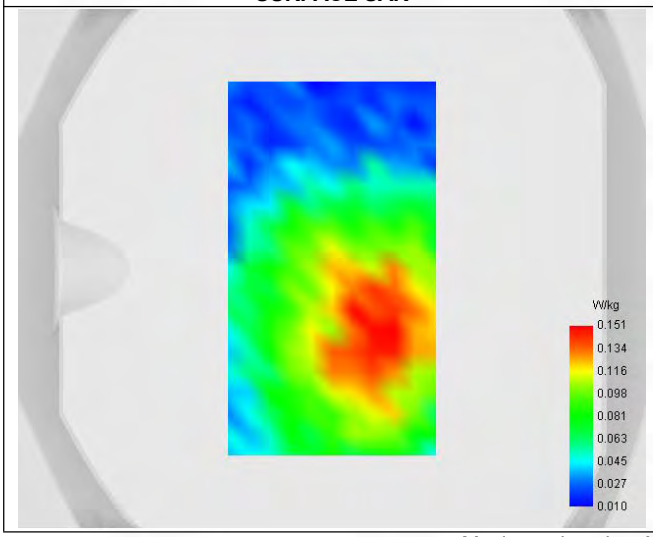
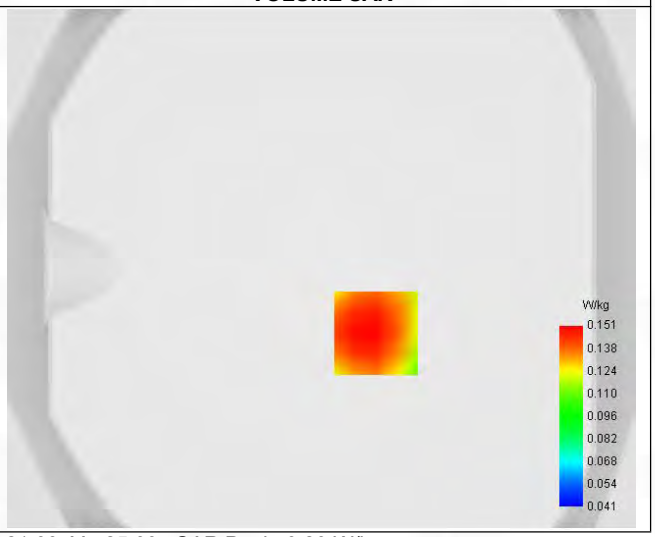
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 5
Channels	Lower (20450)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	49
RB size	1

B. Permitivity

Frequency (MHz)	833.410
Relative permitivity (real part)	41.417
Relative permitivity (imaginary part)	19.527
Conductivity (S/m)	0.870

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=21.00, Y=-25.00 ; SAR Peak: 0.20 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.113
SAR 1g (W/Kg)	0.149
Variation (%)	-3.540
Horizontal validation criteria: minimum distance (mm)	10.362
Vertical validation criteria: SAR ratio M2/M1 (%)	67.55%

E. Z Axis Scan

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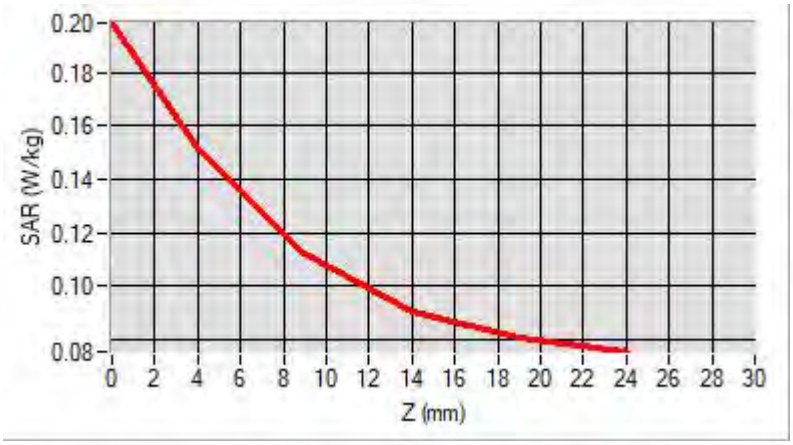
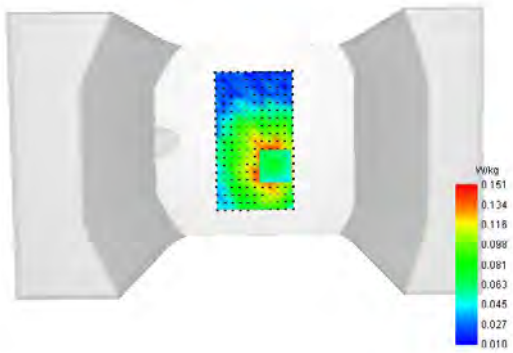
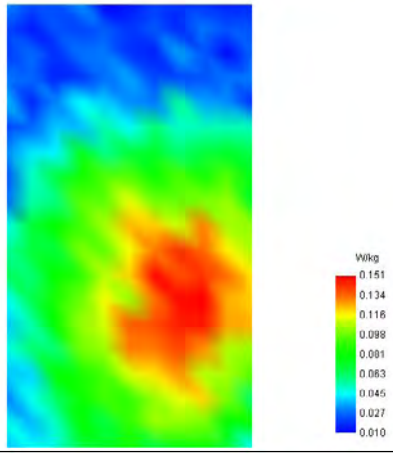
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.198	0.151	0.102	0.091	0.080



F. 3D Image

3D screen shot	Hot spot position
	

17-Head with front position in dist. 0mm on Channel 23095 in LTE band 12

SAR Measurement at LTE band 12 (Cheek, Right)

Date of measurement: 31/5/2024

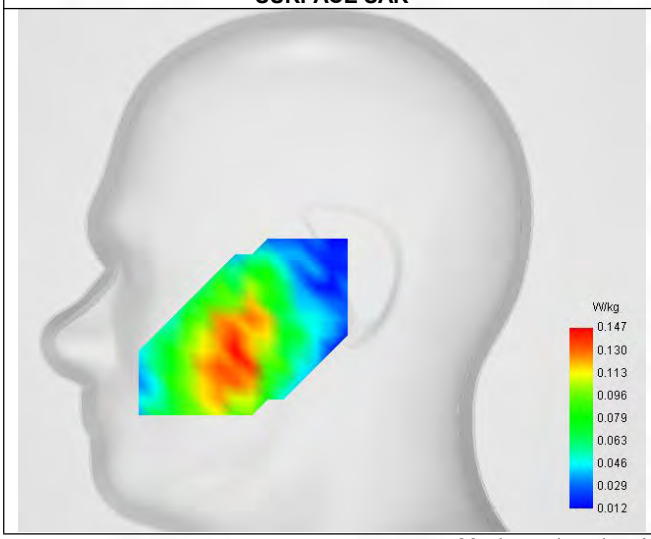
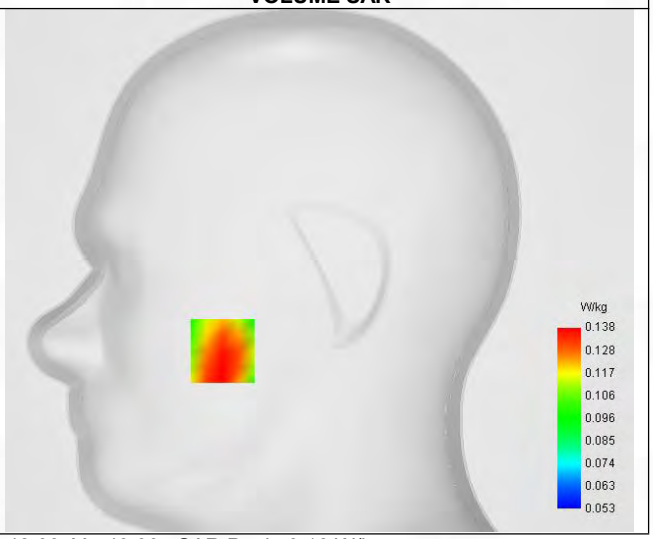
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.65
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 12
Channels	Middle (23095)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	49
RB size	1

B. Permitivity

Frequency (MHz)	711.910
Relative permitivity (real part)	41.975
Relative permitivity (imaginary part)	22.343
Conductivity (S/m)	0.856

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-48.00, Y=-40.00 ; SAR Peak: 0.16 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.110
SAR 1g (W/Kg)	0.135
Variation (%)	-2.970
Horizontal validation criteria: minimum distance (mm)	9.124
Vertical validation criteria: SAR ratio M2/M1 (%)	78.26%

E. Z Axis Scan

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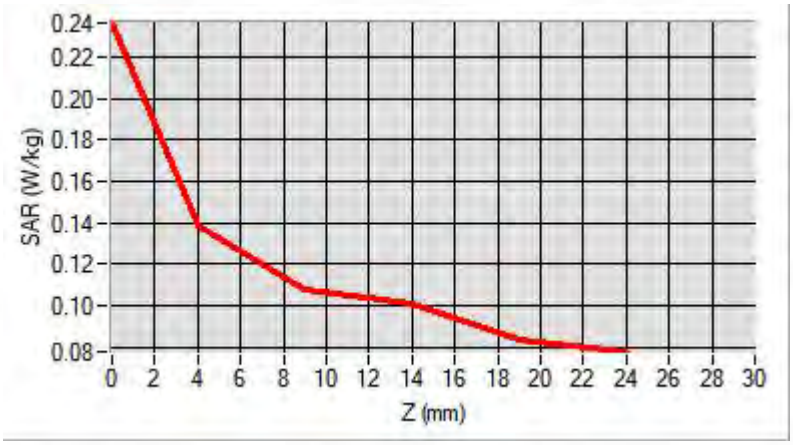
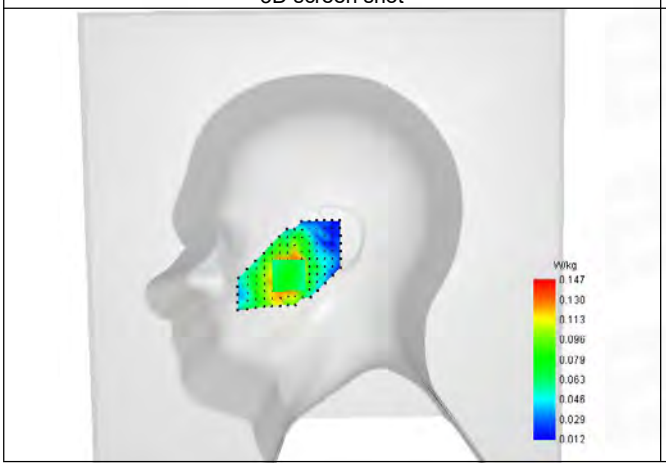
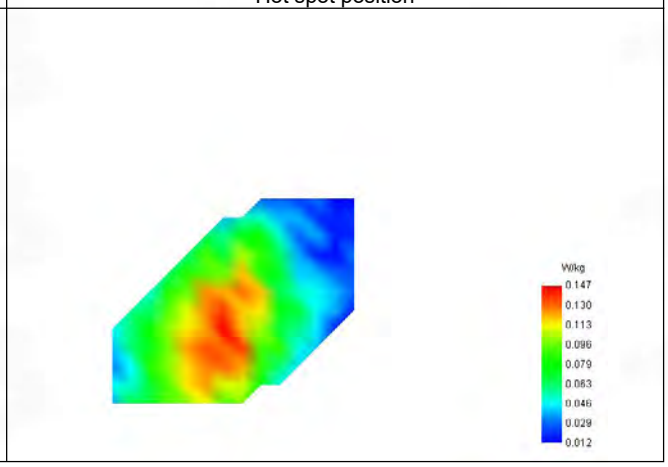
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.236	0.138	0.108	0.101	0.084



F. 3D Image

3D screen shot	Hot spot position
	

18-Body with front position in dist. 10mm on Channel 23095 in LTE band 12

SAR Measurement at LTE band 12 (Body, Validation Plane)

Date of measurement: 31/5/2024

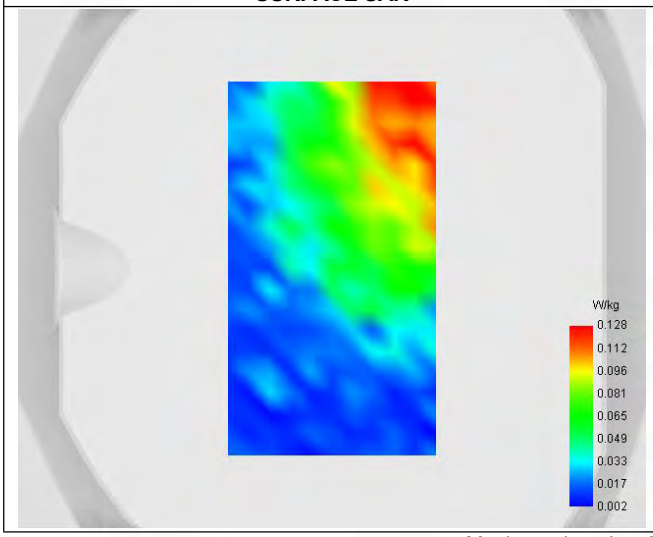
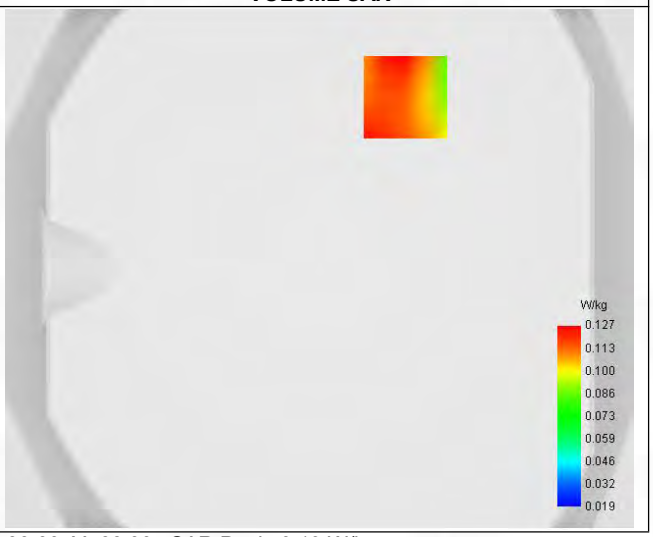
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.65
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 12
Channels	Middle (23095)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	49
RB size	1

B. Permitivity

Frequency (MHz)	711.910
Relative permitivity (real part)	41.975
Relative permitivity (imaginary part)	22.343
Conductivity (S/m)	0.856

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=33.00, Y=66.00 ; SAR Peak: 0.19 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.088
SAR 1g (W/Kg)	0.123
Variation (%)	0.640
Horizontal validation criteria: minimum distance (mm)	8.235
Vertical validation criteria: SAR ratio M2/M1 (%)	71.65%

E. Z Axis Scan

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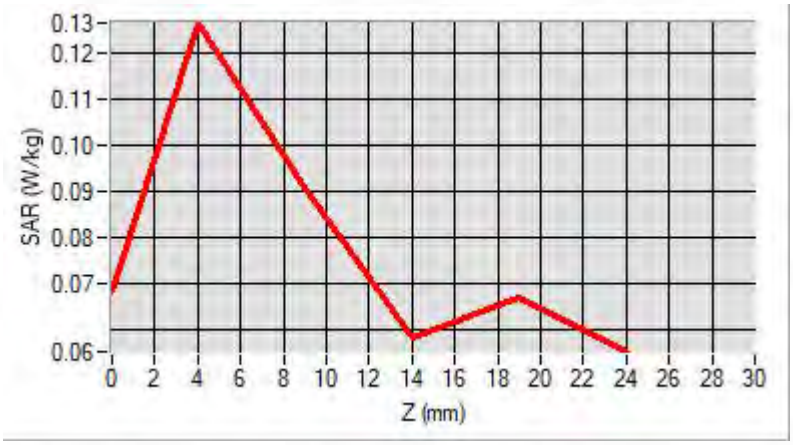
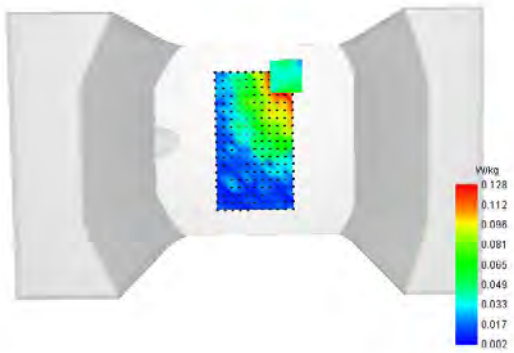
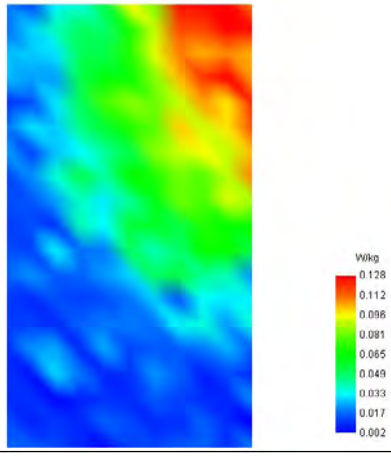
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.068	0.127	0.091	0.058	0.067



F. 3D Image

3D screen shot	Hot spot position
	

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19-Head with front position in dist. 0mm on Channel 23230 in LTE band 13

SAR Measurement at LTE band 13 (Cheek, Right)

Date of measurement: 31/5/2024

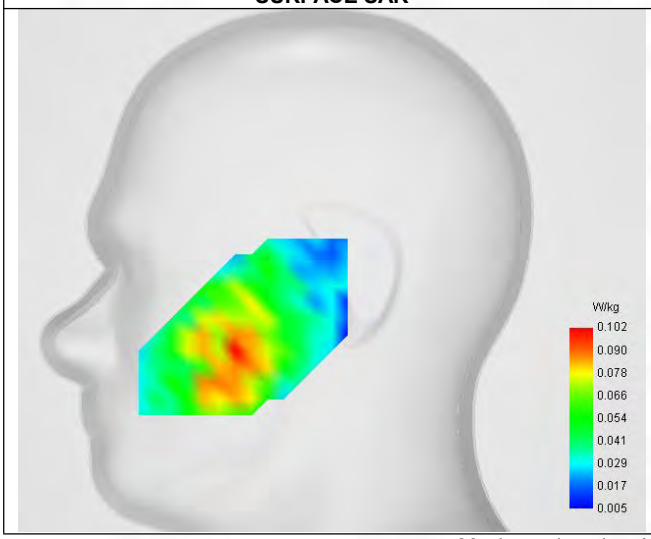
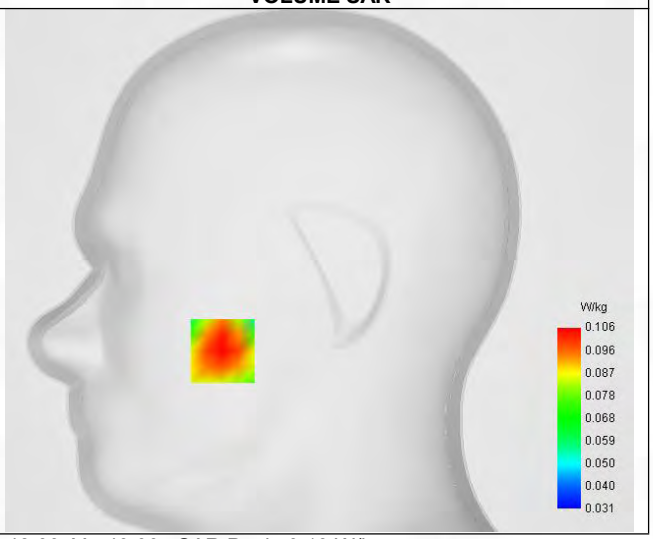
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.65
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 13
Channels	Middle (23230)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	25
RB size	1

B. Permitivity

Frequency (MHz)	782.090
Relative permitivity (real part)	41.653
Relative permitivity (imaginary part)	20.716
Conductivity (S/m)	0.864

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-48.00, Y=-40.00 ; SAR Peak: 0.13 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.085
SAR 1g (W/Kg)	0.105
Variation (%)	-4.730
Horizontal validation criteria: minimum distance (mm)	8.865
Vertical validation criteria: SAR ratio M2/M1 (%)	68.87%

E. Z Axis Scan

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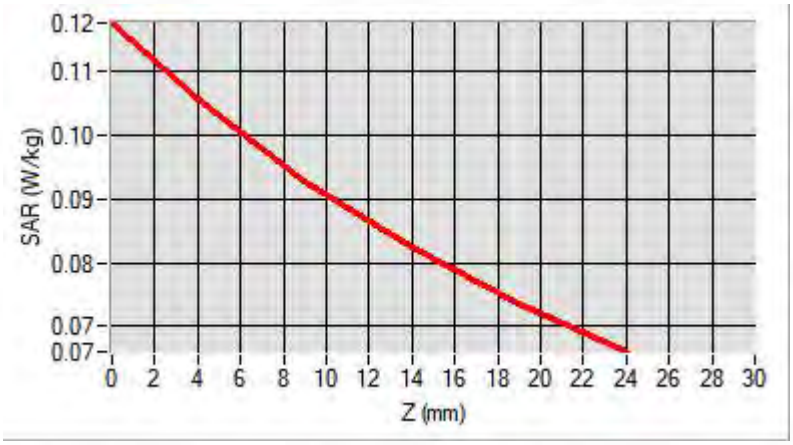
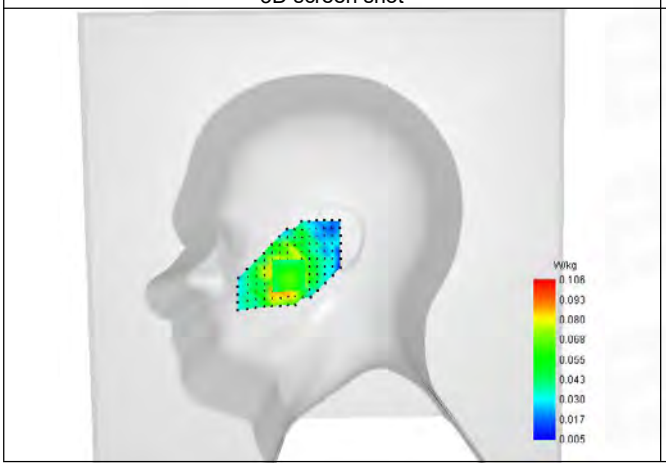
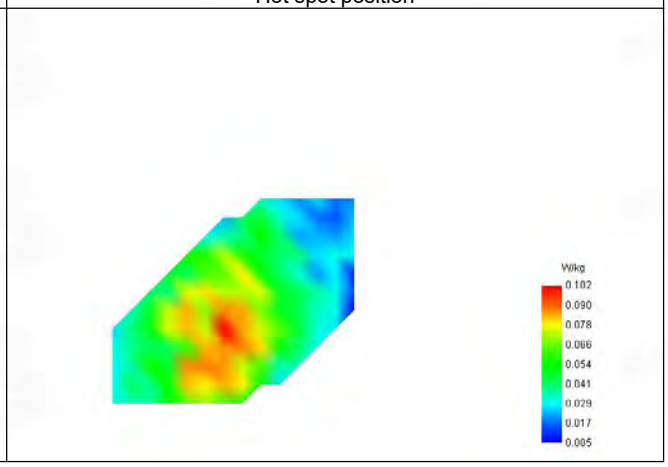
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.118	0.106	0.073	0.062	0.054



F. 3D Image

3D screen shot	Hot spot position
	

20-Body with front position in dist. 10mm on Channel 23230 in LTE band 13

SAR Measurement at LTE band 13 (Body, Validation Plane)

Date of measurement: 31/5/2024

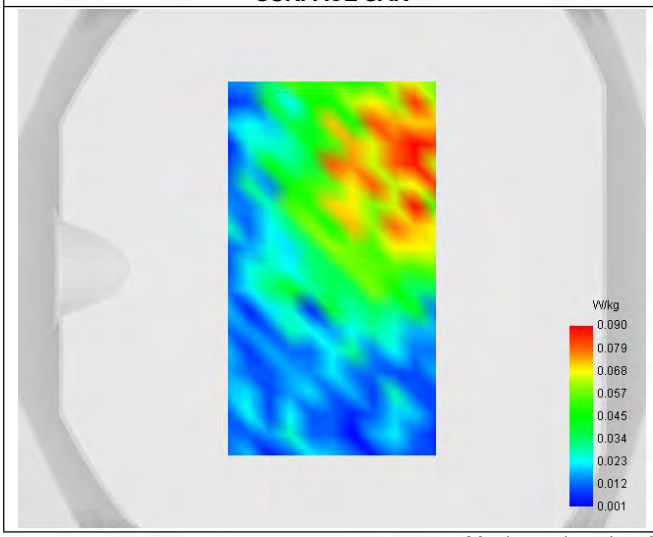
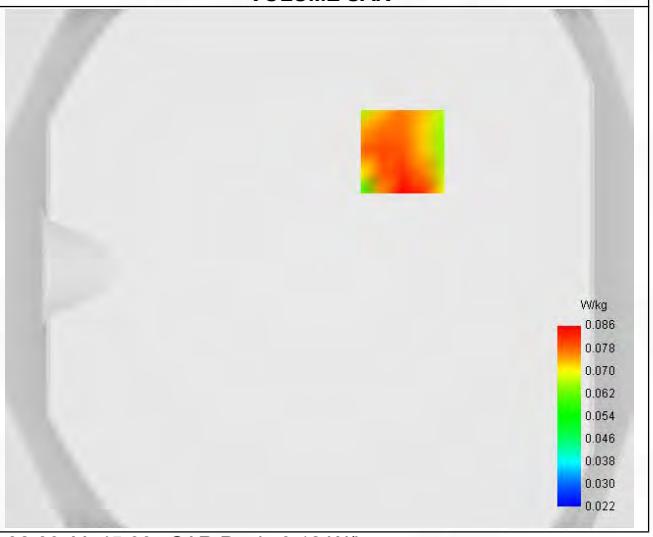
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.65
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 13
Channels	Middle (23230)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	25
RB size	1

B. Permitivity

Frequency (MHz)	782.090
Relative permitivity (real part)	41.653
Relative permitivity (imaginary part)	20.716
Conductivity (S/m)	0.864

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=32.00, Y=45.00 ; SAR Peak: 0.12 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.062
SAR 1g (W/Kg)	0.082
Variation (%)	4.090
Horizontal validation criteria: minimum distance (mm)	8.236
Vertical validation criteria: SAR ratio M2/M1 (%)	62.79%

E. Z Axis Scan

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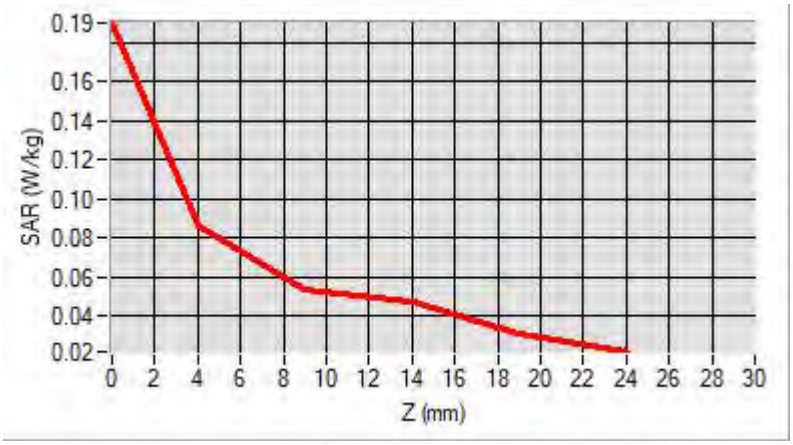
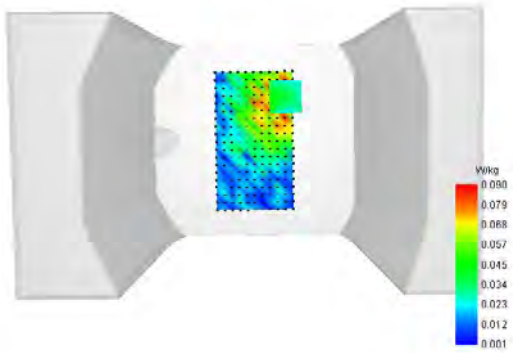
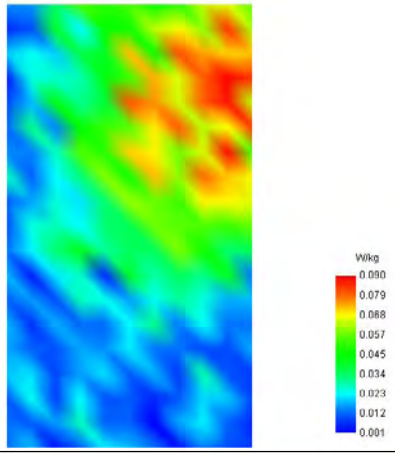
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.190	0.086	0.054	0.047	0.031



F. 3D Image

3D screen shot	Hot spot position
	

21-Head with front position in dist. 0mm on Channel 26365 in LTE band 25

SAR Measurement at LTE band 25 (Cheek, Right)

Date of measurement: 5/6/2024

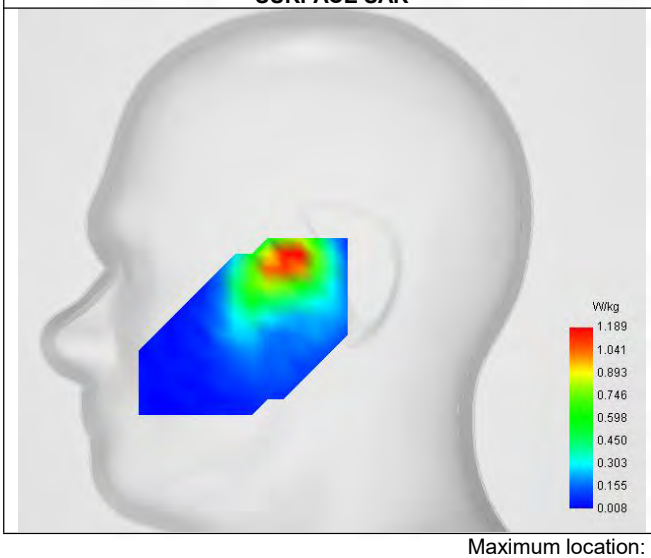
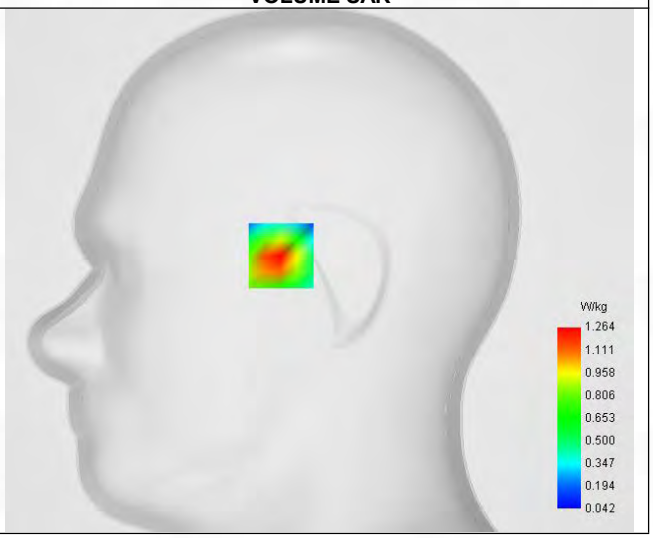
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.07
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 25
Channels	Middle (26365)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	99
RB size	1

B. Permitivity

Frequency (MHz)	1891.410
Relative permitivity (real part)	39.883
Relative permitivity (imaginary part)	13.441
Conductivity (S/m)	1.407

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-19.00, Y=7.00 ; SAR Peak: 1.92 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.650
SAR 1g (W/Kg)	1.096
Variation (%)	-3.740
Horizontal validation criteria: minimum distance (mm)	8.226
Vertical validation criteria: SAR ratio M2/M1 (%)	59.18%

E. Z Axis Scan

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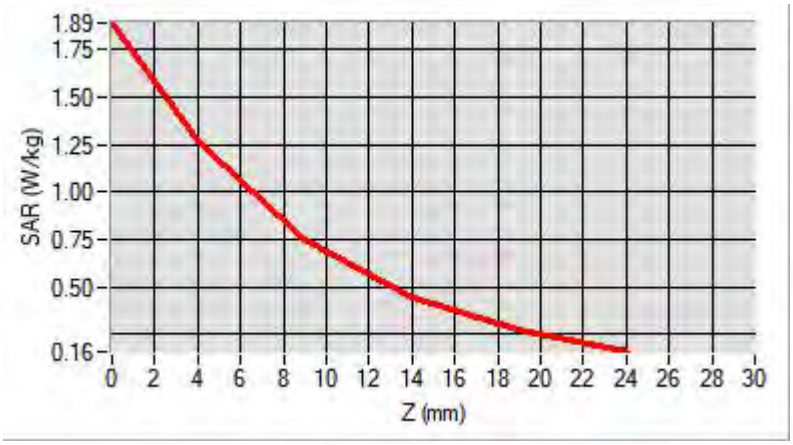
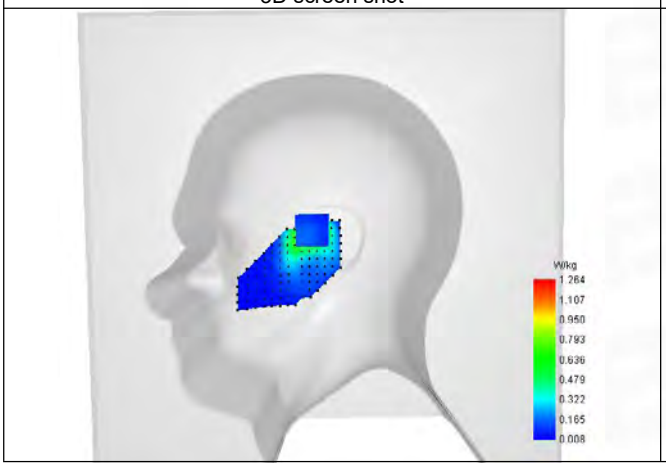
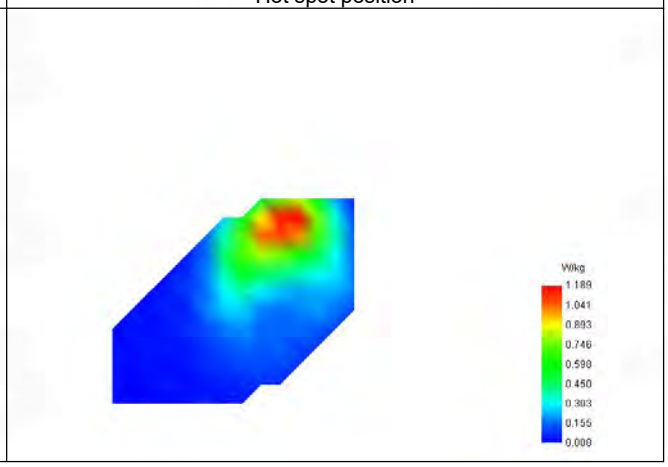
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.892	1.264	0.748	0.443	0.268



F. 3D Image

3D screen shot	Hot spot position
	

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22-Body with back position in dist. 10mm on Channel 26365 in LTE band 25

SAR Measurement at LTE band 25 (Body, Validation Plane)

Date of measurement: 5/6/2024

A. Experimental conditions.

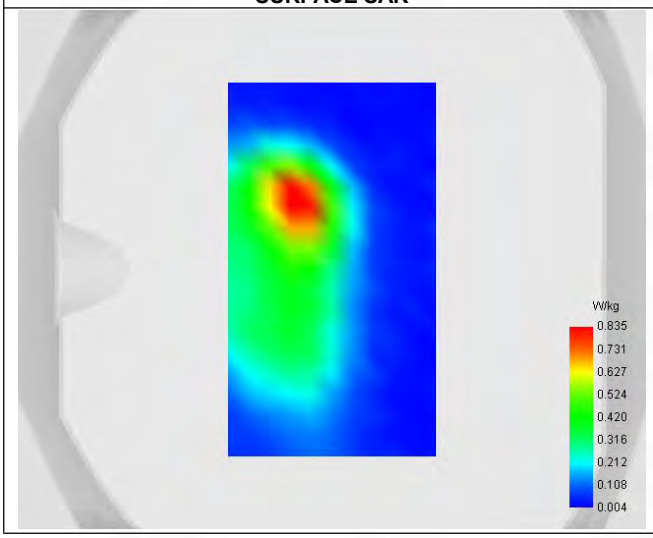
Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 25
Channels	Middle (26365)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	99
RB size	1

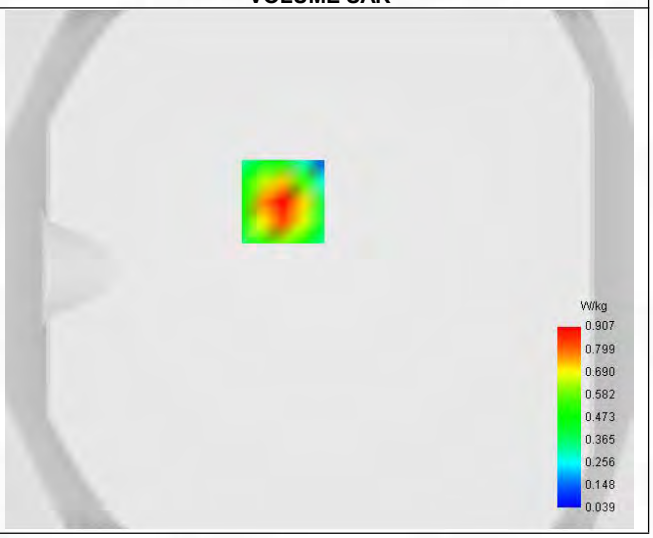
B. Permitivity

Frequency (MHz)	1891.410
Relative permitivity (real part)	39.883
Relative permitivity (imaginary part)	13.441
Conductivity (S/m)	1.407

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR





Maximum location: X=-14.00, Y=26.00 ; SAR Peak: 1.41 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.464
SAR 1g (W/Kg)	0.751
Variation (%)	-0.060
Horizontal validation criteria: minimum distance (mm)	8.633
Vertical validation criteria: SAR ratio M2/M1 (%)	56.67%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00

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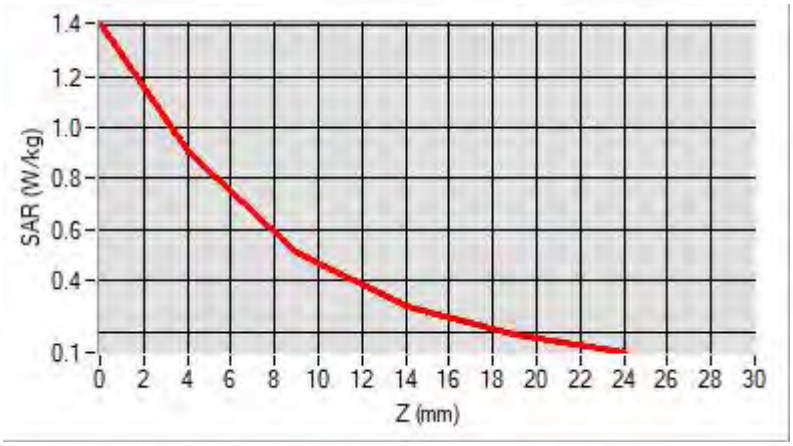
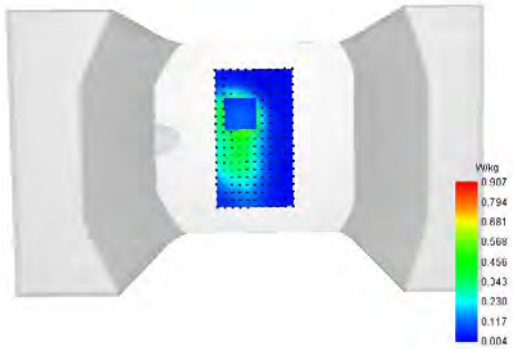
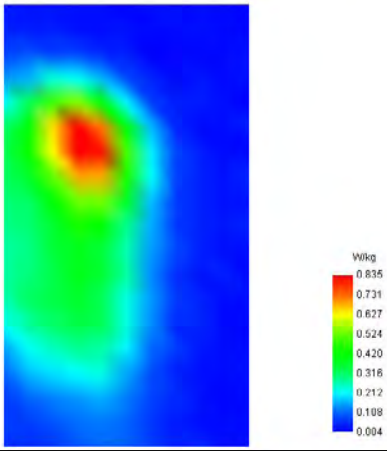
SAR (W/Kg)	1.409	0.907	0.514	0.299	0.186



F. 3D Image

3D screen shot	Hot spot position
	

23-Head with front position in dist. 0mm on Channel 26740 in LTE band 26 Part 90

SAR Measurement at LTE band 26 (Cheek, Right)

Date of measurement: 3/6/2024

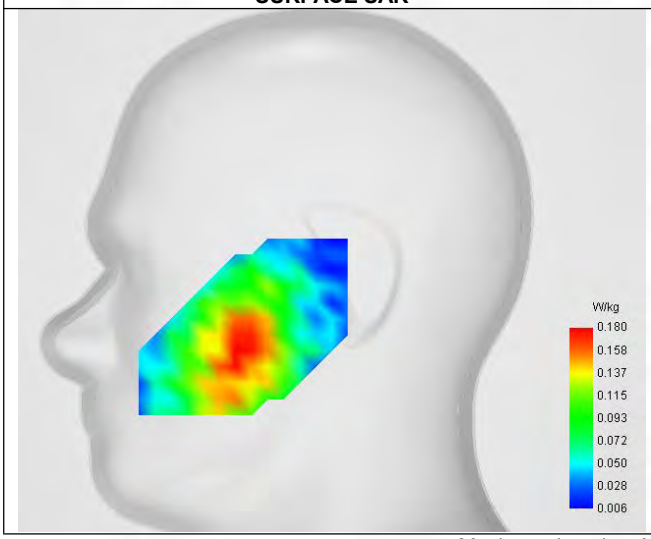
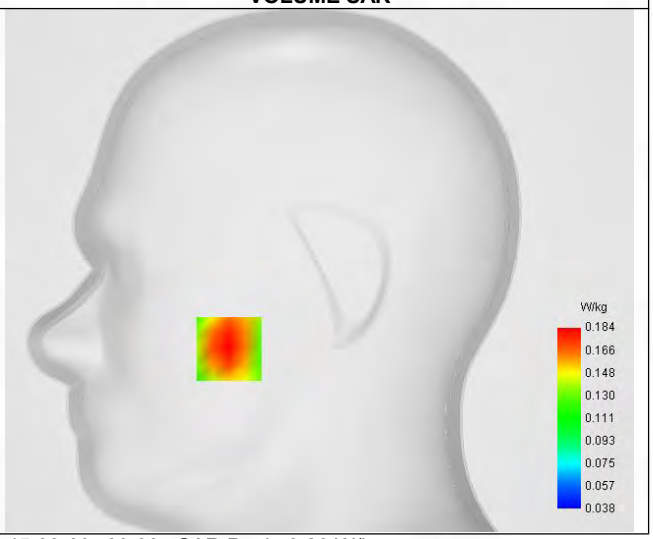
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 26
Channels	Lower (26740)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1

B. Permitivity

Frequency (MHz)	814.590
Relative permitivity (real part)	41.504
Relative permitivity (imaginary part)	19.963
Conductivity (S/m)	0.868

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-45.00, Y=-39.00 ; SAR Peak: 0.26 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.134
SAR 1g (W/Kg)	0.180
Variation (%)	2.950
Horizontal validation criteria: minimum distance (mm)	8.297
Vertical validation criteria: SAR ratio M2/M1 (%)	69.02%

E. Z Axis Scan

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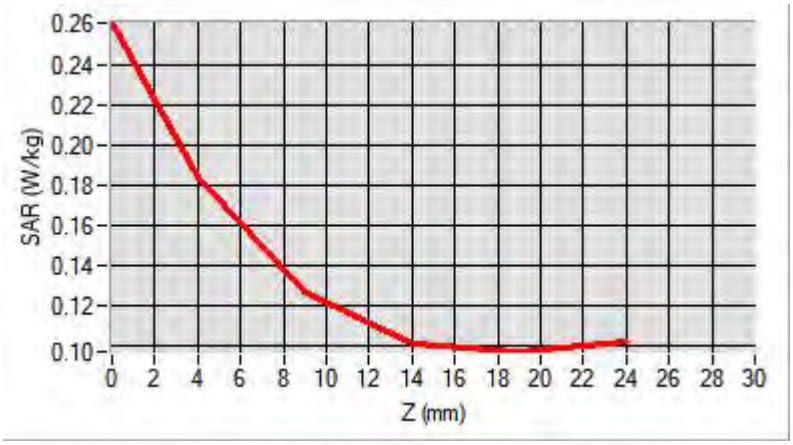
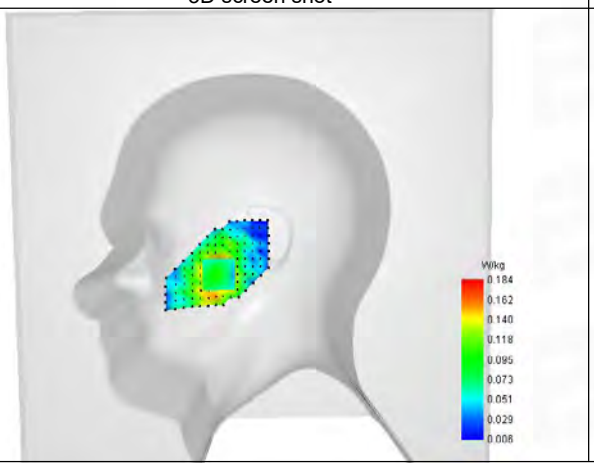
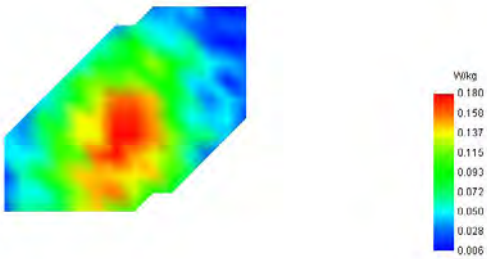
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.260	0.184	0.127	0.102	0.097



F. 3D Image

3D screen shot	Hot spot position
	

24-Body with front position in dist. 10mm on Channel 26740 in LTE band 26 Part 90

SAR Measurement at LTE band 26 (Body, Validation Plane)

Date of measurement: 3/6/2024

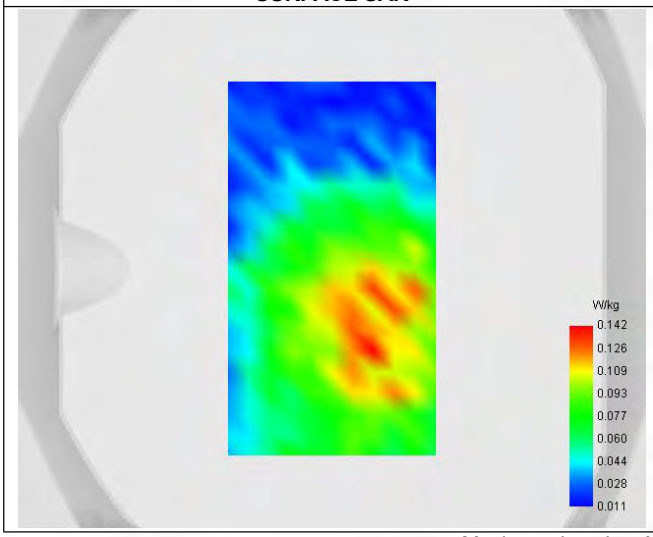
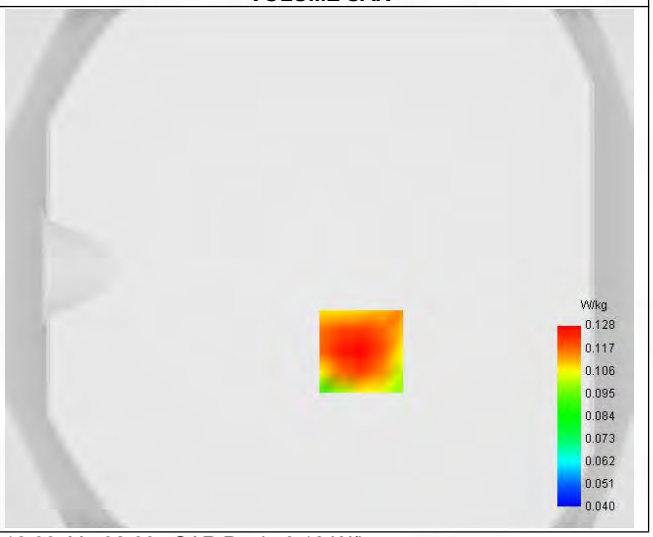
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 26
Channels	Lower (26740)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1

B. Permitivity

Frequency (MHz)	814.590
Relative permitivity (real part)	41.504
Relative permitivity (imaginary part)	19.963
Conductivity (S/m)	0.868

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=16.00, Y=-32.00 ; SAR Peak: 0.18 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.097
SAR 1g (W/Kg)	0.128
Variation (%)	-3.300
Horizontal validation criteria: minimum distance (mm)	10.366
Vertical validation criteria: SAR ratio M2/M1 (%)	78.13%

E. Z Axis Scan

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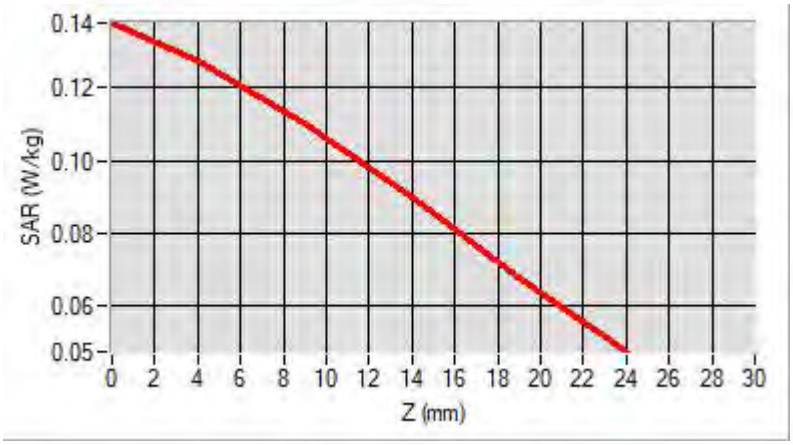
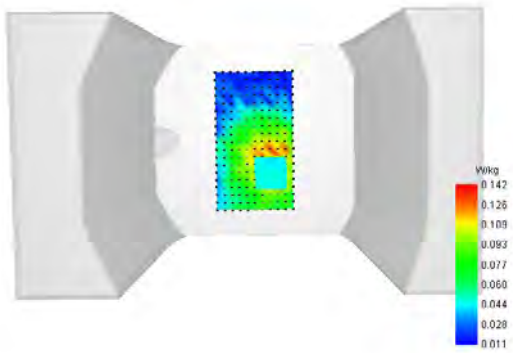
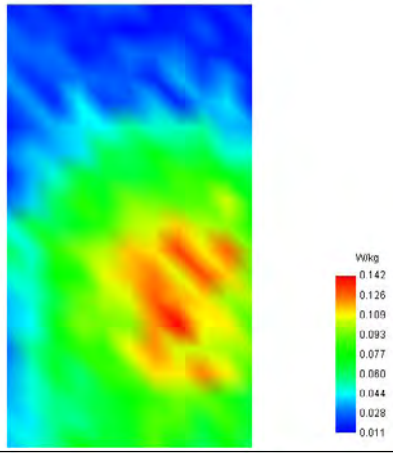
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.138	0.128	0.100	0.090	0.068



F. 3D Image

3D screen shot	Hot spot position
	

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25-Head with front position in dist. 0mm on Channel 26865 in LTE band 26 Part 22

SAR Measurement at LTE band 26 (Cheek, Right)

Date of measurement: 3/6/2024

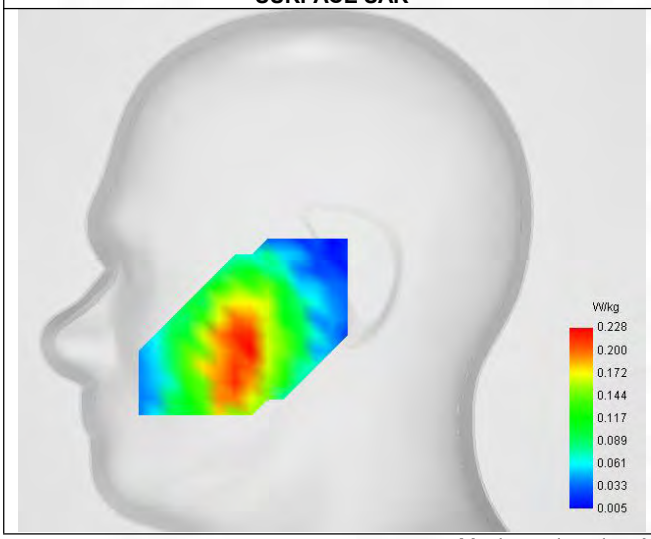
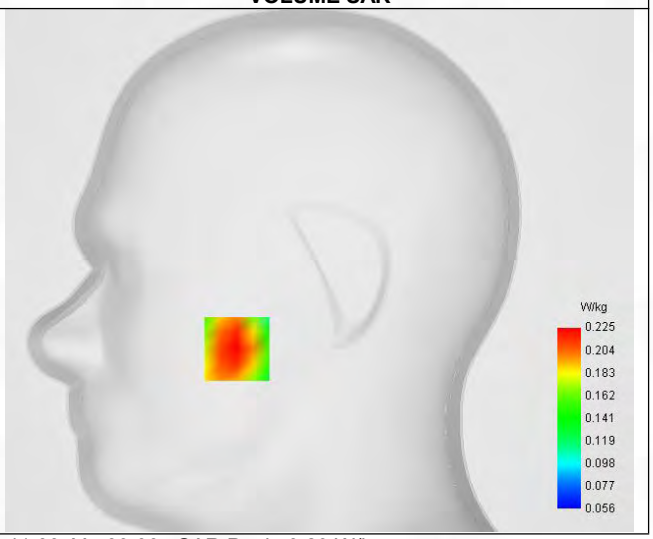
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 26
Channels	Lower (26865)
Signal	LTE FDD
Cell Bandwidth	15 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1

B. Permitivity

Frequency (MHz)	831.500
Relative permitivity (real part)	41.426
Relative permitivity (imaginary part)	19.571
Conductivity (S/m)	0.870

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-41.00, Y=-39.00 ; SAR Peak: 0.29 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.165
SAR 1g (W/Kg)	0.218
Variation (%)	3.550
Horizontal validation criteria: minimum distance (mm)	8.412
Vertical validation criteria: SAR ratio M2/M1 (%)	74.22%

E. Z Axis Scan

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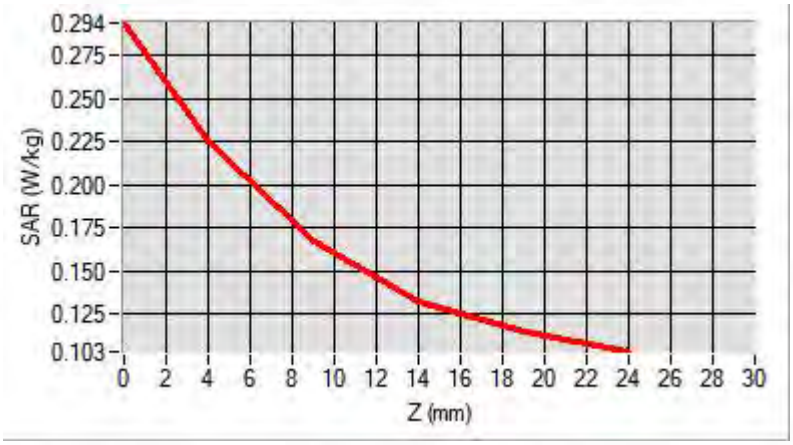
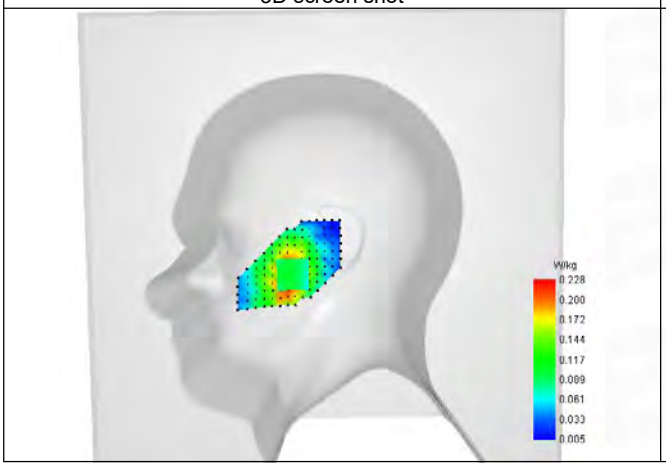
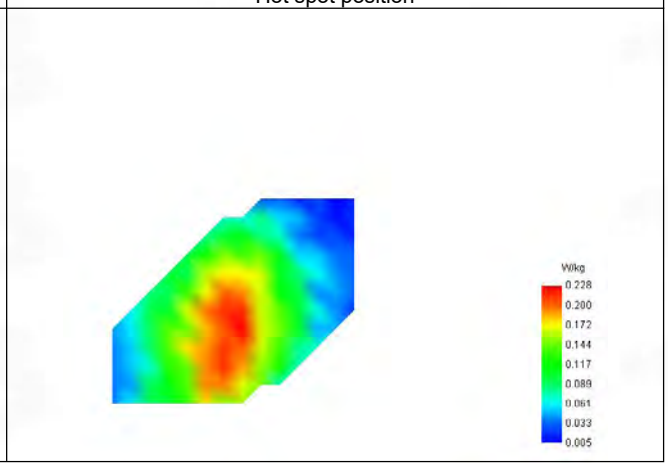
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.294	0.225	0.167	0.132	0.114



F. 3D Image

3D screen shot	Hot spot position
	

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26-Body with front position in dist. 10mm on Channel 26865 in LTE band 26 Part 22

SAR Measurement at LTE band 26 (Body, Validation Plane)

Date of measurement: 31/5/2024

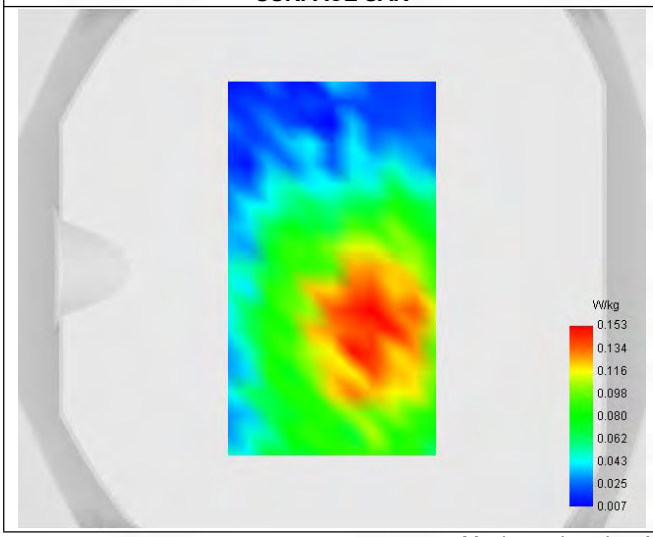
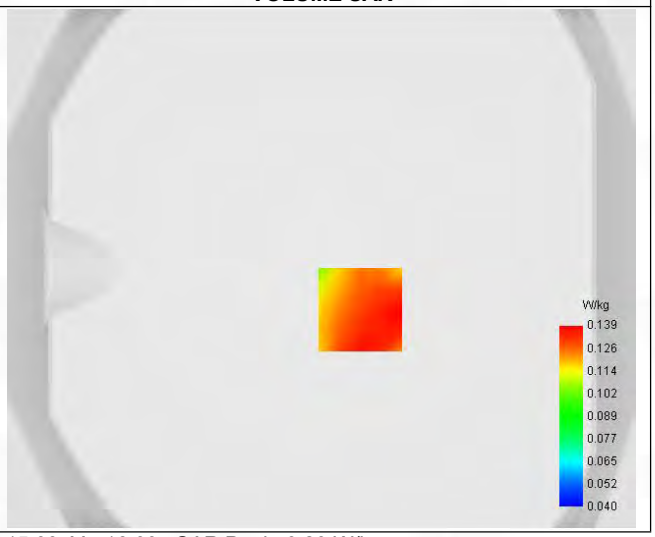
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 26
Channels	Lower (26865)
Signal	LTE FDD
Cell Bandwidth	15 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1

B. Permitivity

Frequency (MHz)	824.840
Relative permitivity (real part)	43.733
Relative permitivity (imaginary part)	19.846
Conductivity (S/m)	0.909

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=15.00, Y=-16.00 ; SAR Peak: 0.20 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.109
SAR 1g (W/Kg)	0.140
Variation (%)	-3.800
Horizontal validation criteria: minimum distance (mm)	9.745
Vertical validation criteria: SAR ratio M2/M1 (%)	71.94%

E. Z Axis Scan

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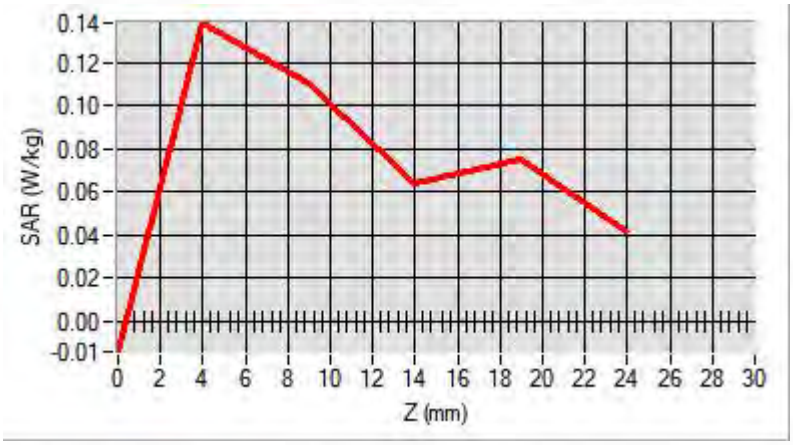
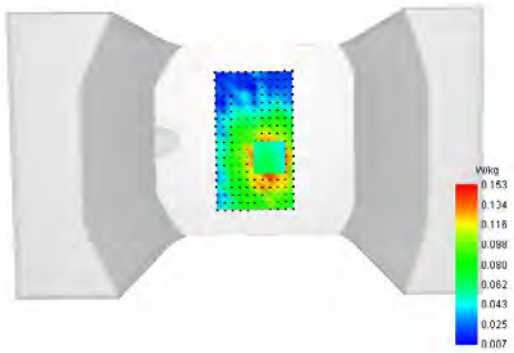
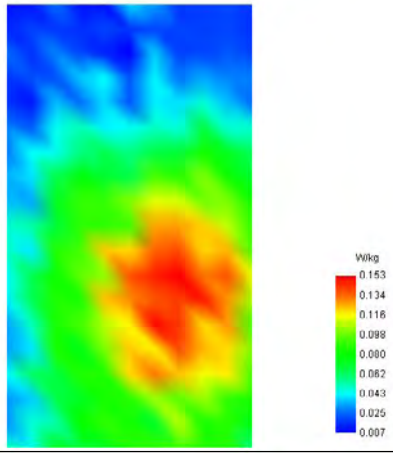
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	-0.014	0.139	0.100	0.064	0.075



F. 3D Image

3D screen shot	Hot spot position
	

27-Head with front position in dist. 0mm on Channel 41490 in LTE band 41

SAR Measurement at LTE band 41 (Cheek, Right)

Date of measurement: 7/6/2024

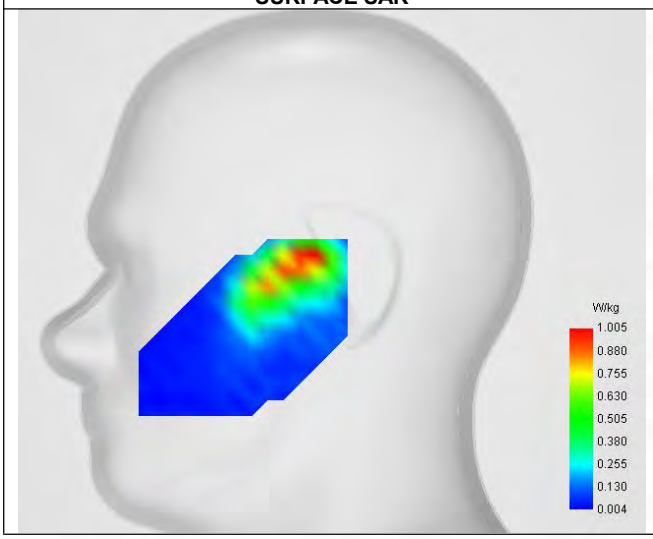
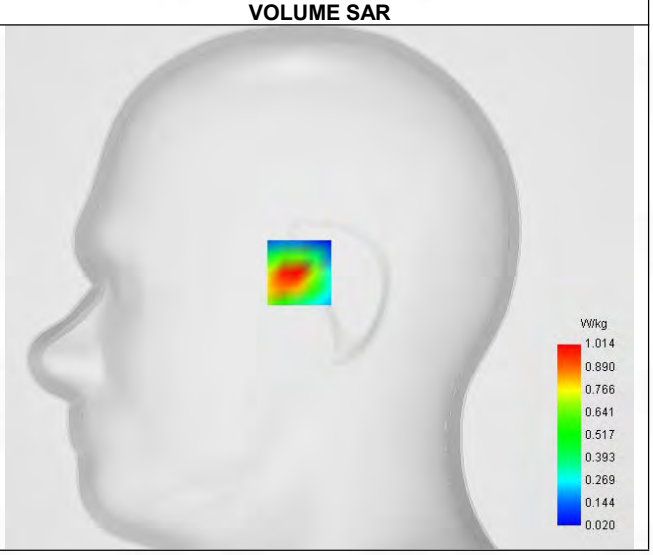
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.40
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 41
Channels	Higher (41490)
Signal	LTE TDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1
Subframe configuration	0
Special subframe configuration	0
Cyclic prefix	Normal
Duty Cycle (%)	0.61

B. Permitivity

Frequency (MHz)	2671.090
Relative permitivity (real part)	38.798
Relative permitivity (imaginary part)	12.787
Conductivity (S/m)	2.045

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-10.00, Y=7.00 ; SAR Peak: 1.85 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.455
SAR 1g (W/Kg)	0.971
Variation (%)	-3.760
Horizontal validation criteria: minimum distance (mm)	8.755

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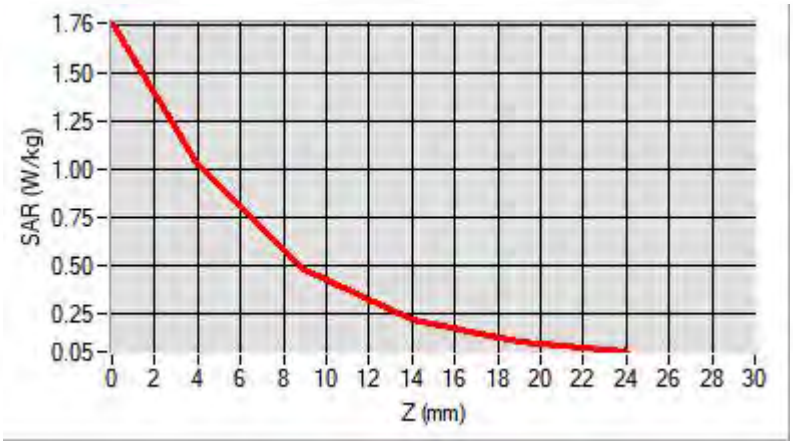
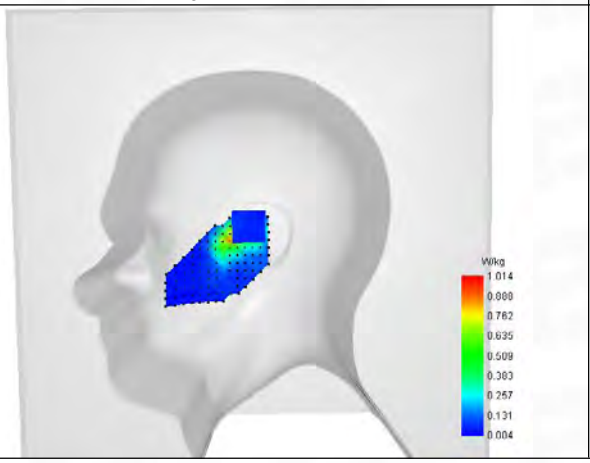
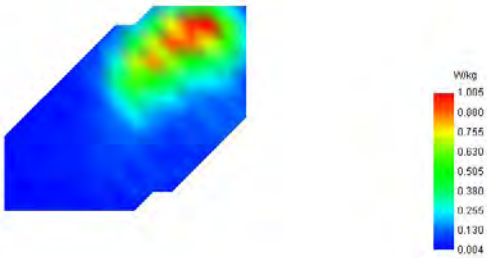
Vertical validation criteria: SAR ratio M2/M1 (%)	47.24%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.757	1.014	0.479	0.221	0.106



F. 3D Image

3D screen shot	Hot spot position
	

28-Body with back position in dist. 10mm on Channel 41490 in LTE band 41

SAR Measurement at LTE band 41 (Body, Validation Plane)

Date of measurement: 7/6/2024

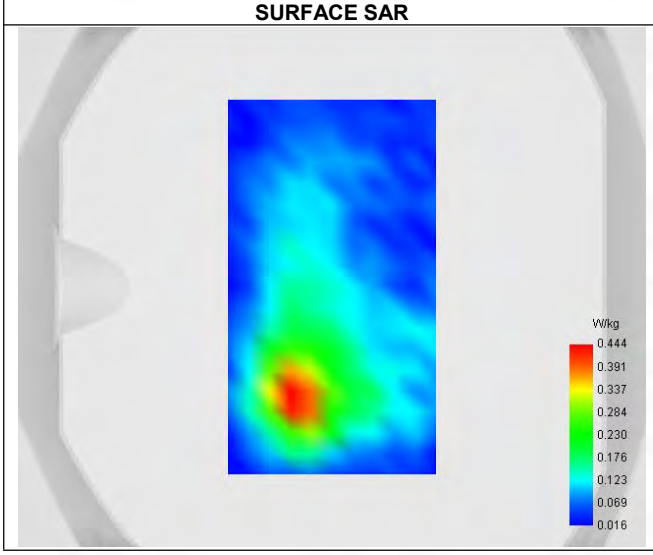
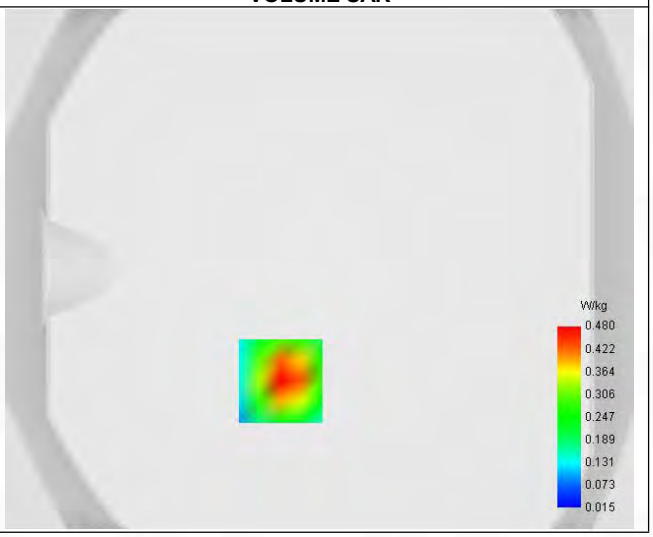
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.40
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 41
Channels	Higher (41490)
Signal	LTE TDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1
Subframe configuration	0
Special subframe configuration	0
Cyclic prefix	Normal
Duty Cycle (%)	0.61

B. Permitivity

Frequency (MHz)	2671.090
Relative permitivity (real part)	38.798
Relative permitivity (imaginary part)	12.787
Conductivity (S/m)	2.045

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-15.00, Y=-43.00 ; SAR Peak: 0.81 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.234
SAR 1g (W/Kg)	0.452
Variation (%)	-2.730
Horizontal validation criteria: minimum distance (mm)	9.625

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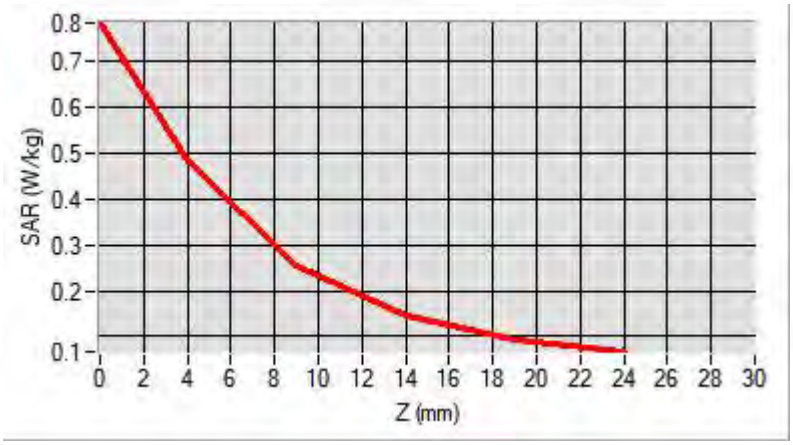
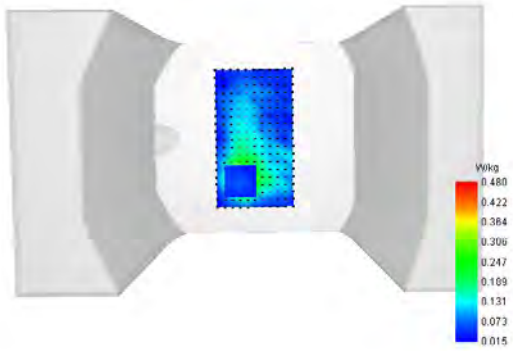
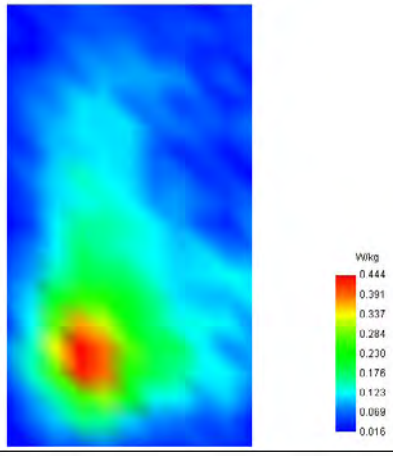
Vertical validation criteria: SAR ratio M2/M1 (%)	53.33%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.783	0.480	0.256	0.144	0.094



F. 3D Image

3D screen shot	Hot spot position
	

29-Head with front position in dist. 0mm on Channel 132072 in LTE band 66

SAR Measurement at LTE band 66 (Cheek, Right)

Date of measurement: 4/6/2024

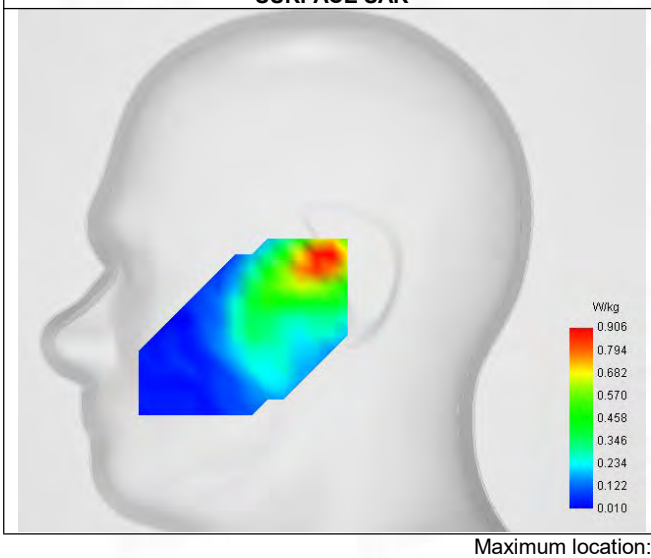
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.79
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 66
Channels	Lower (132072)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	99
RB size	1

B. Permitivity

Frequency (MHz)	1728.910
Relative permitivity (real part)	40.021
Relative permitivity (imaginary part)	14.488
Conductivity (S/m)	1.333

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-3.00, Y=7.00 ; SAR Peak: 1.30 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.418
SAR 1g (W/Kg)	0.710
Variation (%)	-1.650
Horizontal validation criteria: minimum distance (mm)	8.636
Vertical validation criteria: SAR ratio M2/M1 (%)	65.04%

E. Z Axis Scan

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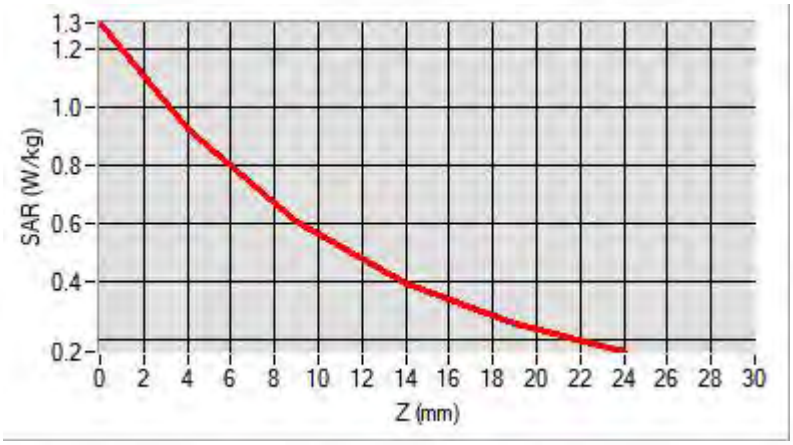
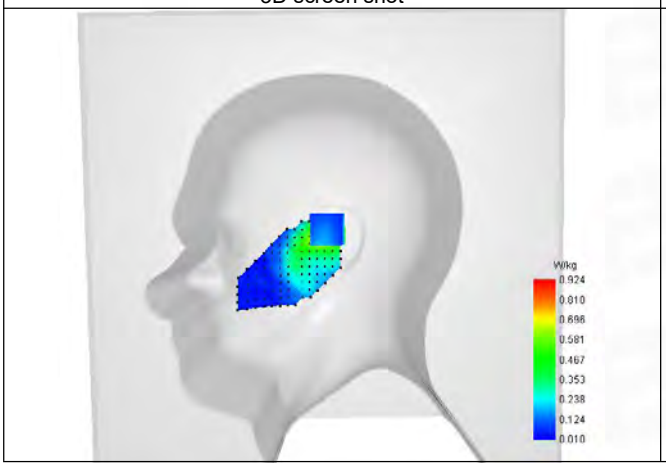
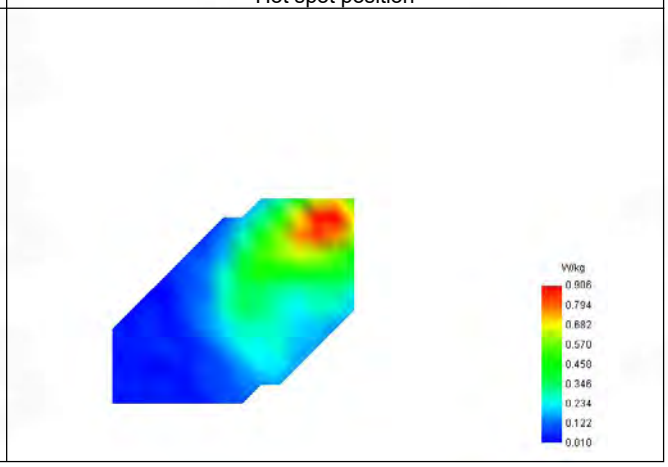
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.288	0.924	0.601	0.389	0.252



F. 3D Image

3D screen shot	Hot spot position
	

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30-Body with back position in dist. 10mm on Channel 132072 in LTE band 66

SAR Measurement at LTE band 66 (Body, Validation Plane)

Date of measurement: 4/6/2024

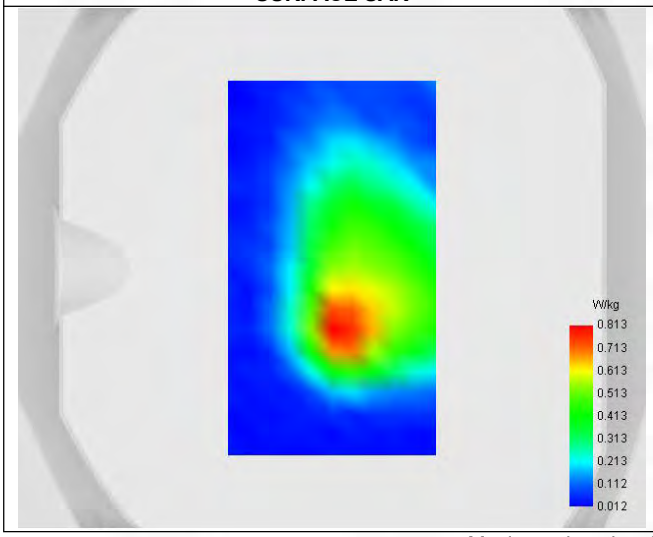
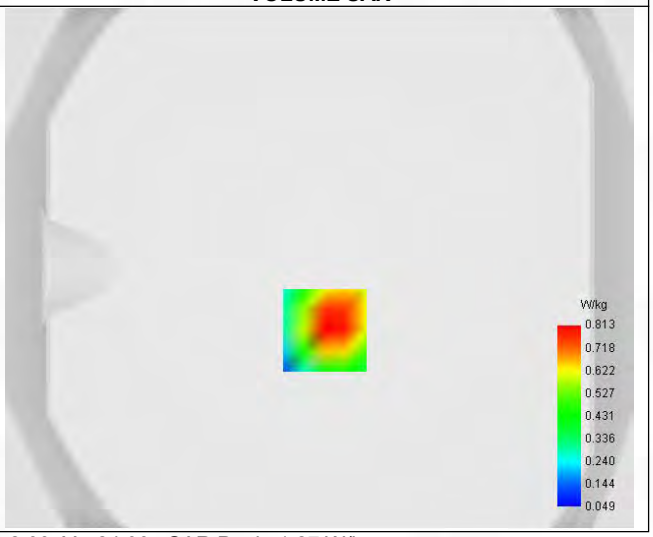
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.96
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 66
Channels	Lower (132072)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	99
RB size	1

B. Permitivity

Frequency (MHz)	1728.910
Relative permitivity (real part)	40.021
Relative permitivity (imaginary part)	14.488
Conductivity (S/m)	1.333

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=2.00, Y=-24.00 ; SAR Peak: 1.27 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.458
SAR 1g (W/Kg)	0.727
Variation (%)	-4.790
Horizontal validation criteria: minimum distance (mm)	11.302
Vertical validation criteria: SAR ratio M2/M1 (%)	58.55%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00

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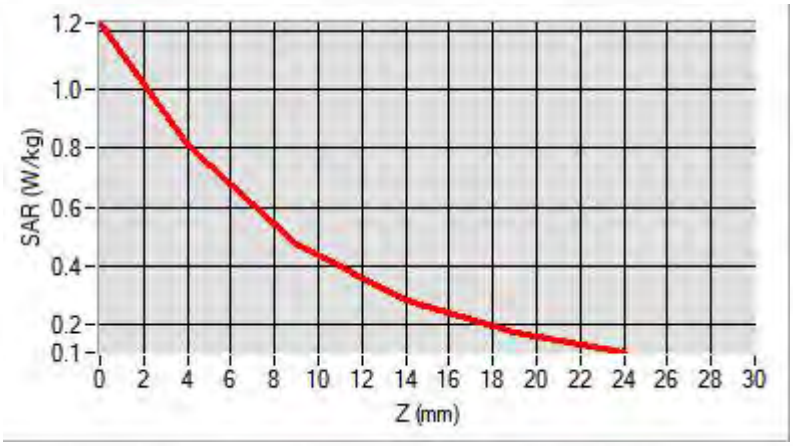
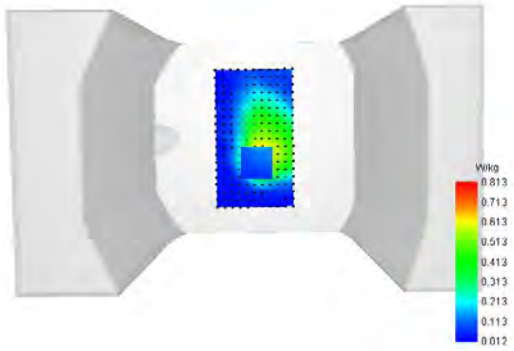
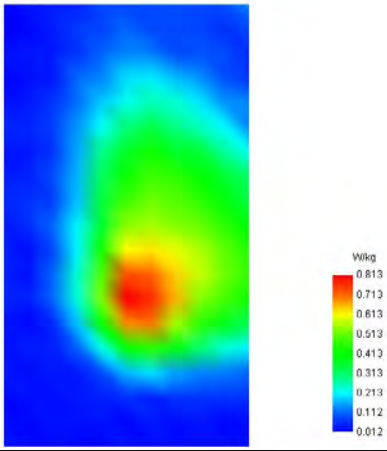
SAR (W/Kg)	1.230	0.813	0.476	0.280	0.170



F. 3D Image

3D screen shot	Hot spot position
	

31-Head with front position in dist. 0mm on Channel 133222 in LTE band 71

SAR Measurement at LTE band 71 (Cheek, Right)

Date of measurement: 31/5/2024

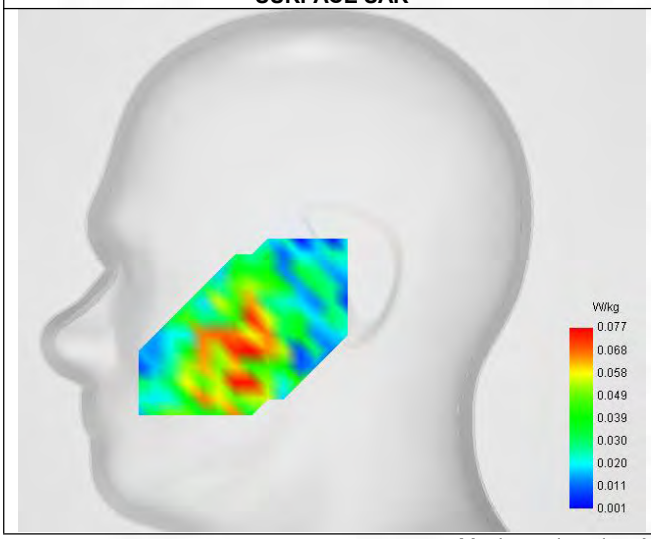
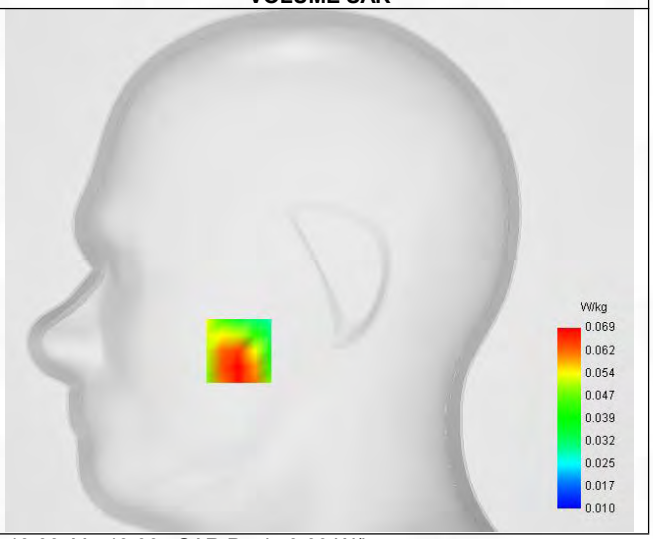
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.65
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 71
Channels	Lower (133222)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1

B. Permitivity

Frequency (MHz)	664.090
Relative permitivity (real part)	42.194
Relative permitivity (imaginary part)	23.451
Conductivity (S/m)	0.850

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-40.00, Y=-40.00 ; SAR Peak: 0.09 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.055
SAR 1g (W/Kg)	0.066
Variation (%)	-3.930
Horizontal validation criteria: minimum distance (mm)	8.664
Vertical validation criteria: SAR ratio M2/M1 (%)	62.32%

E. Z Axis Scan

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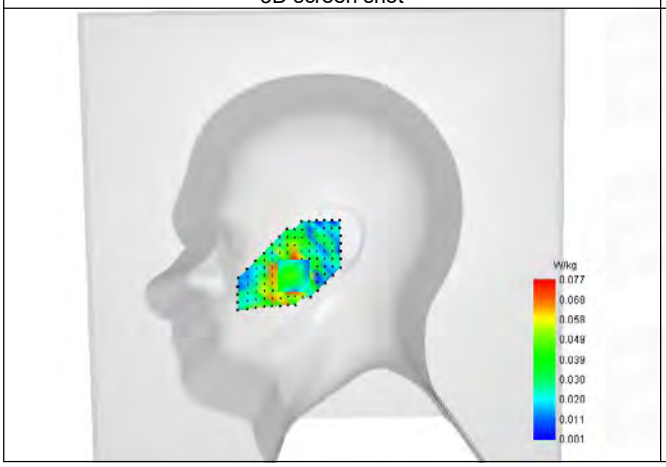
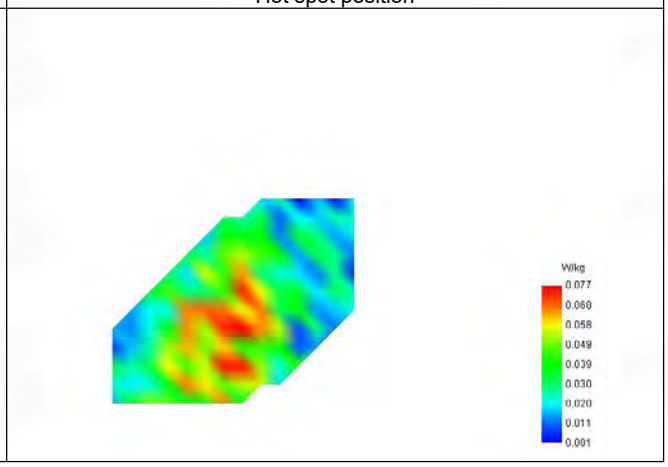
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.038	0.069	0.043	0.032	0.021

F. 3D Image

3D screen shot	Hot spot position
	

32-Body with front position in dist. 10mm on Channel 133222 in LTE band 71

SAR Measurement at LTE band 71 (Body, Validation Plane)

Date of measurement: 31/5/2024

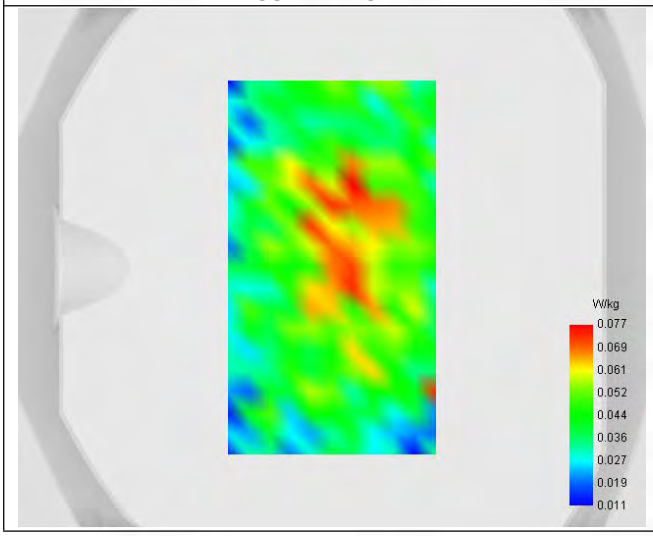
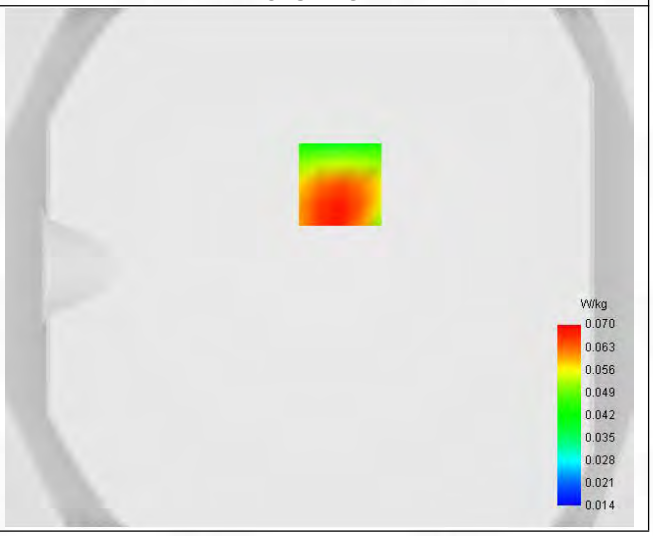
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.65
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 71
Channels	Lower (133222)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	0
RB size	1

B. Permitivity

Frequency (MHz)	664.090
Relative permitivity (real part)	42.194
Relative permitivity (imaginary part)	23.451
Conductivity (S/m)	0.850

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=8.00, Y=32.00 ; SAR Peak: 0.12 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.055
SAR 1g (W/Kg)	0.072
Variation (%)	2.890
Horizontal validation criteria: minimum distance (mm)	8.312
Vertical validation criteria: SAR ratio M2/M1 (%)	76.47%

E. Z Axis Scan

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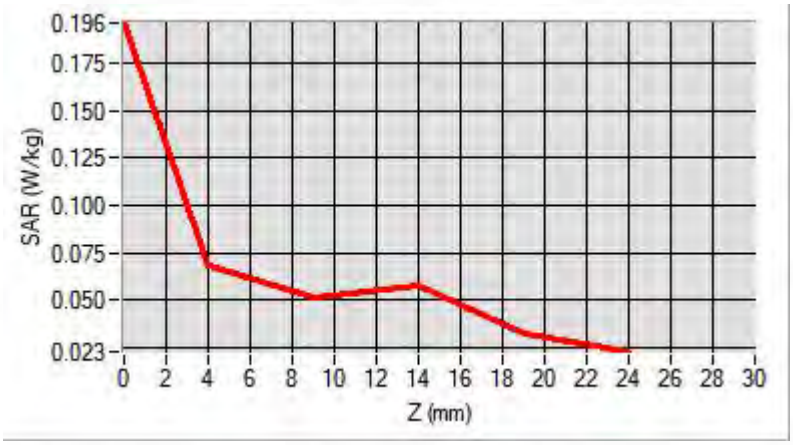
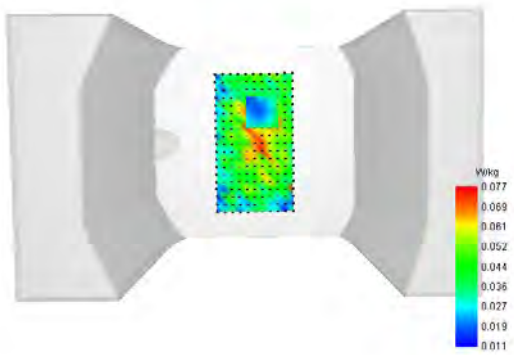
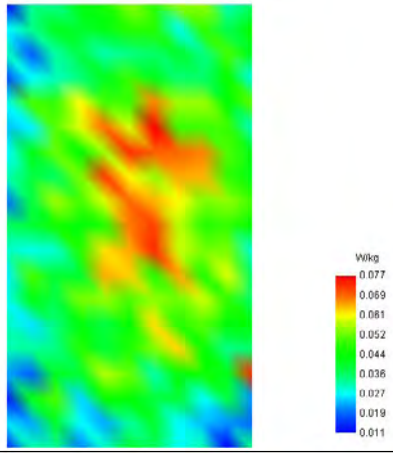
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.196	0.068	0.052	0.058	0.032



F. 3D Image

3D screen shot	Hot spot position
	

33-Head with front position in dist. 0mm on Channel 6 in IEEE 802.11b ISM

SAR Measurement at IEEE 802.11b ISM (Cheek, Right)

Date of measurement: 6/6/2024

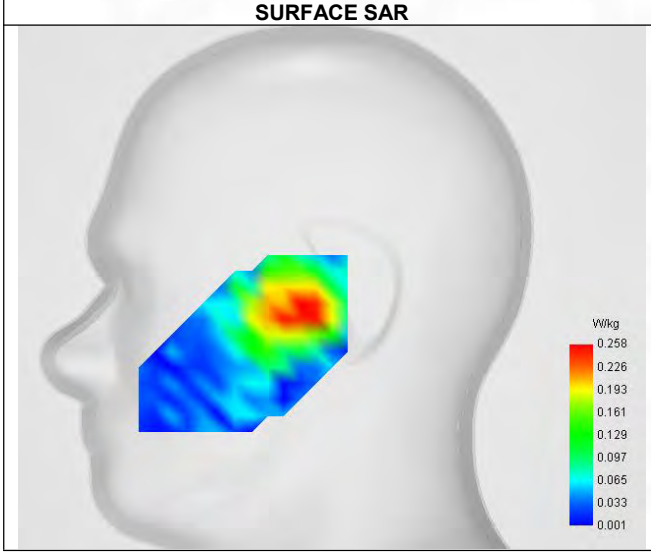
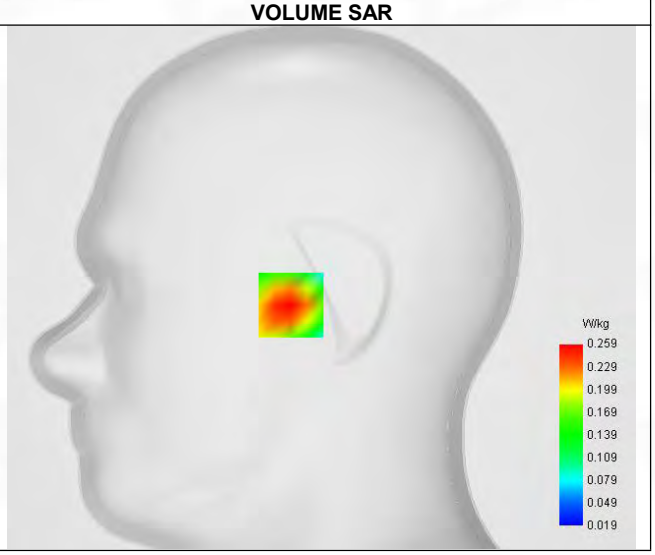
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.12
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	IEEE 802.11b ISM
Channels	Middle (6)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	2437.000
Relative permitivity (real part)	39.099
Relative permitivity (imaginary part)	13.341
Conductivity (S/m)	1.801

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-15.00, Y=-9.00 ; SAR Peak: 0.41 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.145
SAR 1g (W/Kg)	0.249
Variation (%)	-2.540
Horizontal validation criteria: minimum distance (mm)	8.542
Vertical validation criteria: SAR ratio M2/M1 (%)	56.76%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.410	0.259	0.147	0.091	0.067

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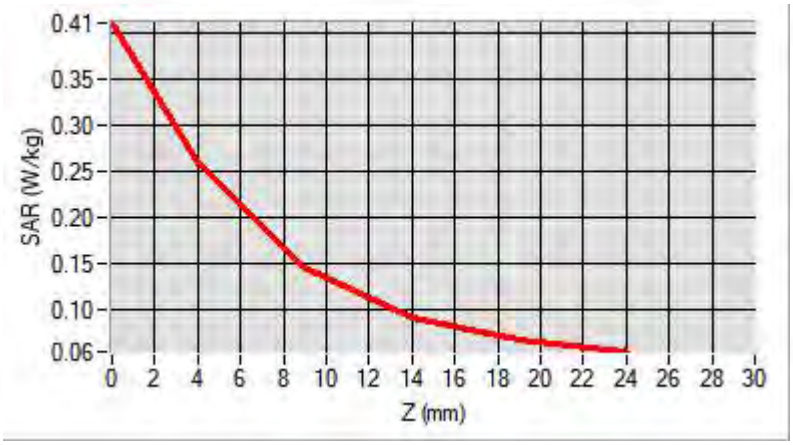
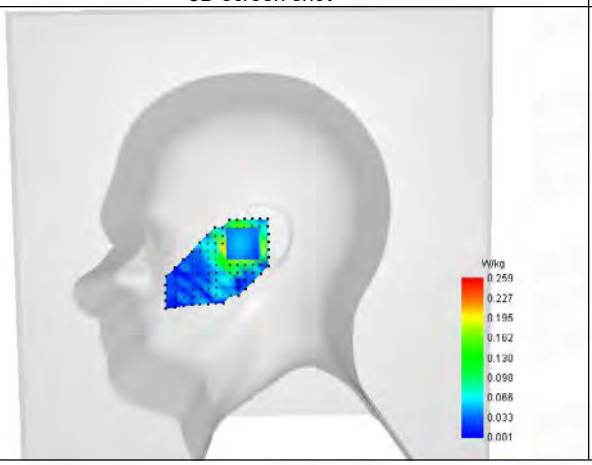
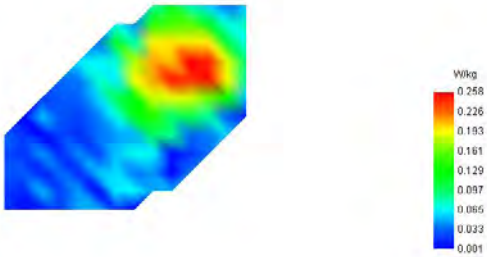


F. 3D Image

3D screen shot	Hot spot position
	

34-Body with back position in dist. 10mm on Channel 6 in IEEE 802.11b ISM

SAR Measurement at IEEE 802.11b ISM (Body, Validation Plane)

Date of measurement: 6/6/2024

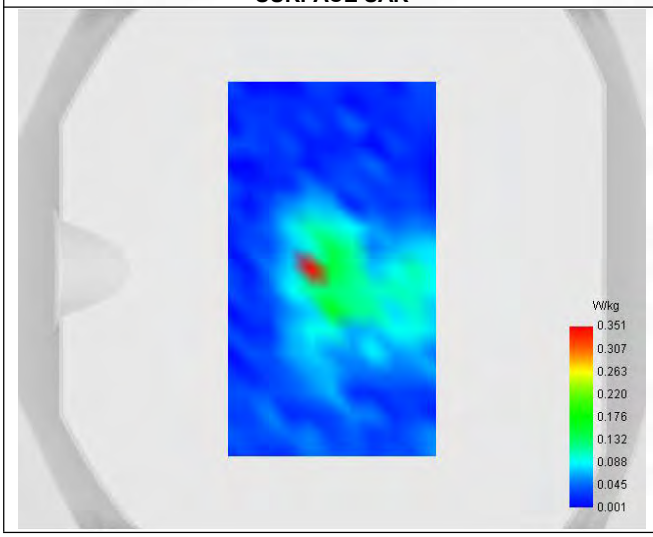
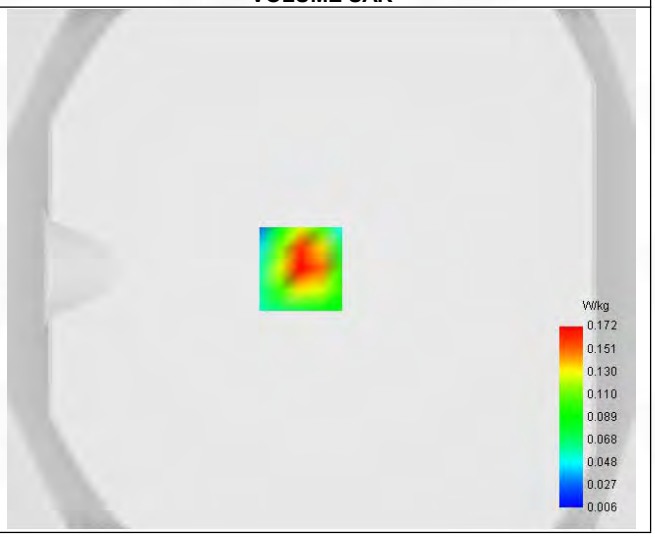
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	IEEE 802.11b ISM
Channels	Middle (6)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	2437.000
Relative permitivity (real part)	39.099
Relative permitivity (imaginary part)	13.341
Conductivity (S/m)	1.801

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-8.00, Y=0.00 ; SAR Peak: 0.33 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.094
SAR 1g (W/Kg)	0.168
Variation (%)	-4.070
Horizontal validation criteria: minimum distance (mm)	8.558
Vertical validation criteria: SAR ratio M2/M1 (%)	45.35%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.322	0.172	0.078	0.048	0.049

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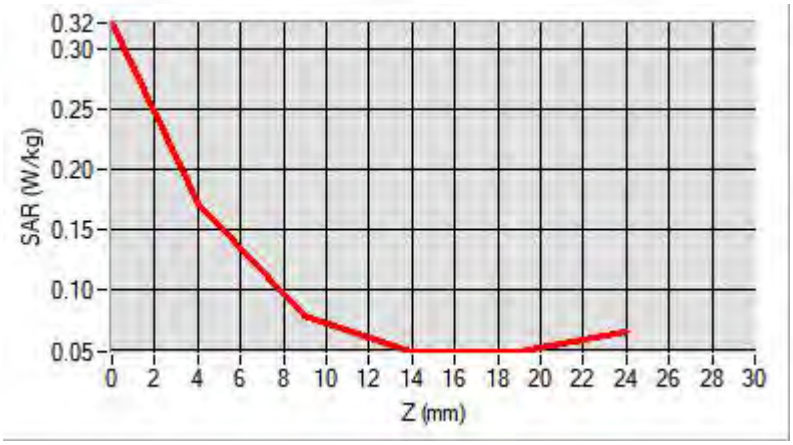
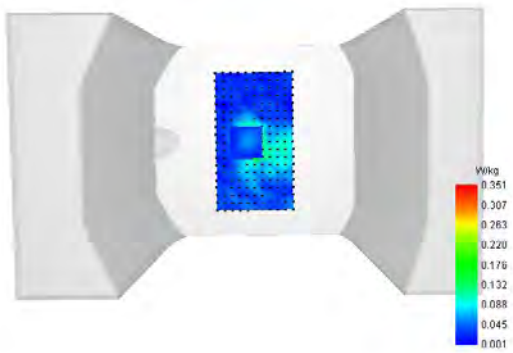
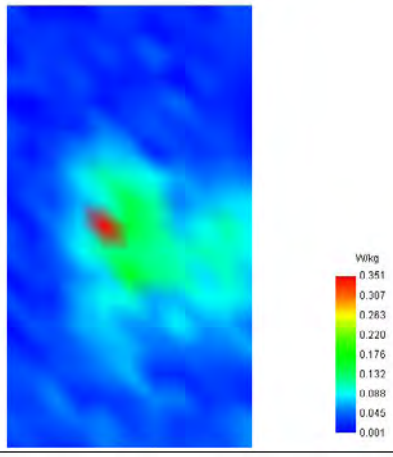


F. 3D Image

3D screen shot	Hot spot position
	

35-Head with front position in dist. 0mm on Channel 36 in IEEE 802.11a U-NII

SAR Measurement at IEEE 802.11a U-NII (Cheek, Right)

Date of measurement: 11/6/2024

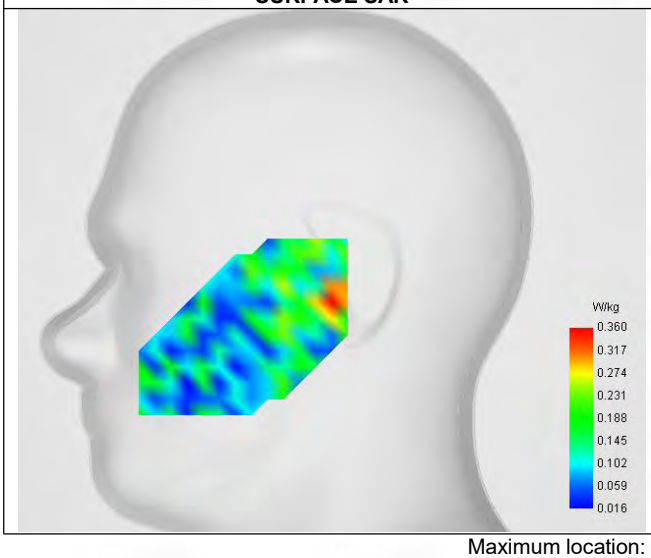
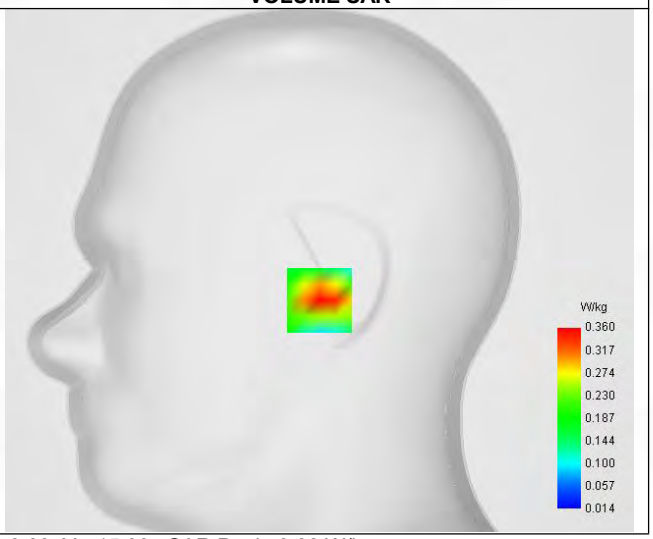
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.79
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Right head
Device Position	Cheek
Band	IEEE 802.11a U-NII
Channels	Lower (36)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	5180.000
Relative permitivity (real part)	35.903
Relative permitivity (imaginary part)	16.223
Conductivity (S/m)	4.679

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=-15.00 ; SAR Peak: 0.88 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.193
SAR 1g (W/Kg)	0.356
Variation (%)	3.530
Horizontal validation criteria: minimum distance (mm)	6.695
Vertical validation criteria: SAR ratio M2/M1 (%)	55.28%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	0.456	0.360	0.199	0.116	0.591	0.031	0.094	0.093	0.178

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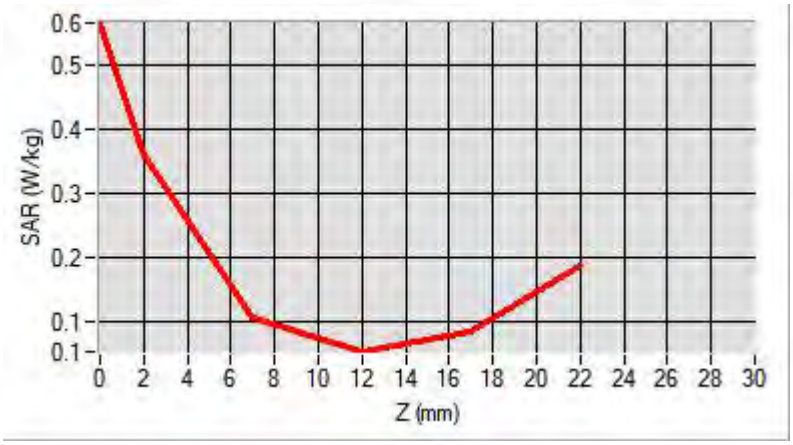
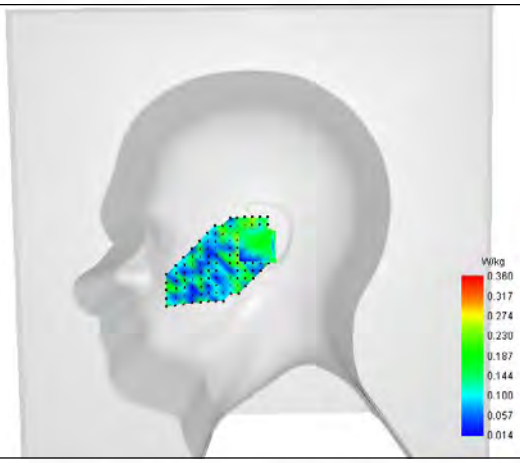
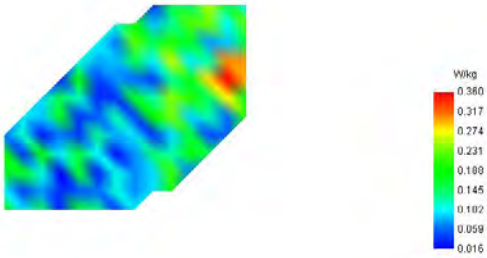


F. 3D Image

3D screen shot	Hot spot position
	

36-Body with back position in dist. 10mm on Channel 36 in IEEE 802.11a U-NII

SAR Measurement at IEEE 802.11a U-NII (Body, Validation Plane)

Date of measurement: 11/6/2024

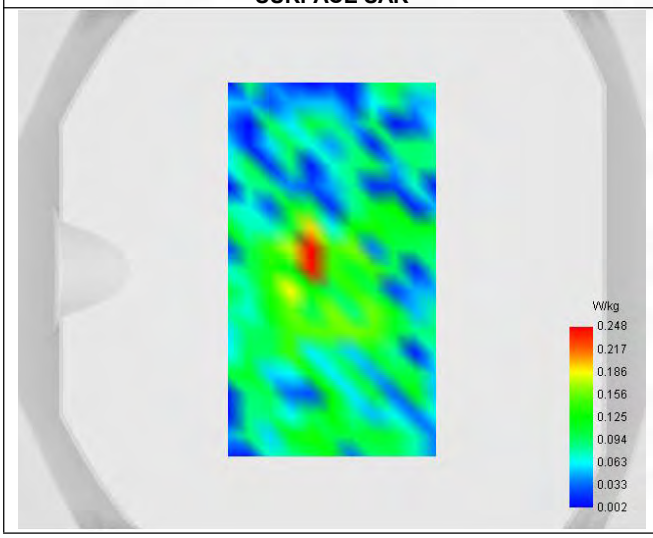
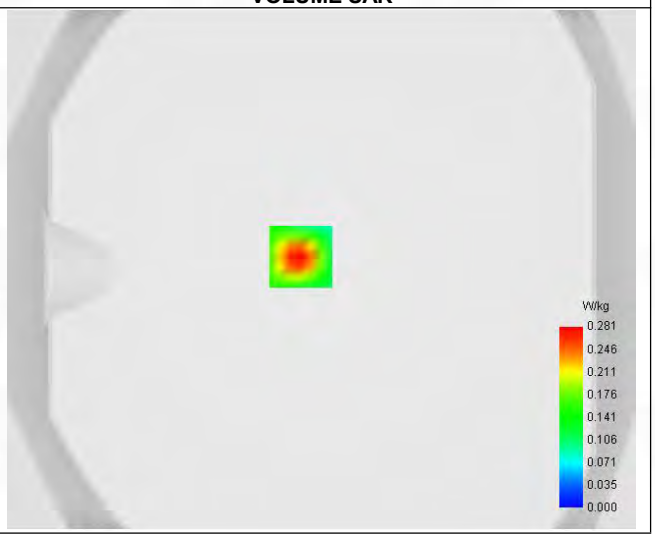
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Validation plane
Device Position	Body
Band	IEEE 802.11a U-NII
Channels	Lower (36)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	5180.000
Relative permitivity (real part)	35.903
Relative permitivity (imaginary part)	16.223
Conductivity (S/m)	4.679

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-8.00, Y=5.00 ; SAR Peak: 0.60 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.072
SAR 1g (W/Kg)	0.177
Variation (%)	-2.660
Horizontal validation criteria: minimum distance (mm)	7.255
Vertical validation criteria: SAR ratio M2/M1 (%)	42.70%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	0.571	0.281	0.120	0.045	0.025	0.009	0.049	0.023	0.041

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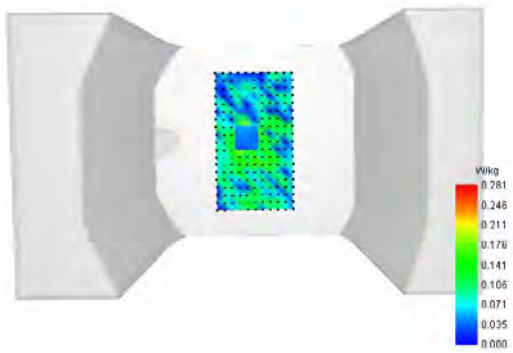
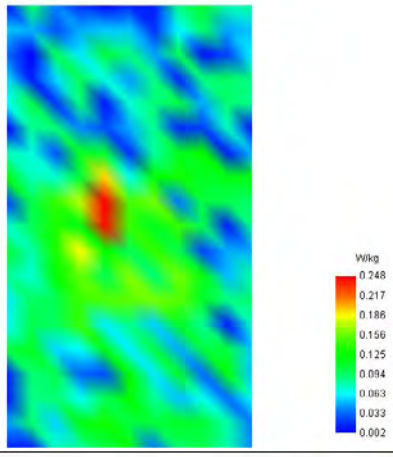
F. 3D Image

3D screen shot	Hot spot position
	

37-Head with front position in dist. 0mm on Channel 149 in IEEE 802.11n U-NII

SAR Measurement at IEEE 802.11n U-NII (Cheek, Right)

Date of measurement: 11/6/2024

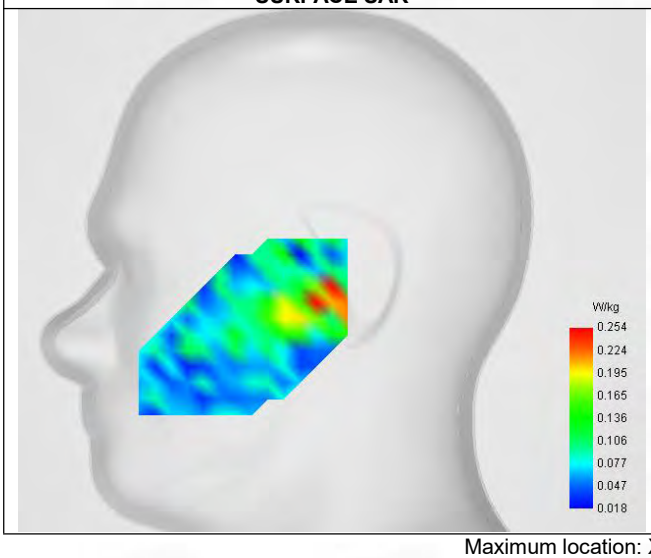
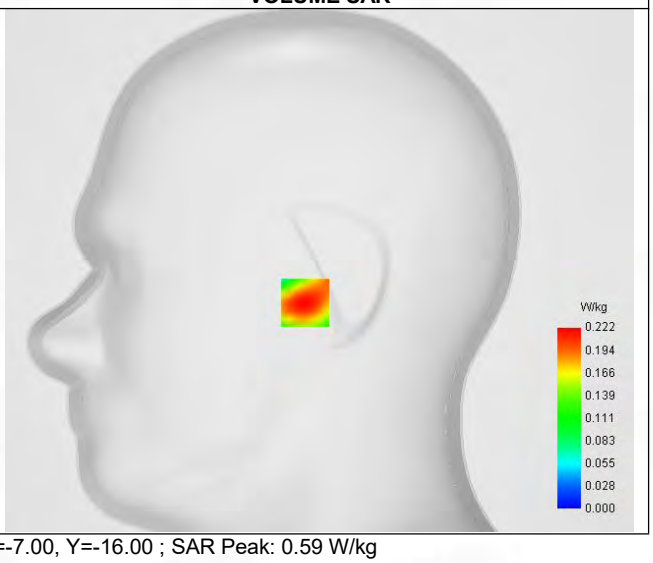
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.04
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Right head
Device Position	Cheek
Band	IEEE 802.11n U-NII
Channels	Lower (149)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	5745.000
Relative permitivity (real part)	35.235
Relative permitivity (imaginary part)	16.464
Conductivity (S/m)	5.255

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-7.00, Y=-16.00 ; SAR Peak: 0.59 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.118
SAR 1g (W/Kg)	0.212
Variation (%)	-1.270
Horizontal validation criteria: minimum distance (mm)	7.265
Vertical validation criteria: SAR ratio M2/M1 (%)	61.71%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	0.351	0.222	0.137	0.087	0.062	0.051	0.050	0.054	0.064

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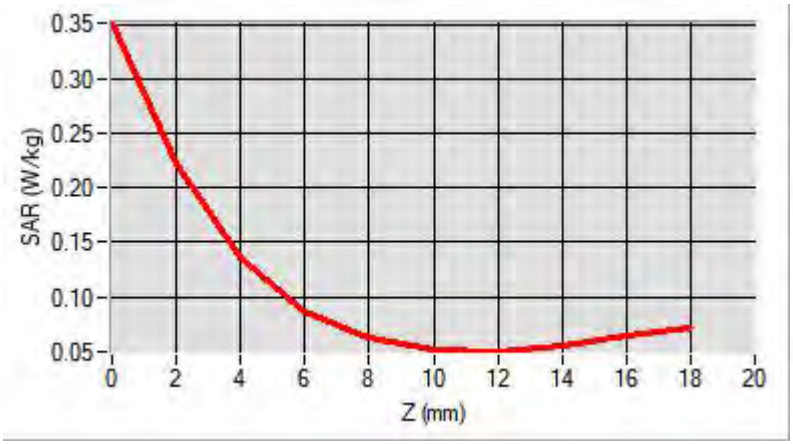
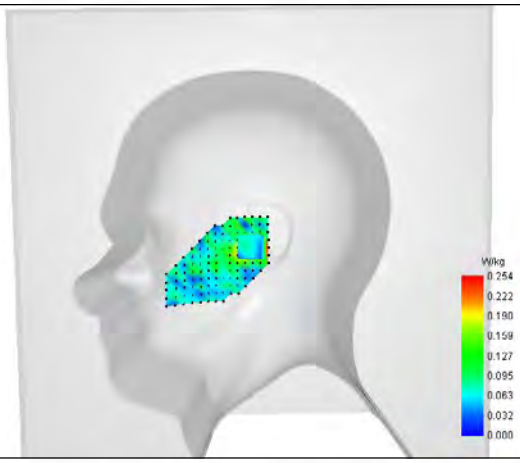
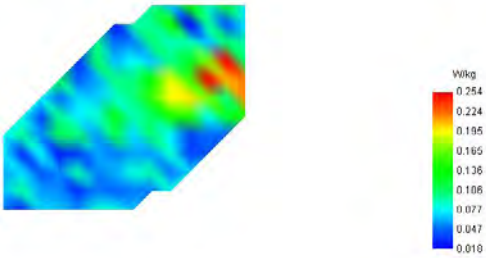


F. 3D Image

3D screen shot	Hot spot position
	

38-Body with back position in dist. 10mm on Channel 149 in IEEE 802.11n U-NII

SAR Measurement at IEEE 802.11n U-NII (Body, Validation Plane)

Date of measurement: 11/6/2024

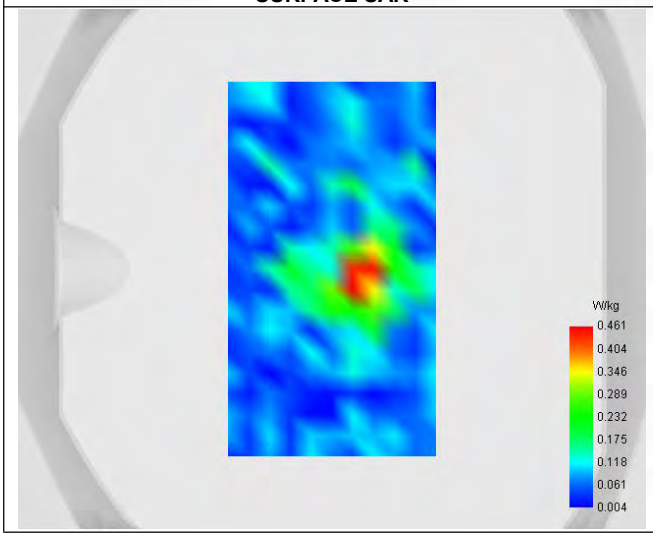
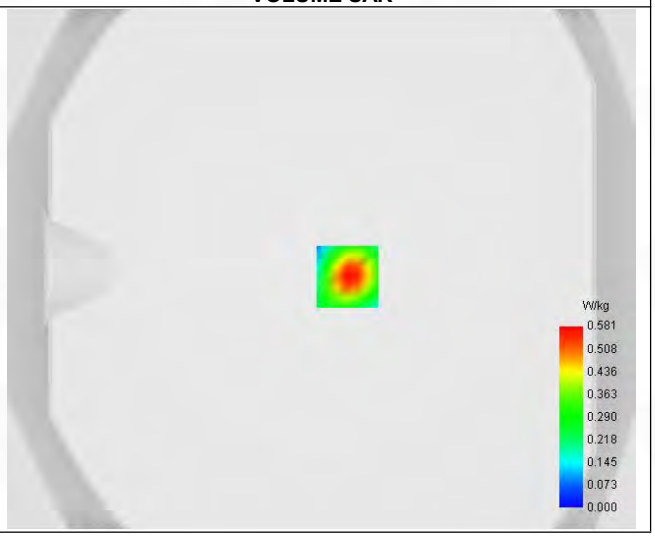
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.04
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Validation plane
Device Position	Body
Band	IEEE 802.11n U-NII
Channels	Lower (149)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	5745.000
Relative permitivity (real part)	35.235
Relative permitivity (imaginary part)	16.464
Conductivity (S/m)	5.255

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=10.00, Y=-3.00 ; SAR Peak: 0.92 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.140
SAR 1g (W/Kg)	0.354
Variation (%)	2.340
Horizontal validation criteria: minimum distance (mm)	6.447
Vertical validation criteria: SAR ratio M2/M1 (%)	63.34%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	0.798	0.581	0.368	0.231	0.138	0.013	0.050	0.017	0.049

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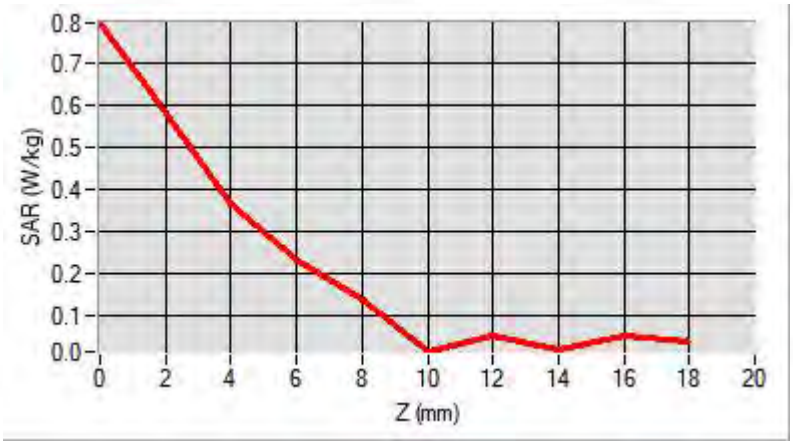
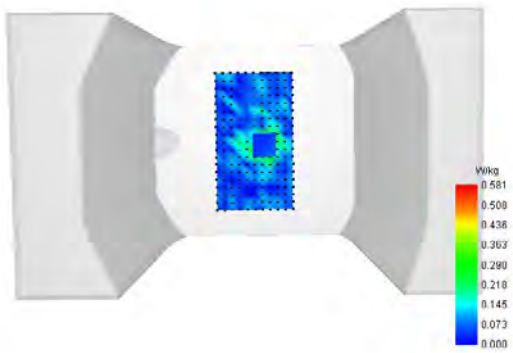
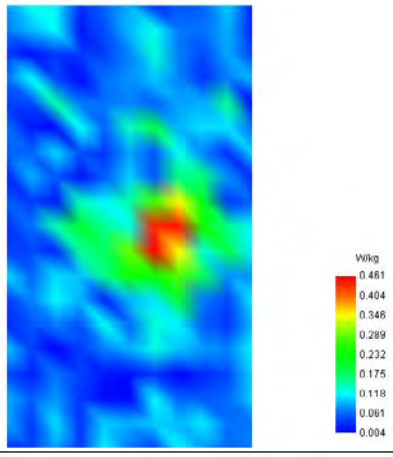


F. 3D Image

3D screen shot	Hot spot position
	

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39-Head with front position in dist. 0mm on Channel 39 in Bluetooth

SAR Measurement at Bluetooth (Cheek, Right)

Date of measurement: 6/6/2024

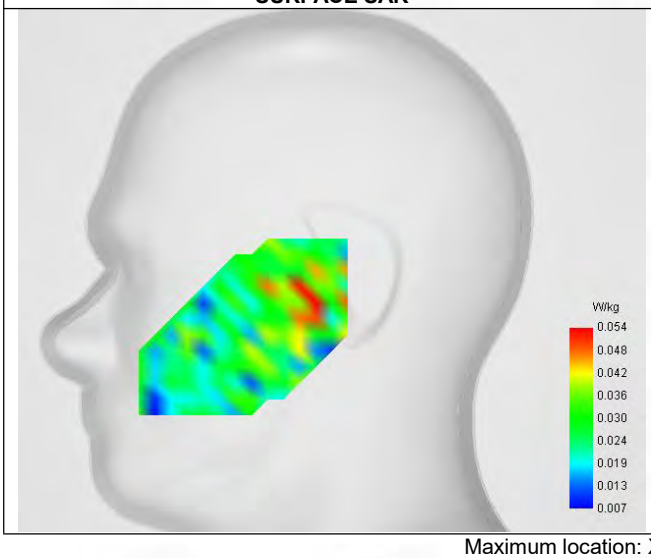
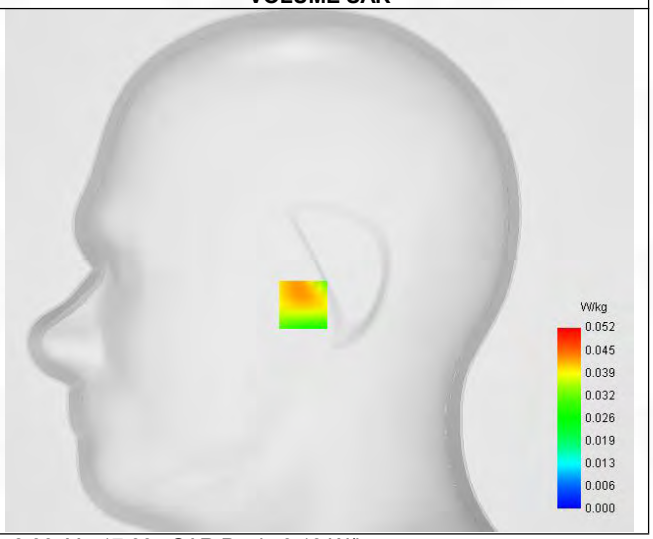
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	Bluetooth
Channels	Middle (39)
Signal	Bluetooth

B. Permitivity

Frequency (MHz)	2441.000
Relative permitivity (real part)	41.792
Relative permitivity (imaginary part)	13.847
Conductivity (S/m)	1.878

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-8.00, Y=-17.00 ; SAR Peak: 0.13 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.034
SAR 1g (W/Kg)	0.043
Variation (%)	-1.890
Horizontal validation criteria: minimum distance (mm)	8.265
Vertical validation criteria: SAR ratio M2/M1 (%)	65.38%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.127	0.052	0.034	0.022	0.024

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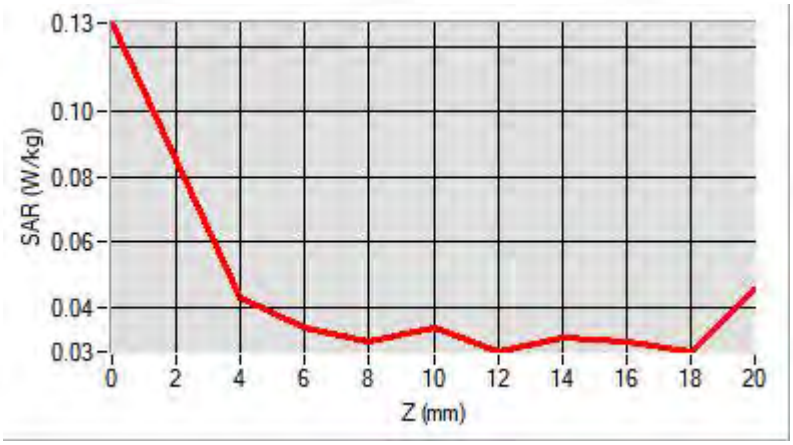
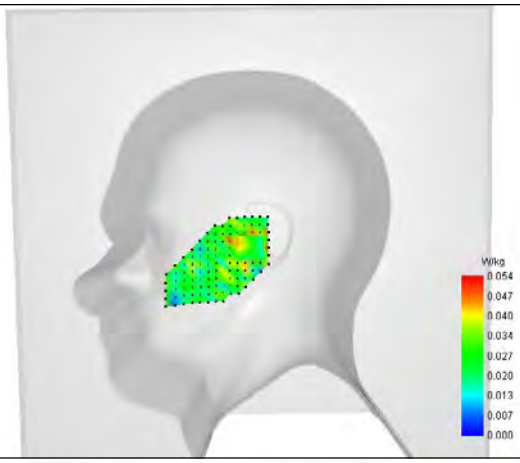
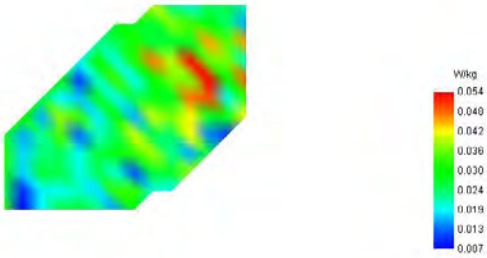


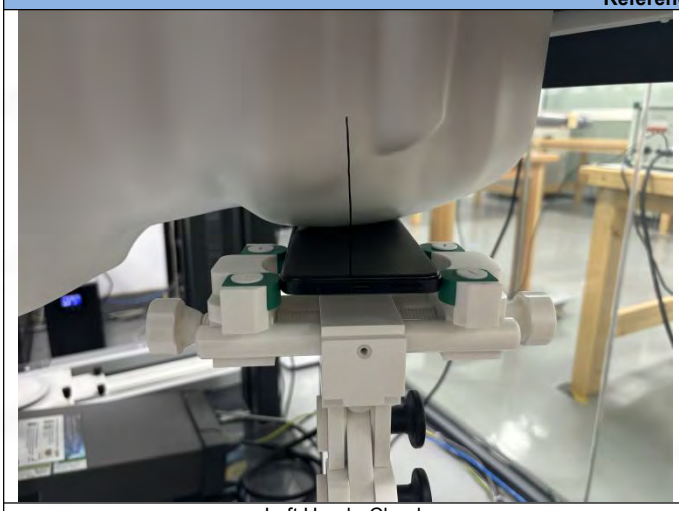
F. 3D Image

3D screen shot	Hot spot position
	

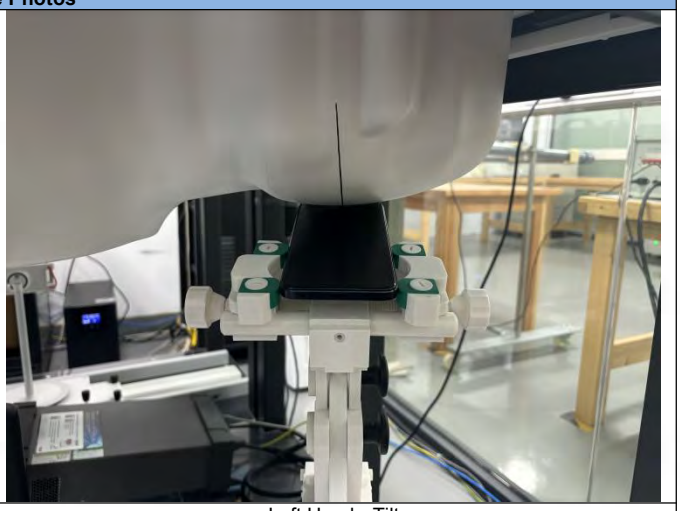
ANNEX E SAR Test Setup Photos

Reference Photo: simulation liquid depth 15cm

Reference Photos

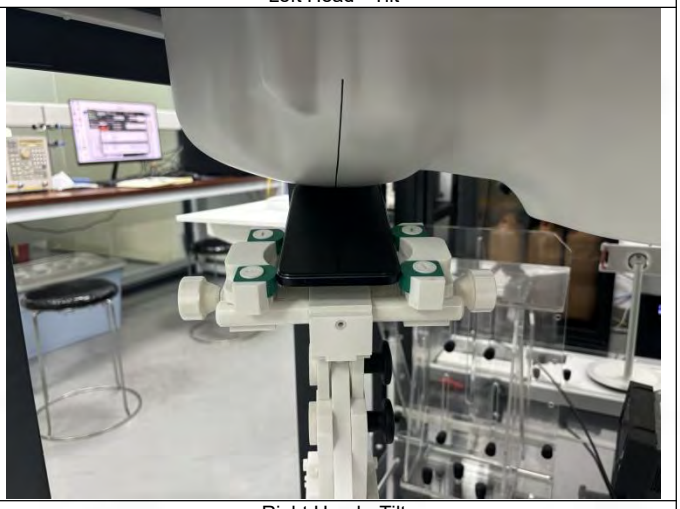


Left Head - Cheek



Left Head - Tilt

Right Head - Cheek



Right Head - Tilt

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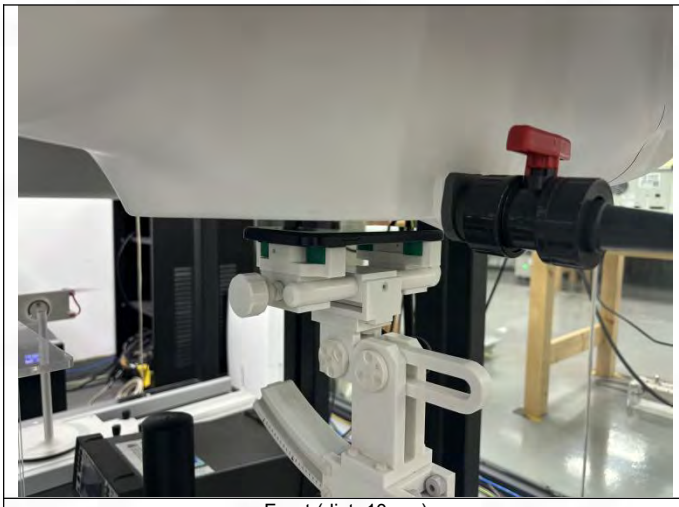
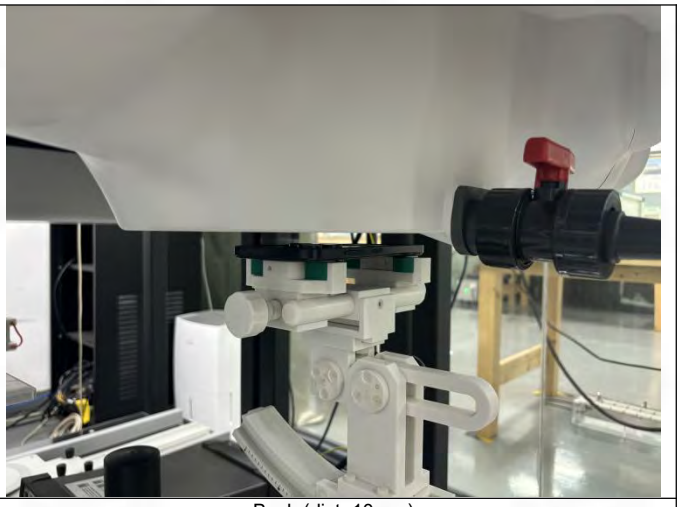
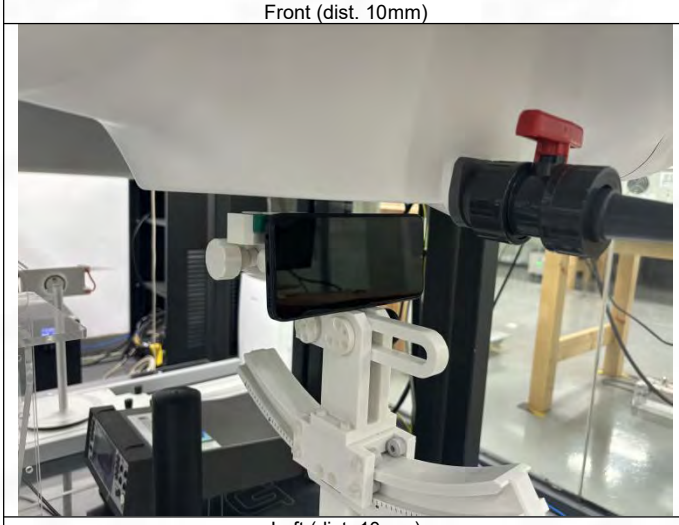


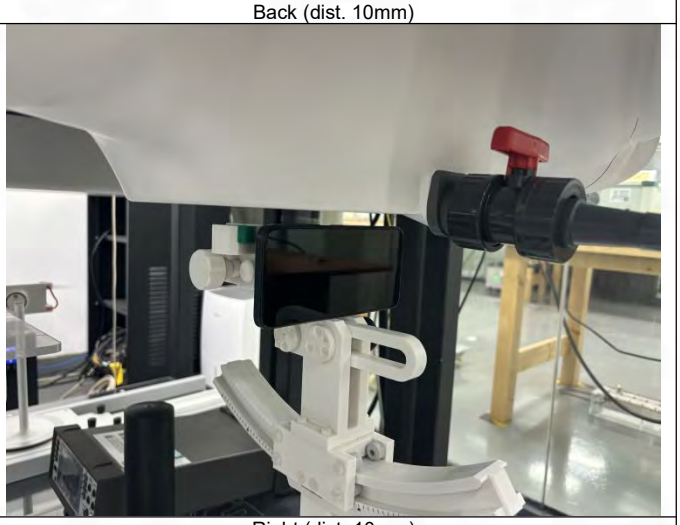
Front (dist. 10mm)



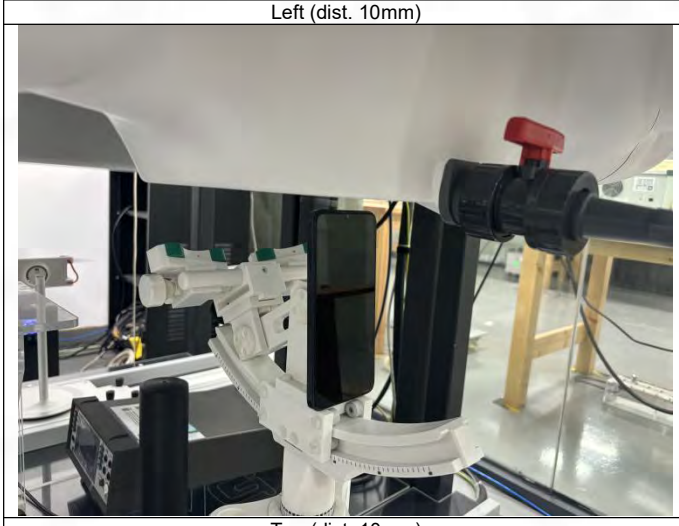
Back (dist. 10mm)



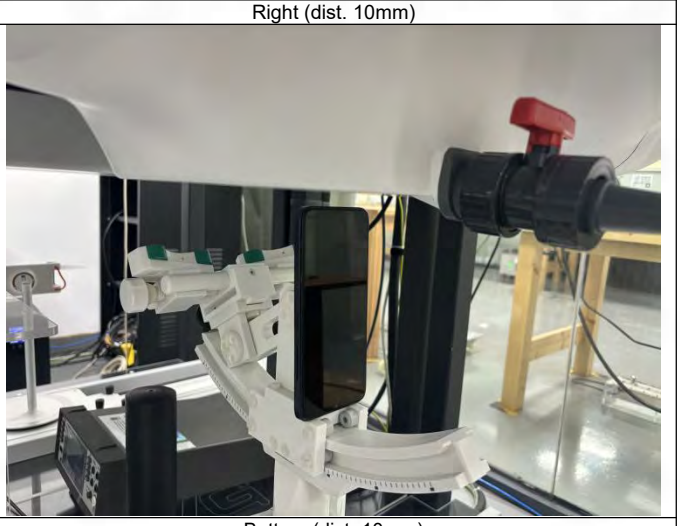
Left (dist. 10mm)



Right (dist. 10mm)



Top (dist. 10mm)



Bottom (dist. 10mm)

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ANNEX F EUT External and Internal Photos

Please refer to RF Report.

ANNEX G Calibration Information

Please refer to the document “Calibration.pdf”.

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